muRata

Innovator in Electronics

Manufacturing Co., Ltd.

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• Please refer to "Specifications and Test Methods" at the end of each chapter of 14 - 19 .

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### Part Numbering

Chip Monolithic Ceramic Capacitors

GR M 18 8 B1 1H 102 K A01 K (Part Number) 0 0 0 0 0 0 0

#### Product ID

### 2 Series

Product ID	Code	Series	
	М	Tin Plated Layer	
GR	4	Only for Information Devices / Tip & Ring	
7		Only for Camera Flash Circuit	
ER	В	High Frequency Type	
GQ	M	High Frequency for Flow/Reflow Soldering	
GM	Α	Monolithic Microchip	
GN	М	Capacitor Array	
	L Low ESL Wide Width Typ		
LL	Α	Eight-termination Low ESL Type	
	M	Ten-termination Low ESL Type	
GJ	М	High Frequency Low Loss Type Tin Plated Type	
GA	2	for AC250V (r.m.s.)	
GA	3	Safety Standard Recognized Type	

### 3Dimension (LXW)

Code	Dimension (LXW)	EIA	
02	0.4×0.2mm	01005	
03	0.6×0.3mm	0201	
05	0.5×0.5mm	0202	
08	0.8×0.8mm	0303	
11	1.25×1.0mm	0504	
15	1.0×0.5mm	0402	
18	1.6×0.8mm	0603	
1D	1.4×1.4mm		
1X	Depends on individual standards.		
21	2.0×1.25mm	0805	
22	2.8×2.8mm 1111		
31	3.2×1.6mm 1206		
32	3.2×2.5mm	1210	
3X	Depends on individual standards.		
42	4.5×2.0mm 1808		
43	4.5×3.2mm 181		
52	5.7×2.8mm 2211		
55	5.7×5.0mm 2220		

### 4 Dimension (T)

Code	Dimension (T)		
2	0.2mm		
2	2-elements (Array Type)		
3	0.3mm		
4	4-elements (Array Type)		
5	0.5mm		
6	0.6mm		
7	0.7mm		
8	0.8mm		
9	0.85mm		
Α	1.0mm		
В	1.25mm		
С	1.6mm		
D	2.0mm		
E	2.5mm		
F	3.2mm		
М	1.15mm		
N	1.35mm		
R	1.8mm		
s	2.8mm		
Q	1.5mm		
Х	Depends on individual standards.		

With the array type GNM series, "Dimension(T)" indicates the number of elements.

Continued on the following page.  $\begin{tabular}{|c|c|c|c|} \hline \end{tabular}$ 





**⑤**Temperature Characteristics

Temperature Characteristic Codes							
Code	Public STD (	Code	Referance Temperature	Temperature Range	Capacitance Change or Temperature Coefficient	Operating Temperature Range	
1X	SL *1	JIS	20°C	20 to 85°C	+350 to -1000ppm/°C	-55 to 125°C	
2C	CH *1	JIS	20°C	20 to 125°C	0±60ppm/°C	-55 to 125°C	
2P	PH *1	JIS	20°C	20 to 85°C	-150±60ppm/°C	-25 to 85°C	
2R	RH *1	JIS	20°C	20 to 85°C	-220±60ppm/°C	-25 to 85°C	
2S	SH *1	JIS	20°C	20 to 85°C	-330±60ppm/°C	-25 to 85°C	
2T	TH *1	JIS	20°C	20 to 85°C	-470±60ppm/°C	-25 to 85°C	
3C	CJ *1	JIS	20°C	20 to 125°C	0±120ppm/°C	-55 to 125°C	
3P	PJ *1	JIS	20°C	20 to 85°C	-150±120ppm/°C	-25 to 85°C	
3R	RJ *1	JIS	20°C	20 to 85°C	-220±120ppm/°C	-25 to 85°C	
38	SJ *1	JIS	20°C	20 to 85°C	-330±120ppm/°C	-25 to 85°C	
3T	TJ *1	JIS	20°C	20 to 85°C	-470±120ppm/°C	-25 to 85°C	
3U	UJ *1	JIS	20°C	20 to 85°C	-750±120ppm/°C	-25 to 85°C	
4C	CK *1	JIS	20°C	20 to 125°C	0±250ppm/°C	-55 to 125°C	
5C	C0G *1	EIA	25°C	25 to 125°C	0±30ppm/°C	-55 to 125°C	
5G	X8G *1	EIA	25°C	25 to 150°C	0±30ppm/°C	-55 to 150°C	
6C	C0H *1	EIA	25°C	25 to 125°C	0±60ppm/°C	-55 to 125°C	
6P	P2H *1	EIA	25°C	25 to 85°C	-150±60ppm/°C	-55 to 125°C	
6R	R2H *1	EIA	25°C	25 to 85°C	-220±60ppm/°C	-55 to 125°C	
6S	S2H *1	EIA	25°C	25 to 85°C	-330±60ppm/°C	-55 to 125°C	
6T	T2H *1	EIA	25°C	25 to 85°C	-470±60ppm/°C	-55 to 125°C	
7U	U2J *1	EIA	25°C	25 to 85°C	-750±120ppm/°C	-55 to 125°C	
B1	B *2	JIS	20°C	-25 to 85°C	±10%	-25 to 85°C	
В3	В	JIS	20°C	-25 to 85°C	±10%	-25 to 85°C	
C7	X7S	EIA	25°C	-55 to 125°C	±22%	-55 to 125°C	
C8	X6S	EIA	25°C	-55 to 105°C	±22%	-55 to 105°C	
F1	F *2	JIS	20°C	-25 to 85°C	+30, -80%	-25 to 85°C	
F5	Y5V	EIA	25°C	-30 to 85°C	+22, -82%	-30 to 85°C	
L8	X8L	EIA	25°C	-55 to 150°C	+15, -40%	-55 to 150°C	
R1	R *2	JIS	20°C	-55 to 125°C	±15%	-55 to 125°C	
R3	R	JIS	20°C	-55 to 125°C	±15%	-55 to 125°C	
R6	X5R	EIA	25°C	-55 to 85°C	±15%	-55 to 85°C	
R7	X7R	EIA	25°C	-55 to 125°C	±15%	-55 to 125°C	
R9	X8R	EIA	25°C	-55 to 150°C	±15%	-55 to 150°C	
	7	-25 to 20°C -4700+1000/-2500ppm/°C		-4700+1000/-2500ppm/°C	25 1 2500		
9E	ZLM	*3	20°C	20°C 20 to 85°C	-4700+500/-1000ppm/°C	-25 to 85°C	
14/0			25.0	FE 1- 40500	±10% *4	FE 4 - 4050C	
W0	-	_	25°C	-55 to 125°C	+22, -33% *5	-55 to 125°C	

<sup>\*1</sup> Please refer to table for Capacitance Change under reference temperature.

Continued on the following page.  $\begin{tabular}{|c|c|c|c|} \hline \end{tabular}$ 





<sup>\*2</sup> Capacitance change is specified with 50% rated voltage applied.

<sup>\*3,\*4</sup> Murata Temperature Characteristic Code.

<sup>\*4</sup> Apply DC350V bias.

<sup>\*5</sup> No DC bias.

● Capacitance Change from each temperature

### JIS Code

	Capacitance Change from 20°C (%)						
Murata Code	−55°C		-25	5°C	−10°C		
	Max.	Min.	Max.	Min.	Max.	Min.	
1X	-	-	-	-	-	-	
2C	0.82	-0.45	0.49	-0.27	0.33	-0.18	
2P	-	-	1.32	0.41	0.88	0.27	
2R	-	-	1.70	0.72	1.13	0.48	
2S	_	_	2.30	1.22	1.54	0.81	
2T	_	_	3.07	1.85	2.05	1.23	
3C	1.37	-0.90	0.82	-0.54	0.55	-0.36	
3P	-	-	1.65	0.14	1.10	0.09	
3R	-	-	2.03	0.45	1.35	0.30	
38	-	-	2.63	0.95	1.76	0.63	
3T	-	-	3.40	1.58	2.27	1.05	
3U	-	-	4.94	2.84	3.29	1.89	
4C	2.56	-1.88	1.54	-1.13	1.02	-0.75	

#### EIA Code

	Capacitance Change from 25°C (%)						
Murata Code	-5!	−55°C		−30°C		D <sub>o</sub> C	
	Max.	Min.	Max.	Min.	Max.	Min.	
5C/5G	0.58	-0.24	0.40	-0.17	0.25	-0.11	
6C	0.87	-0.48	0.59	-0.33	0.38	-0.21	
6P	2.33	0.72	1.61	0.50	1.02	0.32	
6R	3.02	1.28	2.08	0.88	1.32	0.56	
6S	4.09	2.16	2.81	1.49	1.79	0.95	
6T	5.46	3.28	3.75	2.26	2.39	1.44	
7U	8.78	5.04	6.04	3.47	3.84	2.21	

#### 6 Rated Voltage

Code	Rated Voltage			
0G	DC4V			
0J	DC6.3V			
1A	DC10V			
1C	DC16V			
1E	DC25V			
1H	DC50V			
2A	DC100V			
2D	DC200V			
2E	DC250V			
YD	DC300V			
2H	DC500V			
2J	DC630V			
3A	DC1kV			
3D	DC2kV			
3F	DC3.15kV			
ВВ	DC350V (for Camera Flash Circuit)			
E2	AC250V			
GB	X2; AC250V (Safety Standard Recognized Type GB)			
GC	X1/Y2; AC250V (Safety Standard Recognized Type GC)			
GD	Y3; AC250V (Safety Standard Recognized Type GD)			
GF	Y2, X1/Y2; AC250V (Safety Standard Recognized Type GF)			

#### Capacitance

Expressed by three-digit alphanumerics. The unit is pico-farad (pF). The first and second figures are significant digits, and the third figure expresses the number of zeros which follow the two numbers.If there is a decimal point, it is expressed by the capital letter "R". In this case, all figures are significant digits.

Ex.)	Code	Capacitance
	R50	0.5pF
	1R0	1.0pF
	100	10pF
	103	10000pF

Continued on the following page.  $\begin{tabular}{|c|c|c|c|} \hline \end{tabular}$ 





8 Capacitance Tolerance

Code	Capacitance Tolerance	TC	Series	Capaci	tance Step	
W	±0.05pF	СΔ	GRM/GJM	≦9.9pF	0.1pF	
В	±0.1pF	СΔ	GRM/GJM	≦9.9pF	0.1pF	
		СΔ	GRM/GJM	≦9.9pF	0.1pF	
С	±0.25pF	except CΔ	GRM	≦5pF	* 1pF	
		СΔ	ERB/GQM	≦5pF	* 1pF	
		СΔ	GRM/GJM	5.1 to 9.9pF	0.1pF	
D	±0.5pF	except CΔ	GRM	5.1 to 9.9pF	* 1pF	
		СΔ	ERB/GQM	5.1 to 9.9pF	* 1pF	
	±2%	СΔ	GJM	≥10pF	E12 Series	
G		СΔ	GQM	≥10pF	E24 Series	
	±5%	CΔ-SL	GRM/GA3	≥10pF	E12 Series	
J		СΔ	ERB/GQM/GJM	≥10pF	E24 Series	
1/	1100/	D D V7D VFD 7LM	GRM/GR7/GA3	E6	Series	
K	±10%	B, R, X7R, X5R, ZLM	GR4	E12	2 Series	
		Z5U	GRM	E3	Series	
M	±20%	B, R, X7R, X7S	GRM/GMA/LLL/LLA/LLM	E6	Series	
		X7R	GA2	E3	Series	
Z	+80%, -20%	F, Y5V	GRM	E3 Series		
R	Depends on individual standards.					

<sup>\*</sup> E24 series is also available.

Individual Specification Code

Expressed by three figures.

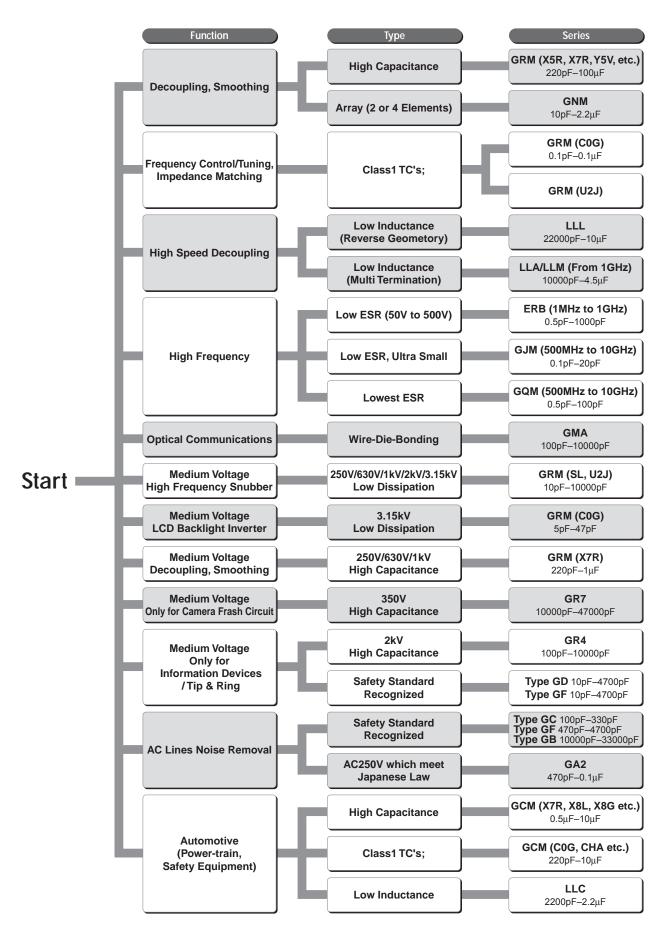
#### Packaging

Code	Packaging
L	ø180mm Embossed Taping
D	ø180mm Paper Taping
K	ø330mm Embossed Taping
J	ø330mm Paper Taping
В	Bulk
С	Bulk Case
Т	Bulk Tray

Please check MURATA home page (http://www.murata.com/index.html) in case you can not find the part number on the catalog.



## **Selection Guide of Chip Monolithic Ceramic Capacitors**



# **Chip Monolithic Ceramic Capacitors**

# muRata

# for General Purpose GRM15/18/21/31 Series

### ■ Features

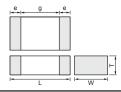
- Terminations are made of metal highly resistant to migration.
- A wide selection of sizes is available, from the miniature LxW: 1.0x0.5mm to LxW: 3.2x1.6mm.
   GRM18, 21 and GRM31 types are suited to flow and reflow soldering.
  - GRM15 type is applied to only reflow soldering.
- 3. Smaller size and higher capacitance value
- 4. High reliability and no polarity
- 5. Excellent pulse responsibility and noise reduction due to the low impedance at high frequency.
- 6. Ta replacement

### Applications

Dart Number

General electronic equipment





Part Number		Dir	nensions (m	nm)	
Part Number	L	W	T	е	g min.
GRM155	1.0 ±0.05	0.5 ±0.05	0.5 ±0.05	0.15 to 0.35	0.3
GRM185	1.6 ±0.1	0.8 +0.1	0.5 +0/-0.1	0.2 to 0.5	0.5
GRM188*	1.0 ±0.1	0.6 ±0.1	0.8 ±0.1	0.2 10 0.5	0.5
GRM216			0.6 ±0.1		
GRM219	2.0 +0.1	1.25 +0.1	0.85 ±0.1	0.2 to 0.7	0.7
GRM21A	2.0 ±0.1	1.23 ±0.1	1.0 +0/-0.2	0.2 10 0.7	0.7
GRM21B			1.25 ±0.1		
GRM316			0.6 ±0.1		
GRM319	3.2 ±0.15	1.6 ±0.15	0.85 ±0.1	0.2 +0.0 0	1.5
GRM31M			1.15 ±0.1	0.3 to 0.8	1.5
GRM31C	3.2 ±0.2	1.6 ±0.2	1.6 ±0.2		

<sup>\*</sup> Bulk Case: 1.6 ±0.07(L) × 0.8 ±0.07(W) × 0.8 ±0.07(T)

## Temperature Compensating Type GRM15 Series (1.00x0.50mm) 50/25V

Part Number				GR	M15			
L x W [EIA]				1.0x0.!	5 [0402]			
тс	C0G ( <b>5C</b> )	P2H ( <b>6P</b> )	R2H ( <b>6R</b> )	S2H ( <b>6S</b> )		SL ( <b>X</b> )	T2H ( <b>6T</b> )	U2J ( <b>7U</b> )
Rated Volt.	50 ( <b>1H</b> )	50 ( <b>1H</b> )	50 ( <b>1H</b> )	50 ( <b>1H</b> )	50 ( <b>1H</b> )	25 ( <b>1E</b> )	50 ( <b>1H</b> )	50 ( <b>1H</b> )
Capacitance (Cap	acitance part r	numbering code)	and T (mm) Dim	ension (T Dimer	sion part numbe	ering code)		
3.0pF( <b>3R0</b> )	0.5 <b>(5</b> )	0.5( <b>5</b> )	0.5 <b>(5</b> )	0.5( <b>5</b> )			0.5 <b>(5</b> )	0.5( <b>5</b> )
4.0pF( <b>4R0</b> )	0.5 <b>(5</b> )	0.5( <b>5</b> )	0.5 <b>(5</b> )	0.5( <b>5</b> )			0.5 <b>(5</b> )	0.5( <b>5</b> )
5.0pF( <b>5R0</b> )	0.5 <b>(5)</b>	0.5( <b>5</b> )	0.5 <b>(5</b> )	0.5( <b>5</b> )			0.5 <b>(5</b> )	0.5( <b>5</b> )
6.0pF( <b>6R0</b> )	0.5 <b>(5)</b>	0.5( <b>5</b> )	0.5 <b>(5</b> )	0.5( <b>5</b> )			0.5 <b>(5</b> )	0.5( <b>5</b> )
7.0pF( <b>7R0</b> )	0.5 <b>(5)</b>	0.5( <b>5</b> )	0.5 <b>(5</b> )	0.5( <b>5</b> )			0.5 <b>(5</b> )	0.5( <b>5</b> )
8.0pF( <b>8R0</b> )	0.5 <b>(5</b> )	0.5( <b>5</b> )	0.5 <b>(5</b> )	0.5 <b>(5</b> )			0.5 <b>(5</b> )	0.5( <b>5</b> )
9.0pF( <b>9R0</b> )	0.5 <b>(5</b> )	0.5( <b>5</b> )	0.5 <b>(5</b> )	0.5( <b>5</b> )			0.5 <b>(5</b> )	0.5( <b>5</b> )
10pF( <b>100</b> )	0.5 <b>(5</b> )	0.5( <b>5</b> )	0.5 <b>(5</b> )	0.5( <b>5</b> )			0.5 <b>(5</b> )	0.5( <b>5</b> )
12pF( <b>120</b> )	0.5 <b>(5)</b>	0.5( <b>5</b> )	0.5 <b>(5</b> )	0.5( <b>5</b> )	0.5( <b>5</b> )	0.5( <b>5</b> )	0.5 <b>(5</b> )	0.5( <b>5</b> )
15pF( <b>150</b> )	0.5 <b>(5</b> )	0.5( <b>5</b> )	0.5 <b>(5</b> )	0.5( <b>5</b> )	0.5( <b>5</b> )	0.5( <b>5</b> )	0.5 <b>(5</b> )	0.5( <b>5</b> )
18pF( <b>180</b> )	0.5 <b>(5</b> )	0.5( <b>5</b> )	0.5 <b>(5</b> )	0.5( <b>5</b> )	0.5( <b>5</b> )	0.5( <b>5</b> )	0.5 <b>(5</b> )	0.5( <b>5</b> )
22pF( <b>220</b> )	0.5 <b>(5</b> )	0.5( <b>5</b> )	0.5 <b>(5</b> )	0.5( <b>5</b> )	0.5( <b>5</b> )	0.5( <b>5</b> )	0.5 <b>(5</b> )	0.5( <b>5</b> )
27pF( <b>270</b> )	0.5 <b>(5)</b>	0.5( <b>5</b> )	0.5 <b>(5</b> )	0.5 <b>(5</b> )	0.5( <b>5</b> )	0.5 <b>(5)</b>	0.5 <b>(5</b> )	0.5( <b>5</b> )
33pF( <b>330</b> )	0.5 <b>(5</b> )		0.5 <b>(5</b> )	0.5( <b>5</b> )	0.5( <b>5</b> )	0.5( <b>5</b> )	0.5 <b>(5</b> )	0.5( <b>5</b> )
39pF( <b>390</b> )	0.5 <b>(5</b> )			0.5( <b>5</b> )	0.5( <b>5</b> )	0.5( <b>5</b> )	0.5 <b>(5</b> )	0.5( <b>5</b> )
47pF( <b>470</b> )	0.5 <b>(5)</b>				0.5( <b>5</b> )	0.5( <b>5</b> )	0.5 <b>(5</b> )	0.5( <b>5</b> )
56pF( <b>560</b> )	0.5 <b>(5</b> )				0.5( <b>5</b> )	0.5( <b>5</b> )	0.5 <b>(5</b> )	0.5( <b>5</b> )
68pF( <b>680</b> )	0.5 <b>(5)</b>				0.5( <b>5</b> )	0.5( <b>5</b> )	0.5 <b>(5</b> )	0.5( <b>5</b> )
82pF( <b>820</b> )	0.5 <b>(5</b> )				0.5( <b>5</b> )	0.5( <b>5</b> )	0.5 <b>(5</b> )	0.5( <b>5</b> )
100pF( <b>101</b> )	0.5 <b>(5)</b>				0.5( <b>5</b> )	0.5( <b>5</b> )	0.5 <b>(5</b> )	0.5( <b>5</b> )
120pF( <b>121</b> )	0.5 <b>(5</b> )				0.5( <b>5</b> )	0.5( <b>5</b> )		0.5( <b>5</b> )
150pF( <b>151</b> )	0.5( <b>5</b> )				0.5( <b>5</b> )	0.5 <b>(5</b> )		0.5( <b>5</b> )
180pF( <b>181</b> )	0.5 <b>(5</b> )				0.5( <b>5</b> )	0.5( <b>5</b> )		0.5( <b>5</b> )
220pF( <b>221</b> )	0.5 <b>(5</b> )					0.5( <b>5</b> )		
270pF( <b>271</b> )	0.5( <b>5</b> )					0.5( <b>5</b> )		

CDM15

Part Number				GR	M15			
L x W [EIA]				1.0x0.5	5 [0402]			
тс	C0G ( <b>5C</b> )	P2H ( <b>6P</b> )	R2H ( <b>6R</b> )	S2H ( <b>6S</b> )		SL <b>1X</b> )	T2H ( <b>6T</b> )	U2J ( <b>7U</b> )
Rated Volt.	50 ( <b>1H</b> )	50 ( <b>1H</b> )	50 ( <b>1H</b> )	50 ( <b>1H</b> )	50 ( <b>1H</b> )	25 ( <b>1E</b> )	50 ( <b>1H</b> )	50 ( <b>1H</b> )
Capacitance (Ca	pacitance part n	umbering code)	and T (mm) Dim	ension (T Dimen	sion part number	ering code)		
330pF( <b>331</b> )	0.5( <b>5</b> )					0.5( <b>5</b> )		
390pF( <b>391</b> )	0.5( <b>5</b> )					0.5( <b>5</b> )		
470pF( <b>471</b> )	0.5( <b>5</b> )							
560pF( <b>561</b> )	0.5( <b>5</b> )							
680pF( <b>681</b> )	0.5( <b>5</b> )							
820pF( <b>821</b> )	0.5( <b>5</b> )							
1000pF( <b>102</b> )	0.5( <b>5</b> )							

The part numbering code is shown in  $\ (\ ).$ 

## Temperature Compensating Type GRM18 Series (1.60x0.80mm) 100/50V

Part Number							GR	M18						
L x W [EIA]							1.6x0.8	3 [0603]						
тс		DG <b>C</b> )		2H <b>P</b> )		2H <b>R</b> )		2H ( <b>S</b> )		SL X)		2H <b>ST</b> )		2J <b>U</b> )
Rated Volt.	100 ( <b>2A</b> )	50 ( <b>1H</b> )												
Capacitance (Ca	pacitanc	e part nui	mbering c	ode) and	T (mm) D	imension	(T Dimen	sion part	numberir	ng code)				
0.50pF( <b>R50</b> )	0.8(8)													
3.0pF( <b>3R0</b> )	0.8(8)		0.8(8)		0.8(8)		0.8(8)				0.8(8)			
4.0pF( <b>4R0</b> )	0.8(8)		0.8(8)		0.8(8)		0.8(8)				0.8(8)			
5.0pF( <b>5R0</b> )	0.8(8)		0.8(8)		0.8(8)		0.8(8)				0.8(8)			
6.0pF( <b>6R0</b> )	0.8(8)		0.8(8)		0.8(8)		0.8(8)				0.8(8)			
7.0pF( <b>7R0</b> )	0.8(8)		0.8(8)		0.8(8)		0.8(8)				0.8(8)			
8.0pF( <b>8R0</b> )	0.8(8)		0.8(8)		0.8(8)		0.8(8)				0.8(8)			
9.0pF( <b>9R0</b> )	0.8(8)		0.8(8)		0.8(8)		0.8(8)				0.8(8)			
10pF( <b>100</b> )	0.8(8)		0.8(8)		0.8(8)		0.8(8)				0.8(8)		0.8(8)	
12pF( <b>120</b> )	0.8(8)		0.8(8)		0.8(8)		0.8(8)		0.8(8)		0.8(8)		0.8(8)	
15pF( <b>150</b> )	0.8(8)		0.8(8)		0.8(8)		0.8(8)		0.8(8)		0.8(8)		0.8(8)	
18pF( <b>180</b> )	0.8(8)		0.8(8)		0.8(8)		0.8(8)		0.8(8)		0.8(8)		0.8(8)	
22pF( <b>220</b> )	0.8(8)		0.8(8)		0.8(8)		0.8(8)		0.8(8)		0.8(8)		0.8(8)	
27pF( <b>270</b> )	0.8(8)		0.8(8)		0.8(8)		0.8(8)		0.8(8)		0.8(8)		0.8(8)	
33pF( <b>330</b> )	0.8(8)		0.8(8)	0.8(8)	0.8(8)		0.8(8)		0.8(8)		0.8(8)		0.8(8)	
39pF( <b>390</b> )	0.8(8)		0.8(8)	0.8(8)	0.8(8)	0.8(8)	0.8(8)		0.8(8)		0.8(8)		0.8(8)	
47pF( <b>470</b> )	0.8(8)		0.8(8)	0.8(8)	0.8(8)	0.8(8)	0.8(8)	0.8(8)	0.8(8)		. ,		0.8(8)	
56pF( <b>560</b> )	0.8(8)		0.8(8)	0.8(8)	0.8(8)	0.8(8)	0.8(8)	0.8(8)	0.8(8)				0.8(8)	
68pF( <b>680</b> )	0.8(8)		0.8(8)	0.8(8)	0.8(8)	0.8(8)	0.8(8)	0.8(8)	0.8(8)				0.8(8)	
82pF( <b>820</b> )	0.8(8)		0.8(8)	0.8(8)	0.8(8)	0.8(8)	0.8(8)	0.8(8)	0.8(8)				0.8(8)	
100pF( <b>101</b> )	0.8(8)		0.8(8)	0.8(8)	0.8(8)	0.8(8)	0.8(8)	0.8(8)	0.8(8)				0.8(8)	
120pF( <b>121</b> )	0.8(8)		0.8(8)	0.8(8)	0.8(8)	0.8(8)	0.8(8)	0.8(8)	0.8(8)			0.8(8)	0.8(8)	
150pF( <b>151</b> )	0.8(8)		, ,	0.8(8)	0.8(8)	0.8(8)	. ,	0.8(8)	0.8(8)			0.8(8)	0.8(8)	
180pF( <b>181</b> )	0.8(8)			. ,	.,	0.8(8)		0.8(8)	0.8(8)			0.8(8)	0.8(8)	
220pF( <b>221</b> )	0.8(8)					. (-,		0.8(8)	0.8(8)	0.8(8)		0.8(8)	0.8(8)	0.8(8)
270pF( <b>271</b> )	0.8(8)							- (-,	0.8(8)	0.8(8)		0.8(8)	0.8(8)	0.8(8)
330pF( <b>331</b> )	0.8(8)								0.8(8)	0.8(8)		0.8(8)	0.8(8)	0.8(8)
390pF( <b>391</b> )	0.8(8)								0.8(8)	0.8(8)		0.8(8)	0.8(8)	0.8(8)
470pF( <b>471</b> )	0.8(8)								(-)	0.8(8)		0.8(8)	(-)	0.8(8)
560pF( <b>561</b> )	0.8(8)									0.8(8)		(-)		0.8(8)
680pF( <b>681</b> )	0.8(8)									0.8(8)				0.8(8)
820pF( <b>821</b> )	0.8(8)									0.5(0)				0.0(0)

Dimensions are shown in mm and Rated Voltage in Vdc.

Part Number							GR	M18						
L x W [EIA]							1.6x0.8	3 [0603]						
тс		0G <b>C</b> )		2H <b>P</b> )		2H <b>R</b> )		2H ( <b>S</b> )		<b>X</b> )		2H <b>T</b> )		2J <b>'U</b> )
Rated Volt.	100 ( <b>2A</b> )	50 ( <b>1H</b> )												
Capacitance (Ca	pacitanc	e part nur	mbering c	ode) and	T (mm) D	imension	(T Dimen	sion part	numberin	ng code)				
1000pF( <b>102</b> )	0.8(8)									0.8(8)				0.8(8)
1200pF( <b>122</b> )		0.8(8)								0.8(8)				0.8(8)
1500pF( <b>152</b> )		0.8(8)								0.8(8)				0.8(8)
1800pF( <b>182</b> )		0.8(8)								0.8(8)				0.8(8)
2200pF( <b>222</b> )		0.8(8)								0.8(8)				0.8(8)
2700pF( <b>272</b> )		0.8(8)								0.8(8)				0.8(8)
3300pF( <b>332</b> )										0.8(8)				0.8(8)
3900pF( <b>392</b> )										0.8(8)				0.8(8)
4700pF( <b>472</b> )										0.8(8)				0.8(8)
5600pF( <b>562</b> )										0.8(8)				0.8(8)
6800pF( <b>682</b> )										0.8(8)				0.8(8)
8200pF( <b>822</b> )										0.8(8)				0.8(8)
10000pF( <b>103</b> )										0.8(8)				0.8(8)

The part numbering code is shown in ().

## Temperature Compensating Type GRM21 Series (2.00x1.25mm) 100/50V

Part Number							GR	M21						
L x W [EIA]							2.0x1.2	5 [0805]						
тс	C( ( <b>5</b> )			2H <b>P</b> )		2H <b>R</b> )		2H <b>S</b> )		<b>X</b> )		2H <b>T</b> )		2J <b>'U</b> )
Rated Volt.	100 ( <b>2A</b> )	50 ( <b>1H</b> )												
Capacitance (Ca	apacitance	e part nur	mbering c	ode) and	T (mm) D	imension	(T Dimen	sion part	numberin	g code)	I.			-
33pF( <b>330</b> )				0.6(6)										
39pF( <b>390</b> )				0.6(6)		0.6(6)								
47pF( <b>470</b> )				0.6(6)		0.6(6)		0.6(6)			1.25( <b>B</b> )			
56pF( <b>560</b> )				0.6(6)		0.6(6)		0.6(6)			1.25( <b>B</b> )			
68pF( <b>680</b> )				0.6(6)		0.6(6)		0.6(6)			1.25( <b>B</b> )			
82pF( <b>820</b> )				0.6(6)		0.6(6)		0.6(6)			1.25( <b>B</b> )			
100pF( <b>101</b> )				0.6(6)		0.6(6)		0.6(6)			1.25( <b>B</b> )			
120pF( <b>121</b> )				0.6(6)		0.6(6)		0.6(6)			1.25( <b>B</b> )	0.6(6)		
150pF( <b>151</b> )			0.85( <b>9</b> )	0.6(6)		0.6(6)	0.85( <b>9</b> )	0.6(6)			1.25( <b>B</b> )			
180pF( <b>181</b> )			0.85( <b>9</b> )	0.85( <b>9</b> )	0.85( <b>9</b> )	0.6(6)	0.85( <b>9</b> )	0.6(6)			1.25( <b>B</b> )			
220pF( <b>221</b> )			0.85( <b>9</b> )	0.85( <b>9</b> )	0.85( <b>9</b> )	0.85( <b>9</b> )	0.85( <b>9</b> )	0.6(6)		0.6(6)	1.25( <b>B</b> )			0.6(6)
270pF( <b>271</b> )			0.85( <b>9</b> )	0.85( <b>9</b> )	0.85( <b>9</b> )	0.85( <b>9</b> )	0.85( <b>9</b> )			0.6(6)				0.6(6)
330pF( <b>331</b> )			0.85( <b>9</b> )	0.85( <b>9</b> )	0.85( <b>9</b> )	0.85( <b>9</b> )	0.85( <b>9</b> )			0.6(6)				0.6(6)
390pF( <b>391</b> )			1.25( <b>B</b> )	1.25( <b>B</b> )	0.85( <b>9</b> )	0.85( <b>9</b> )	0.85( <b>9</b> )			0.6(6)				0.6(6)
470pF( <b>471</b> )			1.25( <b>B</b> )	1.25( <b>B</b> )	0.85( <b>9</b> )	0.85( <b>9</b> )	0.85( <b>9</b> )		0.85(9)	0.6(6)			0.85( <b>9</b> )	0.6(6)
560pF( <b>561</b> )				1.25( <b>B</b> )	1.25( <b>B</b> )	0.85( <b>9</b> )	1.25( <b>B</b> )	0.85( <b>9</b> )	0.85(9)	0.6(6)		1.25( <b>B</b> )	0.85( <b>9</b> )	0.6(6)
680pF( <b>681</b> )	0.6(6)					1.25( <b>B</b> )		1.25( <b>B</b> )	0.85(9)	0.6(6)		1.25( <b>B</b> )	0.85( <b>9</b> )	0.6(6)
820pF( <b>821</b> )	0.6(6)							1.25( <b>B</b> )	1.25( <b>B</b> )	0.6(6)		1.25( <b>B</b> )	1.25( <b>B</b> )	0.6(6)
1000pF( <b>102</b> )	0.85( <b>9</b> )								1.25( <b>B</b> )	0.6(6)		1.25( <b>B</b> )	1.25( <b>B</b> )	0.6(6)
1200pF( <b>122</b> )	0.85( <b>9</b> )	0.6(6)							1.25( <b>B</b> )	0.6(6)		1.25( <b>B</b> )	1.25( <b>B</b> )	0.6(6)
1500pF( <b>152</b> )	0.85( <b>9</b> )	0.6(6)							1.25( <b>B</b> )	0.85(9)		1.25( <b>B</b> )	1.25( <b>B</b> )	0.85(9
1800pF( <b>182</b> )		0.6(6)							1.25( <b>B</b> )	0.85(9)		1.25( <b>B</b> )	1.25( <b>B</b> )	0.85(9
2200pF( <b>222</b> )		0.6(6)								0.85(9)				0.85(9
2700pF( <b>272</b> )		0.6(6)								1.25( <b>B</b> )				1.25( <b>B</b>
3300pF( <b>332</b> )		0.6(6)								1.25( <b>B</b> )				1.25( <b>B</b>
3900pF( <b>392</b> )		0.6(6)												

Dimensions are shown in mm and Rated Voltage in Vdc.

Continued from	tne precea	ing page.												
Part Number							GR	M21						
L x W [EIA]							2.0x1.2	5 [0805]						
TC		0G <b>C</b> )		2H <b>P</b> )		2H <b>R</b> )		2H <b>S</b> )		SL I <b>X</b> )		2H <b>T</b> )		2J <b>'U</b> )
Rated Volt.	100 ( <b>2A</b> )	50 ( <b>1H</b> )												
Capacitance (Ca	pacitanc	e part nur	mbering c	ode) and	T (mm) D	imension	(T Dimen	sion part	numberir	ng code)				
4700pF( <b>472</b> )		0.6(6)												
5600pF( <b>562</b> )		0.85( <b>9</b> )												
6800pF( <b>682</b> )		0.85( <b>9</b> )												
8200pF( <b>822</b> )		0.85( <b>9</b> )												
10000pF( <b>103</b> )		0.85( <b>9</b> )								0.6(6)				0.6(6)
12000pF( <b>123</b> )		0.85( <b>9</b> )								0.6(6)				0.6(6)
15000pF( <b>153</b> )		0.85( <b>9</b> )								0.6(6)				0.6(6)
18000pF( <b>183</b> )		1.25( <b>B</b> )								0.6(6)				0.6(6)
22000pF( <b>223</b> )		1.25( <b>B</b> )								0.85( <b>9</b> )				0.85( <b>9</b> )
27000pF( <b>273</b> )										0.85( <b>9</b> )				0.85( <b>9</b> )
33000pF( <b>333</b> )										1.0( <b>A</b> )				1.0( <b>A</b> )
39000pF( <b>393</b> )										1.25( <b>B</b> )				1.25( <b>B</b> )
47000pF( <b>473</b> )										1.25( <b>B</b> )				1.25( <b>B</b> )

The part numbering code is shown in ().

# Temperature Compensating Type GRM31 Series (3.20x1.60mm) 100/50/25V

Part Number								GRM31							
L x W [EIA]							3.2	x1.6 [12	06]						
тс		C0G ( <b>5C</b> )			2H <b>P</b> )		2H <b>R</b> )	S2 ( <b>6</b>	2H <b>S</b> )	S ( <b>1</b>	<b>X</b> )		2H <b>T</b> )	U2 ( <b>7</b> 0	
Rated Volt.	100 ( <b>2A</b> )	50 ( <b>1H</b> )	25 ( <b>1E</b> )	100 ( <b>2A</b> )	50 ( <b>1H</b> )										
Capacitance (Ca	pacitano	e part n	umbering	code) ar	nd T (mm	) Dimens	ion (T Di	mension	part nun	nbering c	ode)				
47pF( <b>470</b> )												0.85(9)			
56pF( <b>560</b> )												0.85(9)			
68pF( <b>680</b> )												0.85(9)			
82pF( <b>820</b> )												0.85(9)			
100pF( <b>101</b> )												1.15( <b>M</b> )			
120pF( <b>121</b> )												1.15( <b>M</b> )			
150pF( <b>151</b> )												1.15( <b>M</b> )			
180pF( <b>181</b> )					0.6(6)							1.15( <b>M</b> )			
220pF( <b>221</b> )					0.6(6)		0.6(6)					1.15( <b>M</b> )			
270pF( <b>271</b> )					0.6(6)		0.6(6)		0.6(6)			1.15( <b>M</b> )			
330pF( <b>331</b> )					0.6(6)		0.6(6)		0.6(6)			1.15( <b>M</b> )			
390pF( <b>391</b> )				0.85(9)			0.6(6)		0.6(6)			1.15( <b>M</b> )			
470pF( <b>471</b> )				0.85( <b>9</b> )					0.6(6)			1.15( <b>M</b> )			
560pF( <b>561</b> )				0.85( <b>9</b> )		0.85( <b>9</b> )		0.85( <b>9</b> )	0.85( <b>9</b> )						
680pF( <b>681</b> )				0.85( <b>9</b> )		0.85( <b>9</b> )	0.85( <b>9</b> )	0.85( <b>9</b> )	0.85( <b>9</b> )						
820pF( <b>821</b> )				0.85( <b>9</b> )		0.85( <b>9</b> )	0.85( <b>9</b> )	0.85( <b>9</b> )	0.85( <b>9</b> )	0.85( <b>9</b> )			1.15( <b>M</b> )	0.85( <b>9</b> )	
1000pF( <b>102</b> )				1.15( <b>M</b> )		1.15( <b>M</b> )	1.15( <b>M</b> )	0.85( <b>9</b> )	0.85( <b>9</b> )	0.85( <b>9</b> )			1.15( <b>M</b> )	0.85( <b>9</b> )	
1200pF( <b>122</b> )				1.15( <b>M</b> )		1.15( <b>M</b> )	1.15( <b>M</b> )	1.15( <b>M</b> )	1.15( <b>M</b> )	0.85( <b>9</b> )			1.15( <b>M</b> )	0.85( <b>9</b> )	
1500pF( <b>152</b> )					1.15( <b>M</b> )		1.15( <b>M</b> )	1.15( <b>M</b> )	1.15( <b>M</b> )	0.85( <b>9</b> )			1.15( <b>M</b> )	0.85( <b>9</b> )	
1800pF( <b>182</b> )	0.85( <b>9</b> )								1.15( <b>M</b> )	0.85( <b>9</b> )			1.15( <b>M</b> )	0.85( <b>9</b> )	
2200pF( <b>222</b> )	0.85( <b>9</b> )									1.15( <b>M</b> )			1.15( <b>M</b> )	1.15( <b>M</b> )	
2700pF( <b>272</b> )	0.85( <b>9</b> )									1.15( <b>M</b> )			1.15( <b>M</b> )	1.15( <b>M</b> )	
3300pF( <b>332</b> )	0.85( <b>9</b> )									1.15( <b>M</b> )			1.15( <b>M</b> )	1.15( <b>M</b> )	
3900pF( <b>392</b> )	0.85( <b>9</b> )									1.15( <b>M</b> )			1.15( <b>M</b> )	1.15( <b>M</b> )	
4700pF( <b>472</b> )	0.85( <b>9</b> )									1.15( <b>M</b> )				1.15( <b>M</b> )	
5600pF( <b>562</b> )	0.85( <b>9</b> )														

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Dimensions are shown in mm and Rated Voltage in Vdc.

Part Number								GRM31							
L x W [EIA]							3.2	2x1.6 [12	06]						
тс		C0G ( <b>5C</b> )		P2 ( <b>6</b>			2H <b>R</b> )	S2 ( <b>6</b>	2H <b>S</b> )		<b>X</b> )		2H <b>T</b> )		2J ' <b>U</b> )
Rated Volt.	100 ( <b>2A</b> )	50 ( <b>1H</b> )	25 ( <b>1E</b> )	100 ( <b>2A</b> )	50 ( <b>1H</b> )										
Capacitance (Ca	pacitano	e part nu	ımbering	code) ar	nd T (mm	) Dimens	ion (T Di	mension	part nun	nbering o	ode)				
18000pF( <b>183</b> )		0.85( <b>9</b> )													
22000pF( <b>223</b> )		0.85( <b>9</b> )													
27000pF( <b>273</b> )		0.85( <b>9</b> )													
33000pF( <b>333</b> )		0.85( <b>9</b> )													
39000pF( <b>393</b> )		1.15( <b>M</b> )													
47000pF( <b>473</b> )		1.15( <b>M</b> )													
56000pF( <b>563</b> )		1.6( <b>C</b> )									0.85( <b>9</b> )				0.85(9)
68000pF( <b>683</b> )		1.6( <b>C</b> )									1.15( <b>M</b> )				1.15( <b>M</b> )
82000pF( <b>823</b> )		1.6( <b>C</b> )									1.15( <b>M</b> )				1.15( <b>M</b> )
0.10μF( <b>104</b> )			1.6( <b>C</b> )								1.15( <b>M</b> )				1.15( <b>M</b> )

The part numbering code is shown in ().

# High Dielectric Constant Type X5R (R6) Characteristics

тс										X5R ( <b>R6</b> )									
Part Number			GRM15	5				GRM18	3			GR	M21				GRM31		
L x W [EIA]		1.0	x0.5 [0	402]			1.6	x0.8 [0	603]		2	2.0x1.2	5 [0805	5]		3.2	<1.6 [12	206]	
Rated Volt.	50 ( <b>1H</b> )	25 ( <b>1E</b> )	16 ( <b>1C</b> )	10 ( <b>1A</b> )	6.3 ( <b>0J</b> )	50 ( <b>1H</b> )	25 ( <b>1E</b> )	16 ( <b>1C</b> )	10 ( <b>1A</b> )	6.3 ( <b>0J</b> )	25 ( <b>1E</b> )	16 ( <b>1C</b> )	10 ( <b>1A</b> )	6.3 ( <b>0J</b> )	25 ( <b>1E</b> )	16 ( <b>1C</b> )	10 ( <b>1A</b> )	6.3 ( <b>0J</b> )	4 ( <b>0G</b> )
Capacitance (Ca	pacita	nce pa	rt numk	pering o	code) a	nd T (n	nm) Din	nensior	n (T Din	nensio	n part r	number	ing cod	le)					
1000pF ( <b>102</b> )	0.5 ( <b>5</b> )	0.5 ( <b>5</b> )																	
2200pF ( <b>222</b> )	0.5 ( <b>5</b> )	0.5 ( <b>5</b> )																	
4700pF ( <b>472</b> )	0.5 ( <b>5</b> )	0.5 ( <b>5</b> )																	
10000pF ( <b>103</b> )						0.8 ( <b>8</b> )													
22000pF ( <b>223</b> )			0.5 ( <b>5</b> )			0.8 ( <b>8</b> )													
33000pF ( <b>333</b> )			0.5 ( <b>5</b> )	0.5 ( <b>5</b> )															
47000pF ( <b>473</b> )			0.5 ( <b>5</b> )	0.5 ( <b>5</b> )															
68000pF ( <b>683</b> )			0.5 ( <b>5</b> )	0.5 ( <b>5</b> )															
0.10μF ( <b>104</b> )			0.5 ( <b>5</b> )	0.5 ( <b>5</b> )			0.8 ( <b>8</b> )												
0.15μF ( <b>154</b> )				0.5* ( <b>5</b> )	0.5* ( <b>5</b> )														
0.22μF ( <b>224</b> )				0.5* ( <b>5</b> )	0.5* ( <b>5</b> )		0.8 ( <b>8</b> )	0.8 ( <b>8</b> )											
0.33μF ( <b>334</b> )				0.5* ( <b>5</b> )	0.5* ( <b>5</b> )														
0.47μF ( <b>474</b> )				0.5* ( <b>5</b> )	0.5* ( <b>5</b> )		0.8* ( <b>8</b> )	0.8* ( <b>8</b> )											
0.68μF ( <b>684</b> )				0.5* ( <b>5</b> )	0.5* ( <b>5</b> )														

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Dimensions are shown in mm and Rated Voltage in Vdc.

тс										X5R ( <b>R6</b> )									
Part Number			GRM15	5				GRM18	3			GRI	W21				GRM31	ı	
L x W [EIA]		1.0	к0.5 [О	402]			1.6	(0.8 [0	503]		2	.0x1.2	5 [0805	5]		3.2	κ1.6 [1 <i>i</i>	206]	
Rated Volt.	50 ( <b>1H</b> )	25 ( <b>1E</b> )	16 ( <b>1C</b> )	10 ( <b>1A</b> )	6.3 ( <b>0J</b> )	50 ( <b>1H</b> )	25 ( <b>1E</b> )	16 ( <b>1C</b> )	10 ( <b>1A</b> )	6.3 ( <b>0J</b> )	25 ( <b>1E</b> )	16 ( <b>1C</b> )	10 ( <b>1A</b> )	6.3 ( <b>0J</b> )	25 ( <b>1E</b> )	16 ( <b>1C</b> )	10 ( <b>1A</b> )	6.3 ( <b>0J</b> )	4 ( <b>0G</b> )
Capacitance (Ca	pacita	nce pai	rt numb	pering o	code) a	nd T (m	nm) Din	nensior	T Din	nensior	n part n	umber	ing coc	le)					
1.0μF ( <b>105</b> )				0.5* ( <b>5</b> )	0.5* ( <b>5</b> )		0.8* ( <b>8</b> )	0.8* ( <b>8</b> )											
2.2μF ( <b>225</b> )								0.8* ( <b>8</b> )	0.8* ( <b>8</b> )	0.8* ( <b>8</b> )	1.25* ( <b>B</b> )					1.15 ( <b>M</b> )			
3.3μF ( <b>335</b> )									0.8* ( <b>8</b> )		1.25* ( <b>B</b> )	1.25* ( <b>B</b> )				1.6 ( <b>C</b> )			
4.7μF ( <b>475</b> )										0.8* ( <b>8</b> )	1.25* ( <b>B</b> )	1.25* ( <b>B</b> )	1.25* ( <b>B</b> )		1.6 ( <b>C</b> )	1.6 ( <b>C</b> )	1.6 ( <b>C</b> )		
10μF ( <b>106</b> )													1.25* ( <b>B</b> )	1.25* ( <b>B</b> )	1.6* ( <b>C</b> )	1.6 ( <b>C</b> )			
15μF ( <b>156</b> )																		1.6* ( <b>C</b> )	
22μF ( <b>226</b> )														1.25* ( <b>B</b> )				1.6* ( <b>C</b> )	
47μF ( <b>476</b> )																		1.6* ( <b>C</b> )	
100μF ( <b>107</b> )																		1.6* ( <b>C</b> )	1.6* ( <b>C</b> )

The part numbering code is shown in each ( ).

Dimensions are shown in mm and Rated Voltage in Vdc.

# High Dielectric Constant Type X6S (C8) Characteristics

тс						X6S ( <b>C8</b> )					
Part Number	GR	M15	GR	M18		GR	M21			GRM31	
L x W [EIA]	1.0x0.5	5 [0402]	1.6x0.8	3 [0603]		2.0x1.2	5 [0805]		3	.2x1.6 [120	6]
Rated Volt.	6.3 ( <b>0J</b> )	4 ( <b>0G</b> )	6.3 ( <b>0J</b> )	4 ( <b>0G</b> )	25 ( <b>1E</b> )	16 ( <b>1C</b> )	6.3 ( <b>0J</b> )	4 ( <b>0G</b> )	10 ( <b>1A</b> )	6.3 ( <b>0J</b> )	4 ( <b>0G</b> )
Capacitance (Ca	pacitance p	art number	ing code) an	d T (mm) Di	mension (T	Dimension p	art numberi	ng code)	'	'	
0.15μF( <b>154</b> )	0.5*( <b>5</b> )										
0.22μF( <b>224</b> )	0.5*( <b>5</b> )										
0.33μF( <b>334</b> )	0.5*( <b>5</b> )										
0.47μF( <b>474</b> )	0.5*( <b>5</b> )										
0.68μF( <b>684</b> )		0.5*( <b>5</b> )	0.8(8)								
1.0μF( <b>105</b> )		0.5*( <b>5</b> )									
2.2μF( <b>225</b> )			0.8*(8)								
4.7μF( <b>475</b> )				0.8*( <b>8</b> )	1.25*( <b>B</b> )	1.25*( <b>B</b> )					
10μF( <b>106</b> )							1.25*( <b>B</b> )		1.15*( <b>M</b> )		
22μF( <b>226</b> )								1.25*( <b>B</b> )		1.6*( <b>C</b> )	1.6*( <b>C</b> )
47μF( <b>476</b> )											1.6*( <b>C</b> )

The part numbering code is shown in ().

 $<sup>3.3\</sup>mu F$  and  $4.7\mu F,\,6.3V$  rated are GRM21 series of L: 2±0.15, W: 1.25±0.15, T: 1.25±0.15.

T: 1.15 $\pm$ 0.1mm is also available for GRM31 1.0 $\mu$ F for 16V.

 $L: 3.2 \pm 0.2, W: 1.6 \pm 0.2 \text{ for GRM31 16V } 1.0 \mu\text{F type. Also } L: 3.2 \pm 0.2, W: 1.6 \pm 0.2, T: 1.15 \pm 0.15 \text{ for GRM31 16V } 1.5 \mu\text{F and } 2.2 \mu\text{F type.} L: 3.2 \pm 0.2, W: 1.6 \pm 0.2, T: 1.15 \pm 0.15 \text{ for GRM31 16V } 1.5 \mu\text{F and } 2.2 \mu\text{F type.} L: 3.2 \pm 0.2, W: 1.6 \pm 0.2, T: 1.15 \pm 0.15 \text{ for GRM31 16V } 1.5 \mu\text{F and } 2.2 \mu\text{F type.} L: 3.2 \pm 0.2, W: 1.6 \pm 0.2, T: 1.15 \pm 0.15 \text{ for GRM31 16V } 1.5 \mu\text{F and } 2.2 \mu\text{F type.} L: 3.2 \pm 0.2, W: 1.6 \pm 0.2, T: 1.15 \pm 0.15 \text{ for GRM31 16V } 1.5 \mu\text{F and } 2.2 \mu\text{F type.} L: 3.2 \pm 0.2, W: 1.6 \pm 0.2, T: 1.15 \pm 0.15 \text{ for GRM31 16V } 1.5 \mu\text{F and } 2.2 \mu\text{F type.} L: 3.2 \pm 0.2, W: 1.6 \pm 0.2, T: 1.15 \pm 0.15 \text{ for GRM31 16V } 1.5 \mu\text{F and } 2.2 \mu\text{F type.} L: 3.2 \pm 0.2, W: 1.6 \pm 0.2, T: 1.15 \pm 0.15 \text{ for GRM31 16V } 1.5 \mu\text{F and } 2.2 \mu\text{F type.} L: 3.2 \pm 0.2, T: 1.15 \pm 0.15 \text{ for GRM31 16V } 1.5 \mu\text{F and } 2.2 \mu\text{F type.} L: 3.2 \pm 0.2, T: 1.15 \pm 0.15 \text{ for GRM31 16V } 1.5 \mu\text{F and } 2.2 \mu\text{F type.} L: 3.2 \pm 0.2, T: 1.15 \pm 0.15 \text{ for GRM31 16V } 1.5 \mu\text{F and } 2.2 \mu\text{F type.} L: 3.2 \pm 0.2, T: 1.15 \pm 0.15 \text{ for GRM31 16V } 1.5 \mu\text{F and } 2.2 \mu\text{F type.} L: 3.2 \pm 0.2, T: 1.15 \pm 0.15 \text{ for GRM31 16V } 1.5 \mu\text{F and } 2.2 \mu\text{F type.} L: 3.2 \pm 0.2, T: 1.15 \pm 0.15 \text{ for GRM31 16V } 1.5 \mu\text{F and } 2.2 \mu\text{F type.} L: 3.2 \pm 0.2, T: 1.15 \pm 0.15 \text{ for GRM31 16V } 1.5 \mu\text{F and } 2.2 \mu\text{F type.} L: 3.2 \mu\text{F and } 2.2 \mu\text{F and } 2$ 

<sup>\*:</sup> Please refer to GRM Series Specifications and Test Methods (2) (P.30).

Dimensions are shown in mm and Rated Voltage in Vdc.

<sup>\*:</sup> Please refer to GRM Series Specifications and Test Methods (2) (P.30).

# **High Dielectric Constant Type X7R (R7) Characteristics**

тс												7R <b>?7</b> )										
Part Number		(	GRM1	5				GRI	M18					GR	M21				(	GRM3	1	
L x W [EIA]		1.0x	(0.5 [0	402]			1	.6x0.8	[060	3]			2.	0x1.2	5 [080	5]			3.2x	1.6 [1	206]	
Rated Volt.	100 ( <b>2A</b> )	50 ( <b>1H</b> )	25 ( <b>1E</b> )	16 ( <b>1C</b> )	10 ( <b>1A</b> )	100 ( <b>2A</b> )	50 ( <b>1H</b> )	25 ( <b>1E</b> )	16 ( <b>1C</b> )	10 ( <b>1A</b> )	6.3 ( <b>0J</b> )	100 ( <b>2A</b> )	50 ( <b>1H</b> )	25 ( <b>1E</b> )	16 ( <b>1C</b> )	10 ( <b>1A</b> )	6.3 ( <b>0J</b> )	100 ( <b>2A</b> )	50 ( <b>1H</b> )	25 ( <b>1E</b> )	16 ( <b>1C</b> )	10 ( <b>1A</b> )
Capacitance (Ca	pacita	ance p	oart nu	ımberi	ng co	de) an	d T (m	m) Dii	mensi	on (T I	Dimen	sion p	art nu	mberi	ng co	de)	1					
220pF ( <b>221</b> )		0.5 ( <b>5</b> )				0.8 ( <b>8</b> )																
330pF ( <b>331</b> )		0.5 ( <b>5</b> )				0.8 ( <b>8</b> )																
470pF ( <b>471</b> )		0.5 ( <b>5</b> )				0.8 ( <b>8</b> )																
680pF ( <b>681</b> )		0.5 ( <b>5</b> )				0.8 ( <b>8</b> )																
1000pF ( <b>102</b> )		0.5 ( <b>5</b> )				0.8 ( <b>8</b> )																
1500pF ( <b>152</b> )		0.5 ( <b>5</b> )				0.8 ( <b>8</b> )																
2200pF ( <b>222</b> )		0.5 ( <b>5</b> )				0.8																
3300pF ( <b>332</b> )		0.5 ( <b>5</b> )				0.8																
4700pF ( <b>472</b> )	0.5 ( <b>5</b> )	0.5 ( <b>5</b> )				. ,						0.85 ( <b>9</b> )										
6800pF ( <b>682</b> )		0.5 ( <b>5</b> )	0.5 ( <b>5</b> )									0.85										
10000pF ( <b>103</b> )		0.5 ( <b>5</b> )	0.5 ( <b>5</b> )									1.25 ( <b>B</b> )										
15000pF ( <b>153</b> )			0.5 ( <b>5</b> )	0.5 ( <b>5</b> )			0.8					1.25 ( <b>B</b> )										
22000pF ( <b>223</b> )			0.5 ( <b>5</b> )	0.5 ( <b>5</b> )			0.8					1.25 ( <b>B</b> )										
33000pF ( <b>333</b> )			0.5 ( <b>5</b> )	0.5 ( <b>5</b> )	0.5 ( <b>5</b> )		0.8					1.25 ( <b>B</b> )										
47000pF ( <b>473</b> )			0.5 ( <b>5</b> )	0.5 ( <b>5</b> )	0.5 ( <b>5</b> )		0.8					1.25 ( <b>B</b> )										
68000pF ( <b>683</b> )				0.5 ( <b>5</b> )	0.5 ( <b>5</b> )		0.8	0.8 ( <b>8</b> )										1.15 ( <b>M</b> )				
0.10μF ( <b>104</b> )				0.5 ( <b>5</b> )	0.5 ( <b>5</b> )		0.8	0.8 ( <b>8</b> )														
0.15μF ( <b>154</b> )								0.8 ( <b>8</b> )	0.8				1.25 ( <b>B</b> )						1.15 ( <b>M</b> )			
0.22μF ( <b>224</b> )								0.8 ( <b>8</b> )	0.8	0.8		1.0 ( <b>A</b> )	1.25 ( <b>B</b> )						0.85 ( <b>9</b> )			
0.33μF ( <b>334</b> )									0.8	0.8		1.0 ( <b>A</b> )	0.85 ( <b>9</b> )	1.25 ( <b>B</b> )								
0.47μF ( <b>474</b> )								0.8* ( <b>8</b> )	0.8 ( <b>8</b> )	0.8 ( <b>8</b> )	0.8		1.25 ( <b>B</b> )	0.85 ( <b>9</b> )					1.15 ( <b>M</b> )			
0.68μF ( <b>684</b> )										0.8 ( <b>8</b> )				0.85 ( <b>9</b> )	0.85 ( <b>9</b> )							
1.0μF ( <b>105</b> )									0.8* ( <b>8</b> )	0.8* ( <b>8</b> )	0.8*			1.25 ( <b>B</b> )	1.25 ( <b>B</b> )			1.6 ( <b>C</b> )	1.15 ( <b>M</b> )	1.15 ( <b>M</b> )		
1.5μF ( <b>155</b> )														1.25 ( <b>B</b> )	1.25 ( <b>B</b> )				1.6 ( <b>C</b> )	1.15 ( <b>M</b> )	1.15 ( <b>M</b> )	

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Continued from	the pre	ceding	page.																			
тс												7R ? <b>7</b> )										
Part Number		(	SRM1	5				GR	M18					GRI	M21				(	GRM3	1	
L x W [EIA]		1.0x0.5 [0402] 1.6x0.8 [0603]						3]			2.	0x1.2	5 [080	5]			3.2x	1.6 [1	206]			
Rated Volt.	100 ( <b>2A</b> )	50 ( <b>1H</b> )	25 ( <b>1E</b> )	16 ( <b>1C</b> )	10 ( <b>1A</b> )	100 ( <b>2A</b> )	50 ( <b>1H</b> )	25 ( <b>1E</b> )	16 ( <b>1C</b> )	10 ( <b>1A</b> )	6.3 ( <b>0J</b> )	100 ( <b>2A</b> )	50 ( <b>1H</b> )	25 ( <b>1E</b> )	16 ( <b>1C</b> )	10 ( <b>1A</b> )	6.3 ( <b>0J</b> )	100 ( <b>2A</b> )	50 ( <b>1H</b> )	25 ( <b>1E</b> )	16 ( <b>1C</b> )	10 ( <b>1A</b> )
Capacitance (Ca	pacita	ance p	art nu	ımberi	ng co	de) an	d T (m	m) Di	mensi	on (T [	Dimen	sion p	art nu	mberi	ng cod	de)						
2.2μF ( <b>225</b> )										0.8* ( <b>8</b> )				1.25* ( <b>B</b> )	1.25* ( <b>B</b> )				1.6 ( <b>C</b> )		1.15 ( <b>M</b> )	
3.3μF ( <b>335</b> )															1.25* ( <b>B</b> )					1.6 ( <b>C</b> )	1.6 ( <b>C</b> )	
4.7μF ( <b>475</b> )															1.25* ( <b>B</b> )	1.25* ( <b>B</b> )				1.6 ( <b>C</b> )	1.6 ( <b>C</b> )	1.6 ( <b>C</b> )
10μF ( <b>106</b> )																1.25* ( <b>B</b> )	1.25* ( <b>B</b> )				1.6* ( <b>C</b> )	

The part numbering code is shown in each ().

## High Dielectric Constant Type X7S (C7) Characteristics

тс		X7S ( <b>C7</b> )	
Part Number	GRM18	GRM21	GRM31
L x W [EIA]	1.6x0.8 [0603]	2.0x1.25 [0805]	3.2x1.6 [1206]
Rated Volt.	6.3 ( <b>0J</b> )	10 ( <b>1A</b> )	4 ( <b>0G</b> )
Capacitance (Ca	pacitance part numbering code) and T (mm	n) Dimension (T Dimension part numbering o	code)
2.2μF( <b>225</b> )	0.8*(8)		
3.3μF( <b>335</b> )		1.25*( <b>B</b> )	
22μF( <b>226</b> )			1.6*( <b>C</b> )

The part numbering code is shown in  $\ (\ ).$ 

Dimensions are shown in mm and Rated Voltage in Vdc.

# High Dielectric Constant Type Y5V (F5) Characteristics

TC						Y5V ( <b>F5</b> )					
Part Number			GRM15			GR	M18	GR	M21	GRM31	
L x W [EIA]		1	.0x0.5 [040	2]		1.6x0.8	8 [0603]	2.0x1.2	5 [0805]	3.2x1.6 [1206]	
Rated Volt.	50 ( <b>1H</b> )	25 ( <b>1E</b> )	16 ( <b>1C</b> )	10 ( <b>1A</b> )	6.3 ( <b>0J</b> )	50 ( <b>1H</b> )	25 ( <b>1E</b> )	50 ( <b>1H</b> )	25 ( <b>1E</b> )	50 ( <b>1H</b> )	6.3 ( <b>0J</b> )
Capacitance (Ca	pacitance p	art numberi	ing code) an	d T (mm) Di	mension (T I	Dimension p	art numberi	ng code)			
1000pF( <b>102</b> )	0.5( <b>5</b> )										
2200pF( <b>222</b> )	0.5( <b>5</b> )										
4700pF( <b>472</b> )	0.5( <b>5</b> )										
10000pF( <b>103</b> )	0.5( <b>5</b> )					0.8(8)					
22000pF( <b>223</b> )		0.5( <b>5</b> )				0.8(8)					
47000pF( <b>473</b> )		0.5( <b>5</b> )	0.5( <b>5</b> )			0.8(8)					
0.10μF( <b>104</b> )		0.5( <b>5</b> )	0.5( <b>5</b> )			0.8(8)		0.85( <b>9</b> )	0.6(6)		
0.22μF( <b>224</b> )			0.5( <b>5</b> )			0.8(8)	0.8(8)		0.85( <b>9</b> )		
0.47μF( <b>474</b> )			0.5( <b>5</b> )	0.5( <b>5</b> )			0.8(8)	0.85( <b>9</b> )	0.6(6)	1.15( <b>M</b> )	
1.0μF( <b>105</b> )				0.5*( <b>5</b> )	0.5*( <b>5</b> )						
100μF( <b>107</b> )											1.6*( <b>C</b> )

The part numbering code is shown in each ( ).

The tolerance will be changed to L:  $3.2\pm0.2$ , W:  $1.6\pm0.2$  for GRM31 16V  $1.0\mu$ F type. Also L:  $3.2\pm0.2$ , W:  $1.6\pm0.2$ , T:  $1.15\pm0.15$  for GRM31 16V  $1.5\mu$ F and  $2.2\mu$ F type. Dimensions are shown in mm and Rated Voltage in Vdc.

<sup>\*:</sup> Please refer to GRM Series Specifications and Test Methods (2) (P.30).

<sup>\*:</sup> Please refer to GRM Series Specifications and Test Methods (2) (P.30).

T: 1.25 $\pm$ 0.1mm is also available for GRM21 25V or 16V 1.0 $\mu$ F type.

Dimensions are shown in mm and Rated Voltage in Vdc.

<sup>\*:</sup> Please refer to GRM Series Specifications and Test Methods (2) (P.30).

# **Chip Monolithic Ceramic Capacitors**



# for General Purpose GRM32 Series

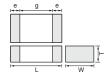
### ■ Features

- 1. Terminations are made of metal highly resistant to migration.
- 2. Smaller size and higher capacitance value
- 3. High reliability and no polarity
- 4. Excellent pulse responsibility and noise reduction due to the low impedance at high frequency.
- 5. Ta replacement

### Applications

General electronic equipment





Part Number		D	imensions (r	nm)	
Part Number	L	W	T	е	g min.
GRM329			0.85 ±0.1		
GRM32A			1.0 +0/-0.2		
GRM32M			1.15 ±0.1		
GRM32N	3.2 +0.3	2.5 +0.2	1.35 ±0.15	0.3 min.	1.0
GRM32C	3.2 ±0.3	2.5 ±0.2	1.6 ±0.2	0.3 mm.	1.0
GRM32R			1.8 ±0.2		
GRM32D			2.0 ±0.2		
GRM32E			2.5 ±0.2		

## **Temperature Compensating Type GRM32 Series**

Part Number	TC Code (Standard)	Rated Voltage (Vdc)	Capacitance (pF)	Length L (mm)	Width W (mm)	Thickness T (mm)
GRM3291X2A222JZ01	SL (JIS)	100	2200 ±5%	3.2	2.5	0.85
GRM3291X2A272JZ01	SL (JIS)	100	2700 ±5%	3.2	2.5	0.85
GRM3291X2A332JZ01	SL (JIS)	100	3300 ±5%	3.2	2.5	0.85
GRM32N1X2A562JZ01	SL (JIS)	100	5600 ±5%	3.2	2.5	1.35
GRM32N1X2A682JZ01	SL (JIS)	100	6800 ±5%	3.2	2.5	1.35

## High Dielectric Constant Type GRM32 Series (3.20x2.50mm)

Part Number	TC Code (Standard)	Rated Voltage (Vdc)	Capacitance (μF)	Length L (mm)	Width W (mm)	Thickness T (mm)
GRM32ER61E226ME15	X5R (EIA)	25	22 ±20%*	3.2	2.5	2.5
GRM32ER61C226ME20	X5R (EIA)	16	22 ±20%*	3.2	2.5	2.5
GRM32ER61C476ME15	X5R (EIA)	16	47 ±20%*	3.2	2.5	2.5
GRM32ER61A226ME20	X5R (EIA)	10	22 ±20%*	3.2	2.5	2.5
GRM32ER61A476ME20	X5R (EIA)	10	47 ±20%*	3.2	2.5	2.5
GRM32DR60J226KA01	X5R (EIA)	6.3	22 ±10%*	3.2	2.5	2.0
GRM32DR60J336ME19	X5R (EIA)	6.3	33 ±20%*	3.2	2.5	2.0
GRM32ER60J476ME20	X5R (EIA)	6.3	47 ±20%*	3.2	2.5	2.5
GRM32ER60J107ME20	X5R (EIA)	6.3	100 ±20%*	3.2	2.5	2.5
GRM32DC81E106KA12	X6S(EIA)	25	10 ±10%	3.2	2.5	2.0
GRM32EC80J476ME64	X6S(EIA)	6.3	47 ±20%*	3.2	2.5	2.5
GRM32EC80G107ME20	X6S(EIA)	4	100 ±20%*	3.2	2.5	2.5
GRM32CR72A684KA01	X7R (EIA)	100	0.68 ±10%	3.2	2.5	1.6
GRM32CR72A105KA35	X7R (EIA)	100	1.0 ±10%	3.2	2.5	1.6
GRM32DR72A155KA35	X7R (EIA)	100	1.5 ±10%	3.2	2.5	2.0
GRM32ER72A225KA35	X7R (EIA)	100	2.2 ±10%*	3.2	2.5	2.5
GRM32ER71H105KA01	X7R (EIA)	50	1.0 ±10%	3.2	2.5	2.5
GRM32DR71H335KA88	X7R (EIA)	50	3.3 ±10%	3.2	2.5	2.0
GRM32ER71H475KA88	X7R (EIA)	50	4.7 ±10%	3.2	2.5	2.5
GRM32DR71E335KA01	X7R (EIA)	25	3.3 ±10%	3.2	2.5	2.0
GRM32DR71E475KA61	X7R (EIA)	25	4.7 ±10%	3.2	2.5	2.0
GRM32DR71E106KA12	X7R (EIA)	25	10 ±10%	3.2	2.5	2.0

 $\begin{tabular}{|c|c|c|c|}\hline \end{tabular}$  Continued from the preceding page.

Part Number	TC Code (Standard)	Rated Voltage (Vdc)	Capacitance (μF)	Length L (mm)	Width W (mm)	Thickness T (mm)
GRM32ER71C226ME18	X7R (EIA)	16	22 ±20%*	3.2	2.5	2.5
GRM32ER71A226ME20	X7R (EIA)	10	22 ±20%*	3.2	2.5	2.5
GRM32EF50J107ZE20	Y5V (EIA)	6.3	100 +80/-20%*	3.2	2.5	2.5

<sup>\*:</sup> Please refer to GRM Series Specifications and Test Methods (2) (P.30).

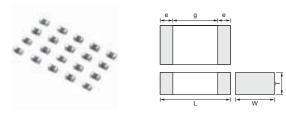
# **Chip Monolithic Ceramic Capacitors**



## **Ultra-small GRM03 Series**

#### ■ Features

- 1. Small chip size (LxWxT: 0.6x0.3x0.3mm)
- Terminations are made of metal highly resistant to migration.
- 3. GRM03 series is suited to only reflow soldering.
- Stringent dimensional tolerances allow highly reliable, high speed automatic chip placement on PCBs
- GRM03 series is suited to miniature microwave module, portable equipment and high frequency circuits.



Part Number		Din	nensions (n	nm)	
Part Number	L	W	T	е	g min.
GRM033	0.6 ±0.03	0.3 ±0.03	0.3 ±0.03	0.1 to 0.2	0.2

### ■ Applications

- 1. Miniature microwave module
- 2. Portable equipment
- 3. High frequency circuit

Part Number						GRI	M03					
LxW						0.6x0.3	[0201]					
тс	C0G ( <b>5C</b> )	R2H ( <b>6R</b> )	S2H ( <b>6S</b> )	T2H ( <b>6T</b> )		2J ' <b>U</b> )		5R <b>R6</b> )	X6S ( <b>C8</b> )		X7R ( <b>R7</b> )	
Rated Volt.	25 ( <b>1E</b> )	25 ( <b>1E</b> )	25 ( <b>1E</b> )	25 ( <b>1E</b> )	50 ( <b>1H</b> )	25 ( <b>1E</b> )	10 ( <b>1A</b> )	6.3 ( <b>0J</b> )	4 ( <b>0G</b> )	25 ( <b>1E</b> )	16 ( <b>1C</b> )	10 ( <b>1A</b> )
Capacitance (Ca	pacitance	part numbe	ering code)	and T (mm	) Dimensio	n (T Dimen	sion part n	umbering o	code)			
1.0pF( <b>1R0</b> )	0.3( <b>3</b> )	0.3( <b>3</b> )	0.3( <b>3</b> )	0.3( <b>3</b> )								
2.0pF( <b>2R0</b> )	0.3( <b>3</b> )	0.3( <b>3</b> )	0.3( <b>3</b> )	0.3( <b>3</b> )								
3.0pF( <b>3R0</b> )	0.3( <b>3</b> )	0.3( <b>3</b> )	0.3( <b>3</b> )	0.3( <b>3</b> )	0.3( <b>3</b> )							
4.0pF( <b>4R0</b> )	0.3( <b>3</b> )	0.3( <b>3</b> )	0.3( <b>3</b> )	0.3( <b>3</b> )	0.3( <b>3</b> )							
5.0pF( <b>5R0</b> )	0.3(3)	0.3( <b>3</b> )	0.3(3)	0.3( <b>3</b> )	0.3(3)							
6.0pF( <b>6R0</b> )	0.3(3)	0.3(3)	0.3( <b>3</b> )	0.3(3)	0.3(3)							
7.0pF( <b>7R0</b> )	0.3(3)	0.3(3)	0.3( <b>3</b> )	0.3( <b>3</b> )	0.3(3)							
8.0pF( <b>8R0</b> )	0.3(3)	0.3(3)	0.3(3)	0.3(3)	0.3(3)							
9.0pF( <b>9R0</b> )	0.3( <b>3</b> )	0.3(3)	0.3(3)	0.3( <b>3</b> )	0.3( <b>3</b> )							
10pF( <b>100</b> )	0.3( <b>3</b> )	0.3(3)	0.3(3)	0.3( <b>3</b> )	0.3( <b>3</b> )							
12pF( <b>120</b> )	0.3(3)	0.3(3)	0.3(3)	0.3( <b>3</b> )	0.3(3)							
15pF( <b>150</b> )	0.3(3)	0.3(3)	0.3(3)	0.3(3)	0.3(3)							
18pF( <b>180</b> )	0.3(3)	0.3(3)	0.3( <b>3</b> )	0.3( <b>3</b> )		0.3(3)						
22pF( <b>220</b> )	0.3(3)	0.3(3)	0.3( <b>3</b> )	0.3( <b>3</b> )		0.3(3)						
27pF( <b>270</b> )	0.3(3)	0.3(3)	0.3( <b>3</b> )	0.3( <b>3</b> )		0.3(3)						
33pF( <b>330</b> )	0.3(3)	0.3(3)	0.3( <b>3</b> )	0.3(3)		0.3(3)						
39pF( <b>390</b> )	0.3(3)	0.3(3)	0.3( <b>3</b> )	0.3( <b>3</b> )		0.3(3)						
47pF( <b>470</b> )	0.3(3)	0.3(3)	0.3( <b>3</b> )	0.3( <b>3</b> )		0.3(3)						
56pF( <b>560</b> )	0.3(3)	0.3(3)	0.3( <b>3</b> )	0.3( <b>3</b> )		0.3(3)						
68pF( <b>680</b> )	0.3( <b>3</b> )	0.3(3)	0.3( <b>3</b> )	0.3( <b>3</b> )		0.3(3)						
82pF( <b>820</b> )	0.3(3)	0.3(3)	0.3( <b>3</b> )	0.3(3)		0.3(3)						
100pF( <b>101</b> )	0.3(3)	0.3(3)	0.3( <b>3</b> )	0.3(3)		0.3(3)				0.3( <b>3</b> )		
150pF( <b>151</b> )										0.3(3)		
220pF( <b>221</b> )										0.3(3)		
330pF( <b>331</b> )										0.3(3)		
470pF( <b>471</b> )										0.3(3)		
680pF( <b>681</b> )										0.3(3)		

Part Number						GR	M03					
LxW						0.6x0.3	[0201]					
тс	C0G ( <b>5C</b> )	R2H ( <b>6R</b> )	S2H ( <b>6S</b> )	T2H ( <b>6T</b> )		2J ' <b>U</b> )		5R <b>86</b> )	X6S ( <b>C8</b> )		X7R ( <b>R7</b> )	
Rated Volt.	25 ( <b>1E</b> )	25 ( <b>1E</b> )	25 ( <b>1E</b> )	25 ( <b>1E</b> )	50 ( <b>1H</b> )	25 ( <b>1E</b> )	10 ( <b>1A</b> )	6.3 ( <b>0J</b> )	4 ( <b>0G</b> )	25 ( <b>1E</b> )	16 ( <b>1C</b> )	10 ( <b>1A</b> )
Capacitance (Ca	pacitance	part numb	ering code)	and T (mm	) Dimensio	n (T Dimen	sion part n	umbering c	ode)			
1000pF( <b>102</b> )										0.3(3)		
1500pF( <b>152</b> )							0.3( <b>3</b> )			0.3(3)		0.3(3)
2200pF( <b>222</b> )							0.3( <b>3</b> )				0.3(3)	0.3(3)
3300pF( <b>332</b> )							0.3( <b>3</b> )				0.3(3)	0.3(3)
4700pF( <b>472</b> )							0.3(3)					0.3(3)
6800pF( <b>682</b> )							0.3(3)					0.3(3)
10000pF( <b>103</b> )							0.3(3)					0.3(3)
15000pF( <b>153</b> )								0.3*( <b>3</b> )				
22000pF( <b>223</b> )								0.3*( <b>3</b> )				
33000pF( <b>333</b> )								0.3*( <b>3</b> )				
47000pF( <b>473</b> )								0.3*( <b>3</b> )				
68000pF( <b>683</b> )								0.3*( <b>3</b> )				
0.10μF( <b>104</b> )								0.3*( <b>3</b> )	0.3(3)			

The part numbering code is shown in ().

Dimensions are shown in mm and Rated Voltage in Vdc.

<sup>\*:</sup> Please refer to GRM Series Specifications and Test Methods (2) (P.30).

# **Chip Monolithic Ceramic Capacitors**

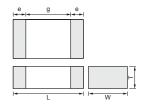


# **Tight Tolerance GRM03/15 Series**

#### ■ Features

- 1. Terminations are made of metal highly resistant to migration.
- 2. A wide selection of sizes is available, from the miniature LxWxT: 0.6x0.3x0.3mm or LxWxT: 1.0x0.5x0.5mm.
- 3. GRM03 type is a complete line of chip ceramic capacitors in 25V ratings, GRM15 type is a complete line of chip ceramic capacitors in 50V ratings.
- 4. These capacitors have temperature characteristics ranging C0G.
- 5. GRM03 and GRM15 type are applied to only reflow
- 6. Stringent dimensional tolerances allow highly reliable, high speed automatic chip placement on PCBs.
- 7. GRM series is available in paper tape and reel packaging for automatic placement.





Part Number		Din	nensions (r	nm)	
rait Number	L	W	T	е	g min.
GRM033	0.6 ±0.03	0.3 ±0.03	0.3 ±0.03	0.1 to 0.2	0.2
GRM155	1.0 ±0.05	0.5 ±0.05	0.5 ±0.05	0.15 to 0.35	0.3

### Applications

General electronic equipment

## **Temperature Compensating Type GRM03/15 Series**

Part Number		GRM03	GRM15
L x W [EIA]		0.6x0.3 [0201]	1.0x0.5 [0402]
тс		C0G ( <b>5C</b> )	C0G ( <b>5C</b> )
Rated Volt.		25 ( <b>1E</b> )	50 ( <b>1H</b> )
Capacitance, Ca	pacitanc	e Tolerance and T Dimension	
0.30pF( <b>R30</b> )	W, B	0.3(3)	0.5 <b>(5</b> )
0.40pF( <b>R40</b> )	W, B	0.3(3)	0.5 <b>(5</b> )
0.50pF( <b>R50</b> )	W, B	0.3(3)	0.5( <b>5</b> )
0.60pF( <b>R60</b> )	W, B	0.3(3)	0.5 <b>(5</b> )
0.70pF( <b>R70</b> )	W, B	0.3(3)	0.5( <b>5</b> )
0.80pF( <b>R80</b> )	W, B	0.3(3)	0.5 <b>(5</b> )
0.90pF( <b>R90</b> )	W, B	0.3(3)	0.5 <b>(5</b> )
1.0pF( <b>1R0</b> )	W, B	0.3(3)	0.5 <b>(5</b> )
1.1pF( <b>1R1</b> )	W, B	0.3(3)	0.5 <b>(5</b> )
1.2pF( <b>1R2</b> )	W, B	0.3(3)	0.5 <b>(5</b> )
1.3pF( <b>1R3</b> )	W, B	0.3(3)	0.5 <b>(5</b> )
1.4pF( <b>1R4</b> )	W, B	0.3(3)	0.5 <b>(5</b> )
1.5pF( <b>1R5</b> )	W, B	0.3(3)	0.5 <b>(5</b> )
1.6pF( <b>1R6</b> )	W, B	0.3(3)	0.5 <b>(5</b> )
1.7pF( <b>1R7</b> )	W, B	0.3(3)	0.5 <b>(5</b> )
1.8pF( <b>1R8</b> )	W, B	0.3(3)	0.5( <b>5</b> )
1.9pF( <b>1R9</b> )	W, B	0.3(3)	0.5( <b>5</b> )
2.0pF( <b>2R0</b> )	W, B	0.3(3)	0.5( <b>5</b> )
2.1pF( <b>2R1</b> )	W, B	0.3(3)	0.5( <b>5</b> )
2.2pF( <b>2R2</b> )	W, B	0.3(3)	0.5( <b>5</b> )
2.3pF( <b>2R3</b> )	W, B	0.3(3)	0.5( <b>5</b> )

Part Number	<u> </u>	GRM03	GRM15
L x W [EIA]		0.6x0.3 [0201]	1.0x0.5 [0402]
TC		C0G ( <b>5C</b> )	C0G ( <b>5C</b> )
Rated Volt.		25 ( <b>1E</b> )	50 ( <b>1H</b> )
Capacitance, Ca	pacitano	ce Tolerance and T Dimension	
2.4pF( <b>2R4</b> )	W, B	0.3(3)	0.5(5)
2.5pF( <b>2R5</b> )	W, B	0.3(3)	0.5(5)
2.6pF( <b>2R6</b> )	W, B	0.3(3)	0.5(5)
2.7pF( <b>2R7</b> )	W, B	0.3(3)	0.5(5)
2.8pF( <b>2R8</b> )	W, B	0.3(3)	0.5( <b>5</b> )
2.9pF( <b>2R9</b> )	W, B	0.3(3)	0.5( <b>5</b> )
3.0pF( <b>3R0</b> )	W, B	0.3(3)	0.5( <b>5</b> )
3.1pF( <b>3R1</b> )	W, B	0.3(3)	0.5( <b>5</b> )
3.2pF( <b>3R2</b> )	W, B	0.3(3)	0.5( <b>5</b> )
3.3pF( <b>3R3</b> )	W, B	0.3(3)	0.5( <b>5</b> )
3.4pF( <b>3R4</b> )	W, B	0.3(3)	0.5( <b>5</b> )
3.5pF( <b>3R5</b> )	W, B	0.3(3)	0.5( <b>5</b> )
3.6pF( <b>3R6</b> )	W, B	0.3(3)	0.5( <b>5</b> )
3.7pF( <b>3R7</b> )	W, B	0.3(3)	0.5(5)
3.8pF( <b>3R8</b> )	W, B	0.3(3)	0.5(5)
3.9pF( <b>3R9</b> )	W, B	0.3(3)	0.5( <b>5</b> )
4.0pF( <b>4R0</b> )	W, B	0.3(3)	0.5(5)
4.1pF( <b>4R1</b> )	W, B	0.3(3)	0.5(5)
4.2pF( <b>4R2</b> )	W, B	0.3(3)	0.5(5)
4.3pF( <b>4R3</b> )	W, B	0.3(3)	0.5( <b>5</b> )
4.4pF( <b>4R4</b> )	W, B	0.3(3)	0.5( <b>5</b> )
4.5pF( <b>4R5</b> )	W, B	0.3(3)	0.5( <b>5</b> )
4.6pF( <b>4R6</b> )	W, B	0.3(3)	0.5( <b>5</b> )
4.7pF( <b>4R7</b> )	W, B	0.3(3)	0.5( <b>5</b> )
4.8pF( <b>4R8</b> )	W, B	0.3(3)	0.5( <b>5</b> )
4.9pF( <b>4R9</b> )	W, B	0.3(3)	0.5( <b>5</b> )
5.0pF( <b>5R0</b> )	W, B	0.3(3)	0.5(5)
5.1pF( <b>5R1</b> )	W, B, C	0.3(3)	0.5(5)
	W, B, C		0.5(5)
5.3pF( <b>5R3</b> )	W, B, C		0.5( <b>5</b> )
5.4pF( <b>5R4</b> )			0.5( <b>5</b> )
5.5pF( <b>5R5</b> )	W, B, C		0.5( <b>5</b> )
			0.5( <b>5</b> )
5.7pF( <b>5R7</b> )	W, B, C	0.3(3)	0.5( <b>5</b> )
5.8pF( <b>5R8</b> )	W, B, C	0.3(3)	0.5( <b>5</b> )
5.9pF( <b>5R9</b> )	W, B, C	0.3(3)	0.5( <b>5</b> )
6.0pF( <b>6R0</b> )	W, B, C	0.3(3)	0.5( <b>5</b> )
6.1pF( <b>6R1</b> )	W, B, C	0.3(3)	0.5( <b>5</b> )
6.2pF( <b>6R2</b> )	W, B, C	0.3(3)	0.5( <b>5</b> )
6.3pF( <b>6R3</b> )	W, B, C	0.3(3)	0.5(5)
	W, B, C		0.5( <b>5</b> )
6.5pF( <b>6R5</b> )	W, B, C	0.3(3)	0.5( <b>5</b> )
6.6pF( <b>6R6</b> )	W, B, C	0.3(3)	0.5( <b>5</b> )
	W, B, C		0.5( <b>5</b> )
	W, B, C		0.5(5)
	W, B, C		0.5(5)
	W, B, C		0.5(5)
7.1pF( <b>7R1</b> )			0.5(5)
			0.5(5)
			0.5(5)
7.4pF( <b>7R4</b> )			0.5(5)
7.5pF( <b>7R5</b> )	W, B, C	0.3(3)	0.5(5)

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☐ Continued from	the preced	ling page.	
Part Number		GRM03	GRM15
L x W [EIA]		0.6x0.3 [0201]	1.0x0.5 [0402]
тс		C0G ( <b>5C</b> )	C0G ( <b>5C</b> )
Rated Volt.		25 ( <b>1E</b> )	50 ( <b>1H</b> )
Capacitance, Ca	apacitanc	e Tolerance and T Dimension	
7.6pF( <b>7R6</b> )	W, B, C	0.3(3)	0.5(5)
7.7pF( <b>7R7</b> )	W, B, C	0.3(3)	0.5(5)
7.8pF( <b>7R8</b> )	W, B, C	0.3(3)	0.5(5)
7.9pF( <b>7R9</b> )	W, B, C	0.3(3)	0.5(5)
8.0pF( <b>8R0</b> )	W, B, C	0.3(3)	0.5( <b>5</b> )

The part numbering code is shown in ().

8.1pF(**8R1**) **W, B, C** 

8.2pF(**8R2**) **W, B, C** 

8.3pF(**8R3**) **W, B, C** 

8.4pF(**8R4**) **W, B, C** 

8.5pF(**8R5**) **W, B, C** 

8.6pF(**8R6**) **W, B, C** 

8.7pF(**8R7**) **W, B, C** 

8.8pF(**8R8**) **W, B, C** 

8.9pF(**8R9**) **W, B, C** 

9.0pF(**9R0**) **W, B, C** 

9.1pF(**9R1**) **W, B, C** 

9.2pF(**9R2**) **W, B, C** 

9.3pF(**9R3**) **W, B, C** 

9.4pF(**9R4**) **W, B, C** 

9.5pF(**9R5**) **W, B, C** 

9.6pF(**9R6**) **W, B, C** 

9.7pF(**9R7**) **W, B, C** 

9.8pF(**9R8**) **W, B, C** 

9.9pF(**9R9**) **W, B, C** 

Dimensions are shown in mm and Rated Voltage in Vdc.

# **Chip Monolithic Ceramic Capacitors**

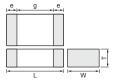


# **Thin Type**

### ■ Features

- 1. This series is suited to flow and reflow soldering. Capacitor terminations are made of metal highly resistant to migration.
- 2. Large capacitance values enable excellent bypass effects to be realized.
- 3. GRM18, 21 and GRM31 types are suited to flow and reflow soldering. GRM15 and GRM32 types are applied to only reflow soldering.
- 4. Its thin package makes this series ideally suited for the production of small electronic products and for mounting underneath ICs.





Part Number		Dir	nensions (m	nm)	
Fait Number	L	W	T	е	g min.
GRM15X	1.0 ±0.05	0.5 +0.05	0.25 ±0.05	0.1 to 0.3	0.4
GRM153	1.0 ±0.05	0.5 ±0.05	0.3 ±0.03	0.1 10 0.3	0.4
GRM216			0.6 ±0.1		
GRM219	$2.0 \pm 0.1$	1.25 ±0.1	0.85 ±0.1	0.2 to 0.7	0.7
GRM21A			1.0 +0/-0.2		
GRM316	3.2 ±0.15	1.6 ±0.15	0.6 ±0.1	0.3 to 0.8	1.5
GRM319	3.2 ±0.15	1.6 ±0.15	0.85 ±0.1	0.3 10 0.8	1.5
GRM329	3.2 +0.3	2.5 +0.2	0.85 ±0.1	0.3 min.	1.0
GRM32A	3.∠ ±0.3	2.5 ±0.2	1.0 +0/-0.2	U.S Min.	1.0

### Applications

Thin equipment such as IC cards

## **Temperature Compensating Type**

Part Number	TC Code (Standard)	Rated Voltage (Vdc)	Capacitance (pF)	Length L (mm)	Width W (mm)	Thickness T (mm)	EIA
GRM1535C1H1R0CDD5	C0G (EIA)	50	1.0 ±0.25pF	1.0	0.5	0.3	0402
GRM1535C1H2R0CDD5	C0G (EIA)	50	2.0 ±0.25pF	1.0	0.5	0.3	0402
GRM1535C1H3R0CDD5	C0G (EIA)	50	3.0 ±0.25pF	1.0	0.5	0.3	0402
GRM1535C1H4R0CDD5	C0G (EIA)	50	4.0 ±0.25pF	1.0	0.5	0.3	0402
GRM1535C1H5R0CDD5	C0G (EIA)	50	5.0 ±0.25pF	1.0	0.5	0.3	0402
GRM1535C1H6R0DDD5	COG (EIA)	50	6.0 ±0.5pF	1.0	0.5	0.3	0402
GRM1535C1H7R0DDD5	COG (EIA)	50	7.0 ±0.5pF	1.0	0.5	0.3	0402
GRM1535C1H8R0DDD5	COG (EIA)	50	8.0 ±0.5pF	1.0	0.5	0.3	0402
GRM1535C1H9R0DDD5	COG (EIA)	50	9.0 ±0.5pF	1.0	0.5	0.3	0402
GRM1535C1H100JDD5	COG (EIA)	50	10 ±5%	1.0	0.5	0.3	0402
GRM1535C1H120JDD5	COG (EIA)	50	12 ±5%	1.0	0.5	0.3	0402
GRM1535C1H150JDD5	COG (EIA)	50	15 ±5%	1.0	0.5	0.3	0402
GRM1535C1H180JDD5	COG (EIA)	50	18 ±5%	1.0	0.5	0.3	0402
GRM1535C1H220JDD5	C0G (EIA)	50	22 ±5%	1.0	0.5	0.3	0402
GRM1535C1H270JDD5	C0G (EIA)	50	27 ±5%	1.0	0.5	0.3	0402
GRM1535C1H330JDD5	C0G (EIA)	50	33 ±5%	1.0	0.5	0.3	0402
GRM1535C1H390JDD5	C0G (EIA)	50	39 ±5%	1.0	0.5	0.3	0402
GRM1535C1H470JDD5	C0G (EIA)	50	47 ±5%	1.0	0.5	0.3	0402
GRM1535C1H560JDD5	C0G (EIA)	50	56 ±5%	1.0	0.5	0.3	0402
GRM1535C1H680JDD5	C0G (EIA)	50	68 ±5%	1.0	0.5	0.3	0402
GRM1535C1H820JDD5	COG (EIA)	50	82 ±5%	1.0	0.5	0.3	0402
GRM1535C1H101JDD5	COG (EIA)	50	100 ±5%	1.0	0.5	0.3	0402

# **High Dielectric Constant Type**

Part Number	TC Code (Standard)	Rated Voltage (Vdc)	Capacitance	Length L (mm)	Width W (mm)	Thickness T (mm)	EIA
GRM15XR71H221KA86	X7R (EIA)	50	220pF ±10%	1.0	0.5	0.25	0402
GRM15XR71H331KA86	X7R (EIA)	50	330pF ±10%	1.0	0.5	0.25	0402
GRM15XR71H471KA86	X7R (EIA)	50	470pF ±10%	1.0	0.5	0.25	0402
GRM15XR71H681KA86	X7R (EIA)	50	680pF ±10%	1.0	0.5	0.25	0402
GRM15XR71H102KA86	X7R (EIA)	50	1000pF ±10%	1.0	0.5	0.25	0402
GRM15XR71H152KA86	X7R (EIA)	50	1500pF ±10%	1.0	0.5	0.25	0402
GRM15XR71E222KA86	X7R (EIA)	25	2200pF ±10%	1.0	0.5	0.25	0402
GRM219R71E105KA88	X7R (EIA)	25	1.0μF ±10%	2.0	1.25	0.85	0805
GRM15XR71C332KA86	X7R (EIA)	16	3300pF ±10%	1.0	0.5	0.25	0402
GRM15XR71C472KA86	X7R (EIA)	16	4700pF ±10%	1.0	0.5	0.25	0402
GRM15XR71C682KA86	X7R (EIA)	16	6800pF ±10%	1.0	0.5	0.25	0402
GRM15XR71C103KA86	X7R (EIA)	16	10000pF ±10%	1.0	0.5	0.25	0402
GRM216C81C105KA12	X6S(EIA)	16	1.0μF ±10%	2.0	1.25	0.6*	0805
GRM316C81C225KA12	X6S(EIA)	16	2.2μF ±10%	3.2	1.6	0.6*	1206
GRM219C81C225KA12	X6S(EIA)	16	2.2μF ±10%	2.0	1.25	0.85*	0805
GRM319C81C475KA12	X6S(EIA)	16	4.7μF ±10%	3.2	1.6	0.85*	1206
GRM219C81A475KE34	X6S(EIA)	10	4.7μF ±10%	2.0	1.25	0.85*	0805
GRM219C80J475KE19	X6S(EIA)	6.3	4.7μF ±10%	2.0	1.25	0.85*	0805
GRM319C80J106KE19	X6S(EIA)	6.3	10μF ±10%	3.2	1.6	0.85*	1206
GRM219C80G106KE19	X6S(EIA)	4	10μF ±10%	2.0	1.25	0.85*	0805
GRM216R61E105KA12	X5R (EIA)	25	1.0μF ±10%	2.0	1.25	0.6*	0805
GRM316R61E225KA12	X5R (EIA)	25	2.2μF ±10%	3.2	1.6	0.6*	1206
GRM219R61E225KA12	X5R (EIA)	25	2.2μF ±10%	2.0	1.25	0.85*	0805
GRM319R61E475KA12	X5R (EIA)	25	4.7μF ±10%	3.2	1.6	0.85*	1206
GRM216R61C105KA88	X5R (EIA)	16	1.0μF ±10%	2.0	1.25	0.6*	0805
GRM316R61C225KA88	X5R (EIA)	16	2.2μF ±10%	3.2	1.6	0.6*	1206
GRM219R61C225KA88	X5R (EIA)	16	2.2μF ±10%	2.0	1.25	0.85*	0805
GRM219R61C475KE15	X5R (EIA)	16	4.7μF ±10%	2.0	1.25	0.85*	0805
GRM319R61C475KA88	X5R (EIA)	16	4.7μF ±10%	3.2	1.6	0.85*	1206
GRM319R61C106KE15	X5R (EIA)	16	10μF ±10%	3.2	1.6	0.85*	1206
GRM216R61A225KE24	X5R (EIA)	10	2.2μF ±10%	2.0	1.25	0.6*	0805
GRM219R61A225KA01	X5R (EIA)	10	2.2μF ±10%	2.0	1.25	0.85*	0805
GRM316R61A335KE19	X5R (EIA)	10	3.3μF ±10%	3.2	1.6	0.6*	1206
GRM219R61A335KE19	X5R (EIA)	10	3.3μF ±10%	2.0	1.25	0.85*	0805
GRM316R61A475KE19	X5R (EIA)	10	4.7μF ±10%	3.2	1.6	0.6*	1206
GRM219R61A475KE34	X5R (EIA)	10	4.7μF ±10%	2.0	1.25	0.85*	0805
GRM319R61A106KE19	X5R (EIA)	10	10μF ±10%	3.2	1.6	0.85*	1206
GRM219R60J475KE19	X5R (EIA)	6.3	4.7μF ±10%	2.0	1.25	0.85*	0805
GRM319R60J106KE19	X5R (EIA)	6.3	10μF ±10%	3.2	1.6	0.85*	1206

<sup>\*:</sup> Please refer to GRM Series Specifications and Test Methods (2) (P.30).

Below GRM Series Specifications and Test Methods (1) are applied to Non "\*" PNs in capacitance table. In case "\*" is added in capacitance table, please refer to GRM Series Specifications and Test Methods (2) (P.30).

			cations	ter to GRM Series Specifications and Test Methods (2) (P.30).
No.	Item	Temperature Compensating Type	High Dielectric Type	Test Method
1	Operating Temperature Range	-55 to +125℃	B1, B3, F1, R6: −25 to +85°C R1, R7: −55 to +125°C C8: −55 to +105°C E4: +10 to +85°C F5: −30 to +85°C	Reference temperature: $25^{\circ}$ C ( $2\Delta$ , $3\Delta$ , $4\Delta$ , B1, B3, F1, R1: $20^{\circ}$ C)
2	Rated Voltage	See the previous pages.		The rated voltage is defined as the maximum voltage which may be applied continuously to the capacitor.  When AC voltage is superimposed on DC voltage, V <sup>p,p</sup> or V <sup>o,p</sup> , whichever is larger, should be maintained within the rated voltage range.
3	Appearance	No defects or abnormalities		Visual inspection
4	Dimensions	Within the specified dimensions	i	Using calipers (GRM02 size is based on Microscope)
5	Dielectric Strength	No defects or abnormalities		No failure should be observed when 300%* of the rated voltage (temperature compensating type) or 250% of the rated voltage (high dielectric constant type) is applied between the terminations for 1 to 5 seconds, provided the charge/discharge current is less than 50mA. *200% for 500V
6	Insulation Resistance	C≦0.047μF: More than 10,000M C>0.047μF: 500Ω · F	$\Omega$ C: Nominal Capacitance	The insulation resistance should be measured with a DC voltage not exceeding the rated voltage at 20/25°C and 75%RH max. and within 2 minutes of charging, provided the charge/ discharge current is less than 50mA.
7	Capacitance	Within the specified tolerance		
8	Q/ Dissipation Factor (D.F.)	30pF and over: Q≥1000 30pF and below: Q≥400+20C C: Nominal Capacitance (pF)	[R6, R7, C8] W.V.: 100V : 0.025 max. (C<0.068μF) : 0.05 max. (C≥0.068μF) W.V.: 50/25V : 0.025 max. (C≥10μF) : 0.035 max. (C≥10μF) W.V.: 16/10V: 0.035 max. W.V.: 6.3/4V : 0.05 max. (C≥3.3μF) : 0.1 max. (C≥3.3μF) [E4] W.V.: 25Vmin: 0.025 max. [F1, F5] W.V.: 25V min. : 0.05 max. (C<0.1μF) : 0.09 max. (C≥0.1μF) W.V.: 16/10V: 0.125 max. W.V.: 6.3V: 0.15 max. W.V.: 6.3V: 0.15 max.	The capacitance/Q/D.F. should be measured at 20/25°C at the frequency and voltage shown in the table.



Below GRM Series Specifications and Test Methods (1) are applied to Non "\*" PNs in capacitance table. In case "\*" is added in capacitance table, please refer to GRM Series Specifications and Test Methods (2) (P.30). Continued from the preceding page.

				d in capacitance table, please re	erer to divini	beries opecifications and	a rest Methods (2) (F.30).
No.	lt∈	em	Temperature Compensating Type	High Dielectric Type	-	Test Metho	d
		No bias	Within the specified tolerance (Table A-1)	B1, B3: Within $\pm 10\%$ ( $-25$ to $+85\%$ ) R1, R7: Within $\pm 15\%$ ( $-55$ to $+125\%$ ) R6: Within $\pm 15\%$ ( $-55$ to $+85\%$ ) E4: Within $\pm 22/-56\%$ ( $\pm 10$ to $\pm 85\%$ ) F1: Within $\pm 30/-80\%$ ( $\pm 22/-82\%$ ) F5: Within $\pm 22/-82\%$ ( $\pm 30$ to $\pm 85\%$ ) C8: Within $\pm 22\%$ ( $\pm 55$ to $\pm 105\%$ )	each specific (1)Tempera The tempera capacitance When cyclim 5 (5C: +25 the specifier capacitance The capacit between the step 1, 3 an	to +125°C/ΔC: +20 to +1 °C/+20 to +85°C) the capa d tolerance for the temper change as Table A-1. ance drift is calculated by maximum and minimum d 5 by the cap. value in s	nined using the reference. ntially from step 1 through 25°C: other temp. coeffs.: acitance should be within rature coefficient and dividing the differences measured values in the tep 3.
		50% of the Rated Voltage		B1: Within +10/–30% R1: Within +15/–40% F1: Within +30/–95%	Ste123	Reference -55±3 (for ΔC -30±3 (for -25±3 Reference	Derature (°C) Temperature ±2 C to 7U/1X/R6/R7/C8) F5), 10±3 (for E4) (for other TC) Temperature ±2
	Capacitance				5	85±3	c/R7), 105±3 (for C8) (for other TC) Temperature ±2
9	Temperature Characteristics	Capacitance Drift	Within ±0.2% or ±0.05pF (Whichever is larger.) *Do not apply to 1X/25V	*Initial measurement for high dielectric constant type Perform a heat treatment at 150+0/-10°C for one hour and then set for 24±2 hours at room temperature. Perform the initial measurement.	The ranges value over to be within the In case of a measured a	electric Constant Type of capacitance change of the temperature ranges st e specified ranges.* pplying voltage, the capaciter 1 more min. with app to of each temp. stage.  Temperature (°C) Reference Temperature  -55±3 (for R1, R7, R6 -25±3 (for B1, B3, F1 -30±3 (for F5)/10±3 (for Reference Temperature  125±3 (for R1, R7)/ 85±3 (for B1, B3, R6 F1, F5, E4)  Reference Temperature  -55±3 (for B1, F1)  Reference Temperature  125±3 (for B1, F1)  Reference Temperature  125±3 (for B1, F1)	Applying Voltage (V)  Applying Voltage (V)  Applying Voltage (V)  E4)  No bias  ±2  50% of the rated
10	Adhesive of Termin	Strength		or other defect should occur.  C  Solder resist  Baked electrode or copper foil	Fig. 1a using parallel with The soldering reflow meth soldering is	g an eutectic solder. Then the test jig for 10±1 sec. ng should be done either od and should be conduct uniform and free of defection, 2N (GRM03), 5N (GR	with an iron or using the ted with care so that the ets such as heat shock.





Below GRM Series Specifications and Test Methods (1) are applied to Non "\*" PNs in capacitance table. In case "\*" is added in capacitance table, please refer to GRM Series Specifications and Test Methods (2) (P.30). Continued from the preceding page.

			Specif	ications		-,		(=) (= 100)
NIo	Itom				_	Toot Ma	ath a d	
No.	Iten	n	Temperature Compensating Type	High Dielectric Type		Test Me	etnoa	
		Appearance	No defects or abnormalities					
		Capacitance	Within the specified tolerance					
11	Vibration Resistance	Q/D.F.	30pF and over: Q≥1000 30pF and below: Q≥400+20C C: Nominal Capacitance (pF)	[B1, B3, R6, R7, C8] W.V.: 100V : 0.025 max. (C<0.068μF) : 0.05 max. (C≥0.068μF) W.V.: 50/25V : 0.025 max. (C≥10μF) : 0.035 max. (C≥10μF) W.V.: 16/10V: 0.035 max. W.V.: 6.3/4V : 0.05 max. (C≥3.3μF) : 0.1 max. (C≥3.3μF) [E4] W.V.: 25Vmin: 0.025 max. [F1, F5] W.V.: 25V min. : 0.05 max. (C<0.1μF) : 0.09 max. (C≥0.1μF) W.V.: 16/10V: 0.125 max. W.V.: 6.3V: 0.15 max.	Solder the capacite same manner and The capacitor shound having a total ampuniformly between frequency range, fibe traversed in appaplied for a period perpendicular direction.	under the samuld be subjected litude of 1.5mm the approximation 10 to 55Hz proximately 1 rd of 2 hours in	the conditions and to a simple in the frequency the limits of 10 is a and return to minute. This may each of 3 mutu.	s (10). narmonic motion by being varied and 55Hz. The 10Hz, should btion should be
			No crack or marked defect shou	uld occur.	Solder the capacite in Fig. 2a using an direction shown in done by the reflow so that the solderir	eutectic solde Fig. 3a for 5± method and s	r. Then apply a 1 sec. The sold hould be condu	a force in the dering should be ucted with care
12	Deflection		R230 Capacitance (45 Fig. 3a	0 Pressurizing speed: 1.0mm/sec. Pressurize Flexure: ≤1 meter 45	Type GRM02 GRM03 GRM15 GRM18 GRM21 GRM31 GRM32 GRM43 GRM43	100 Fig. 100 100 100 100 100 1.0 1.0 1.2 2.2 2.2 2.2 3.5 4.5	04.5 22a t: 1.6mm (GRM02) 0.56 0.9 1.5 3.0 4.0 5.0 7.0 8.0	03/15: t: 0.8mm)  C 0.23 0.3 0.5 1.2 1.65 2.0 2.9 3.7 5.6 (in mm)
13	Solderabili Terminatio		75% of the terminations are to l continuously.	pe soldered evenly and	Immerse the capac rosin (JIS-K-5902) Preheat at 80 to 12 After preheating, ir 2±0.5 seconds at 2 for 2±0.5 seconds	(25% rosin in 20℃ for 10 to 3 nmerse in an 6 230±5℃ or Sn	weight proporti 0 seconds. eutectic solder	JIS-K-8101) and ion) .





Below GRM Series Specifications and Test Methods (1) are applied to Non "\*" PNs in capacitance table. In case "\*" is added in capacitance table, please refer to GRM Series Specifications and Test Methods (2) (P.30). Continued from the preceding page.

	Continued ii	om the pree		ications	efer to GRM Series Specifications and Test Methods (2) (P.30).
No.	Ite	em	Temperature Compensating Type	High Dielectric Type	Test Method
			The measured and observed chapecifications in the following ta	-	
		Appearance	No defects or abnormalities		
		Capacitance Change	Within ±2.5% or ±0.25pF (Whichever is larger)	B1, B3, R1, R6, R7, C8 : Within ±7.5% F1, F5, E4: Within ±20%	
14	Resistance to Soldering Heat	Q/D.F.	30pF and over: Q≥1000 30pF and below: Q≥400+20C C: Nominal Capacitance (pF)	[B1, B3, R6, R7, C8] W.V.: 100V : 0.025 max. (C<0.068μF) : 0.05 max. (C≥0.068μF) W.V.: 50/25V : 0.025 max. (C≥10μF) : 0.035 max. (C≥10μF) W.V.: 16/10V: 0.035 max. W.V.: 6.3/4V : 0.05 max. (C≥3.3μF) : 0.1 max. (C≥3.3μF) [E4] W.V.: 25Vmin: 0.025 max. [F1, F5] W.V.: 25V min. : 0.05 max. (C<0.1μF) : 0.09 max. (C≥0.1μF) U.V.: 16/10V: 0.125 max.	Preheat the capacitor at 120 to 150°C for 1 minute. Immerse the capacitor in an eutectic solder or Sn-3.0Ag-0.5Cu solder solution at 270±5°C for 10±0.5 seconds. Set at room temperature for 24±2 hours, then measure.  •Initial measurement for high dielectric constant type Perform a heat treatment at 150+0/−10°C for one hour and then set at room temperature for 24±2 hours. Perform the initial measurement.  •Preheating for GRM32/43/55  Step Temperature Time 1 100 to 120°C 1 min. 2 170 to 200°C 1 min.
		I.R.	More than $10,000\text{M}\Omega$ or $500\Omega$	W.V.: 6.3V: 0.15 max.	
		Dielectric Strength	No defects	(Willichever is Smaller)	
		g	The measured and observed chapecifications in the following ta		
		Appearance	No defects or abnormalities		
		Capacitance Change	Within ±2.5% or ±0.25pF (Whichever is larger)	B1, B3, R1, R6, R7, C8 : Within ±7.5% F1, F5, E4: Within ±20%	Fix the capacitor to the supporting jig in the same manner and under the same conditions as (10).  Perform the five cycles according to the four heat treatments
				[R6, R7, C8]	shown in the following table. Set for 24±2 hours at room temperature, then measure.
				W.V.: 100V : 0.05 max. (C<0.068µF)	Step         1         2         3         4
				: 0.075 max. (C≧0.068µF) W.V.: 50/25/16/10V : 0.05 max.	Temp. (°C) Min. Operating Temp. +0/-3 Room Temp. +3/-0 Room Temp.
15	Temperature Cycle		30pF and over: Q≧1000	W.V.: 6.3/4V : 0.075 max. (C<3.3µF)	Time (min.) 30±3 2 to 3 30±3 2 to 3
	0,5.0	Q/D.F.	30pF and below: Q≥400+20C C: Nominal Capacitance (pF)	: 0.125 max. (C≥3.3μF)  [E4]  W.V.: 25Vmin: 0.05 max.  [F1, F5]  W.V.: 25V min.  : 0.05 max. (C<0.1μF)	•Initial measurement for high dielectric constant type Perform a heat treatment at 150+0/-10°C for one hour and then set at room temperature for 24±2 hours. Perform the initial measurement.
				: 0.09 max. (C≧0.1µF) W.V.: 16/10V: 0.125 max. W.V.: 6.3V: 0.15 max.	
		I.R.	More than $10,000 \text{M}\Omega$ or $500 \Omega$	F (Whichever is smaller)	
		Dielectric Strength	No defects		





Below GRM Series Specifications and Test Methods (1) are applied to Non "\*" PNs in capacitance table. In case "\*" is added in capacitance table, please refer to GRM Series Specifications and Test Methods (2) (P.30). Continued from the preceding page.

			Specifi	cations	
0.	Item		Temperature Compensating Type	High Dielectric Type	Test Method
			The measured and observed chapecifications in the following ta	•	
	Appear	earance	No defects or abnormalities		
	Capacit Change		Within ±5% or ±0.5pF (Whichever is larger)	B1, B3, R1, R6, R7, C8 : Within ±12.5% F1, F5, E4: Within ±30%	
Humid 6 (Stead State)	-	D.F.	30pF and over: Q≥350 10pF and over 30pF and below: Q≥275+2.5C 10pF and below: Q≥200+10C C: Nominal Capacitance (pF)	[R6, R7, C8] W.V.: 100V : 0.05 max. (C<0.068μF) : 0.075 max. (C≥0.068μF) W.V.: 50/25/16/10V : 0.05 max. W.V.: 6.3/4V : 0.075 max. (C≥3.3μF) : 0.125 max. (C≥3.3μF) [E4] W.V.: 25Vmin: 0.05 max. [F1, F5] W.V.: 25V min. : 0.075 max. (C<0.1μF) : 0.125 max. (C≥0.1μF) W.V.: 16/10V: 0.15 max. W.V.: 6.3V: 0.2 max.	Set the capacitor at 40±2°C and in 90 to 95% humidity for 500±12 hours.  Remove and set for 24±2 hours at room temperature, then measure.
	I.R.		More than 1,000M $\Omega$ or $50\Omega \cdot \text{F}$	(Whichever is smaller)	
			The measured and observed ch	naracteristics should satisfy the	
			specifications in the following ta	ble.	
	Appear		specifications in the following ta No defects or abnormalities	ble.	
	Appear Capacit Change	earance		ble.  B1, B3, R1, R6, R7, C8 : Within ±12.5% F1, F5, E4: Within ±30% [W.V.: 10V max.] F1, F5: Within +30/-40%	
7 Humid Load	Capacil Change	earance citance ge	No defects or abnormalities  Within ±7.5% or ±0.75pF	B1, B3, R1, R6, R7, C8 : Within ±12.5% F1, F5, E4: Within ±30% [W.V.: 10V max.]	Apply the rated voltage at 40±2°C and 90 to 95% humidity fo 500±12 hours. Remove and set for 24±2 hours at room temperature, then measure.  The charge/discharge current is less than 50mA.  •Initial measurement for F1, F5/10V max.  Apply the rated DC voltage for 1 hour at 40±2°C.  Remove and set for 24±2 hours at room temperature.  Perform initial measurement.





Below GRM Series Specifications and Test Methods (1) are applied to Non "\*" PNs in capacitance table. In case "\*" is added in capacitance table, please refer to GRM Series Specifications and Test Methods (2) (P.30). Continued from the preceding page.

		<u> </u>	Specifications		erer to GRM Series Specifications and Test Methods (2) (P.30).
No.	Ite	em	Temperature Compensating Type	High Dielectric Type	Test Method
			The measured and observed characteristics should satisfy the specifications in the following table.  No defects or abnormalities		
		Appearance			
		Capacitance Change	Within ±3% or ±0.3pF (Whichever is larger)	B1, B3, R1, R6, R7, C8 : Within ±12.5% F1, F5, E4: Within ±30% [Except 10V max. and. C≥1.0µF] F1, F5: Within +30/−40% [10V max. and C≥1.0µF]	Apply 200%* of the rated voltage at the maximum operating temperature ±3℃ for 1000±12 hours.
18	High Temperature Load	Q/D.F.	30pF and over: Q≥350 10pF and over 30pF and below: Q≥275+2.5C 10pF and below: Q≥200+10C C: Nominal Capacitance (pF)	[B1, B3, R6, R7, C8] W.V.: 100V : 0.05 max. (C<0.068μF) : 0.075 max. (C≥0.068μF) W.V.: 50/25/16/10V : 0.05 max. W.V.: 6.3/4V : 0.075 max. (C≤3.3μF) : 0.125 max. (C≥3.3μF) [E4] W.V.: 25Vmin: 0.05 max. [F1, F5] W.V.: 25V min. : 0.075 max.(C<0.1μF) : 0.125 max.(C≥0.1μF) W.V.: 16/10V: 0.15 max. W.V.: 6.3V: 0.2 max.	Set for 24±2 hours at room temperature, then measure. The charge/discharge current is less than 50mA.  •Initial measurement for high dielectric constant type. Apply 200% of the rated DC voltage at the maximum operating temperature ±3°C for one hour. Remove and set for 24±2 hours at room temperature. Perform initial measurement.  *150% for 500V
		I.R.	More than 1,000M $\Omega$ or 50 $\Omega$ · F	(Whichever is smaller)	

## Table A-1

		Capacitance Change from 25°C (%)						
Char.	Nominal Values (ppm/℃)*1	<b>-</b> 55		-30		-10		
		Max.	Min.	Max.	Min.	Max.	Min.	
5C	0± 30	0.58	-0.24	0.40	-0.17	0.25	-0.11	
6C	0± 60	0.87	-0.48	0.59	-0.33	0.38	-0.21	
6P	-150± 60	2.33	0.72	1.61	0.50	1.02	0.32	
6R	-220± 60	3.02	1.28	2.08	0.88	1.32	0.56	
6S	-330± 60	4.09	2.16	2.81	1.49	1.79	0.95	
6T	-470± 60	5.46	3.28	3.75	2.26	2.39	1.44	
7U	-750±120	8.78	5.04	6.04	3.47	3.84	2.21	
1X	+350 to -1000	_	_	_	_	_	_	

<sup>\*1:</sup> Nominal values denote the temperature coefficient within a range of 25°C to 125°C (for △C)/85°C (for other TC).

(2)

		Capacitance Change from 20℃ (%)						
Char.	Nominal Values (ppm/°C)*2	<b>-</b> 55		<b>—</b> 25		-10		
		Max.	Min.	Max.	Min.	Max.	Min.	
2C	0± 60	0.82	-0.45	0.49	-0.27	0.33	-0.18	
3C	0±120	1.37	-0.90	0.82	-0.54	0.55	-0.36	
4C	0±250	2.56	-1.88	1.54	-1.13	1.02	-0.75	
2P	-150± 60	_	_	1.32	0.41	0.88	0.27	
3P	-150±120	_	_	1.65	0.14	1.10	0.09	
4P	-150±250	_	_	2.36	-0.45	1.57	-0.30	
2R	-220± 60	_	_	1.70	0.72	1.13	0.48	
3R	-220±120	_	_	2.03	0.45	1.35	0.30	
4R	-220±250	_	_	2.74	-0.14	1.83	-0.09	
2S	-330± 60	_	_	2.30	1.22	1.54	0.81	
3S	-330±120	_	_	2.63	0.95	1.76	0.63	
4S	-330±250	_	_	3.35	0.36	2.23	0.24	
2T	-470± 60	_	_	3.07	1.85	2.05	1.23	
3T	-470±120	_	_	3.40	1.58	2.27	1.05	
4T	-470±250	_	_	4.12	0.99	2.74	0.66	
3U	-750±120	_	_	4.94	2.84	3.29	1.89	
4U	-750±250	_	_	5.65	2.25	3.77	1.50	

<sup>\*2:</sup> Nominal values denote the temperature coefficient within a range of 20°C to 125°C (for △C)/85°C (for other TC).

Below GRM Series Specifications and Test Methods (2) are applied to "\*" PNs in capacitance table. In case "\*" is not added in capacitance table, please refer to GRM Series Specifications and Test Methods (1) (P.24).

No.	Ite	em	Specifications		Test Method				
1	B1, B3, F1: -25 to +85°C  R6: -55 to +85°C  R7, C7: -55 to +125°C  Range  R3, C7: -55 to +125°C  C8: -55 to +105°C,			Reference temperature: 25°C (B1, B3, F1: 20°C)					
2	Rated Vo	ltage	See the previous pages.	The rated voltage is defined as the maximum voltage whimay be applied continuously to the capacitor.  When AC voltage is superimposed on DC voltage, V <sup>p.p</sup> or whichever is larger, should be maintained within the rated voltage range.					
3	Appearan	nce	No defects or abnormalities	Visual insp	isual inspection				
4	Dimensio	ns	Within the specified dimensions	Using calip	ers				
5	Dielectric	Strength	No defects or abnormalities	is applied b	should be observed when 250% between the terminations for 1 to be charge/discharge current is le	to 5 seconds,			
6	Insulation Resistance		More than $50\Omega \cdot F$	The insulation resistance should be measured with a DC voltage not exceeding the rated voltage at reference temperature and 75%RH max. and within 1 minutes of charging, provided the charge/discharge current is less than 50mA.					
7	Capacitar	nce	Within the specified tolerance		itance/D.F. should be measured				
8	Dissipation Factor (D.F.)		B1, B3, R6* <sup>2</sup> , R7, C7, C8: 0.1 max. F1, F5: 0.2 max.	temperature at the frequency and voltage shown in the tab  Capacitance Frequency Voltage  C≤10μF (10V min.)**¹ 1±0.1kHz 1.0±0.2Vrms  C≤10μF (6.3V max.) 1±0.1kHz 0.5±0.1Vrms  C>10μF 120±24Hz 0.5±0.1Vrms  *1 However the voltage is 0.5±0.1Vrms about Table 1 items on the left side.					
		No bias	B1, B3: Within ±10% (-25 to +85°C) F1 : Within +30/-80% (-25 to +85°C) R6 : Within ±15% (-55 to +85°C) R7 : Within ±15% (-55 to +125°C) F5 : Within +22/-82% (-30 to +85°C) C7 : Within ±22% (-55 to +125°C) C8 : Within ±22% (-55 to +105°C)	each speci The ranges reference t shown in the In case of a measured	itance change should be measurated temp. stage.  s of capacitance change comparemperature value over the temperature value over the spapplying voltage, the capacitanual fer 1 more min. with applying n of each temp. stage.	ared with the perature ranges becified ranges.* Ice change should be			
							*CDM42 F	04/D6 0 1/4	0.2)/****
				Step	31/R6 0J/1A 336/476 only: 1.0±0.2Vrms  Temperature (°C) Applying Voltage				
			1	Reference temperature ±2	Applying voltage (v)				
9	Capacitance Temperature			2	-55±3 (for R6, C7, C8)/ -25±3 (for B1, B3, F1) -30±3 (for F5)				
	Characteristics			3	Reference temperature ±2	No bias			
		50% of the Rated Voltage	B1: Within +10/-30% F1: Within +30/-95%	4	85±3 (for B1, B3, F1, R6, F5) 125±3 (for C7)/ 105±3 (for C8)				
				5	20±2				
				6	–25±3 (for B1, F1)	50% of the rated			
				7	20 <u>±</u> 2	voltage			
				8	85±3 (for B1, F1)				
				Perform a then set for	isurement for high dielectric co heat treatment at 150 +0/–10° r 24±2 hours at room temperat e initial measurement.	C for one hour and			

\*2: GRM31CR60J107: 0.15 max.





Below GRM Series Specifications and Test Methods (2) are applied to "\*" PNs in capacitance table. Continued from the preceding page.

$\supset$	Continued from the preceding page. In case "*" is not added in capacitance table, please refer to GRM Series Specifications and Test Methods (1) (P.2)						thods (1) (P.24).	
No.	Ite	em	Specifications		Test Me	ethod		
10	Adhesive Strength of Termination		No removal of the terminations or other defects should occur.	Solder the capacitor on the test jig (glass epox in Fig. 1a using an eutectic solder. Then apply parallel with the test jig for 10±1sec.  The soldering should be done either with an irreflow method and should be conducted with cooldering is uniform and free of defects such a *5N: GRM15/GRM18, 2N: GRM03  Type a b GRM02  GRM02  GRM03  GRM15  GRM15  GRM15  GRM16  GRM16  GRM17  GRM17  GRM18  GRM18  GRM19  GRM19  GRM19  GRM19  GRM19  GRM10  GRM		10N* force in n or using the are so that the		
			N. I.C. I. IV					
		Appearance	No defects or abnormalities	Solder the capacito	-			
		Capacitance	Within the specified tolerance	same manner and The capacitor shou			, ,	
11	Vibration	D.F.	B1, B3, R6* <sup>2</sup> , R7, C7, C8: 0.1 max. F1, F5: 0.2 max.	The capacitor should be subjected to a si having a total amplitude of 1.5mm, the fre uniformly between the approximate limits frequency range, from 10 to 55Hz and ret be traversed in approximately 1 minute. T applied for a period of 2 hours in each of perpendicular directions (total of 6 hours)			equency being varied of 10 and 55Hz. The turn to 10Hz, should This motion should be 3 mutually	
			No cracking or marking defects should occur.	Solder the capacito	or on the test ji	g (glass epoxy	/ board) shown	
	R230_		20 50 Pressurizing speed : 1.0mm/sec.  Pressurize  R230  Flexure : ≦1	in Fig. 2a using an eutectic solder. Then apply a force in the direction shown in Fig. 3a for 5±1 sec. The soldering should I done by the reflow method and should be conducted with car so that the soldering is uniform and free of defects such as he shock.				
12	Deflectio	ection Capacitance meter			100 Fig. 2	<del></del>	t: 1.6mm	
			45 45				//03/15: t: 0.8mm)	
			Fig.3a	Туре	a	b	С	
			ı ıg.sa	GRM02	0.2	0.56	0.23	
				GRM03	0.3	0.9	0.3	
				GRM15 GRM18	1.0	1.5 3.0	0.5 1.2	
				GRM21	1.0	4.0	1.65	
				GRM31	2.2	5.0	2.0	
				GRM32	2.2	5.0	2.9	
				GRM43	3.5	7.0	3.7	
				GRM55	4.5	8.0	5.6	
				GKIVIOO	7.0	1 0.0	(in mm)	
13	Solderab Terminati		75% of the terminations is to be soldered evenly and continuously.	Immerse the capacinosin (JIS-K-5902) Preheat at 80 to 12 After preheating, ir 2±0.5 seconds at 2	(25% rosin in 20℃ for 10 to 3 mmerse in an 6 230±5℃ or Sn	weight proport 0 seconds. eutectic solder	ion) .	
				for 2±0.5 seconds	at 245±5°C.			
*2	· GRM31CI	260 I107: 0	15 may					

\*2: GRM31CR60J107: 0.15 max.





Below GRM Series Specifications and Test Methods (2) are applied to "\*" PNs in capacitance table. Continued from the preceding page. In case "\*" is not added in capacitance table, please refer to GRM Series Specifications and Test Methods (1) (P.24).

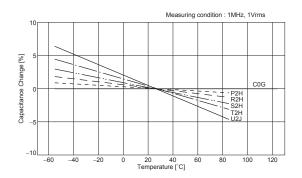
No. It	em	Specifications	Test Method					
	Appearance Capacitance Change	No defects or abnormalities  B1, B3, R6, R7, C7, C8: Within ±7.5%  F1, F5: Within ±20%	Immerse the o	Preheat the capacitor at 120 to 150°C for 1 minute.  Immerse the capacitor in an eutectic solder or Sn-3.0Ag solder solution at 270±5°C for 10±0.5 seconds. Set at ro				
	D.F.	B1, B3, R6* <sup>2</sup> , R7, C7, C8: 0.1 max. F1, F5: 0.2 max.		temperature for 24±2 hours, then measure. *Do not apply to GRM02.		asure.		
Resistance	I.R.	More than $50\Omega \cdot F$		•		c constant type 10℃ for one ho		
14 to Soldering Heat	Dialogtria		then set at roo Perform the in	om temperature nitial measurem	e for 24± ent.		ui anu	
	Dielectric Strength	No defects	*Preheating for GRM32/43/55  Step Temperature Time					
			1		o 120°C		min.	
			2		200℃		min.	
	Appearance	No defects or abnormalities	Fix the capac	itor to the supp	orting jig	in the same m	anner and	
	Capacitance Change	B1, B3, R6, R7, C7, C8: Within ±7.5% F1, F5: Within ±20%	under the same conditions as (10).  Perform the five cycles according to the four heat treatments shown in the following table.					
	D.F.	B1, B3, R6*2, R7, C7, C8: 0.1 max. F1, F5: 0.2 max.	Set for 24±2	hours at room	temperat	ure, then meas		
Temperature	I.R.	More than $50\Omega \cdot F$	Step	Min.	2	3 Max.	4	
Sudden Change		No detects	Temp. (℃)	Operating Temp. +0/-3	Room Temp.	Operating Temp. +3/-0	Room Temp.	
			Time (min.) 30±3 2 to 3 30±3 2 to 3  •Initial measurement for high dielectric constant type Perform a heat treatment at 150+0/−10°C for one hour and then set at room temperature for 24±2 hours. Perform the initial measurement.					
	Appearance	No defects or abnormalities	Apply the rated voltage at 40±2℃ and 90 to 95% humidity for					
High	Capacitance Change	B1, B3, R6, R7, C7, C8: Within ±12.5% F1, F5: Within ±30%	500±12 hours. The charge/discharge current is less that  •Initial measurement				than 50m/	
Temperature High Humidity	D.F.	B1, B3, R6, R7, C7, C8: 0.2 max. F1, F5: 0.4 max.	Perform a hea	Perform a heat treatment at 150+0/-10°C for one hour are then let sit for 24±2 hours at room temperature. Perform to initial measurement.				
(Steady)	I.R.	More than 12.5 $\Omega$ · F	Measurement after test  Perform a heat treatment at 150+0/-10°C for one I then let sit for 24±2 hours at room temperature, the					
	Appearance	No defects or abnormalities	1 1 1		0	000±12 hours a		
	Capacitance Change	B1, B3, R6, R7, C7, C8: Within ±12.5% F1, F5: Within ±30%	room tempera	operating temperature ±3°C. Let sit for 24±2 hours perature, then measure. e/discharge current is less than 50mA.				
	D.F.	B1, B3, R6, R7, C7, C8: 0.2 max. F1, F5: 0.4 max.	Initial measurement					
17 Durability	I.R.	More than $25\Omega \cdot F$	then let sit for initial measure  •Measuremer Perform a hea	24±2 hours at ement. at after test at treatment at	room ter 150+0/-	10℃ for one ho nperature. Perf 10℃ for one ho nperature, then	orm the	

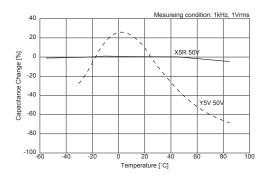
<sup>\*2:</sup> GRM31CR60J107: 0.15 max.



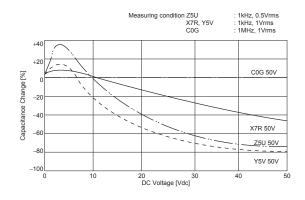
## **GRM Series Data**

### ■ Capacitance - Temperature Characteristics

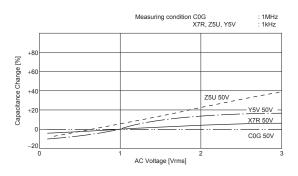




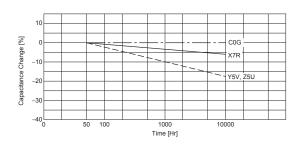
### ■ Capacitance - DC Voltage Characteristics



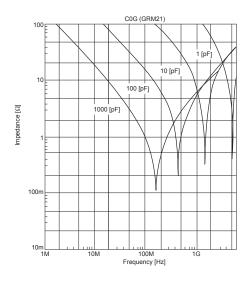
### ■ Capacitance - AC Voltage Characteristics



### ■ Capacitance Change - Aging



### ■ Impedance - Frequency Characteristics



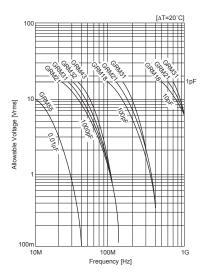




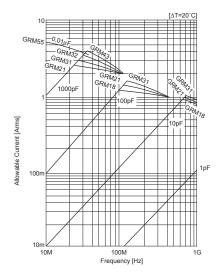
## **GRM Series Data**

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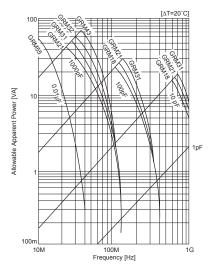
### ■ Allowable Voltage - Frequency



## ■ Allowable Current - Frequency



### ■ Allowable Apparent Power - Frequency



# **Chip Monolithic Ceramic Capacitors**

# **Microchips GMA Series**

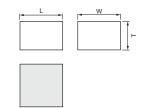
#### ■ Features

- 1. Better microwave characteristics
- 2. Suitable for by-passing
- 3. High density mounting

#### Applications

- 1. Optical device for telecommunication
- 2. IC, IC packaging built-in
- 3. Measuring equipment





Part Number		Dimensions (mm)	
Part Number	L	W	T
GMA05X	0.5 ±0.05	0.5 ±0.05	0.35 ±0.05
GMA085	0.8 ±0.05	0.8 ±0.05	0.5 ±0.1

Part Number	TC Code (Standard)	Rated Voltage (Vdc)	Capacitance	Length L (mm)	Width W (mm)	Thickness T (mm)
GMA05XR72A101MD01	X7R (EIA)	100	100pF ±20%	0.5	0.5	0.35
GMA05XR72A151MD01	X7R (EIA)	100	150pF ±20%	0.5	0.5	0.35
GMA05XR72A221MD01	X7R (EIA)	100	220pF ±20%	0.5	0.5	0.35
GMA05XR72A331MD01	X7R (EIA)	100	330pF ±20%	0.5	0.5	0.35
GMA085R72A331MD01	X7R (EIA)	100	330pF ±20%	0.8	0.8	0.5
GMA085R72A471MD01	X7R (EIA)	100	470pF ±20%	0.8	0.8	0.5
GMA085R72A681MD01	X7R (EIA)	100	680pF ±20%	0.8	0.8	0.5
GMA085R72A102MD01	X7R (EIA)	100	1000pF ±20%	0.8	0.8	0.5
GMA05XR71H161MD01	X7R (EIA)	50	160pF ±20%	0.5	0.5	0.35
GMA05XR71H331MD01	X7R (EIA)	50	330pF ±20%	0.5	0.5	0.35
GMA05XR71H471MD01	X7R (EIA)	50	470pF ±20%	0.5	0.5	0.35
GMA05XR71C431MD01	X7R (EIA)	16	430pF ±20%	0.5	0.5	0.35
GMA05XR71C471MD01	X7R (EIA)	16	470pF ±20%	0.5	0.5	0.35
GMA05XR71C681MD01	X7R (EIA)	16	680pF ±20%	0.5	0.5	0.35
GMA05XR71C102MD01	X7R (EIA)	16	1000pF ±20%	0.5	0.5	0.35
GMA085R71C102MD01	X7R (EIA)	16	1000pF ±20%	0.8	0.8	0.5
GMA05XR71C152MD01	X7R (EIA)	16	1500pF ±20%	0.5	0.5	0.35
GMA085R71C152MD01	X7R (EIA)	16	1500pF ±20%	0.8	0.8	0.5
GMA05XR71C222MD01	X7R (EIA)	16	2200pF ±20%	0.5	0.5	0.35
GMA085R71C222MD01	X7R (EIA)	16	2200pF ±20%	0.8	0.8	0.5
GMA085R71C332MD01	X7R (EIA)	16	3300pF ±20%	0.8	0.8	0.5
GMA085R71C472MD01	X7R (EIA)	16	4700pF ±20%	0.8	0.8	0.5
GMA085R71C682MD01	X7R (EIA)	16	6800pF ±20%	0.8	0.8	0.5
GMA085R71C103MD01	X7R (EIA)	16	10000pF ±20%	0.8	0.8	0.5

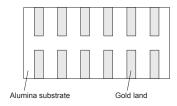
No.	Ite	em	Specifications		Test Method																	
1	Operating Temperating Range	_	R7: −55 to +125°C	Reference	Temperature: 25℃																	
may be applied cont 2 Rated Voltage See the previous pages. When AC voltage is				voltage is defined as the maxi plied continuously to the capa voltage is superimposed on D is larger, should be maintained	acitor. C voltage, V <sup>p-p</sup> or V <sup>o-p</sup> ,																	
3	Appearar	nce	No defects or abnormalities	Using calip	pers																	
4	Dimensio	ns	Within the specified dimersions	Visual insp	ection																	
5	Dielectric	Strength	No defects or abnormalities	rated voltage	should be observed when a voge is applied between the both provided the charge/discharge	h terminations for 1 to 5																
6	Insulation	Resistance	10,000MΩ min.	voltage no	tion resistance should be mea t exceeding the rated voltage ity and within 2 minutes of cha	at normal temperature																
7	Capacita	nce	Within the specified tolerance		itance/D.F. should be measur																	
8	Dissipatio (D.F.)	n Factor	R7: 0.035 max.	Freque		kHz																
		No bias	No bias F		The capacitance change should be measured after 5min. at each specified temp. stage.  • The ranges of capacitance change compared with the Reference Temperature value over the temperature ranges shown in the table should be within the specified ranges.* In case of applying voltage, the capacitance change should be measured after 1 more min. with applying voltage in equilibration of each temp. stage.																	
	Capacitance			No bias		Step 1	Temperature (°C) Reference Temperature±2	Applying Voltage (V)														
9	Temperature Characteristics				No bias	No bias	R7: Within +/–15% (–55 to +125°C)	2	-55±3 (for R7) -30±3 (for F5)	No bias												
																				3	Reference Temperature±2	⊢
								4	125±3 (for R7) 85±3 (for F5)													
				*Initial measurement for high dielectric constant type Perform a heat treatment at 150 +0/-10°C for one hour and then let sit for 24±2 hours at room temperature. Perform the initial measurement.																		
10	Mechanical	Bond Strength	Pull force: 0.03N min.	Mount the 6	883 Method 2011 Condition D capacitor on a gold metallized 20) and bond a 25μm (0.0008 erminal using an ultrasonic ball	inch) gold wire to the																
	Strength	Die Shear Strength	Die Shear force: 2N min.	Mount the	883 Method 2019 capacitor on a gold metallized (80/20). Apply the force para																	
		Appearance	No defects or abnormalities		uency from 10 to 55Hz then re																	
11	Vibration Capacitance		Within the specified tolerance		Amplitude: 1.5 mm (0.06 inch) motion for a period of 2 hours																	
	rtesistance	D.F.	R7: 0.035 max.	perpendicular directions (total 6 hours).																		
		Appearance	No defects or abnormalities		itor should be set for 24±2 ho																	
		Capacitance Change	R7: Within ±7.5%	temperature after one hour heat of treatment at 150+0/-10°C, then measure for the initial measurement. Fix the capacitor to the supporting jig in the same manner and under the same																		
	Temperature	D.F.	R7: 0.035 max.	_	as (11) and conduct the five o																	
12	Temperature Cycle	I.R.	10,000M $\Omega$ min.		res and time shown in the folk is at room temperature, then n	•																
		Dielectric Strength	No defects	Step Temp. (%	Temp. +0/-3  1 2 Room Marganian Room Temp. T	3 4 ax. Operating Room Temp. +3/-0 Temp. 30±3 2 to 3																
			•																			

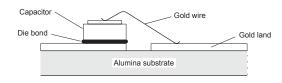


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No.	Ite	em	Specifications	Test Method						
		Appearance	No defects or abnormalities							
13	Humidity (Standy State)	Capacitance Change	R7: Within ±12.5%	Set the capacitor for 500±12 hours at 40±20°C, in 90 to 95% humidity.  Take it out and set it for 24±2 hours at room temperature, then						
	(Steady State)	D.F.	R7: 0.05 max.	measure.						
		I.R.	1,000M $\Omega$ min.							
		Appearance	No defects or abnormalities							
14	Humidity	Capacitance Change	R7: Within ±12.5%	Apply the rated voltage for 500±12 hours at 40±2°C, in 90 to 95% humidity and set it for 24±2 hours at room temperature, then measure. The charge/discharge current is						
	Load	D.F.	R7: 0.05 max.	less than 50mA.						
		I.R.	500M $\Omega$ min.							
		Appearance	No defects or abnormalities	A voltage treatment should be given to the capacitor, in which a						
	High	Capacitance Change	R7: Within ±12.5%	DC voltage of 200% the rated voltage is applied for one hour at the maximum operating temperature ±3°C then it should be set for 24±2 hours at room temperature and the initial measurement						
15	Temperature	D.F.	R7: 0.05 max.	should be conducted.						
	Load	I.R.	1,000MΩ min.	Then apply the above mentioned voltage continuously for 1000±12 hours at the same temperature, remove it from the bath, and set it for 24±2 hours at room temperature, then measure. The charge/discharge current is less than 50mA.						

Mounting for testing: The capacitors should be mounted on the substrate as shown below using die bonding and wire bonding when tests No.11 to 15 are performed.





# **Chip Monolithic Ceramic Capacitors**



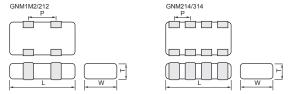
# **Capacitor Arrays GNM Series**

#### ■ Features

- 1. High density mounting due to mounting space saving
- 2. Mounting cost saving

#### ■ Applications

General electronic equipment



Part Number	Dimensions (mm)							
Part Number	L	W	Т	Р				
GNM1M2	1.37 +0.15	1.0 ±0.15	0.6 ±0.1	0.64 +0.05				
GNIVITIVIZ	1.37 ±0.13	1.0 ±0.15	0.8 +0/-0.15	0.04 ±0.05				
GNM212	2.0 +0.15	1.25 +0.15	0.85 ±0.1	1.0 ±0.1				
GNM214	2.0 ±0.13	1.25 ±0.15	0.6 ±0.1	0.5 ±0.05				
GNM314	3.2 +0.15	1.6 ±0.15	0.8 ±0.1	0.8 +0.1				
GNW314	3.2 ±0.13	1.0 ±0.15	1.0 ±0.1	0.6 ±0.1				

#### **Temperature Compensating Type**

Part Number		GNM1M	GNM21	GNI	N31
LxW		1.37x1.0	2.0x1.25	3.2x	1.6
тс		C0G ( <b>5C</b> )	C0G ( <b>5C</b> )	C0 ( <b>5</b> 0	
Rated Volt.		50 ( <b>1H</b> )	50 ( <b>1H</b> )	100 ( <b>2A</b> )	50 ( <b>1H</b> )
Capacitance, Ca	pacitanc	e Tolerance and T Dimension			
10pF( <b>100</b> )	K	0.6(2)	0.6(4)	0.8(4)	0.8(4)
15pF( <b>150</b> )	K	0.6(2)	0.6(4)	0.8(4)	0.8(4)
22pF( <b>220</b> )	K	0.6(2)	0.6(4)	0.8(4)	0.8(4)
27pF( <b>270</b> )	K	0.6(2)	0.6(4)	0.8(4)	0.8(4)
33pF( <b>330</b> )	K	0.6(2)	0.6(4)	0.8(4)	0.8(4)
39pF( <b>390</b> )	K	0.6(2)	0.6(4)	0.8(4)	0.8(4)
47pF( <b>470</b> )	K	0.6(2)	0.6(4)	0.8(4)	0.8(4)
68pF( <b>680</b> )	K	0.6(2)	0.6(4)	0.8(4)	0.8(4)
100pF( <b>101</b> )	K	0.6(2)	0.6(4)	0.8(4)	0.8(4)
150pF( <b>151</b> )	K	0.6(2)	0.6(4)	0.8(4)	0.8(4)
220pF( <b>221</b> )	K	0.6(2)	0.6(4)		0.8(4)
270pF( <b>271</b> )	K				0.8(4)
330pF( <b>331</b> )	K				0.8(4)

The part numbering code is shown in each ( ). The (4) code in T (mm) means number of elements (four). Dimensions are shown in mm and Rated Voltage in Vdc.

#### **High Dielectric Constant Type GNM1M Series**

Part Number			GNM1M							
LxW					1.37x1.0					
TC X5R X7R (R6) (R7)										
Rated Volt.		16 ( <b>1C</b> )	10 ( <b>1A</b> )	6.3 ( <b>0J</b> )	50 ( <b>1H</b> )	25 ( <b>1E</b> )	16 ( <b>1C</b> )	10 ( <b>1A</b> )		
Capacitance, Ca	pacitanc	e Tolerance and	T Dimension							
1000pF( <b>102</b> )	М				0.6(2)					
2200pF( <b>222</b> )	K, M					0.6(2)				
4700pF( <b>472</b> )	K, M					0.6(2)				
10000pF( <b>103</b> )	М					0.6(2)				
22000pF( <b>223</b> )	K, M	0.6(2)	0.6(2)				0.6(2)	0.6(2)		

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Part Number		GNM1M						
LxW					1.37x1.0			
тс	X5R ( <b>R6</b> )				X7R ( <b>R7</b> )			
Rated Volt.		16 ( <b>1C</b> )	10 ( <b>1A</b> )	6.3 ( <b>0J</b> )	50 ( <b>1H</b> )	25 ( <b>1E</b> )	16 ( <b>1C</b> )	10 ( <b>1A</b> )
Capacitance, Ca	pacitano	e Tolerance and	T Dimension					•
47000pF( <b>473</b> )	K, M	0.6(2)	0.6(2)				0.6(2)	0.6(2)
0.10μF( <b>104</b> )	М		0.6(2)					
1.0μF( <b>105</b> )	М	0.8(2)	0.8(2)	0.8(2)				

The part numbering code is shown in each ( ). The (2) code in T (mm) means number of elements (two).

Continued from the preceding page.

#### **High Dielectric Constant Type GNM21 Series**

Part Number		GNM21					
LxW		2.0x1.25					
тс		X5R (R6) X7R (R7)					
Rated Volt. 16 (1C)			10 ( <b>1A</b> )	50 (1H) 25 (1E)		16 ( <b>1C</b> )	
Capacitance, Ca	pacitano	e Tolerance and T Dime	nsion		'		
1000pF( <b>102</b> )	М			0.6(4)			
2200pF( <b>222</b> )	K, M				0.6(4)		
4700pF( <b>472</b> )	K, M				0.6(4)		
10000pF( <b>103</b> )	М				0.6(4)		
22000pF( <b>223</b> )	K, M					0.85(4)	
47000pF( <b>473</b> )	K, M					0.85(4)	
0.10μF( <b>104</b> )	М					0.85(4)	
0.47μF( <b>474</b> )	М	0.85( <b>2</b> )					
1.0μF( <b>105</b> )	М	0.85( <b>2</b> )	0.85(4)				
2.2μF( <b>225</b> )	K, M		0.85( <b>2</b> )				

The part numbering code is shown in each ( ). The (2) code in T (mm) means number of elements (two).

#### **High Dielectric Constant Type GNM31 Series**

Part Number		GNM31					
LxW		3.2x1.6					
тс			X7R ( <b>R7</b> )		X5R ( <b>R6</b> )		
Rated Volt.		100 ( <b>2A</b> )	50 ( <b>1H</b> )	16 ( <b>1C</b> )	10 ( <b>1A</b> )		
Capacitance, Ca	pacitanc	e Tolerance and T Dimension					
220pF( <b>221</b> )	K, M	0.8(4)					
330pF( <b>331</b> )	K, M	0.8(4)					
470pF( <b>471</b> )	K, M	0.8(4)	0.8(4)				
680pF( <b>681</b> )	K, M	0.8(4)	0.8(4)				
1000pF( <b>102</b> )	K, M	0.8(4)	0.8(4)				
1500pF( <b>152</b> )	K, M	0.8(4)	0.8(4)				
2200pF( <b>222</b> )	K, M	0.8(4)	0.8(4)				
3300pF( <b>332</b> )	K, M	0.8(4)	0.8(4)				
4700pF( <b>472</b> )	K, M	0.8(4)	0.8(4)				
6800pF( <b>682</b> )	K, M		0.8(4)				
10000pF( <b>103</b> )	K, M		0.8(4)				

Dimensions are shown in mm and Rated Voltage in Vdc.

Please refer to Specifications and Test Methods (2) about  $1.0\mu F$  products.

Dimensions are shown in mm and Rated Voltage in Vdc.

Please refer to Specifications and Test Methods (2) about X5R, 10V products.

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Part Number			GI	NM31	
LxW			3.:	2x1.6	
тс			X7R ( <b>R7</b> )		
Rated Volt.		100 ( <b>2A</b> )	50 ( <b>1H</b> )	16 ( <b>1C</b> )	10 ( <b>1A</b> )
Capacitance, Ca	pacitano	e Tolerance and T Dimension			
15000pF( <b>153</b> )	K, M		0.8(4)		
22000pF( <b>223</b> )	K, M			0.8(4)	
33000pF( <b>333</b> )	K, M			0.8(4)	
47000pF( <b>473</b> )	K, M			1.0(4)	
68000pF( <b>683</b> )	K, M			1.0(4)	
0.10μF( <b>104</b> )	K, M			1.0(4)	
1.0μF( <b>105</b> )	М				0.85( <b>4</b> )

The part numbering code is shown in each ( ). The (4) code in T (mm) means number of elements (four). Dimensions are shown in mm and Rated Voltage in Vdc.

No.	. Item		Specifications		Tost	Method			
INO.	THE	2111	Temperature Compensating Type	High Dielectric Type		1630	ivietriou		
1	Operating Temperating Range	,	5C: -55 to +125°C	R7: -55 to +125°C R6: -30 to +85°C					
2	Rated Vo	ltage	See the previous pag	ges.	The rated voltage is defined as the maximum voltage which may be applied continuously to the capacitor.  When AC voltage is superimposed on DC voltage, V <sup>p,p</sup> or V <sup>O,p</sup> , whichever is larger, should be maintained within the rated voltage range.				V <sup>P-P</sup> or V <sup>O-P</sup> ,
3	Appearar	nce	No defects or abnorr	nalities	Visual inspe	ction			
4	Dimensio	ns	Within the specified	dimensions	Using calipe	rs			
5	Dielectric	: Strength	ngth No defects or abnormalities			ould be observed 6 of the rated volt for 1 to 5 second ss than 50mA.	age (R7) i	s applied be	etween the
6	Insulation Resistant		More than 10,000MΩ (Whichever is smalle		voltage not e	on resistance show exceeding the rate thin 2 minutes of	ed voltage		
7	Capacita	nce	Within the specified t	olerance		ance/Q/D.F. shou			°C at the
	30pF min.: Q≥1000 30pF max.: Char. 25V min. 16V 10V 6.3V		Cr	nd voltage shown	in the tabl	e.	7		
8	Dissipation	on Factor	Q≧400+20C	R7, R6 0.025 0.035 0.035 0.05 max. max. max. max.	Item Frequence		1Hz	1±0.1	
	(D.F.)		C: Nominal Capacitance (pF)		Voltage	0.5 to 5\	rms/	1.0±0.2	2Vrms
	Capacitance	Capacitance Change  Temperature Coefficent	Within the specified tolerance (Table A)  Within the specified tolerance	Char.         Temp. Range Range Temp.         Reference Change Change         Cap. Change           R7         -55°C to +125°C to +85°C         25°C         Within ±15%	each specific (1) Tempera The tempera tance measu temperature should be wi coefficient ai The capacita between the	ance change should the compensation of the com	age.  ng Type determine a reference step1 thre tolerance nange as 1 ated by disinimum me	ed using the e. When cyc ough 5, the for the tem lable A. viding the deasured val	e capaci- cling the capacitance perature ifferences
9	Temperature Characteristics		(Table A)		Step 1		emperature 25±2	-	
					2	−55±3 (for	5C/R7), -	-30±3 (for F	5)
		Canacitanas	Within ±0.2%		3 4	125±3 (fo	25±2 r 5C/R7). 8	85±3 (for F	5)
		Capacitance Drift	or ±0.05pF (Whichever is		5	(	20±2	(	
			larger.)		The ranges of 25°C value of	lectric Constant T of capacitance ch over the temperat ithin the specified	ange com ure ranges	•	
10	Adhesive Strength of Termination		GNM	GNM 2  GNM 2  Solder resist Copper foil	Fig.1 using a the test jig for The soldering reflow metho	g should be done of d and should be do uniform and free of the document of the	hen apply either with onducted v	5N force in an iron or us with care so	parallel with sing the that the



	Continued fr		•	ns and Test Methods (1		
				Specifications		
lo.	Ite	em	Temperature Compensating Type	High Dielectric Type	Test Method	
		Appearance	No defects or abnorr	nalities	Solder the capacitor to the test jig (glass epoxy board) in the	
		Capacitance	Within the specified	tolerance	same manner and under the same conditions as (10). The capacitor should be subjected to a simple harmonic motion	
11	Vibration Resistance	Sistance Q/D.F. 3UPF max.: Q≥400+20C Char. 25V min. 16V 10V 6.3 R7 R6 0.025 0.035 0.035 0.035 0.005 0		P7 P6 0.025 0.035 0.035 0.05	having a total amplitude of 1.5mm, the frequency being varied uniformly between the approximate limits of 10 and 55Hz. The frequency range, from 10 to 55Hz and return to 10Hz, should be traversed in approximately 1 minute. This motion should be applied for a period of 2 hours in each of 3 mutually perpendicular directions (total of 6 hours).	
			No cracking or marking defects should occur.		Solder the capacitor on the test jig (glass epoxy board) shown	
			•GNM□□4	•GNM□□2	in Fig. 2 using a eutectic solder.  Then apply a force in the direction shown in Fig. 3 for 5±1 sec	
	Deflection		5.0	5.0 100	The soldering should be done by the reflow method and should be conducted with care so that the soldering is uniform and fre of defects such as heat shock.  20,450 Pressurizing	
12			GNM212 2	t=0.8mm  t=0.8mm  c d c.0±0.05 0.5±0.05 0.32±0.05 0.32±0.05 c.0±0.05 0.6±0.05 0.5±0.05 c.0±0.05 0.7±0.05 0.3±0.05 c.0±0.05 0.7±0.05 0.3±0.05 0.2±0.05	speed : 1.0mm/sec. Pressurize  R230  Flexure : ≤1  Capacitance meter  45  45	
			GNM314 2	2.5±0.05   0.8±0.05   0.4±0.05   0.4±0.05	Fig. 3	
				(in mm) Fig. 2		
13	Solderabi Terminati	-	75% of the termination continuously.	ons are to be soldered evenly and	Immerse the capacitor in a solution of ethanol (JIS-K-8101) an rosin (JIS-K-5902) (25% rosin in weight proportion). Preheat a 80 to 120°C for 10 to 30 seconds. After preheating, immerse ir eutectic solder solution for 2±0.5 seconds at 230±5°C or Sn-3.0Ag-0.5Cu solder solution for 2±0.5 seconds at 245±5°C	
	Resistanc Soldering		The measured and of specifications in the	observed characteristics should satisfy the following table.		
		Appearance	No marking defects			
		Capacitance Change	Within ±2.5% or ±0.25pF (Whichever is larger)	R7, R6: Within ±7.5%	Preheat the capacitor at 120 to 150°C for 1 minute. Immerse the capacitor in a eutectic solder or Sn-3.0Ag-0.5Cu solder solution at 270±5°C for 10±0.5 seconds. Let sit at room temperature for 24±2 hours, then measure.	
14		Q/D.F.	30pF min.: Q≥1000 30pF max.: Q≥400+20C C: Nominal	Char.         25V min.         16V         10V         6.3V           R7, R6         0.025 max.         0.035 max.         0.035 max.         0.05 max.	Initial measurement for high dielectric constant type Perform a heat treatment at 150+0/-10°C for one hour and then let sit for 24±2 hours at room temperature. Perform the initial measurement.	

Continued on the following page.



No failure

I.R.

Dielectric

Strength

Capacitance (pF)

More than  $10{,}000M\Omega$  or  $500\Omega\cdot\text{F}$  (Whichever is smaller)

7	Continued f	rom the prec	eding page.										
No.	1+.	em		Specificatio	ns				To	st Metho	d		
NO.	110	=111	Temperature Compensating Type		High Die	electric <sup>-</sup>	Гуре		Te:	st ivietilo	<u> </u>		
	Tempera Cycle	ture	The measured and conspecifications in the		eristics s	hould sa	tisfy the	Fix the capaci	tor to the supp	orting jig	in the same m	anner and	
		Appearance	No marking defects					under the same conditions as (10). Perform the five cycles according to the four heat treatments listed in the following					
		Capacitance Change	Within ±2.5% or ±0.25pF (Whichever is larger)	R7, R6: Within	±7.5%			table. Let sit for 24±2 hours (temperature compensating type) or 48±4 hours (high dielectric constant type) at room temperature, then measure.					
15			30pF min.: Q≧1000					Step	1 Min.	2	3 Max.	4	
13		Q/D.F.	30pF max.: Q≧400+20C	Char. 25V mi		10V 0.035	6.3V 0.05	Temp. (°C)	Operating Temp. +0/–3	Room Temp.	Operating Temp. +3/–0	Room Temp.	
		Q/D.I .	C:Nominal	R7, R6 max.	max.	max.	max.	Time (min.)	30±3	2 to 3	30±3	2 to 3	
			Capacitance (pF)						_		ic constant type		
		I.R.	More than 10,000Mg	2 or 500Ω · F (W	hichever	is smalle	er)				-10°C for one h	our and	
		Dielectric Strength	No failure					then let sit for 24±2 hours at room temperature.  Perform the initial measurement.					
	Humidity State		The measured and o		eristics s	hould sa	tisfy the						
		Appearance	No marking defects					1					
			Within ±5%										
		Capacitance Change	or ±0.5pF (Whichever is larger)	R7, R6: Within	±12.5%								
16		Q/D.F.	30pF and over:  Q≥350 10pF and over, 30pF and ober, Q≥275+5C/2 10pF and below: Q≥200+10C C: Nominal Capacitance (pF)	Char. 25V r R7, R6 0.0 ma	5 0.0	)5	0.05 max.	Sit the capacitor at 40±2°C and 90 to 95% humidity for 500 hours.  Remove and let sit for 24±2 hours at room temperature, the measure.					
		I.R.	More than 1,000MΩ	or 50Ω · F (Whice	hever is	smaller)							
		Dielectric Strength	No failure					-					
	Humidity	Load	The measured and o		eristics s	hould sa	tisfy the						
		Appearance	No marking defects										
		Capacitance Change	Within ±7.5% or ±0.75pF (Whichever is larger)	R7, R6: Within	±12.5%			Apply the rated voltage at 40±2°C and 90 to 95% humidity for 500±12 hours.  Remove and let sit for 24±2 hours at room temperature, then measure.  The charge/discharge current is less than 50mA.			umidity for		
17		Q/D.F.	30pF and over:  Q≥200 30pF and below:  Q≥100+10C/3  C: Nominal	Char. 25V n R7, R6 0.0 max	5 0.0	5	V/6.3V 0.05 max.				ture, then		
		I.R.	Capacitance (pF)  More than 500MΩ or	250 · E (\\/bich	aver is sn	naller\		-					
		Dielectric		ZOZZ - I. (AALIICLI	5 V CI 15 SI	naner)		-					
		Strength	No failure										



Continued from the preceding page

	S Continued from the preceding page.						
				Specifications			
No.	Item		Temperature Compensating Type	High Dielectric Type	Test Method		
	High Tem Load	perature	The measured and conspecifications in the	observed characteristics should satisfy the following table.			
		Appearance	No marking defects				
		Capacitance Change	Within ±3% or ±0.3pF (Whichever is larger)	R7, R6: Within ±12.5%	Apply 200% of the rated voltage for 1000±12 hours at the maximum operating temperature ±3°C. Let sit for 24±2 hours at room temperature, then measure.  The charge/discharge current is less than 50mA.		
18		Q/D.F.	30pF and over:  Q≥350 10pF and over, 30pF and below: Q≥275+5C/2 10pF and below: Q≥200+10C C: Nominal Capacitance (pF)	Char.         25V min.         16V         10V/6.3V           R7, R6         0.04 max.         0.05 max.         0.05 max.	Initial measurement for high dielectric constant type. Apply 200% of the rated DC voltage for one hour at the maximum operating temperature ±3°C. Remove and let sit for 24±2 hours at room temperature. Perform initial measurement.		
		I.R.	More than 1,000MΩ	or $50\Omega \cdot F$ (Whichever is smaller)			

#### Table A

			(	Capacitance Cha	nge from 25℃ (%)	)	
Char.	Nominal Values (ppm/℃) Note 1	-55°C		-30℃		−10°C	
	(ppin/c) Note i	Max.	Min.	Max.	Min.	Max.	Min.
5C	0±30	0.58	-0.24	0.40	-0.17	0.25	-0.11

Note 1: Nominal values denote the temperature coefficient within a range of 25 to 125°C.

No.	Ite	em	Specifications		Test Method		
1	Operating Temperati		R6: -55°C to +85°C				
2	Rated Vo	ltage	See the previous pages.	The rated voltage is defined as the maximum voltage which may be applied continuously to the capacitor.  When AC voltage is superimposed on DC voltage, VP-P or VC-P, whichever is larger, should be maintained within the rated voltage range.			<sup>/P-P</sup> or V <sup>O-P</sup> ,
3	Appearar	nce	No defects or abnormalities	Visual inspection			
4	Dimensio	ns	Within the specified dimension	Using calipers			
5	Dielectric	Strength	No defects or abnormalities	No failure should be is applied between t provided the charge.	he terminations for 1	to 5 seco	nds,
6				The insulation resist voltage not exceedir max. and within 1 m	ng the rated voltage		
7	Capacita	nce	Within the specified tolerance	The capacitance/D.F			at the
	Dissipation Factor			frequency and voltage	ge snown in the table	e. 	
8	(D.F.)	on Factor	0.1 max.	Capacitance R6	Frequency 1±0.1kHz		Itage ).1Vrms
9	Capacitar Temperat Character	ure	Char. Temp. Range Reference Temp. Cap. Change R6 -55 to +85°C 25°C Within ±15%	value over the tempor within the specified re- Initial measuremen Perform a heat treat then set for 24±2 h Perform the initial n	Tempers 25 25 25 85 25 citance change comperature ranges showlanges. t for high dielectric cutment at 150+0/-10° ours at room temperneasurement.	ature (°C) ±±2 5±3 ±±2 ±±3 ±±2 pared with n in the tab onstant typ C for one interest	the 25°C ole should be oe.
10	Adhesive Strength of Termination		No removal of the terminations or other defects should occur.    Date	Solder the capacitor to the test jig (glass epoxy board) shown in Fig. 1 using a eutectic solder.  Then apply 5N force in parallel with the test jig for 10±1 sec. The soldering should be done either with an iron or using the reflow method and should be conducted with care so that the soldering is uniform and free of defects such as heat shock.  Type a b c d GNM1M2 0.5 1.6 0.32 0.32 GNM212 0.6 1.8 0.5 0.5  (in mm)			±1 sec. The the reflow he soldering  d 0.32 0.5
		Appearance	No defects or abnormalities	Solder the capacitor	to the test jig (glass	epoxy boa	ard) in
		Capacitance	Within the specified tolerance	the same manner ar			
11	Vibration	D.F.	0.1 max.	The capacitor should be subjected to a simple harmonic me having a total amplitude of 1.5mm, the frequency being var uniformly between the approximate limits of 10 and 55Hz. The frequency range, from 10 to 55Hz and return to 10Hz, should be traversed in approximately 1 minute. This motion should be applied for a period of 2 hours in each of 3 mutus perpendicular directions (total of 6 hours).			eing varied I 55Hz. o 10Hz, s motion





J.	Continued from	om the prec	eding page.					
Vo.	Ite	em	Specifications	Test Method				
12	2 Deflection		No cracking or marking defects should occur.  20 50 Pressurizing speed : 1.0mm/sec. Pressurize  Pressurize  Capacitance meter  45 45	Solder the capacitor to the test jig (glass epoxy board) shown in Fig. 2 using a eutectic solder. Then apply a force in the direction shown in Fig. 3. The soldering should be done by the reflow method and should be conducted with care so that the soldering is uniform and free of defects such as heat shock.  Thickness: 0.8mm				
			Fig. 3	$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$				
13	Solderability of Termination		75% of the terminations are to be soldered evenly and continuously.	Immerse the capacitor in a solution of ethanol (JIS-K-8101) and rosin (JIS-K-5902) (25% rosin in weight proportion). Preheat at 80 to 120°C for 10 to 30 seconds. After preheating, immerse in eutectic solder solution for 2±0.5 seconds at 230±5°C or Sn-3.0Ag-0.5Cu solder solution for 2±0.5 seconds at 245±5°C.				
		Appearance	No marking defects	-				
	Dagiotomas	Capacitance Change	R6: Within ±7.5%	Preheat the capacitor at 120 to 150°C for 1 minute. Immerse the capacitor in a eutectic solder or Sn-3.0Ag-0.5Cu solder solution at 270±5°C for 10±0.5 seconds.				
14	Resistance to Soldering	D.F.	0.1 max.	Let sit at room temperature for 24±2 hours, then measure.				
	Heat	I.R.	$50Ω \cdot F$ min.	Initial measurement     Perform a heat treatment at 150 +0/-10°C for one hour and				
		Dielectric Strength	No failure	then let sit for 24±2 hours at room temperature. Perform the initial measurement.				
		Appearance	No marking defects	Fix the capacitor to the supporting jig in the same manner and				
		Capacitance Change	R6: Within ±12.5%	under the same conditions as (10).  Perform the five cycles according to the four heat treatments  listed in the following table.				
		D.F.	0.1 max.	Let sit for 24±2 hours at room temperature, then measure.				
4.5	Temperature	I.R.	$50\Omega \cdot$ F min.	Step 1 2 3 4				
15	Cycle	Dielectric Strength	No failure	Temp. (°C) Min. Operating Room Temp. Temp. Temp.  Time (min.) 30±3 2 to 3 30±3 2 to 3  • Initial measurement Perform a heat treatment at 150 +0/-10 °C for one hour and then let sit for 24±2 hours at room temperature. Perform the initial measurement.				
		Appearance	No marking defects	Apply the rated voltage at 40±2°C and 90 to 95% humidity for				
	High Temperature	Capacitance Change	R6: Within ±12.5%	500±12 hours. The charge/discharge current is less than 50mA.  • Initial measurement  Perform a heat treatment at 150 +0/-10°C for one hour				
16	High	D.F.	0.2 max.	and then let sit for 24±2 hours at room temperature.				
	Humidity (Steady)	I.R.	12.5Ω · F min.	Perform the initial measurement.  • Measurement after test				
	(otoday)	Dielectric Strength	No failure	Perform a heat treatment at 150 +0/-10°C for one hour and then let sit for 24±2 hours at room temperature, then measure.				
		Appearance	No marking defects	Apply 125% of the rated voltage for 1000±12 hours at the				
		Capacitance Change	R6: Within ±12.5%	maximum operating temperature ±3°C. Let sit for 24±2 hours at room temperature, then measure.  The charge/discharge current is less than 50mA.				
		D.F.	0.2 max.	Initial measurement				
17	Durability	I.R.	$25Ω \cdot F$ min.	Perform a heat treatment at 150 +0/-10°C for one hour and then let sit for 24±2 hours at room temperature.				
		Dielectric Strength	No failure	Perform the initial measurement.  • Measurement after test Perform a heat treatment at 150 +0/-10°C for one hour and then let sit for 24±2 hours at room temperature, then measure.				

# **Chip Monolithic Ceramic Capacitors**



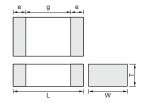
# for Ultrasonic Sensors GRM Series

- Features
- 1. Proper to compensate for ultrasonic sensor
- 2. Small chip size and high cap. value
- Applications

Ultrasonic sensor

(Back sonar, Corner sonar, etc.)





Part Number	Dimensions (mm)						
Part Number	L	W	T	е	g min.		
GRM219	2.0 ±0.1	1.25 ±0.1	0.85 ±0.1	0.2 to 0.7	0.7		

Part Number	TC Code	Rated Voltage (Vdc)	Capacitance (pF)	Length L (mm)	Width W (mm)	Thickness T (mm)
GRM2199E2A102KD42	ZLM (Murata)	100	1000 ±10%	2.0	1.25	0.85
GRM2199E2A152KD42	ZLM (Murata)	100	1500 ±10%	2.0	1.25	0.85

No.	Ite	em	Specifications		Test Method	
1	Operating Temperat		−25 to +85°C	Reference Tempera	ature: 20°C	
2	Rated Vo	ltage	See the previous pages.	may be applied con When AC voltage is	defined as the maximum voltage which tinuously to the capacitor. superimposed on DC voltage, V <sup>p-p</sup> or V <sup>0-p</sup> , should be maintained within the rated volt-	
3	Appearar	nce	No defects or abnormalities	Visual inspection		
4	Dimensio	ns	Within the specified dimensions	Using calipers		
5	Dielectric	Strength	No defects or abnormalities	is applied between t	e observed when 300% of the rated voltage the terminations for 1 to 5 seconds, providarge current is less than 50mA.	
6	Insulation (I.R.)	Resistance	More than 10,000M $\Omega$		tance should be measured with a DC volthe rated voltage at 20°C and 75%RH max. s of charging.	
7	Capacita	nce	Within the specified tolerance	The capacitance/D	F. should be measured at 20℃ with	
8	Dissipatio (D.F.)	n Factor	0.01 max.		ncy and 1±0.2Vrms in voltage.	
9	Capacitance 9 Temperature		Within −4,700 <sup>±1</sup> .200 ppm/°C (at −25 to ±20°C) Within −4,700 <sup>±500</sup> .000 ppm/°C (at ±20 to ±85°C)	when cycling the te 5, the capacitance s the temperature coe The capacitance ch each specified temp	ange should be measured after 5 min. at perature stage.	
	Character		Within −4,700 ±1,000 ppm/ € (at +20 to +85 €)	Step 1	Temperature (℃) 20±2	
				2	——————————————————————————————————————	
				3	20±2	
				4	85±3	
				5 20±2		
10	Adhesive Strength of Termination		No removal of the terminations or other defect should occur.	Fig.1 using a eutect direction of the arrow The soldering shoul reflow method and s	d be done either with an iron or using the should be conducted with care so that the and free of defects such as heat shock.  Solder resist  Baked electrode or copper foil  a b c  1.2 4.0 1.65  (in mm)	
		Annos	No defects or obverselities	Colden the	Fig. 1	
		Appearance	No defects or abnormalities		r to the test jig (glass epoxy board) in the inder the same conditions as (10).	
11	Vibration Resistance	D.F.	0.01 max.	The capacitor should be subjected to a simple harmonic motion having a total amplitude of 1.5mm, the frequency being varied uniformly between the approximate limits of 10 and 55Hz. The frequency range, from 10 to 55Hz and return to 10Hz, should be traversed in approximately 1 minute. This motion should be applied for a period of 2 hours in each of 3 mutually perpendicular directions (total of 6 hours).		





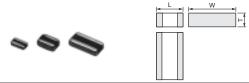
$\overline{A}$	Continued fr	om the prec	eding page.				
No.	Ite	em	Specifications	Test Method			
			No cracking or marking defects should occur.	Solder the capacitor to the test jig (glass epoxy boards) shown in Fig. 2 using a eutectic solder.  Then apply a force in the direction shown in Fig. 3.  The soldering should be done by the reflow method and should			
12	2 Deflection		Type a b c GRM21 1.2 4.0 1.65 (in mm)	be conducted with care so that the soldering is uniform and free of defects such as heat shock.  20 50 Pressurizing speed: 1.0mm/sec.  Pressurize  Flexure: ≤1  Capacitance meter  45 45 (in mm)  Fig.3			
13	Solderability of Termination 75% of the terminations are to be soldered evenly and continuously.			Immerse the capacitor in a solution of ethanol (JIS-K-8101) and rosin (JIS-K-5902) (25% rosin in weight proportion). Preheat at 80 to 120℃ for 10 to 30 seconds. After preheating, immerse in eutectic solder solution for 2±0.5 seconds at 230±5℃ or Sn-3.0Ag-0.5Cu solder solution for 2±0.5 seconds at 245±5°C.			
		Appearance	No defects or abnormalities				
	Resistance to Soldering Heat	Capacitance Change	Within ±7.5%	Preheat the capacitor at 120 to 150°C for 1 minute. Immerse the capacitor in a eutectic solder or Sn-3.0Ag-0.5Cu solder solution			
14		D.F.	0.01 max.	at 270±5°C for 10±0.5 seconds. Let sit at room temperature for			
	ricat	I.R.	More than 10,000M $\Omega$	24±2 hours, then measure.			
		Dielectric Strength	No failure				
		Appearance	No defects or abnormalities	Fix the capacitor to the supporting jig in the same manner and under the same conditions as (11).			
	Temperature	Capacitance Change	Within ±7.5%	Perform the five cycles according to the four heat treatments  listed in the following table. Let sit for 24±2 hours at room tem-			
15	Cycle	D.F.	0.01 max.	perature, then measure.			
		I.R.	More than 10,000M $\Omega$	Step 1 2 3 4  Temp. (°C) -25 +3 Room Temp. 85 +3 Room Temp.			
		Dielectric Strength	No failure	Time (min.) 30±3 2 to 3 30±3 2 to 3			
		Appearance	No defects or abnormalities	_			
	Humidity,	Capacitance Change	Within ±12.5%	Sit the capacitor at 40±2°C and 90 to 95% humidity for 500±12 hours.			
16	Steady State	D.F.	0.02 max.	Remove and let sit for 24±2 hours at room temperature, then			
	State	I.R. Dielectric	More than 1,000M $\Omega$ No failure	measure.			
		Strength	No. defeate as also association				
		Appearance	No defects or abnormalities	Apply the rated voltage at 40±2°C and 90 to 95% humidity for			
17	Humidity Load	Capacitance Change	Within ±12.5%	500±12 hours. Remove and let sit for 24±2 hours at room temperature, then measure. The charge/discharge current is less			
		D.F.	0.02 max.	than 50mA.			
		I.R.	More than $500M\Omega$				
		Appearance	No defects or abnormalities	_			
18	High Temperature	Capacitance Change	Within ±12.5%	Apply 200% of the rated voltage for 1,000±12 hours at 85±3°C. Let sit for 24±2 hours at room temperature, then measure.			
	Load	D.F.	0.02 max.	The charge/discharge current is less than 50mA.			
		I.R.	More than 1,000M $\Omega$				

# **Chip Monolithic Ceramic Capacitors**



### Low ESL LLL/LLA/LLM Series

- Features (Reversed Geometry Low ESL Type)
- 1. Low ESL, good for noise reduction for high frequency
- 2. Small, high cap
- Applications
- 1. High speed microprocessor
- 2. High frequency digital equipment



Part Number		Dimensions (mm)	)
T dit ivallibei	L	W	T
LLL153	0.5 ±0.05	1.0 ±0.05	0.3 ±0.05
LLL185	0.8 ±0.1	1.6 ±0.1	0.6 max.
LLL215			0.5 +0/-0.15
LLL216	1.25 ±0.1	2.0 ±0.1	0.6 ±0.1
LLL219			0.85 ±0.1
LLL315			0.5 +0/-0.15
LLL317	1.6 +0.15	3.2 +0.15	0.7 ±0.1
LLL31M	1.6 ±0.15	3.2 ±0.13	1.15 ±0.1
LLL31B			1.25 +0.15/-0.05

#### **Reversed Geometry Low ESL Type**

Part Number	LLL15			LLI	L18					LLI	L21					LLI	L31		
LxW	0.5x1.0			0.8	x1.6					1.25	x2.0					1.62	x3.2		
тс	X6S ( <b>C8</b> )			X7R ( <b>R7</b> )			X7S ( <b>C7</b> )			X7R ( <b>R7</b> )			X7S ( <b>C7</b> )			X7R ( <b>R7</b> )			X7S ( <b>C7</b> )
Rated Volt.	6.3 ( <b>0J</b> )	50 ( <b>1H</b> )	25 ( <b>1E</b> )	16 ( <b>1C</b> )	10 ( <b>1A</b> )	6.3 ( <b>0J</b> )	4 ( <b>0G</b> )	50 ( <b>1H</b> )	25 ( <b>1E</b> )	16 ( <b>1C</b> )	10 ( <b>1A</b> )	6.3 ( <b>0J</b> )	4 ( <b>0G</b> )	50 ( <b>1H</b> )	25 ( <b>1E</b> )	16 ( <b>1C</b> )	10 ( <b>1A</b> )	6.3 ( <b>0J</b> )	4 ( <b>0G</b> )
Capacitance (Ca	apacita	nce pai	rt numb	pering o	code) a	nd T (n	nm) Din	nensior	(T Din	nensior	part n	umber	ing cod	le)					
2200pF ( <b>222</b> )		0.5 ( <b>5</b> )																	
4700pF ( <b>472</b> )		0.5 ( <b>5</b> )						0.6 ( <b>6</b> )											
10000pF ( <b>103</b> )			0.5 ( <b>5</b> )					0.6 ( <b>6</b> )						0.7 ( <b>7</b> )					
22000pF ( <b>223</b> )			0.5 ( <b>5</b> )					0.6 ( <b>6</b> )						0.7 ( <b>7</b> )					
47000pF ( <b>473</b> )				0.5 ( <b>5</b> )					0.6 ( <b>6</b> )					0.7 ( <b>7</b> )					
0.10μF ( <b>104</b> )	0.3 ( <b>3</b> )				0.5 ( <b>5</b> )				0.6 ( <b>6</b> )					1.15 ( <b>M</b> )	0.7 ( <b>7</b> )				
0.22μF ( <b>224</b> )						0.5 ( <b>5</b> )				0.85 ( <b>9</b> )	0.6 ( <b>6</b> )				1.15 ( <b>M</b> )	0.7 ( <b>7</b> )			
0.47μF ( <b>474</b> )							0.5 ( <b>5</b> )				0.85 ( <b>9</b> )				1.15 ( <b>M</b> )	0.7 ( <b>7</b> )			
1.0µF ( <b>105</b> )							0.5 ( <b>5</b> )					0.85 ( <b>9</b> )				1.15 ( <b>M</b> )	0.7 ( <b>7</b> )		
2.2µF ( <b>225</b> )							0.5 ( <b>5</b> )						0.85 ( <b>9</b> )				1.15 ( <b>M</b> )	0.7 ( <b>7</b> )	
4.7μF ( <b>475</b> )																		1.15 ( <b>M</b> )	
10μF ( <b>106</b> )																			1.25 ( <b>B</b> )

The part numbering code is shown in ().

Dimensions are shown in mm and Rated Voltage in Vdc.

Please refer to Specifications and Test Method (2) about LLL15 Series and LLL18 Series 1.0 $\mu$ F/2.2 $\mu$ F type.



### **Reversed Geometry Low ESL Type Low Profile**

Part Number		LLI	L18				LL	L21				LL	L31	
LxW		0.8	x1.6				1.25	x2.0				1.6	x3.2	
тс		X7R ( <b>R7</b> )		X7S ( <b>C7</b> )			X7R ( <b>R7</b> )			X7S ( <b>C7</b> )			7R 2 <b>7</b> )	
Rated Volt.	25 ( <b>1E</b> )	16 ( <b>1C</b> )	10 ( <b>1A</b> )	4 ( <b>0G</b> )	50 ( <b>1H</b> )	25 ( <b>1E</b> )	16 ( <b>1C</b> )	10 ( <b>1A</b> )	6.3 ( <b>0J</b> )	4 ( <b>0G</b> )	50 ( <b>1H</b> )	25 ( <b>1E</b> )	16 ( <b>1C</b> )	10 ( <b>1A</b> )
Capacitance (Ca	pacitanc	e part nur	mbering c	ode) and	T (mm) D	imension	(T Dimen	sion part	numberin	g code)				
1000pF( <b>102</b> )					0.5( <b>5</b> )									
2200pF( <b>222</b> )					0.5( <b>5</b> )									
4700pF( <b>472</b> )					0.5( <b>5</b> )									
10000pF( <b>103</b> )	0.5( <b>5</b> )				0.5( <b>5</b> )						0.5( <b>5</b> )			
22000pF( <b>223</b> )		0.5( <b>5</b> )				0.5( <b>5</b> )					0.5( <b>5</b> )			
47000pF( <b>473</b> )		0.5( <b>5</b> )					0.5( <b>5</b> )					0.5( <b>5</b> )		
0.10μF( <b>104</b> )			0.5( <b>5</b> )				0.5( <b>5</b> )					0.5( <b>5</b> )		
0.22μF( <b>224</b> )				0.5( <b>5</b> )				0.5( <b>5</b> )					0.5( <b>5</b> )	
0.47μF( <b>474</b> )									0.5( <b>5</b> )					0.5( <b>5</b> )
1.0μF( <b>105</b> )										0.5( <b>5</b> )				

The part numbering code is shown in ().

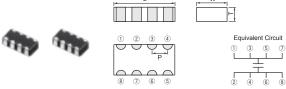
Dimensions are shown in mm and Rated Voltage in Vdc.

#### ■ Features (Eight Terminals Low ESL Type)

- Low ESL(100pH), suitable to decoupling capacitor for 1GHz clock speed IC.
- 2. Small, large cap

#### ■ Applications

- 1. High speed microprocessor
- 2. High frequency digital equipment



Part Number		Dime	nsions (mm)	
Part Number	L	W	T	Р
LLA185	1.6 ±0.1	0.8 ±0.1	0.5 +0.05/-0.1	0.4 ±0.1
LLA215	2.0 ±0.1	1.25 ±0.1	0.5 +0.05/-0.1	0.5 ±0.05
LLA219	2.0 ±0.1	1.25 ±0.1	0.85 ±0.1	0.5 ±0.05
LLA315	3.2 ±0.15	1.6 ±0.15	0.5 +0.05/-0.1	0.8 ±0.1
LLA319	3.2 ±0.15	1.6 ±0.15	0.85 ±0.1	0.8 ±0.1
LLA31M	3.2 ±0.15	1.6 ±0.15	1.15±0.1	0.8 ±0.1

## **Eight Terminals Low ESL Type**

Part Number	LLA18			LLA21				LLA31	
LxW	1.6x0.8			2.0x1.25				3.2x1.6	
тс	X7S ( <b>C7</b> )			7R <b>R7</b> )		X7S ( <b>C7</b> )		X7R ( <b>R7</b> )	
Rated Volt.	4 ( <b>0G</b> )	25 ( <b>1E</b> )	16 ( <b>1C</b> )	10 ( <b>1A</b> )	6.3 ( <b>0J</b> )	4 ( <b>0G</b> )	16 ( <b>1C</b> )	10 ( <b>1A</b> )	( <b>0G</b> )
Capacitance (Ca	pacitance par	t numbering co	de) and T (mn	n) Dimension (1	Dimension pa	rt numbering o	ode)	<u>'</u>	
10000pF( <b>103</b> )		0.85( <b>9</b> )							
22000pF( <b>223</b> )		0.85(9)							
47000pF( <b>473</b> )		0.85( <b>9</b> )							
0.10μF( <b>104</b> )	0.5( <b>5</b> )		0.85( <b>9</b> )				0.85( <b>9</b> )		
0.22μF( <b>224</b> )	0.5 <b>(5)</b>		0.85( <b>9</b> )				0.85( <b>9</b> )		
0.47μF( <b>474</b> )	0.5 <b>(5</b> )			0.85(9)			0.85( <b>9</b> )		
1.0μF( <b>105</b> )	0.5 <b>(5</b> )				0.85( <b>9</b> )			0.85( <b>9</b> )	
2.2μF( <b>225</b> )	0.5 <b>(5</b> )					0.85( <b>9</b> )		1.15( <b>M</b> )	0.85( <b>9</b> )
4.7μF( <b>475</b> )						0.85( <b>9</b> )			

The part numbering code is shown in ().

Dimensions are shown in mm and Rated Voltage in Vdc.

Please refer to Specifications and Test Method (2) about LLA18 Series  $1.0\mu F/2.2\mu F$  type and LLA21 Series  $4.7\mu F$  type.



#### **Eight Terminals Low ESL Type Low Profile**

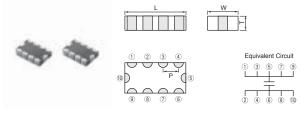
Part Number			LLA21				LLA31	
LxW			2.0x1.25				3.2x1.6	
тс		X7 ( <b>R</b>			X7S ( <b>C7</b> )		X7R ( <b>R7</b> )	
Rated Volt.	25 ( <b>1E</b> )	16 ( <b>1C</b> )	10 ( <b>1A</b> )	6.3 ( <b>0J</b> )	4 ( <b>0G</b> )	16 ( <b>1C</b> )	10 ( <b>1A</b> )	6.3 ( <b>0J</b> )
Capacitance (Cap	pacitance part n	numbering code)	and T (mm) Dim	ension (T Dimen	sion part numbe	ring code)	1	'
10000pF( <b>103</b> )	0.5( <b>5</b> )							
22000pF( <b>223</b> )	0.5( <b>5</b> )							
47000pF( <b>473</b> )		0.5( <b>5</b> )						
0.10μF( <b>104</b> )		0.5( <b>5</b> )				0.5( <b>5</b> )		
0.22μF( <b>224</b> )			0.5 <b>(5)</b>	0.5( <b>5</b> )		0.5( <b>5</b> )		
0.47μF( <b>474</b> )				0.5( <b>5</b> )			0.5( <b>5</b> )	
1.0μF( <b>105</b> )					0.5( <b>5</b> )			0.5( <b>5</b> )
2.2μF( <b>225</b> )					0.5( <b>5</b> )			0.5( <b>5</b> )
4.7μF( <b>475</b> )					0.5( <b>5</b> )			

The part numbering code is shown in ().

Dimensions are shown in mm and Rated Voltage in Vdc.

Please refer to Specifications and Test Method (2) about LLA21 Series (Low Profile)  $2.2\mu\text{F}/4.7\mu\text{F}$  type.

- Features (Ten Terminals Low ESL Type)
- 1. Low ESL(45pH), suitable to decoupling capacitor for 2GHz clock speed IC.
- 2. Small, large cap
- Applications
- 1. High speed microprocessor
- 2. High frequency digital equipment



Part Number	Dimensions (mm)								
Part Number	L	W	T	Р					
LLM215	2.0 ±0.1	1.25 ±0.1	0.5 +0.05/-0.1	0.5 ±0.05					
LLM315	3.2 ±0.15	1.6 ±0.15	0.5 +0.05/-0.1	0.8 ±0.1					

## **Ten Terminals Low ESL Type Low Profile**

Part Number		LL	.M21			LLM31	
LxW		2.0	x1.25			3.2x1.6	
тс		X7R ( <b>R7</b> )		X7S ( <b>C7</b> )		X7R ( <b>R7</b> )	
Rated Volt.	25 ( <b>1E</b> )	16 ( <b>1C</b> )	6.3 ( <b>0J</b> )	4 ( <b>0G</b> )	16 ( <b>1C</b> )	10 ( <b>1A</b> )	6.3 ( <b>0J</b> )
Capacitance (Ca	pacitance part nui	mbering code) and	d T (mm) Dimension	(T Dimension part	numbering code)		•
10000pF( <b>103</b> )	0.5 <b>(5</b> )						
22000pF( <b>223</b> )	0.5 <b>(5</b> )						
47000pF( <b>473</b> )		0.5 <b>(5</b> )					
0.10μF( <b>104</b> )		0.5 <b>(5</b> )			0.5( <b>5</b> )		
0.22μF( <b>224</b> )			0.5 <b>(5</b> )		0.5( <b>5</b> )		
0.47μF( <b>474</b> )			0.5 <b>(5</b> )			0.5( <b>5</b> )	
1.0μF( <b>105</b> )				0.5( <b>5</b> )			
2.2μF( <b>225</b> )				0.5( <b>5</b> )			0.5( <b>5</b> )

The part numbering code is shown in ().

Dimensions are shown in mm and Rated Voltage in Vdc.

Please refer to Specifications and Test Method (2) about LLM21 Series (Low Profile)  $2.2\mu F$  type.

### **LLL/LLA/LLM** Series Specifications and Test Methods (1)

No.	Ite	em	Specifications	Test Method				
1	Operating Temperating Range		R7, C7: -55 to +125°C					
2	Rated Vo	Itage	See the previous pages.	The rated voltage is defined as the maximum voltage which may be applied continuously to the capacitor.  When AC voltage is superimposed on DC voltage, V <sup>P-P</sup> or V <sup>O-P</sup> , whichever is larger, should be maintained within the rated voltage range.				
3	Appearar	nce	No defects or abnormalities	Visual inspection				
4	Dimensio	ns	Within the specified dimension	Using calipers				
5	Dielectric	Strength	No defects or abnormalities	No failure should be observed when 250% of the rated voltage is applied between the terminations for 1 to 5 seconds, provided the charge/discharge current is less than 50mA.				
6	Insulation Resistant		More than 10,000M $\Omega$ or 500 $\Omega$ · F (Whichever is smaller)	The insulation resistance should be measured with a DC voltage not exceeding the rated voltage at 25°C and 75%RH max. and within 2 minutes of charging.				
7	Capacita	nce	Within the specified tolerance	The capacitance/D.F. should be measured at 25°C at the frequency and voltage shown in the table.				
8	Dissipatio (D.F.)	n Factor	W.V.: 25V min.; 0.025 max. W.V.: 16V max.; 0.035 max. *1	Capacitance         Frequency         Voltage           C≤10μF (10V min.)         1±0.1kHz         1.0±0.2Vrms           C≤10μF (6.3V max.)         1±0.1kHz         0.5±0.1Vrms           C>10μF         120±24Hz         0.5±0.1Vrms				
9	Capacitar Temperat Character	ure	Char.         Temp. Range (°C)         Reference Temp.         Cap.Change           R7         -55 to +125         25°C         Within ±15%           C7         -55 to +125         25°C         Within ±22%	The capacitance change should be measured after 5 min. at each specified temperature stage.    Step   Temperature (°C)   1   25±2   2   -55±3   3   25±2   4   125±3   5   25±2				
				The ranges of capacitance change compared with the 25°C value over the temperature ranges shown in the table should be within the specified ranges.				
10	Adhesive of Termin		No removal of the terminations or other defect should occur.	Solder the capacitor to the test jig (glass epoxy board) using a eutectic solder. Then apply 10N* force in parallel with the test jig for 10±1 sec. The soldering should be done either with an iron or using the reflow method and should be conducted with care so that the soldering is uniform and free of defects such as heat shock.  *LLL18 and LLA/LLM Series: 5N				
		Appearance	No defects or abnormalities	Solder the capacitor to the test jig (glass epoxy board) in				
		Capacitance	Within the specified tolerance	the same manner and under the same conditions as (10). The capacitor should be subjected to a simple harmonic motion				
11	Vibration Resistance	D.F.	W.V.: 25V min.; 0.025 max. W.V.: 16V max.; 0.035 max. *1	having a total amplitude of 1.5mm, the frequency being varied uniformly between the approximate limits of 10 and 55Hz. The frequency range, from 10 to 55Hz and return to 10Hz, should be traversed in approximately 1 minute. This motion should be applied for a period of 2 hours in each of 3 mutually perpendicular directions (total of 6 hours).				
12	Solderab Terminati	-	75% of the terminations are to be soldered evenly and continuously.	Immerse the capacitor in a solution of ethanol (JIS-K-8101) and rosin (JIS-K-5902) (25% rosin in weight proportion). Preheat at 80 to 120°C for 10 to 30 seconds. After preheating, immerse in eutectic solder solution for 2±0.5 seconds at 230±5°C, or Sn-3.0Ag-0.5Cu solder solution for 2±0.5 seconds at 245±5°C.				
		Appearance	No marking defects	Preheat the capacitor at 120 to 150°C for 1 minute. Immerse				
	Docietanas	Capacitance Change	Within ±7.5%	the capacitor in a eutectic solder or Sn-3.0Ag-0.5Cu solder solution at 270±5°C for 10±0.5 seconds. Let sit at room				
13	Resistance to Soldering Heat	D.F.	W.V.: 25V min.; 0.025 max. W.V.: 16V max.; 0.035 max. *1	temperature for 24±2 hours, then measure.  • Initial measurement.				
		I.R.	More than 10,000M $\Omega$ or 500 $\Omega \cdot$ F (Whichever is smaller)	Perform a heat treatment at 150 $^{+0}_{-10}$ °C for one hour and then				
		Dielectric Strength	No failure	let sit for 24±2 hours at room temperature. Perform the initial measurement.				



#### LLL/LLA/LLM Series Specifications and Test Methods (1)

Vo.	Ite	em	Specifications		Tes	t Metho	d				
		Appearance Capacitance Change	No marking defects  Within ±7.5% *1	under the san Perform the fi	ne conditions as ve cycles acco	s (10). ding to t	in the same ma	atments			
		D.F.	W.V.: 25V min.; 0.025 max. W.V.: 16V max.; 0.035 max. *1		llowing table. L then measure.	et sit for	24±2 hours at	room 4			
14	Temperature Cycle	I.R.	More than 10,000M $\Omega$ or 500 $\Omega$ · F (Whichever is smaller)	Temp. (°C)	Min. Operating Temp. ±3	Room Temp.	Max. Operating Temp. ±3	Room Temp.			
	<b>y</b>	Dielectric Strength	No failure	Time (min.) 30±3 2 to 3 30±3 2 to 3  • Initial measurement.  Perform a heat treatment at 150±♀₀°C for one hour and the let sit for 24±2 hours at room temperature. Perform the init measurement.							
15	Humidity (Steady	Appearance Capacitance Change	No marking defects  Within ±12.5% *1				95% humidity				
	State)	D.F.	0.05 max. *1	then measure							
		I.R.	More than 1,000M $\Omega$ or 50 $\Omega$ · F (Whichever is smaller)								
		Appearance	No marking defects								
		Capacitance Change	Within ±12.5% *1	Apply the rate	Apply the rated voltage at 40±2°C and 90 to 95% humi						
6	Humidity	D.F.	0.05 max. *1	500±12 hours. Remove and let sit for 24±2 hours at room							
	Load	I.R.	More than 500M $\Omega$ or 25 $\Omega$ · F *1 (Whichever is smaller)		temperature, then measure. The charge/discharge current in less than 50mA.						
		Dielectric Strength	No failure								
		Appearance	No marking defects	Apply 200% of the rated voltage for 1000±12 hours at							
		Capacitance Change	Within ±12.5% *1	maximum operating temperature ±3°C. Let sit for 24±2 hou at room temperature, then measure. The charge/discharge							
17	High Temperature	D.F.	W.V.: 25V min.; 0.04 max. W.V.: 16V max.; 0.05 max. *1	current is less							
	Load	I.R.	More than 1,000M $\Omega$ or 50 $\Omega$ · F *1 (Whichever is smaller)	Apply 200% maximum op	of the rated DO perating temper	ature ±3	for one hour a				
		Dielectric Strength	No failure	maximum operating temperature ±3°C. Remove and let sit 24±2 hours at room temperature.  Perform initial measurement. (*1)							

<sup>\*1:</sup> The figure indicates typical inspection.Please refer to individual specifications.

# LLL/LLA/LLM Series Specifications and Test Methods (2)

No.	Ite	em		Spe	cifications		Te	est Method			
1	Operating Temperat Range	,	R7, C7: -55 C8: -55 to -								
2	Rated Vo	ltage	See the pre	vious pages.			The rated voltage is defined may be applied continuous. When AC voltage is supering whichever is larger, should voltage range.	ly to the capacitomposed on DC v	or. oltage, V <sup>p.p</sup> or V <sup>o.p</sup> ,		
3	Appearar	nce	No defects of	or abnormalities			Visual inspection				
4	Dimensio	ns	Within the s	pecified dimension	on		Using calipers				
5	Dielectric	Strength	No defects of	or abnormalities			No failure should be observed when 250% of the rated voltage is applied between the terminations for 1 to 5 seconds, provided the charge/discharge current is less than 50mA.				
6	Insulation Resistant		50Ω · F min.				The insulation resistance si not exceeding the rated vol within 1 minute of charging	tage at 25°C and	•		
7	Capacita	nce	Within the s	pecified tolerance	9		The capacitance/D.F. shou frequency and voltage show		at 25°C at the		
8	Dissipatio (D.F.)	n Factor	R7, C7, C8:	0.120 max.			Capacitance         C≤10μF (10V min.)         C≤10μF (6.3V max.)         C>10μF	Frequency 1±0.1kHz 1±0.1kHz 120±24Hz	Voltage 1.0±0.2Vrms 0.5±0.1Vrms 0.5±0.1Vrms		
9	Capacitar Temperat Character	ure	Char.  R7  C7  C8	Temp. Range (°C) -55 to +125 -55 to +125 -55 to +105	Reference Temp. 25°C	Cap.Change Within ±15% Within ±22% Within ±22%	The capacitance change sheach specified temperature. The ranges of capacitance value over the temperature be within the specified range.	stage. change compare ranges shown in	ed with the 25°C		
10	Adhesive of Termin		No removal	of the termination	ns or other defe	ct should occur.	Solder the capacitor to the test jig (glass epoxy board) using a eutectic solder. Then apply 10N* force in parallel with the test jig for 10±1 sec. The soldering should be done either with an iron or using the reflow method and should be conducted with care so that the soldering is uniform and free of defects such a heat shock.  *5N (LLL15, LLL18, LLA,LLM Series				
		Appearance	No defects of	or abnormalities			Solder the capacitor to the test jig (glass epoxy board) in				
		Capacitance	Within the s	pecified tolerance	<del></del>		the same manner and under the same conditions as (10). The capacitor should be subjected to a simple harmonic motion				
11	Vibration	D.F.	R7, C7, C8:	0.120 max.			having a total amplitude of 1.5mm, the frequency being varies uniformly between the approximate limits of 10 and 55Hz. The frequency range, from 10 to 55Hz and return to 10Hz, should be traversed in approximately 1 minute. This motion should be applied for a period of 2 hours in each of 3 mutually perpendicular directions (total of 6 hours).  Immerse the capacitor in a solution of ethanol (JIS-K-8101) a rosin (JIS-K-5902) (25% rosin in weight proportion). Preheat 80 to 120°C for 10 to 30 seconds. After preheating, immerse eutectic solder solution for 2±0.5 seconds at 230±5°C, or Sn-3.0Aq-0.5Cu solder solution for 2±0.5 seconds at 245±5°C.				
12	Solderabi Terminati		75% of the to	erminations are to	be soldered eve	nly					
		Appearance	No marking	defects			Preheat the capacitor at 120 to 150°C for 1 minute. Immerse				
	Resistance	Capacitance Change	R7, C7, C8:	Within ±7.5%			the capacitor in a eutectic s solution at 270±5°C for 10- Let sit at room temperature	±0.5 seconds.			
13	to Soldering	D.F.	R7, C7, C8:	0.120 max.							
	Heat	I.R.	50Ω · F min				Initial measurement.     Perform a heat treatment.	at 150 ±0 °C for	one hour and then		
		Dielectric Strength	No failure				let sit for 24±2 hours at ro measurement.				





# LLL/LLA/LLM Series Specifications and Test Methods (2)

Continued from the preceding page.
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Temperature Sudden Change	Appearance Capacitance Change D.F. I.R.	No marking defects $R7, C7, C8: Within \pm 12.5\%$ $R7, C7, C8: 0.120 \ max.$ $50\Omega \cdot F \ min.$	Fix the capacitor to the supporting jig in the same manner and under the same conditions as (10).Perform the five cycles according to the four heat treatments listed in the following table. Let sit for 24±2 hours at room temperature, then measure.  Step 1 2 3 4
Sudden	I.R.	, ,	Step 1 2 3 4
Sudden		3052 - 1 11111.	Mir Or parties   May C ''
	D: 1		Temp. (°C) Min. Operating Room Room Temp. ±3 Temp.
	Dielectric Strength	No failure	Time (min.) 30±3 2 to 3 30±3 2 to 3  • Initial measurement  Perform a heat treatment at 150 <sup>+0</sup> / <sub>10</sub> °C for one hour and then let sit for 24±2 hours at room temperature. Perform the initial measurement.
	Appearance	No marking defects	Apply the rated voltage at 40±2°C and 90 to 95% humidity for
Hiah	Capacitance Change	R7, C7, C8: Within ±12.5%	500±12 hours. The charge/discharge current is less than 50mA.
Temperatue	D.F.	R7, C7, C8: 0.2 max.	•Initial measurement
High Humidity (Steady State)	I.R.	12.5 $\Omega$ · F min.	Perform a heat treatment at 150 <sup>±0</sup> <sub>10</sub> °C for one hour and then let sit for 24±2 hours at room temperature. Perform the initial measurement.  •Measurement after test Perform a heat treatment at 150 <sup>±0</sup> <sub>10</sub> °C for one hour and then let sit for 24±2 hours at room temperature, then measure.
	Appearance	No marking defects	Apply 150% of the rated voltage for 1000±12 hours at the
	Capacitance Change	R7, C7, C8: Within ±12.5%	maximum operating temperature ±3°C. The charge/discharge current is less than 50mA.
	D.F.	R7, C7, C8: 0.2 max.	•Initial measurement
Durability	I.R.	$25\Omega \cdot F$ min.	Perform a heat treatment at 150 <sup>+9</sup> <sub>-9</sub> °C for one hour and then let sit for 24±2 hours at room temperature. Perform the initial measurement.  •Measurement after test Perform a heat treatment at 150 <sup>+9</sup> <sub>-9</sub> °C for one hour and then
	High Humidity (Steady State)	High Temperatue High Humidity (Steady State)  Appearance Capacitance Change  D.F.  Appearance Capacitance Change  D.F.	Capacitance Change   R7, C7, C8: Within ±12.5%

# **Chip Monolithic Ceramic Capacitors**

# muRata

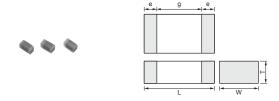
# **High-Q GJM Series**

#### ■ Features

- 1. Mobile telecommunications and RF module, mainly
- 2. Quality improvement of telephone call, low power consumption, yield ratio improvement

#### ■ Applications

VCO, PA, Mobile telecommunications



Part Number	Dimensions (mm)				
Part Number	L	W	T	е	g min.
GJM03	0.6 ±0.03	0.3 ±0.03	0.3 ±0.03	0.1 to 0.2	0.2
GJM15	1.0 ±0.05	0.5 ±0.05	0.5 ±0.05	0.15 to 0.3	0.4

Part Number	GJM03	GJM15
L x W [EIA]	0.6x0.3 [0201]	1.0x0.5 [0402]
тс	C0G ( <b>5C</b> )	C0G ( <b>5C</b> )
Rated Volt.	25 ( <b>1E</b> )	50 ( <b>1H</b> )
Capacitance (Capac	citance part numbering code) and T (mm) Dimension (T Dime	nsion part numbering code)
0.20pF( <b>R20</b> )	0.3(3)	
0.30pF( <b>R30</b> )	0.3(3)	0.5( <b>5</b> )
0.40pF( <b>R40</b> )	0.3(3)	0.5 <b>(5</b> )
0.50pF( <b>R50</b> )	0.3(3)	0.5( <b>5</b> )
0.60pF( <b>R60</b> )	0.3(3)	0.5( <b>5</b> )
0.70pF( <b>R70</b> )	0.3(3)	0.5( <b>5</b> )
0.75pF( <b>R75</b> )	0.3(3)	0.5( <b>5</b> )
0.80pF( <b>R80</b> )	0.3(3)	0.5( <b>5</b> )
0.90pF( <b>R90</b> )	0.3(3)	0.5( <b>5</b> )
1.0pF( <b>1R0</b> )	0.3(3)	0.5( <b>5</b> )
1.1pF( <b>1R1</b> )	0.3(3)	0.5 <b>(5</b> )
1.2pF( <b>1R2</b> )	0.3(3)	0.5( <b>5</b> )
1.3pF( <b>1R3</b> )	0.3(3)	0.5( <b>5</b> )
1.4pF( <b>1R4</b> )	0.3(3)	0.5( <b>5</b> )
1.5pF( <b>1R5</b> )	0.3(3)	0.5(5)
1.6pF( <b>1R6</b> )	0.3(3)	0.5( <b>5</b> )
1.7pF( <b>1R7</b> )	0.3(3)	0.5( <b>5</b> )
1.8pF( <b>1R8</b> )	0.3(3)	0.5( <b>5</b> )
1.9pF( <b>1R9</b> )	0.3(3)	0.5( <b>5</b> )
2.0pF( <b>2R0</b> )	0.3(3)	0.5( <b>5</b> )
2.1pF( <b>2R1</b> )	0.3(3)	0.5 <b>(5</b> )
2.2pF( <b>2R2</b> )	0.3(3)	0.5( <b>5</b> )
2.3pF( <b>2R3</b> )	0.3(3)	0.5(5)
2.4pF( <b>2R4</b> )	0.3( <b>3</b> )	0.5(5)
2.5pF( <b>2R5</b> )	0.3(3)	0.5( <b>5</b> )
2.6pF( <b>2R6</b> )	0.3(3)	0.5( <b>5</b> )
2.7pF( <b>2R7</b> )	0.3(3)	0.5(5)
2.8pF( <b>2R8</b> )	0.3(3)	0.5(5)
2.9pF( <b>2R9</b> )	0.3(3)	0.5(5)
3.0pF( <b>3R0</b> )	0.3(3)	0.5 <b>(5</b> )
3.1pF( <b>3R1</b> )	0.3(3)	0.5(5)
3.2pF( <b>3R2</b> )	0.3(3)	0.5( <b>5</b> )
3.3pF( <b>3R3</b> )	0.3(3)	0.5( <b>5</b> )

Part Number	GJM03	GJM15
L x W [EIA]	0.6x0.3 [0201]	1.0x0.5 [0402]
тс	C0G ( <b>5C</b> )	C0G ( <b>5C</b> )
Rated Volt.	25 ( <b>1E</b> )	50 ( <b>1H</b> )
Capacitance (Capacitance p	part numbering code) and T (mm) Dimension (T Dime	
3.4pF( <b>3R4</b> )	0.3(3)	0.5( <b>5</b> )
3.5pF( <b>3R5</b> )	0.3(3)	0.5(5)
3.6pF( <b>3R6</b> )	0.3(3)	0.5 <b>(5</b> )
3.7pF( <b>3R7</b> )	0.3(3)	0.5( <b>5</b> )
3.8pF( <b>3R8</b> )	0.3(3)	0.5( <b>5</b> )
3.9pF( <b>3R9</b> )	0.3(3)	0.5 <b>(5</b> )
4.0pF( <b>4R0</b> )	0.3(3)	0.5( <b>5</b> )
4.1pF( <b>4R1</b> )	0.3(3)	0.5(5)
4.2pF( <b>4R2</b> )	0.3(3)	0.5( <b>5</b> )
4.3pF( <b>4R3</b> )	0.3(3)	0.5( <b>5</b> )
4.4pF( <b>4R4</b> ) 4.5pF( <b>4R5</b> )	0.3( <b>3</b> ) 0.3( <b>3</b> )	0.5( <b>5</b> ) 0.5( <b>5</b> )
4.6pF( <b>4R6</b> )	0.3(3)	0.5(5)
4.7pF( <b>4R7</b> )	0.3(3)	0.5( <b>5</b> )
4.8pF( <b>4R8</b> )	0.3(3)	0.5( <b>5</b> )
4.9pF( <b>4R9</b> )	0.3(3)	0.5( <b>5</b> )
5.0pF( <b>5R0</b> )	0.3(3)	0.5( <b>5</b> )
5.1pF( <b>5R1</b> )	0.3(3)	0.5( <b>5</b> )
5.2pF( <b>5R2</b> )	0.3(3)	0.5 <b>(5</b> )
5.3pF( <b>5R3</b> )	0.3(3)	0.5 <b>(5</b> )
5.4pF( <b>5R4</b> )	0.3(3)	0.5( <b>5</b> )
5.5pF( <b>5R5</b> )	0.3(3)	0.5(5)
5.6pF( <b>5R6</b> )	0.3(3)	0.5( <b>5</b> )
5.7pF( <b>5R7</b> )	0.3(3)	0.5( <b>5</b> )
5.8pF( <b>5R8</b> ) 5.9pF( <b>5R9</b> )	0.3( <b>3</b> ) 0.3( <b>3</b> )	0.5( <b>5</b> ) 0.5( <b>5</b> )
6.0pF( <b>6R0</b> )	0.3(3)	0.5( <b>5</b> )
6.1pF( <b>6R1</b> )	0.3(3)	0.5( <b>5</b> )
6.2pF( <b>6R2</b> )	0.3(3)	0.5(5)
6.3pF( <b>6R3</b> )	0.3(3)	0.5(5)
6.4pF( <b>6R4</b> )	0.3(3)	0.5( <b>5</b> )
6.5pF( <b>6R5</b> )	0.3(3)	0.5 <b>(5</b> )
6.6pF( <b>6R6</b> )	0.3(3)	0.5(5)
6.7pF( <b>6R7</b> )	0.3(3)	0.5(5)
6.8pF( <b>6R8</b> )	0.3(3)	0.5 <b>(5</b> )
6.9pF( <b>6R9</b> )		0.5( <b>5</b> )
7.0pF( <b>7R0</b> )		0.5(5)
7.1pF( <b>7R1</b> )		0.5(5)
7.2pF( <b>7R2</b> ) 7.3pF( <b>7R3</b> )		0.5( <b>5</b> ) 0.5( <b>5</b> )
7.4pF( <b>7R4</b> )		0.5( <b>5</b> )
7.5pF( <b>7R5</b> )		0.5( <b>5</b> )
7.6pF( <b>7R6</b> )		0.5(5)
7.7pF( <b>7R7</b> )		0.5(5)
7.8pF( <b>7R8</b> )		0.5( <b>5</b> )
7.9pF( <b>7R9</b> )		0.5( <b>5</b> )
8.0pF( <b>8R0</b> )		0.5( <b>5</b> )
8.1pF( <b>8R1</b> )		0.5(5)
8.2pF( <b>8R2</b> )		0.5( <b>5</b> )
8.3pF( <b>8R3</b> )		0.5 <b>(5</b> )
8.4pF( <b>8R4</b> )		0.5( <b>5</b> )
8.5pF( <b>8R5</b> )		0.5(5)

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Continued from the preceding page.

Part Number	GJM03	GJM15
L x W [EIA]	0.6x0.3 [0201]	1.0x0.5 [0402]
тс	C0G ( <b>5C</b> )	C0G ( <b>5C</b> )
Rated Volt.	25 ( <b>1E</b> )	50 ( <b>1H</b> )
Capacitance (Capac	citance part numbering code) and T (mm) Dimension (T Dimen	sion part numbering code)
8.6pF( <b>8R6</b> )		0.5(5)
8.7pF( <b>8R7</b> )		0.5( <b>5</b> )
8.8pF( <b>8R8</b> )		0.5(5)
8.9pF( <b>8R9</b> )		0.5(5)
9.0pF( <b>9R0</b> )		0.5( <b>5</b> )
9.1pF( <b>9R1</b> )		0.5( <b>5</b> )
9.2pF( <b>9R2</b> )		0.5( <b>5</b> )
9.3pF( <b>9R3</b> )		0.5( <b>5</b> )
9.4pF( <b>9R4</b> )		0.5( <b>5</b> )
9.5pF( <b>9R5</b> )		0.5( <b>5</b> )
9.6pF( <b>9R6</b> )		0.5( <b>5</b> )
9.7pF( <b>9R7</b> )		0.5( <b>5</b> )
9.8pF( <b>9R8</b> )		0.5( <b>5</b> )
9.9pF( <b>9R9</b> )		0.5( <b>5</b> )
10pF( <b>100</b> )		0.5( <b>5</b> )
12pF( <b>120</b> )		0.5(5)
15pF( <b>150</b> )		0.5(5)
18pF( <b>180</b> )		0.5( <b>5</b> )

The part numbering code is shown in  $\ (\ ).$ 

Dimensions are shown in mm and Rated Voltage in Vdc.

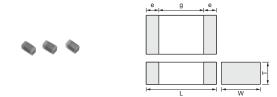
# **Tight Tolerance High-Q GJM Series**

#### ■ Features

- 1. Mobile telecommunications and RF module, mainly
- 2. Quality improvement of telephone call, low power consumption, yield ratio improvement

#### ■ Applications

VCO, PA, Mobile telecommunications



Part Number	Dimensions (mm)					
Part Number	L	W	T	е	g min.	
GJM03	0.6 ±0.03	0.3 ±0.03	0.3 ±0.03	0.1 to 0.2	0.2	
GJM15	1.0 ±0.05	0.5 ±0.05	0.5 ±0.05	0.15 to 0.3	0.4	

Part Number		GJM03	GJM15	
L x W [EIA]		0.6x0.3 [0201]	1.0x0.5 [0402]	
тс		C0G ( <b>5C</b> )	C0G ( <b>5C</b> )	
Rated Volt.		25 ( <b>1E</b> )	50 ( <b>1H</b> )	
Capacitance, Ca	pacitance 1	Folerance and T Dimension		
0.10pF( <b>R10</b> )	W, B		0.5( <b>5</b> )	
0.20pF( <b>R20</b> )	W, B	0.3(3)	0.5( <b>5</b> )	
0.30pF( <b>R30</b> )	W, B	0.3(3)	0.5(5)	
0.40pF( <b>R40</b> )	W, B	0.3(3)	0.5 <b>(5</b> )	
0.50pF( <b>R50</b> )	W, B	0.3(3)	0.5( <b>5</b> )	
0.60pF( <b>R60</b> )	W, B	0.3(3)	0.5( <b>5</b> )	
0.70pF( <b>R70</b> )	W, B	0.3(3)	0.5(5)	
0.80pF( <b>R80</b> )	W, B	0.3(3)	0.5( <b>5</b> )	
0.90pF( <b>R90</b> )	W, B	0.3(3)	0.5(5)	
1.0pF( <b>1R0</b> )	W, B	0.3(3)	0.5(5)	
1.1pF( <b>1R1</b> )	W, B	0.3(3)	0.5( <b>5</b> )	
1.2pF( <b>1R2</b> )	W, B	0.3 <b>(3</b> )	0.5( <b>5</b> )	
1.3pF( <b>1R3</b> )	W, B	0.3(3)	0.5(5)	
1.4pF( <b>1R4</b> )	W, B	0.3(3)	0.5(5)	
1.5pF( <b>1R5</b> )	W, B	0.3(3)	0.5(5)	
1.6pF( <b>1R6</b> )	W, B	0.3(3)	0.5 <b>(5</b> )	
1.7pF( <b>1R7</b> )	W, B	0.3(3)	0.5 <b>(5</b> )	
1.8pF( <b>1R8</b> )	W, B	0.3(3)	0.5 <b>(5</b> )	
1.9pF( <b>1R9</b> )	W, B	0.3(3)	0.5 <b>(5</b> )	
2.0pF( <b>2R0</b> )	W, B	0.3(3)	0.5( <b>5</b> )	
2.1pF( <b>2R1</b> )	W, B	0.3(3)	0.5( <b>5</b> )	
2.2pF( <b>2R2</b> )	W, B	0.3(3)	0.5(5)	
2.3pF( <b>2R3</b> )	W, B	0.3(3)	0.5(5)	
2.4pF( <b>2R4</b> )	W, B	0.3(3)	0.5(5)	
2.5pF( <b>2R5</b> )	W, B	0.3(3)	0.5(5)	
2.6pF( <b>2R6</b> )	W, B	0.3(3)	0.5(5)	
2.7pF( <b>2R7</b> )	W, B	0.3(3)	0.5(5)	
2.8pF( <b>2R8</b> )	W, B	0.3(3)	0.5( <b>5</b> )	
2.9pF( <b>2R9</b> )	W, B	0.3(3)	0.5( <b>5</b> )	
3.0pF( <b>3R0</b> )	W, B	0.3(3)	0.5( <b>5</b> )	
3.1pF( <b>3R1</b> )	W, B	0.3(3)	0.5( <b>5</b> )	
3.2pF( <b>3R2</b> )	W, B	0.3(3)	0.5( <b>5</b> )	
3.3pF( <b>3R3</b> )	W, B	0.3(3)	0.5( <b>5</b> )	

Continued from the preceding page.

Part Number		GJM03	GJM15
L x W [EIA]		0.6x0.3 [0201]	1.0x0.5 [0402]
TC		COG ( <b>5C</b> )	COG ( <b>5C</b> )
Rated Volt.		25	
	nacitana	(1E) ce Tolerance and T Dimension	
3.4pF( <b>3R4</b> )	Ť T	0.3(3)	0.5( <b>5</b> )
3.5pF( <b>3R5</b> )	W, B	0.3(3)	0.5( <b>5</b> )
3.5pF( <b>3R6</b> )	W, B	0.3(3)	0.5(5)
3.7pF( <b>3R7</b> )	W, B	0.3(3)	0.5(5)
3.8pF( <b>3R8</b> )	W, B	0.3(3)	0.5(5)
3.9pF( <b>3R9</b> )	W, B	0.3(3)	0.5(5)
4.0pF( <b>4R0</b> )	W, B	0.3(3)	0.5(5)
	-		
4.1pF( <b>4R1</b> )	W, B	0.3(3)	0.5(5)
4.2pF( <b>4R2</b> )	W, B	0.3(3)	0.5(5)
4.3pF( <b>4R3</b> )	W, B	0.3(3)	0.5(5)
4.4pF( <b>4R4</b> )	W, B	0.3(3)	0.5(5)
4.5pF( <b>4R5</b> )	W, B	0.3(3)	0.5( <b>5</b> )
4.6pF( <b>4R6</b> )	W, B	0.3(3)	0.5(5)
4.7pF( <b>4R7</b> )	W, B	0.3(3)	0.5(5)
4.8pF( <b>4R8</b> )	W, B	0.3(3)	0.5(5)
4.9pF( <b>4R9</b> )	W, B	0.3(3)	0.5(5)
5.0pF( <b>5R0</b> )	W, B	0.3(3)	0.5(5)
5.1pF( <b>5R1</b> )			0.5(5)
5.2pF( <b>5R2</b> )			0.5(5)
5.3pF( <b>5R3</b> )			0.5(5)
5.4pF( <b>5R4</b> )			0.5(5)
5.5pF( <b>5R5</b> )			0.5(5)
5.6pF( <b>5R6</b> )			0.5( <b>5</b> )
5.7pF( <b>5R7</b> )			0.5( <b>5</b> )
5.8pF( <b>5R8</b> )			0.5( <b>5</b> )
5.9pF( <b>5R9</b> )			0.5( <b>5</b> )
6.0pF( <b>6R0</b> )			0.5 <b>(5</b> )
6.1pF( <b>6R1</b> )			0.5 <b>(5</b> )
6.2pF( <b>6R2</b> )			0.5 <b>(5</b> )
6.3pF( <b>6R3</b> )			0.5 <b>(5</b> )
6.4pF( <b>6R4</b> )	W, B, C	0.3(3)	0.5( <b>5</b> )
6.5pF( <b>6R5</b> )			0.5( <b>5</b> )
6.6pF( <b>6R6</b> )			0.5( <b>5</b> )
6.7pF( <b>6R7</b> )	W, B, C	0.3(3)	0.5( <b>5</b> )
6.8pF( <b>6R8</b> )			0.5( <b>5</b> )
6.9pF( <b>6R9</b> )			0.5( <b>5</b> )
7.0pF( <b>7R0</b> )			0.5( <b>5</b> )
7.1pF( <b>7R1</b> )	W, B, C		0.5( <b>5</b> )
7.2pF( <b>7R2</b> )	W, B, C		0.5( <b>5</b> )
7.3pF( <b>7R3</b> )	W, B, C		0.5( <b>5</b> )
7.4pF( <b>7R4</b> )	W, B, C		0.5( <b>5</b> )
7.5pF( <b>7R5</b> )	W, B, C		0.5( <b>5</b> )
7.6pF( <b>7R6</b> )			0.5( <b>5</b> )
7.7pF( <b>7R7</b> )			0.5 <b>(5</b> )
7.8pF( <b>7R8</b> )			0.5 <b>(5</b> )
7.9pF( <b>7R9</b> )			0.5( <b>5</b> )
8.0pF( <b>8R0</b> )			0.5( <b>5</b> )
8.1pF( <b>8R1</b> )			0.5(5)
8.2pF( <b>8R2</b> )			0.5(5)
8.3pF( <b>8R3</b> )			0.5(5)
8.4pF( <b>8R4</b> )			0.5(5)
8.5pF( <b>8R5</b> )			
o.ɔpr( <b>8K3</b> )	vv, ⊠, C		0.5( <b>5</b> )

Continued from the preceding page.

Part Number		GJM03	GJM15
L x W [EIA]		0.6x0.3 [0201]	1.0x0.5 [0402]
тс		C0G ( <b>5C</b> )	C0G ( <b>5C</b> )
Rated Volt.		25 ( <b>1E</b> )	50 ( <b>1H</b> )
Capacitance, Ca	apacitanc	e Tolerance and T Dimension	
8.6pF( <b>8R6</b> )	W, B, C		0.5(5)
8.7pF( <b>8R7</b> )	W, B, C		0.5(5)
8.8pF( <b>8R8</b> )	W, B, C		0.5(5)
8.9pF( <b>8R9</b> )	W, B, C		0.5(5)
9.0pF( <b>9R0</b> )	W, B, C		0.5( <b>5</b> )
9.1pF( <b>9R1</b> )	W, B, C		0.5( <b>5</b> )
9.2pF( <b>9R2</b> )	W, B, C		0.5( <b>5</b> )
9.3pF( <b>9R3</b> )	W, B, C		0.5( <b>5</b> )
9.4pF( <b>9R4</b> )	W, B, C		0.5( <b>5</b> )
9.5pF( <b>9R5</b> )	W, B, C		0.5(5)
9.6pF( <b>9R6</b> )	W, B, C		0.5(5)
9.7pF( <b>9R7</b> )	W, B, C		0.5(5)
9.8pF( <b>9R8</b> )	W, B, C		0.5(5)
9.9pF( <b>9R9</b> )	W, B, C		0.5( <b>5</b> )

The part numbering code is shown in  $\ (\ ).$ 

Dimensions are shown in mm and Rated Voltage in Vdc.

			Specifications			
No.	Ite	Item Temperature Compensating Type		Test Method		
1	Operating Temperati	ure Range	−55 to +125℃	Reference Temperature: 25°C (2C, 3C, 4C: 20°C)		
2	Rated Voltage		See the previous pages.	The rated voltage is defined as the maximum voltage which may be applied continuously to the capacitor.  When AC voltage is superimposed on DC voltage, V <sup>p-p</sup> or V <sup>o-p</sup> , whichever is larger, should be maintained within the rated voltage range.		
3	Appearar	nce	No defects or abnormalities	Visual inspection		
4	Dimensio	ns	Within the specified dimensions	Using calipers		
5	Dielectric	Strength	No defects or abnormalities	No failure should be observed when 300% of the rated voltage is applied between the terminations for 1 to 5 seconds, provided the charge/discharge current is less than 50mA.		
6	Insulation (I.R.)	Resistance	10,000M $\Omega$ min. or 500 $\Omega$ · F min. (Whichever is smaller)	The insulation resistance should be measured with a DC voltage not exceeding the rated voltage at 25℃ and 75%RH max. and within 2 minutes of charging.		
7	Capacita	nce	Within the specified tolerance	The capacitance/Q should be measured at 25°C at the frequency and voltage shown in the table.		
0			30pF max.: Q≥400+20C	Frequency 1±0.1MHz		
8	Q		C: Nominal Capacitance (pF)	Voltage 0.5 to 5Vrms		
	Capacitance 9 Temperature Characteristics	Capacitance Change	Within the specified tolerance (Table A)	The capacitance change should be measured after 5 min. at each specified temperature stage.		
		Temperature Coefficient	Within the specified tolerance (Table A)	Temperature Compensating Type The temperature coefficient is determined using the capacitance measured in step 3 as a reference.		
9		erature cteristics Capacitance V	Emperature Characteristics Capacitance Within	Within ±0.2% or ±0.05pF (Whichever is larger.)	When cycling the temperature sequentially from step 1 through 5, (5C: +25 to 125°C: other temp. coeffs.: +20 to 125°C) the capacitance should be within the specified tolerance for the temperature coefficient and capacitance change as Table A. The capacitance drift is calculated by dividing the differences between the maximum and minimum measured values in step 1, 3 and 5 by the capacitance value in step 3.    Step   Temperature (°C)     1   Reference Temp. ±2     2   -55±3     3   Reference Temp. ±2	
				4 125±3		
				5 Reference Temp. ±2		
10	Adhesive Strength of Termination		No removal of the terminations or other defect should occur.	Solder the capacitor to the test jig (glass epoxy board) shown in Fig. 1 using a eutectic solder. Then apply a 5N* force in parallel with the test jig for 10±1 sec. The soldering should be done either with an iron or using the reflow method and should be conducted with care so that the soldering is uniform and free of defects such as heat shock.  *2N (GJM03)  Solder resist  Baked electrode or copper foil  Type a b c GJM03 0.3 0.9 0.3 GJM15 0.4 1.5 0.5  (in mm)		
				Fig. 1		





$\Box$	Continued fr	om the prec	eding page.	
			Specifications	
No.	Ite	em	Temperature Compensating Type	Test Method
		Appearance	No defects or abnormalities	Solder the capacitor to the test jig (glass epoxy board) in the
11	Vibration Resistance	Capacitance  Q	Within the specified tolerance  Q≥400+20C C: Nominal Capacitance (pF)	same manner and under the same conditions as (10). The capacitor should be subjected to a simple harmonic motion having a total amplitude of 1.5mm, the frequency being varied uniformly between the approximate limits of 10 and 55Hz. The frequency range, from 10 to 55Hz and return to 10Hz, should be traversed in approximately 1 minute. This motion should be applied for a period of 2 hours in each of 3 mutually perpendicular directions (total of 6 hours).
			No cracking or marking defects should occur.	Solder the capacitor to the test jig (glass epoxy boards) shown in Fig. 2 using a eutectic solder.  Then apply a force in the direction shown in Fig. 3.  The soldering should be done by the reflow method and should be conducted with care so that the soldering is uniform and free of defects such as heat shock.
12	P Deflection		Type a b c GJM03 0.3 0.9 0.3 GJM15 0.4 1.5 0.5 (in mm)	20 50 Pressurizing speed: 1.0mm/sec. Pressurize  Pressurize  Flexure: ≤1  Capacitance meter  45 45 (in mm)
13	Solderability of Termination		75% of the terminations are to be soldered evenly and continuously.	Immerse the capacitor in a solution of ethanol (JIS-K-8101) and rosin (JIS-K-5902) (25% rosin in weight proportion). Preheat at 80 to 120°C for 10 to 30 seconds. After preheating, immerse in eutectic solder solution for 2±0.5 seconds at 230±5°C or Sn-3.0Ag-0.5Cu solder solution for 2±0.5 seconds at 245±5°C.
			The measured and observed characteristics should satisfy the specifications in the following table.	
		Appearance	No marking defects	
	Resistance	Capacitance	Within ±2.5% or ±0.25pF	Preheat the capacitor at 120 to 150℃ for 1 minute.
14	to Soldering	Change	(Whichever is larger)	Immerse the capacitor in a eutectic solder or Sn-3.0Ag-0.5Cu solder solution at 270±5°C for 10±0.5 seconds.
	Heat	Q	Q≧400+20C C: Nominal Capacitance (pF)	Let sit at room temperature for 24±2 hours.
		I.R.	More than $10,000M\Omega$ or $500\Omega \cdot F$ (Whichever is smaller)	
		Dielectric Strength	No failure	
			The measured and observed characteristics should satisfy the specifications in the following table.	
		Appearance	No marking defects	Fix the capacitor to the supporting jig in the same manner and under the same conditions as (10). Perform the five cycles
	Temperature	Capacitance Change	Within ±2.5% or ±0.25pF (Whichever is larger)	according to the four heat treatments listed in the following table. Let sit for 24±2 hours at room temperature, then measure.
15	Cycle	,	Q≥400+20C	Step         1         2         3         4
		Q	C: Nominal Capacitance (pF)	Temp. (°C)   Min. Operating   Room   Max. Operating   Room   Temp. +3   Temp. +3   Temp. +3   Temp.
		I.R.	More than 10,000M $\Omega$ or 500 $\Omega$ · F (Whichever is smaller)	Time (min.) 30±3 2 to 3 30±3 2 to 3
		Dielectric Strength	No failure	
			The measured and observed characteristics should satisfy the specifications in the following table.	
		Appearance	No marking defects	
1,	Humidity,	Capacitance	Within ±5% or ±0.5pF	Let the capacitor sit at 40±2℃ and 90 to 95% humidity for 500±12 hours.
16	Steady State	Change	(Whichever is larger)  10pF and over, 30pF and below: Q≥275+ 5 C  10pF and below: Q≥200+10C  C: Naminal Capacitanes (pE)	Remove and let sit for 24±2 hours (temperature compensating type) at room temperature, then measure.
		I.R.	C: Nominal Capacitance (pF)  More than $10,000M\Omega$ or $500\Omega \cdot F$ (Whichever is smaller)	
			·	l .





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	Item		Specifications	T
No.			Temperature Compensating Type	Test Method
			The measured and observed characteristics should satisfy the specifications in the following table.	
		Appearance	No marking defects	
17	Humidity	Capacitance Change	Within ±7.5% or ±0.75pF (Whichever is larger)	Apply the rated voltage at 40±2°C and 90 to 95% humidity for 500±12 hours.
17	Load	Q	30pF and below: Q≥100+ <sup>10</sup> / <sub>3</sub> C C: Nominal Capacitance (pF)	Remove and let sit for 24±2 hours at room temperature, then measure. The charge/discharge current is less than 50mA.
		I.R.	More than $500 \text{M}\Omega$ or $25 \Omega \cdot \text{F}$ (Whichever is smaller)	
		Dielectric Strength	No failure	
			The measured and observed characteristics should satisfy the specifications in the following table.	
		Appearance	No marking defects	
	High	Capacitance Change	Within ±3% or ±0.3pF (Whichever is larger)	Apply 200% of the rated voltage for 1000±12 hours at the maximum operating temperature ±3°C. Let sit for 24±2 hours
18	Temperature Load	Q	10pF and over, 30pF and below: Q≥275+ ½ C 10pF and below: Q≥200+10C C: Nominal Capacitance (pF)	(temperature compensating type) at room temperature, then measure. The charge/discharge current is less than 50mA.
		I.R.	More than 1,000M $\Omega$ or 50 $\Omega$ · F (Whichever is smaller)	
		Dielectric Strength	No failure	
19	ESR		0.5pF≦C≦1pF: 350mΩ below 1pF <c≦5pf: 300mω="" below<br="">5pF<c≦10pf: 250mω="" below<="" td=""><td>The ESR should be measured at room temperature, and frequency 1±0.2GHz with the equivalent of BOONTON Model 34A.</td></c≦10pf:></c≦5pf:>	The ESR should be measured at room temperature, and frequency 1±0.2GHz with the equivalent of BOONTON Model 34A.
			10pF <c≦20pf: 400mω="" below<="" td=""><td>The ESR should be measured at room temperature, and frequency 500±50MHz with the equivalent of HP8753B.</td></c≦20pf:>	The ESR should be measured at room temperature, and frequency 500±50MHz with the equivalent of HP8753B.

# Table A

(1)									
	Temp. Coeff. (ppm/°C) *1	Capacitance Change from 25℃ Value (%)							
Char. Code		-55°C		−30°C		-10℃			
		Max.	Min.	Max.	Min.	Max.	Min.		
5C	0±30	0.58	-0.24	0.40	-0.17	0.25	-0.11		

<sup>\*1:</sup> Nominal values denote the temperature coefficient within a range of 25 to 125°C.

(2)

	<del>\-'</del>									
		Nominal Values (ppm/°C) *2	Capacitance Change from 20℃ Value (%)							
	Char.		<b>−</b> 55℃		-25°C		-10°C			
			Max.	Min.	Max.	Min.	Max.	Min.		
	2C	0±60	0.82	-0.45	0.49	-0.27	0.33	-0.18		
	3C	0±120	0.37	-0.90	0.82	-0.54	0.55	-0.36		
	4C	0±250	0.56	-0.88	1.54	-1.13	1.02	-0.75		

<sup>\*2:</sup> Nominal values denote the temperature coefficient within a range of 20 to 125°C.

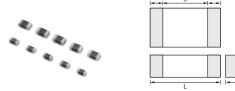
# **High Frequency GQM Series**

#### ■ Features

- 1. HiQ and low ESR at VHF, UHF, Microwave
- 2. Feature improvement, low power consumption for mobile telecommunications (Base station, terminal,

#### ■ Applications

High frequency circuit (Mobile telecommunications, etc.)



Part Number	Dimensions (mm)						
Part Number	L	W	Т	е	g min.		
GQM188	1.6 ±0.1	0.8 ±0.1	0.8 ±0.1	0.2 to 0.5	0.5		
GQM219	2.0 ±0.1	1.25 ±0.1	0.85 ±0.1	0.2 to 0.7	0.7		

Part Number	GQM18	}	GQN	121		
LxW	1.6x0.8		2.0x1.25			
тс	C0G ( <b>5C</b> )			G ;)		
Rated Volt.	100 ( <b>2A</b> )	50 ( <b>1H</b> )	100 ( <b>2A</b> )	50 ( <b>1H</b> )		
Capacitance (Capaci	tance part numbering code) and	d T (mm) Dimension (T Dimen	sion part numbering code)			
0.50pF( <b>R50</b> )	0.8(8)		0.85( <b>9</b> )			
0.75pF( <b>R75</b> )	0.8(8)		0.85( <b>9</b> )			
1.0pF( <b>1R0</b> )	0.8(8)		0.85( <b>9</b> )			
1.1pF( <b>1R1</b> )	0.8(8)		0.85 <b>(9)</b>			
1.2pF( <b>1R2</b> )	0.8(8)		0.85 <b>(9)</b>			
1.3pF( <b>1R3</b> )	0.8(8)		0.85 <b>(9)</b>			
1.5pF( <b>1R5</b> )	0.8(8)		0.85 <b>(9</b> )			
1.6pF( <b>1R6</b> )	0.8(8)		0.85( <b>9</b> )			
1.8pF( <b>1R8</b> )	0.8(8)		0.85( <b>9</b> )			
2.0pF( <b>2R0</b> )	0.8(8)		0.85( <b>9</b> )			
2.2pF( <b>2R2</b> )	0.8(8)		0.85( <b>9</b> )			
2.4pF( <b>2R4</b> )	0.8(8)		0.85( <b>9</b> )			
2.7pF( <b>2R7</b> )	0.8(8)		0.85( <b>9</b> )			
3.0pF( <b>3R0</b> )	0.8(8)		0.85( <b>9</b> )			
3.3pF( <b>3R3</b> )	0.8(8)		0.85( <b>9</b> )			
3.6pF( <b>3R6</b> )	0.8(8)		0.85( <b>9</b> )			
3.9pF( <b>3R9</b> )	0.8(8)		0.85( <b>9</b> )			
4.0pF( <b>4R0</b> )	0.8(8)		0.85( <b>9</b> )			
4.3pF( <b>4R3</b> )	0.8(8)		0.85( <b>9</b> )			
4.7pF( <b>4R7</b> )	0.8(8)		0.85( <b>9</b> )			
5.0pF( <b>5R0</b> )	0.8(8)		0.85( <b>9</b> )			
5.1pF( <b>5R1</b> )	0.8(8)		0.85(9)			
5.6pF( <b>5R6</b> )	0.8(8)		0.85(9)			
6.0pF( <b>6R0</b> )	0.8(8)		0.85( <b>9</b> )			
6.2pF( <b>6R2</b> )	0.8(8)		0.85( <b>9</b> )			
6.8pF( <b>6R8</b> )	0.8(8)		0.85( <b>9</b> )			
7.0pF( <b>7R0</b> )		0.8(8)	0.85( <b>9</b> )			
7.5pF( <b>7R5</b> )		0.8(8)	0.85(9)			
8.0pF( <b>8R0</b> )		0.8(8)	0.85(9)			
8.2pF( <b>8R2</b> )		0.8(8)	0.85(9)			
9.0pF( <b>9R0</b> )		0.8(8)	0.85( <b>9</b> )			
9.1pF( <b>9R1</b> )		0.8(8)	0.85( <b>9</b> )			
10pF( <b>100</b> )		0.8(8)	0.85(9)			

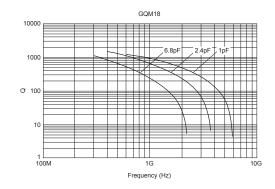
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Part Number			GQM21		
x W	1.6x0	1.6x0.8 2.0x1.25			
с	C00 ( <b>50</b>	G ()		COG ( <b>5C</b> )	
Rated Volt.	100 ( <b>2A</b> )	50 ( <b>1 H</b> )	100 ( <b>2A</b> )	50 ( <b>1H</b> )	
Capacitance (Capacita	nce part numbering code) a	and T (mm) Dimension (T Dimens	sion part numbering code)		
11pF( <b>110</b> )		0.8(8)	0.85 <b>(9</b> )		
12pF( <b>120</b> )		0.8(8)	0.85 <b>(9)</b>		
13pF( <b>130</b> )		0.8(8)	0.85 <b>(9)</b>		
15pF( <b>150</b> )		0.8(8)	0.85 <b>(9)</b>		
16pF( <b>160</b> )		0.8(8)	0.85( <b>9</b> )		
18pF( <b>180</b> )		0.8(8)	0.85( <b>9</b> )		
20pF( <b>200</b> )		0.8(8)		0.85( <b>9</b> )	
22pF( <b>220</b> )		0.8(8)		0.85( <b>9</b> )	
24pF( <b>240</b> )		0.8(8)		0.85( <b>9</b> )	
27pF( <b>270</b> )		0.8(8)		0.85( <b>9</b> )	
30pF( <b>300</b> )		0.8(8)		0.85( <b>9</b> )	
33pF( <b>330</b> )		0.8(8)		0.85( <b>9</b> )	
36pF( <b>360</b> )		0.8(8)		0.85( <b>9</b> )	
39pF( <b>390</b> )		0.8(8)		0.85( <b>9</b> )	
43pF( <b>430</b> )		0.8(8)		0.85( <b>9</b> )	
47pF( <b>470</b> )		0.8(8)		0.85( <b>9</b> )	
51pF( <b>510</b> )		0.8(8)		0.85( <b>9</b> )	
56pF( <b>560</b> )		0.8(8)		0.85( <b>9</b> )	
62pF( <b>620</b> )		0.8(8)		0.85(9)	
68pF( <b>680</b> )		0.8(8)		0.85(9)	
75pF( <b>750</b> )		0.8(8)		0.85(9)	
82pF( <b>820</b> )		0.8(8)		0.85(9)	
91pF( <b>910</b> )		0.8(8)		0.85(9)	
100pF( <b>101</b> )		0.8(8)		0.85(9)	

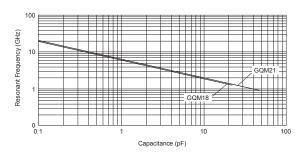
The part numbering code is shown in ().

Dimensions are shown in mm and Rated Voltage in Vdc.

#### ■ Q - Frequency Characteristics



#### ■ Resonant Frequency - Capacitance



No.	No. Item Specifica		Specifications	Test Method			
1	Operating Temperatu	ıre	-55 to 125℃	Reference Temperature: 25°C (2C, 3C, 4C: 20°C)			
2	2 Rated Voltage		See the previous page.	The rated voltage is defined as the maximum voltage which may be applied continuously to the capacitor. When AC voltage is superimposed on DC voltage, V <sup>p,p</sup> or V <sup>o,p</sup> , whichever is larger, should be maintained within the rated voltage range.			
3	Appearar	nce	No defects or abnormalities	Visual inspection			
4	Dimensio	n	Within the specified dimensions	Using calipers			
5	Dielectric	Strength	No defects or abnormalities	No failure should be is applied between the provided the charge/	ne terminatio	ns for 1 to 5 se	conds,
6	Insulation	Resistance	More than 10,000M $\Omega$ (Whichever is smaller)	The insulation resistant voltage not exceeding max. and within 2 minus	g the rated v	oltage at 25℃ a	
7	Capacita	nce	Within the specified tolerance	The capacitance/Q s			at the
8	Q		30pF min.: Q≥1400 30pF max.: Q≥800+20C	Frequency  Voltage	ge shown in the	1±0.1MHz	
			C: Nominal Capacitance (pF)	voltage		0.0 10 0 11110	<u>,                                      </u>
		Capacitance Change	Within the specified tolerance (Table A)	The temperature coefficient is determined using the comeasured in step 3 as a reference.  When cycling the temperature sequentially from step the capacitance should be within the specified tolerantemperature coefficient and capacitance change as in			
		Temperature Coefficient	Within the specified tolerance (Table A)				erance for the
9	Capacitance Temperature Characteristics	Capacitance Drift	Within ±0.2% or ±0.05pF (Whichever is larger)	between the maximu	ift is calculated by dividing the differences um and minimum measured values in the the capacitance value in step 3.  Temperature (°C)  Reference Temp. ±2  -55±3  Reference Temp. ±2  125±3  Reference Temp. ±2		
			No removal of the terminations or other defect should occur.	Solder the capacitor t	o the test jig (	glass epoxy bo	ard) shown in
10	Adhesive Strength of Termination		Solder resist Baked electrode or copper foil	Fig. 1 using a eutectic solder. Then apply 10N* force in parallel with the test jig for 10±1 sec.  The soldering should be done either with an iron or using the reflow method and should be conducted with care so that the soldering is uniform and free of defects such as heat shock.  *5N (GQM188  Type a b c GQM18 1.0 3.0 1.2 GQM21 1.2 4.0 1.65  (in mm)  Fig. 1			ce in parallel or using the e so that the eat shock. *5N (GQM188)  C 1.2 1.65
		Appearance	No defects or abnormalities	Solder the capacitor	to the test jig	(glass epoxy l	ooard) in the
11	Vibration Resistance	Capacitance	Within the specified tolerance  30pF min.: Q≥1400 30pF max.: Q≥800+20C  C: Nominal Capacitance (pF)	same manner and under the same conditions as (10).  The capacitor should be subjected to a simple harmonic motion having a total amplitude of 1.5mm, the frequency being varied uniformly between the approximate limits of 10 and 55Hz. The frequency range, from 10 to 55Hz and return to 10Hz, should be traversed in approximately 1 minute.  This motion should be applied for a period of 2 hours in each of			armonic motion y being varied and 55Hz. The 10Hz, should
				3 mutually perpendicular directions (total of 6 hours).			

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No.	Ite	m	Specifications	Test Method			
12	Deflection	Deflection		Solder the capacitor on the test jig (glass epoxy board) shown in Fig. 2 using a eutectic solder.  Then apply a force in the direction shown in Fig. 3.  The soldering should be done by the reflow method and should be conducted with care so that the soldering is uniform and fre of defects such as heat shock.  20 50 Pressurizing speed: 1.0mm/sec.  Pressurize  Flexure: ≤1			
			GQM21 1.2 4.0 1.65 (in mm)	Fig. 3			
13	Solderabi Terminati		75% of the terminations are to be soldered evenly and continuously.	Immerse the capacitor in a solution of ethanol (JIS-K-8101) and rosin (JIS-K-5902) (25% rosin in weight proportion). Preheat at 80 to 120°C for 10 to 30 seconds. After preheating, immerse in eutectic solder solution for 2±0.5 seconds at 230±5°C or Sn-3.0Ag-0.5Cu solder solution for 2±0.5 seconds at 245±5°C.			
			The measured and observed characteristics should satisfy the specifications in the following table.				
		Appearance	No marking defects				
		Capacitance	Within ±2.5% or ±0.25 pF	1			
	Resistance to Soldering Heat	Change	(Whichever is larger) 30pF min.: Q≥1400	Preheat the capacitor at 120 to 150°C for 1 minute. Immerse the capacitor in a eutectic solder or Sn-3.0Ag-0.5Cu solder solution			
14		Q	30pF max.: Q≥800+20C	at 270 $\pm$ 5°C for 10 $\pm$ 0.5 seconds. Let sit at room temperature for 24 $\pm$ 2 hours.			
		I.R.	C: Nominal Capacitance (pF)  More than 10,000MΩ				
		Dielectric Strength	No failure				
			The measured and observed characteristics should satisfy the specifications in the following table.				
		Appearance	No marking defects	Fix the capacitor to the supporting jig in the same manner and under the same conditions as (10).  Perform the five cycles according to the four heat treatments listed in the following table.			
		Capacitance Change	Within ±2.5% or ±0.25pF (Whichever is larger)				
15	Temperature Cycle	_	30pF min.: Q≥1400 30pF max.: Q≥800+20C	Let sit for 24±2 hours at room temperature, then measure.  Step 1 2 3 4			
		Q	C: Nominal Capacitance (pF)	Temp (%) Min. Operating Room Max. Operating Room			
		I.R.	More than 10,000M $\Omega$	Time (min.) 30±3 2 to 3 30±3 2 to 3			
		Dielectric Strength	No failure				
			The measured and observed characteristics should satisfy the specifications in the following table.				
		Appearance	No marking defects				
		Capacitance Change	Within ±5% or ±0.5pF (Whichever is larger)	Lat the conscitor oit at 40±2% and 00 to 050/ burnidik. fr-			
16	Humidity Steady State	Q	30pF min.: Q≥350 10pF and over, 30pF and below: Q≥275+5C/2 10pF max.: Q≥200+10C	Let the capacitor sit at 40±2°C and 90 to 95% humidity for 500±12 hours.  Remove and let sit for 24±2 hours (temperature compensating type) at room temperature, then measure.			
		LD	C: Nominal Capacitance (pF)				
		I.R. Dielectric	More than 1,000MΩ	-			
		Strength	No failure	Continued on the following page			

Continued from the preceding page.

No.	Ite	em	Specifications	Test Method			
			The measured and observed characteristics should satisfy the specifications in the following table.				
		Appearance	No marking defects				
		Capacitance Change	Within ±7.5% or ±0.75pF (Whichever is larger)	Apply the rated voltage at 40±2°C and 90 to 95% humidity for			
17	Humidity Load	Q	30pF min.: Q≥200 30pF max.: Q≥100+10C/3	500±12 hours. Remove and let sit for 24±2 hours at room temperature then measure. The charge/discharge current is less than 50mA.			
			C: Nominal Capacitance (pF)				
		I.R.	More than $500M\Omega$				
		Dielectric Strength	No failure				
			The measured and observed characteristics should satisfy the specifications in the following table.				
		Appearance	No marking defects				
		Capacitance Change	Within ±3% or ±0.3pF (Whichever is larger)	Apply 200% of the rated voltage for 1000±12 hours at the			
18	High Temperature Load	Q	30pF min.: Q≥350 10pF and over, 30pF and below: Q≥275+5C/2 10pF max.: Q≥200+10C	maximum operating temperature ±3°C.  Let sit for 24±2 hours (temperature compensating type) at room temperature, then measure.  The charge/discharge current is less than 50mA.			
			C: Nominal Capacitance (pF)				
		I.R.	More than 1,000M $\Omega$				
		Dielectric Strength	No failure				

# Table A

(1)									
		Nominal Values (ppm/°C) *1	Capacitance Change from 25℃ (%)						
	Char.		<b>−</b> 55℃		−30°C		-10℃		
			Max.	Min.	Max.	Min.	Max.	Min.	
	5C	0±30	0.58	-0.24	0.40	-0.17	0.25	-0.11	

<sup>\*1:</sup> Nominal values denote the temperature coefficient within a range of 25 to 125°C.

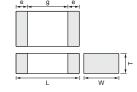
# muRata

# **High Frequency Type ERB Series**

#### ■ Features (ERB Series)

- Negligible inductance is achieved by its monolithic structure so the series can be used at frequencies above 1GHz.
- 2. Nickel barriered terminations of ERB series improve solderability and decrease solder leaching.
- ERB18/21 series are designed for both flow and reflow soldering and ERB32 series are designed for reflow soldering.





Part Number	Dimensions (mm)						
Part Number	L	W	T max.	e min.	g min.		
ERB188	1.6±0.1	0.8±0.1	0.9	0.2	0.5		
ERB21B	2.0±0.3	1.25±0.3	1.35	0.25	0.7		
ERB32Q	3.2±0.3	2.5±0.3	1.7	0.3	1.0		

#### ■ Applications

High frequency and high-power circuits

Part Number	ERB18			ERI	321				ER	B32		
LxW	1.6	x0.8		2.0x	1.25			3.2x2.5				
тс		0G <b>C</b> )		C0 ( <b>5</b> 0			C0G ( <b>5C</b> )					
Rated Volt.	250 ( <b>2E</b> )	200 ( <b>2D</b> )	250 ( <b>2E</b> )	200 ( <b>2D</b> )	100 ( <b>2A</b> )	50 ( <b>1H</b> )	500 ( <b>2H</b> )	300 ( <b>YD</b> )	250 ( <b>2E</b> )	200 ( <b>2D</b> )	100 ( <b>2A</b> )	50 ( <b>1H</b> )
Capacitance (Ca	pacitance	part numb	ering code)	and T (mm	) Dimensio	n (T Dimen	sion part n	umbering o	ode)			
0.50pF( <b>R50</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
0.75pF( <b>R75</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
1.0pF( <b>1R0</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
1.1pF( <b>1R1</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
1.2pF( <b>1R2</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
1.3pF( <b>1R3</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
1.5pF( <b>1R5</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
1.6pF( <b>1R6</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
1.8pF( <b>1R8</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
2.0pF( <b>2R0</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
2.2pF( <b>2R2</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
2.4pF( <b>2R4</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
2.7pF( <b>2R7</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
3.0pF( <b>3R0</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
3.3pF( <b>3R3</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
3.6pF( <b>3R6</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
3.9pF( <b>3R9</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
4.0pF( <b>4R0</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
4.3pF( <b>4R3</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
4.7pF( <b>4R7</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
5.0pF( <b>5R0</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
5.1pF( <b>5R1</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
5.6pF( <b>5R6</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
6.0pF( <b>6R0</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
6.2pF( <b>6R2</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
6.8pF( <b>6R8</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
7.0pF( <b>7R0</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
7.5pF( <b>7R5</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
8.0pF( <b>8R0</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
8.2pF( <b>8R2</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
9.0pF( <b>9R0</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
9.1pF( <b>9R1</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					

☐ Continued from	the precedin	g page.										
Part Number	ER	B18		ER	B21				ER	B32		
LxW	1.6	x0.8	2.0x1.25			3.2x2.5						
тс		0G ( <b>C</b> )			0G <b>C</b> )		C0G ( <b>5C</b> )					
Rated Volt.	250 ( <b>2E</b> )	200 ( <b>2D</b> )	250 ( <b>2E</b> )	200 ( <b>2D</b> )	100 ( <b>2A</b> )	50 ( <b>1H</b> )	500 ( <b>2H</b> )	300 ( <b>YD</b> )	250 ( <b>2E</b> )	200 ( <b>2D</b> )	100 ( <b>2A</b> )	50 ( <b>1H</b> )
Capacitance (Ca	pacitance	part number	ering code)	and T (mm	) Dimensio	n (T Dimen	sion part n	umbering c	ode)			
10pF( <b>100</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
11pF( <b>110</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
12pF( <b>120</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
13pF( <b>130</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
15pF( <b>150</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
16pF( <b>160</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
18pF( <b>180</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
20pF( <b>200</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
22pF( <b>220</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
24pF( <b>240</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
27pF( <b>270</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
30pF( <b>300</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
33pF( <b>330</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
36pF( <b>360</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
39pF( <b>390</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
43pF( <b>430</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
47pF( <b>470</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
51pF( <b>510</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
56pF( <b>560</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
62pF( <b>620</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
68pF( <b>680</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
75pF( <b>750</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
82pF( <b>820</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
91pF( <b>910</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
100pF( <b>101</b> )	0.9(8)	0.9(8)	1.35( <b>B</b> )	1.35( <b>B</b> )			1.7( <b>Q</b> )					
110pF( <b>111</b> )					1.35( <b>B</b> )		1.7( <b>Q</b> )					
120pF( <b>121</b> )					1.35( <b>B</b> )		1.7( <b>Q</b> )					
130pF( <b>131</b> )					1.35( <b>B</b> )			1.7( <b>Q</b> )				
150pF( <b>151</b> )						1.35( <b>B</b> )		1.7( <b>Q</b> )				
160pF( <b>161</b> )						1.35( <b>B</b> )			1.7( <b>Q</b> )	1.7( <b>Q</b> )		
180pF( <b>181</b> )									1.7( <b>Q</b> )	1.7( <b>Q</b> )		
200pF( <b>201</b> )									1.7( <b>Q</b> )	1.7( <b>Q</b> )		
220pF( <b>221</b> )									1.7( <b>Q</b> )	1.7( <b>Q</b> )		
240pF( <b>241</b> )											1.7( <b>Q</b> )	
270pF( <b>271</b> )											1.7( <b>Q</b> )	
300pF( <b>301</b> )											1.7( <b>Q</b> )	
330pF( <b>331</b> )											1.7( <b>Q</b> )	
360pF( <b>361</b> )											1.7( <b>Q</b> )	
390pF( <b>391</b> )											1.7( <b>Q</b> )	
430pF( <b>431</b> )											1.7( <b>Q</b> )	
470pF( <b>471</b> )											1.7( <b>Q</b> )	
510pF( <b>511</b> )												1.7( <b>Q</b> )
560pF( <b>561</b> )												1.7( <b>Q</b> )
620pF( <b>621</b> )												1.7( <b>Q</b> )
680pF( <b>681</b> )												1.7( <b>Q</b> )
750pF( <b>751</b> )												1.7( <b>Q</b> )
820pF( <b>821</b> )												1.7( <b>Q</b> )
910pF( <b>911</b> )												1.7( <b>Q</b> )
1000pF( <b>102</b> )												1.7( <b>Q</b> )

The part numbering code is shown in ().

Dimensions are shown in mm and Rated Voltage in Vdc.

No.	Ite	em	Specifications		Test Met	hod	
1	Operating Temperati		-55 to +125℃	Reference Temperature: 25°C			
2	Rated Vo	iltage	See the previous pages.	The rated voltage is defined as the maximum voltage which may be applied continuously to the capacitor.  When AC voltage is superimposed on DC voltage, V <sup>p-p</sup> or V whichever is larger, should be maintained within the rated voltage range.			ie, V <sup>p.p</sup> or V <sup>o.p</sup> ,
3	Appearar	nce	No defects or abnormalities	Visual inspection			
4	Dimensio	ns	Within the specified dimension	Using calipers			
5	Dielectric	Strength	No defects or abnormalities	No failure should be observed when 300%(*) of the rated vo age is applied between the terminations for 1 to 5 seconds, provided the charge/discharge current is less than 50mA. (*) 300V: 250%, 500V: 200%			5 seconds,
6	Insulation (I.R.)	Resistance	1,000,000MΩ min. (C≤470pF) 100,000MΩ min. (C>470pF)	The insulation resistance should be measured with a DC voltage not exceeding the rated voltage at 25°C and standard humidity and within 2 minutes of charging.			
7	Capacita	nce	Within the specified tolerance	The capacitance/Q should be measured at 25℃ at the			at the
8	Q		C≦ 220pF : Q≥10,000 220pF <c≦ 470pf="" 5,000<br="" :="" q≥="">470pF<c≦1,000pf 3,000<br="" :="" q≥="">C: Nominal Capacitance (pF)</c≦1,000pf></c≦>	frequency and voltage shown in the table.  Frequency 1±0.1MHz  Voltage 1±0.2Vrms			
		Capacitance Change	Within the specified tolerance (Table A-6)	The temperature coefficient is determined using the capacitance measured in step 3 as a reference. When cycling the temperature sequentially from step 1 through 5, the capacitance should be within the specified tolerance for the temperature coefficient and capacitance change as Table A.			
		Temperature Coefficent	Within the specified tolerance (Table A-6)				
9	Capacitance Temperature			The capacitance drift is calculated by dividing the differences between the maximum and minimum measured values in steps 1, 3 and 5 by the capacitance value in step 3.			e differences values in steps
	Characteristics	Capacitance	Within ±0.2% or ±0.05pF	Step 1	16	mperature (℃ 25±2	•)
		Drift	(Whichever is larger)	2		-55±3	
				3		25±2	
				4		125±3	
				5		25±2	
	No removal of the terminations or other defects should occur.		Solder the capacitor in Fig. 1 using an eu		(glass epoxy	board) shown	
10		Strength		Then apply 10N* for The soldering should reflow method and soldering is uniform	ce in parallel was done either hould be cond and free of def	er with an iron ucted with car fects such as	or using the re so that the heat shock.
	of Termir	nation		Type FPR18	1.0	3.0	C 1 2

Solder Resist

Copper Foil

Fig.1

Baked Electrode or

\*5N (ERB188)

b 3.0

4.0

5.0

1.0

1.2

2.2

ERB18

ERB21

ERB32

Continued on the following page.

c 1.2

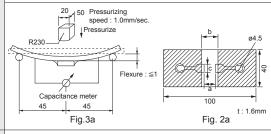
1.65

2.9

(in mm)

$\neg$		_			
11	Continued	from	the	preceding	nage

No.	Ite	em	Specifications	Test Method
		Appearance	No defects or abnormalities	Solder the capacitor to the test jig (glass epoxy board) in the same manner and under the same conditions as (10).
		Capacitance	Within the specified tolerance	The capacitor should be subjected to a simple harmonic motion
11	Vibration Resistance	Q	Satisfies the initial value. $C \le 220 pF : Q \ge 10,000$ $220 pF < C \le 470 pF : Q \ge 5,000$ $470 pF < C \le 1,000 pF : Q \ge 3,000$ C: Nominal Capacitance (pF)	having a total amplitude of 1.5mm, the frequency being varied uniformly between the approximate limits of 10 and 55Hz.  The frequency range, from 10 to 55Hz and return to 10Hz, should be traversed in approximately 1 minute. This motion should be applied for a period of 2 hours in each of 3 mutually perpendicular directions (total of 6 hours).
12	12 Deflection		No crack or marked defect should occur.  20 50 Pressurizing speed : 1.0mm/sec. Pressurize  4.5	Solder the capacitor on the test jig (glass epoxy board) shown in Fig. 2a using an eutectic solder. Then apply a force in the direction shown in Fig. 3a. The soldering should be done by the reflow method and should be conducted with care so that the soldering is uniform and free of defects such as heat shock.



Type b ERB18 1.0 3.0 1.2 ERB21 1.2 4.0 1.65 ERB32 2.2 5.0 2.9 (in mm)

Solderability of 95% of the terminations are to be soldered evenly and Termination continuously.

specifications in the following table.

Immerse the capacitor in a solution of isopropyl alcohol and rosin (25% rosin in weight proportion). Preheat at 80 to 120°C for 10 to 30 seconds. After preheating, immerse in an eutectic solder or Sn-3.0Ag-0.5Cu solder solution for 5±0.5 seconds at 245±5℃.

Resistance to Soldering Heat

Temperature

Humidity

15 Cycle

Item	Specifications		
Appearance	No marked defect		
Capacitance	Within ±2.5% or ±0.25pF		
Change	(Whichever is larger)		
	C≦ 220pF : Q≥10,000		
Q	220pF <c≤ 470pf="" 5,000<="" :="" q≥="" td=""></c≤>		
	470pF <c≦1,000pf 3,000<="" :="" q≥="" td=""></c≦1,000pf>		
Dielectric Strength	No failure		

The measured and observed characteristics should satisfy the

Preheat according to the conditions listed in the table below. Immerse the capacitor in an eutectic solder or Sn-3.0Ag-0.5Cu solder solution at 270±5°C for 10±0.5 seconds. Let sit at room temperature for 24±2 hours.

Chip Size	Preheat Condition
2.0×1.25mm max.	1minute at 120 to 150℃
3.2×2.5mm	Each 1 minute at 100 to 120℃ and then 170 to 200℃

The measured and observed characteristics should satisfy the specifications in the following table.

C: Nominal Capacitance (pF)

muRata

Item	Specifications
Appearance	No marked defect
Capacitance	Within ±5% or ±0.5pF
Change	(Whichever is larger)
	C≧30pF : Q≥350
Q	10pF≦C<30pF : Q≥275+ <del>5</del> C
	C<10pF : Q≥200+10C
I.R.	1,000MΩ min.
Dielectric Strength	No failure
	C: Nominal Capacitance (pF)

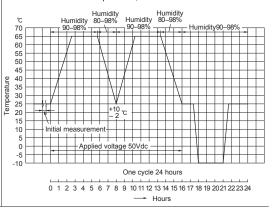
Fix the capacitor to the supporting jig in the same manner and under the same conditions as (10). Perform the five cycles  $\,$ according to the four heat treatments listed in the following table. Let sit for 24±2 hours at room temperature, then measure.

Step	1	2	3	4
Temp. (℃)	Min. Operating Temp. +0/-3	Room Temp.	Max. Operating Temp. +3/-0	Room Temp.
Time (min.)	30±3	5 max.	30±3	5 max.

The measured and observed characteristics should satisfy the specifications in the following table.

Item	Specifications
Appearance	No marked defect
Capacitance	Within ±5% or ±0.5pF
Change	(Whichever is larger)
	C≧30pF : Q≥350
Q	10pF≦C<30pF : Q≥275+ <del>5</del> C
	C<10pF : Q≥200+10C
I.R.	1,000MΩ min.
	C: Nominal Capacitance (pF

Apply the 24-hour heat (−10 to +65°C) and humidity (80 to 100%) treatment shown below, 10 consecutive times. Remove, let sit for 24±2 hours at room temperature, and measure.



Continued from the preceding page.

_						
No.	Item	Specifications		Test Method		
		The measured and observed characteristics should satisfy the specifications in the following table.				
		Item	Specifications			
		Appearance	No marked defect			
		Capacitance	Within ±3% or ±0.3pF	Apply 200% (500V only 150%) of the rated voltage for 1,000±		
17	High Temperature	Change	(Whichever is larger)	hours at 125±3℃.		
17	Load	Load	Q	C≥30pF : Q≥350 10pF≤C<30pF : Q≥275+ ½ C C<10pF : Q≥200+10C	Remove and let sit for 24±2 hours at room temperature, then measure. The charge/discharge current is less than 50mA.	
		I.R.	1,000MΩ min.			
		Dielectric Strength	No failure			
			C: Nominal Capacitance (pF)			

#### Table A-6

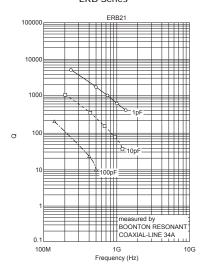
Char.	Nominal Values (ppm/°C) Note 1	Capacitance Change from 25℃ (%)					
		-55		-30		-10	
	(ppili/ c) Note i	Max.	Min.	Max.	Min.	Max.	Min.
5C	0±30	0.58	-0.24	0.40	-0.17	0.25	-0.11

Note 1: Nominal values denote the temperature coefficient within a range of 25 to 125℃ (for 5C)

### **ERB Series Data**

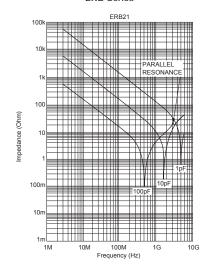
#### ■ Q - Frequency Characteristics

#### ERB Series



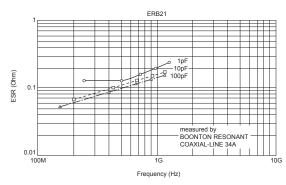
#### ■ Impedance - Frequency Characteristics

#### **ERB Series**



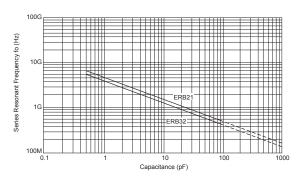
### **■** ESR - Frequency Characteristics

**ERB Series** 

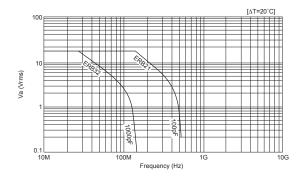


#### ■ Resonant Frequency - Capacitance

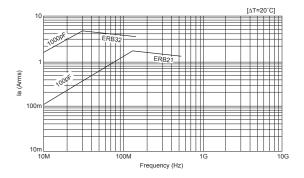
**ERB Series** 



### ■ Allowable Voltage - Frequency



#### ■ Allowable Current - Frequency





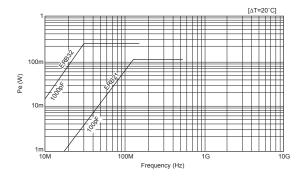
### **ERB Series Data**

\( \) Continued from the preceding page.

#### ■ Allowable Apparent Power - Frequency

# [ΔT=20°C] Pa (VA) Frequency (Hz)

#### ■ Allowable Effective Power - Frequency





#### ■ Minimum Quantity Guide

Dart Number		Dimensions (mm)					ty (pcs.)			
Part Number		L W T		ø180mm Reel Paper Tape Embossed Tape		ø330mm Reel Paper Tape Embossed Tape		Bulk Case	Bulk Bag	
Packaging	a Code	+-		'	D D	L L	J	K	С	Bulk : B
r ackaging	y Code					-	J	K	C	Tray : T
	GRM02	0.4	0.2	0.2	20,000	-	-	-	-	1,000
	GRM03	0.6	0.3	0.3	15,000	-	50,000	-	-	1,000
	GRM15	1.0	0.5	0.25	10,000	-	50,000	-	-	1,000
	CDM40	1.6	0.0	0.5	10,000	-	50,000	-	50,000	1,000
	GRM18	1.6	8.0	0.8	4,000	-	10,000	-	15,000 <sup>1)</sup> 10,000	1,000
	GRM21	2.0	1.25	0.85/1.0	4,000 4,000	-	10,000	-	10,000	1,000
	ORME	2.0	1.20	1.25	-,000	3,000	-	10,000	5,000 <sup>2)</sup>	1,000
				0.6/0.85	4,000	-	10,000	-	-	1,000
	GRM31	3.2	1.6	1.15	-	3,000	-	10,000	-	1,000
				1.6	_	2,000	-	6,000	-	1,000
For General				0.85	-	4,000	-	10,000	-	1,000
Purpose				1.15	-	3,000	-	10,000	-	1,000
	GRM32	3.2	2.5	1.35	-	2,000	-	8,000	-	1,000
				1.6	-	2,000	-	6,000	-	1,000
				1.8/2.0 2.5	-	1,000	-	4,000	-	1,000
				1.15	-	1,000	-	5,000	-	1,000
	GRM43	4.5	3.2	1.35/1.6 1.8/2.0	-	1,000	-	4,000	-	1,000
				2.5	-	500	-	2,000	-	1,000
				2.8	-	500	-	1,500	-	500
	<b>GRM55</b> 5.7			1.15	-	1,000	-	5,000	-	1,000
		5.7	.7 5.0	1.35/1.6 1.8/2.0	-	1,000	-	4,000	-	1,000 500
				2.5 3.2	-	500	-	2,000 1,500	-	500
	GJM03	0.6	0.3	0.3	15,000	300	50,000	-	-	1,000
High Power Type	GJM15	1.0	0.5	0.5	10,000	_	50,000	-	50,000	1,000
	GQM18	1.6	0.8	0.8	4,000	_	10,000	_	-	1,000
	GQM21	2.0	1.25	0.85	4,000	_	10,000	_	-	1,000
ligh Frequency	ERB18	1.6	0.8	0.9 max.	4,000	_	10,000	-	-	1,000
3 . ,	ERB21	2.0	1.25	1.35 max.	-	3,000	-	10,000	-	1,000
	ERB32	3.2	2.5	1.7 max.	-	2,000	-	8,000	-	1,000
For Ultrasonic	GRM21	2.0	1.25	0.85	4,000	-	10,000	-	-	1,000
Microchip	GMA05	0.5	0.5	0.35	-	-	-	-	-	400 <sup>3)</sup>
Microcrip	GMA08	0.8	0.8	0.5	-	-	-	-	-	400 3)
	GNM1M	1.37	1.0	0.6	4,000	-	10,000	-	-	1,000
Array	GNM21	2.0	1.25	0.6/0.85	4,000	-	10,000	-	-	1,000
_,	GNM31	3.2	1.6	0.8	4,000	-	10,000	-	-	1,000
				1.0	- 40.000	3,000	-	10,000	-	1,000
	LLL15	0.5	1.0	0.3	10,000	4 000	50,000	-	-	1,000
	LLL18	8.0	1.6	0.5/0.6	-	4,000	-	10,000	-	1,000
	LLL21	1.25	2.0	0.5/0.6	-	4,000 3,000	-	10,000 10,000	-	1,000
				0.5/0.7	-	4,000	-	10,000	-	1,000
	<b>LLL31</b> 1.6	1.6	3.2	1.15		3,000		10,000	-	1,000
	LLA18	1.6	0.8	0.5		4,000	-	10,000	-	1,000
				0.5	-	4,000	_	10,000	-	1,000
Low ESL	LLA21	2.0	1.25	0.85	_	3,000	-	10,000	-	1,000
				0.5	-	4,000	-	10,000	-	1,000
	LLA31	3.2	1.6	0.85	-	3,000	-	10,000	-	1,000
				1.15	-	3,000	-	10,000	-	1,000
	LLM24	2.0	1.05	0.5	-	4,000	-	10,000	-	1,000
	LLM21	2.0	1.25	0.85	-	3,000	-	10,000	-	1,000
	1.1.M24	2.0	1.6	0.5	-	4,000	-	10,000	-	1,000
	LLM31	3.2	1.6	1.15	-	3,000	-	10,000	-	1,000

<sup>1)</sup>  $68,000 pF/0.1 \mu F$  of 50V R7 rated are not available by bulk case.



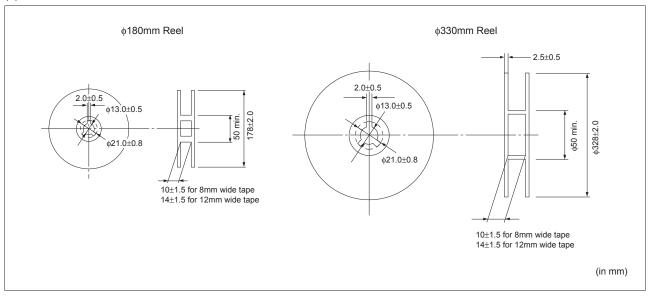
<sup>2)</sup> Dimension tolerance  $\pm 0.15 \text{mm}$  rated are not available by bulk case.

<sup>3)</sup> Tray

Continued from the preceding page.

#### ■ Tape Carrier Packaging

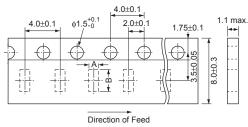
#### (1) Dimensions of Reel



#### (2) Dimensions of Paper Tape



8mm width 4mm pitch Tape



Part Number	Α	В
LLL15	0.65	1.15
GRM18 GQM18 ERB18	1.05±0.1	1.85±0.1
GNM1M	1.17±0.05	1.55±0.05
GRM21 (T≦0.85mm) GQM21 GNM21	1.55±0.15	2.3±0.15
GRM31 (T≦0.85mm) GNM31 (T≦0.8mm)	2.0±0.2	3.6±0.2
<b>GRM32</b> (T≦0.85mm)	2.8±0.2	3.6±0.2

8mm width 2mm pitch Tape	
0.4 max. (GRM02) 0.5 max. (GRM03/GJM03) 0.8 max. (GRM03/GJM03) 0.8 max. (GRM03/GJM03) 0.8 max. (GRM03/GJM03) 0.8 max. (GRM03/GJM03) 0.8 max. (GRM03/GJM03) 0.8 max. (GRM03/GJM03)	
Direction of Feed	

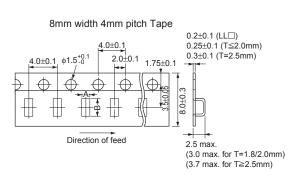
Part Number	A*	B*
GRM02	0.25	0.45
GJM03 GRM03	0.37	0.67
GJM15 GRM15	0.65	1.15

\*Nominal Value

(in mm)

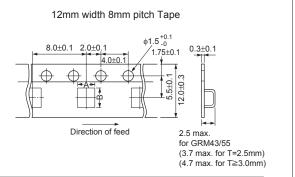
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#### (3) Dimensions of Embossed Tape



Part Number	А	В
LLL18, LLA18	1.05±0.1	1.85±0.1
GRM21, ERB21 (T≥1.0mm) LLL21 LLA21, LLM21	1.45±0.2	2.25±0.2
GRM31 (T≥1.15mm) LLL31 LLA31, LLM31 GNM31 (T≥1.0mm)	1.9±0.2	3.5±0.2
<b>GRM32, ERB32</b> (T≧1.0mm)	2.8±0.2	3.5±0.2

\*Nominal Value



Part Number	A*	B*
GRM43	3.6	4.9
GRM55	5.2	6.1

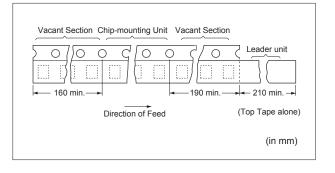
\*Nominal Value

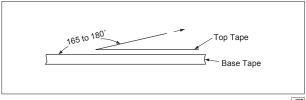
(in mm)

#### (4) Taping Method

- 1 Tapes for capacitors are wound clockwise. The sprocket holes are to the right as the tape is pulled toward the user.
- 2 Part of the leader and part of the empty tape should be attached to the end of the tape as follows.
- 3 The top tape and base tape are not attached at the end of the tape for a minimum of 5 pitches.
- 4 Missing capacitors number within 0.1% of the number per reel or 1 pc, whichever is greater, and are not continuous.
- 5 The top tape and bottom tape should not protrude beyond the edges of the tape and should not cover sprocket holes.
- 6 Cumulative tolerance of sprocket holes, 10 pitches: ±0.3mm.
- 7 Peeling off force: 0.1 to 0.6N\* in the direction shown below. \*GRM02 GRM03 : 0.05 to 0.5N

GJM03

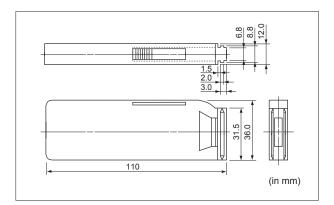






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■ Dimensions of Bulk Case Packaging The bulk case uses antistatic materials. Please contact Murata for details.





#### **1** Caution

#### ■ Storage and Operating Conditions

Chip monolithic ceramic capacitors (chips) can experience degradation of termination solderability when subjected to high temperature or humidity, or if exposed to sulfur or chlorine gases.

Storage environment must be at an ambient temperature of 5-40 degree C and an ambient humidity of 20-70%RH. Use chip within 6 months. If 6 months or more have elapsed, check solderability before use.

Use of Sn-Zn based solder will deteriorate reliability of MLCC.

Please contact Murata factory for the use of Sn-Zn based solder in advance.

FAILURE TO FOLLOW THE ABOVE CAUTIONS MAY RESULT, WORST CASE, IN A SHORT CIRCUIT AND CAUSE FUMING OR PARTIAL DISPERSION WHEN THE PRODUCT IS USED.

#### ■ Handling

1. Inspection

Thrusting force of the test probe can flex the PCB, resulting in cracked chips or open solder joints. Provide support pins on the back side of the PCB to prevent warping or flexing.

- 2. Board Separation (or depanalization)
- (1) Board flexing at the time of separation causes cracked chips or broken solder.
- (2) Severity of stresses imposed on the chip at the time of board break is in the order of: Pushback<Slitter<V Slot<Perforator.
- (3) Board separation must be performed using special jigs, not with hands.

3. Reel and bulk case

In the handling of reel and case, please be careful and do not drop it.

Do not use chips from a case which has been dropped.

FAILURE TO FOLLOW THE ABOVE CAUTIONS MAY RESULT, WORST CASE, IN A SHORT CIRCUIT AND FUMING WHEN THE PRODUCT IS USED.

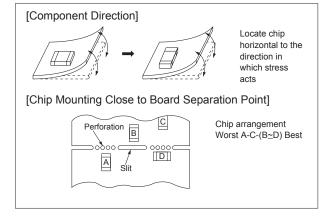




#### ■ **(**Caution (Soldering and Mounting)

#### 1. Mounting Position

Choose a mounting position that minimizes the stress imposed on the chip during flexing or bending of the board.

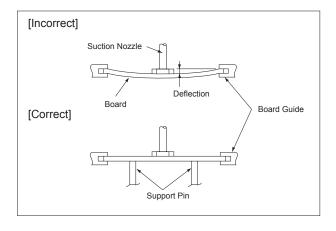


(Reference Data 2. Board bending strength for solder fillet height) (Reference Data 3. Temperature cycling for solder fillet height) (Reference Data 4. Board bending strength for board material)

#### 2. Chip Placing

- An excessively low bottom dead point of the suction nozzle imposes great force on the chip during mounting. causing cracked chips. So adjust the suction nozzle's bottom dead point by correcting warp in the board. Normally, the suction nozzle's bottom dead point must be set on the upper surface of the board. Nozzle pressure for chip mounting must be a 1 to 3N static load.
- Dirt particles and dust accumulated between the suction nozzle and the cylinder inner wall prevent the nozzle from moving smoothly. This imposes great force on the chip during mounting, causing cracked chips. And the locating claw, when worn out, imposes uneven forces on the chip when positioning, causing cracked chips. The suction nozzle and the locating claw must be maintained, checked and replaced periodically.

(Reference Data 5. Break strength)





### **⚠**Caution

#### Continued from the preceding page

#### 3. Reflow Soldering

- When sudden heat is applied to the components, the mechanical strength of the components should go down because remarkable temperature change causes deformity inside components. In order to prevent mechanical damage in the components, preheating should be required for both of the components and the PCB board. Preheating conditions are shown in table 1. It is required to keep temperature differential between the soldering and the components surface (ΔT) as small as possible.
- Solderability of Tin plating termination chip might be deteriorated when low temperature soldering profile where peak solder temperature is below the Tin melting point is used. Please confirm the solderability of Tin plating termination chip before use.
- When components are immersed in solvent after mounting, be sure to maintain the temperature difference ( $\Delta T$ ) between the component and solvent within the range shown in the table 1.

Table 1

Part Number	Temperature Differential
GRM02/03/15/18/21/31	
GJM03/15	
LLL15/18/21/31	ΔT≦190℃
ERB18/21	
GQM18/21	
GRM32/43/55	
LLA18/21/31	
LLM21/31	ΔΤ≦130℃
GNM	
ERB32	

#### **Recommended Conditions**

	Pb-Sn S	Solder	Lead Free Solder	
	Infrared Reflow	Vapor Reflow	Lead Free Solder	
Peak Temperature	230-250°C	230-240°C	240-260°C	
Atmosphere	Air	Air	Air or N2	

Pb-Sn Solder: Sn-37Pb Lead Free Solder: Sn-3.0Ag-0.5Cu

#### Optimum Solder Amount for Reflow Soldering

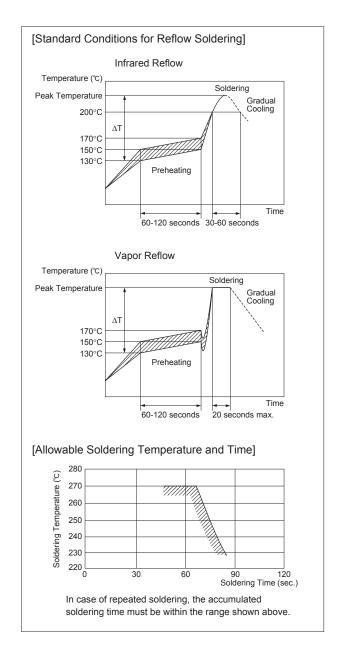
 Overly thick application of solder paste results in excessive fillet height solder.

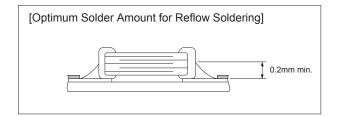
This makes the chip more susceptible to mechanical and thermal stress on the board and may cause cracked chips.

- Too little solder paste results in a lack of adhesive strength on the outer electrode, which may result in chips breaking loose from the PCB.
- Make sure the solder has been applied smoothly to the end surface to a height of 0.2mm min.

#### Inverting the PCB

Make sure not to impose an abnormal mechanical shock on the PCB.







Continued from the preceding page

#### 4. Leaded Component Insertion

If the PCB is flexed when leaded components (such as transformers and ICs) are being mounted, chips may crack and solder joints may break.

Before mounting leaded components, support the PCB using backup pins or special jigs to prevent warping.

#### 5. Flow Soldering

- When sudden heat is applied to the components, the mechanical strength of the components should go down because remarkable temperature change causes deformity inside components. And an excessively long soldering time or high soldering temperature results in leaching of the outer electrodes, causing poor adhesion or a reduction in capacitance value due to loss of contact between electrodes and end termination.
- In order to prevent mechanical damage in the components, preheating shoud be required for the both components and the PCB board. Preheating conditions are shown in table 2. It is required to keep temperature differential between the soldering and the components surface ( $\Delta T$ ) as small as possible.

When components are immersed in solvent after mounting, be sure to maintain the temperature difference between the component and solvent within the range shown in Table 2.

Do not apply flow soldering to chips not listed in Table 2.

Table 2

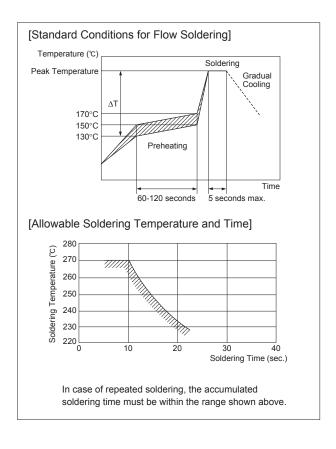
Part Number	Temperature Differential	
GRM18/21/31		
LLL21/31	ΛT≤150°C	
ERB18/21	Δ1≥150 C	
GQM18/21		

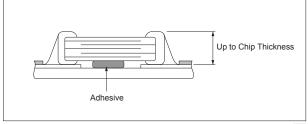
#### **Recommended Conditions**

	Pb-Sn Solder	Lead Free Solder
Peak Temperature	240-250°C	250-260°C
Atmosphere	Air	N <sub>2</sub>

Ph-Sn Solder: Sn-37Ph Lead Free Solder: Sn-3.0Ag-0.5Cu

 Optimum Solder Amount for Flow Soldering The top of the solder fillet should be lower than the thickness of components. If the solder amount is excessively big, the risk of cracking is higher during board bending or under any other stressful conditions.









### **1** Caution

- Continued from the preceding page.
- 6. Correction with a Soldering Iron
- (1) For Chip Type Capacitors
- When sudden heat is applied to the components by soldering iron, the mechanical strength of the components should go down because remarkable temperature change causes deformity inside components. In order to prevent mechanical damage in the components, preheating should be required for both of the components and the PCB board. Preheating conditions are shown in table 3. It is required to keep temperature differential between the soldering and the components surface ( $\Delta T$ ) as small as possible. After soldering, it is not allowed to cool it down rapidly.

Table 3

Part Number	Temperature Differential	Peak Temperature	Atmosphere
GRM15/18/21/31 GJM15 LLL15/18/21/31 GQM18/21 ERB18/21	ΔT≦190℃	300°C max. 3 seconds max. / termination	Air
GRM32/43/55 GNM LLA18/21/31 LLM21/31 ERB32	ΔT≦130℃	270°C max. 3 seconds max. / termination	Air

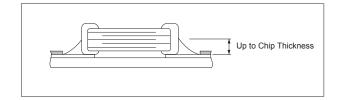
\*Applicable for both Pb-Sn and Lead Free Solder.

Pb-Sn Solder: Sn-37Pb

Lead Free Solder: Sn-3.0Ag-0.5Cu

 Optimum Solder Amount when Corrections Are Made Using a Soldering Iron

The top of the solder fillet should be lower than the thickness of components. If the solder amount is excessively big, the risk of cracking is higher during board bending or under any other stressful conditions. Soldering iron ø3mm or smaller should be required. And it is necessary to keep a distance between the soldering iron and the components without direct touch. Thread solder with ø0.5mm or smaller is required for soldering.



#### 7. Washing

Excessive output of ultrasonic oscillation during cleaning causes PCBs to resonate, resulting in cracked chips or broken solder. Take note not to vibrate PCBs.

FAILURE TO FOLLOW THE ABOVE CAUTIONS MAY RESULT, WORST CASE, IN A SHORT CIRCUIT AND FUMING WHEN THE PRODUCT IS USED.



#### Rating

Die Bonding/Wire Bonding (GMA Series)

- 1. Die Bonding of Capacitors
- •Use the following materials Brazing alloy: Au-Sn (80/20) 300 to 320 degree C in N2 atmosphere
- Mounting
- (1) Control the temperature of the substrate so that it matches the temperature of the brazing
- (2) Place brazing alloy on substrate and place the capacitor on the alloy. Hold the capacitor and gently apply the load. Be sure to complete the operation in 1 minute.

- 2. Wire Bonding
- Wire

Gold wire:

20 micro m (0.0008 inch), 25 micro m (0.001 inch) diameter

- Bonding
- (1) Thermocompression, ultrasonic ball bonding.
- (2) Required stage temperature: 200 to 250 degree C
- (3) Required wedge or capillary weight: 0.5N to 2N.
- (4) Bond the capacitor and base substrate or other devices with gold wire.



#### ■ Notice (Soldering and Mounting)

- 1. PCB Design
- (1) Notice for Pattern Forms

Unlike leaded components, chip components are susceptible to flexing stresses since they are mounted directly on the substrate.

They are also more sensitive to mechanical and thermal stresses than leaded components.

Excess solder fillet height can multiply these stresses and cause chip cracking. When designing substrates, take land patterns and dimensions into consideration to eliminate the possibility of excess solder fillet height.

#### Pattern Forms

	Placing Close to Chassis	Placing of Chip Components and Leaded Components	Placing of Leaded Components after Chip Component	Lateral Mounting
Prohibited	Chassis Solder (ground) Electrode Pattern	Lead Wire	Soldering Iron Lead Wire	
Correct	Solder Resist	Solder Resist	Solder Resist	Solder Resist



- Ontinued from the preceding page.
- (2) Land Dimensions

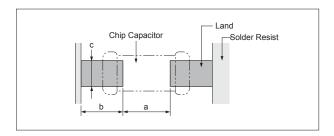


Table 1 Flow Soldering Method

Dimensions Part Number	Dimensions (LXW)	a	b	С	
GRM18	4.000.0	0.0.40	0.0.00	0.0.00	
GQM18	1.6×0.8	0.6-1.0	0.8-0.9	0.6-0.8	
GRM21	0.00/4.05	40.40	0.0.4.0	0.0.4.4	
GQM21	2.0×1.25	1.0-1.2	0.9-1.0	0.8-1.1	
GRM31	3.2×1.6	2.2-2.6	1.0-1.1	1.0-1.4	
LLL21	1.25×2.0	0.4-0.7	0.5-0.7	1.4-1.8	
LLL31	1.6×3.2	0.6-1.0	0.8-0.9	2.6-2.8	
ERB18	1.6×0.8	0.6-1.0	0.8-0.9	0.6-0.8	
ERB21	2.0×1.25	1.0-1.2	0.9-1.0	0.8-1.1	

(in mm)

Table 2 Reflow Soldering Method

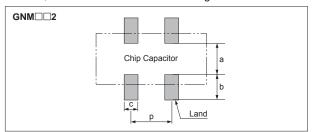
Dimensions Part Number	Dimensions (LXW)	a	b	С	
GRM02	0.4×0.2	0.16-0.2	0.12-0.18	0.2-0.23	
GRM03	0.6×0.3	0.2-0.3	0.2-0.35	0.2-0.4	
GJM03					
GRM15	1.0×0.5	0.3-0.5	0.35-0.45	0.4-0.6	
GJM15					
GRM18	1.6×0.8	0.6-0.8	0.6-0.7	0.6-0.8	
GQM18	1.070.0	0.0 0.0	0.0 0.7	0.0 0.0	
GRM21	2.0×1.25	1.0-1.2	0.6-0.7	0.8-1.1	
GQM21	2.0 × 1.25	1.0—1.2	0.0-0.7	0.0 1.1	
GRM31	3.2×1.6	2.2-2.4	0.8-0.9	1.0-1.4	
GRM32	3.2×2.5	2.0-2.4	1.0-1.2	1.8-2.3	
GRM43	4.5×3.2	3.0-3.5	1.2-1.4	2.3-3.0	
GRM55	5.7×5.0	4.0-4.6	1.4-1.6	3.5-4.8	
LLL15	0.5×1.0	0.15-0.2	0.2-0.3	0.7-1.0	
LLL18	0.8×1.6	0.2-0.4	0.3-0.4	1.0-1.4	
LLL21	1.25×2.0	0.4-0.6	0.3-0.5	1.4-1.8	
LLL31	1.6×3.2	0.6-0.8	0.6-0.7	2.6-2.8	
ERB18	1.6×0.8	0.6-0.8	0.6-0.7	0.6-0.8	
ERB21	2.0×1.25	1.0-1.2	0.6-0.7	0.8-1.1	
ERB32	3.2×2.5	2.0-2.4	1.0-1.2	1.8-2.3	

(in mm)



Continued from the preceding page.

#### GNM, LLA Series for Reflow Soldering Method



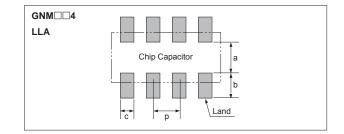


Table 3 GNM, LLA Series for Reflow Soldering Land Dimensions

Part Number	Dimensions (mm)							
Part Number	L	W	a	b	С	р		
GNM1M2	1.37	1.0	0.4 to 0.5	0.35 to 0.45	0.3 to 0.35	0.64		
GNM212	2.0	1.25	0.6 to 0.7	0.5 to 0.7	0.4 to 0.5	1.0		
GNM214	2.0	1.25	0.6 to 0.7	0.5 to 0.7	0.25 to 0.35	0.5		
GNM314	3.2	1.6	0.8 to 1.0	0.7 to 0.9	0.3 to 0.4	0.8		
LLA18	1.6	0.8	0.3 to 0.4	0.25 to 0.4	0.2 to 0.28	0.4		
LLA21	2.0	1.25	0.7 to 0.8	0.4 to 0.6	0.2 to 0.3	0.5		
LLA31	3.2	1.6	0.8 to 1.0	0.7 to 0.9	0.3 to 0.4	0.8		

#### LLM Series for Reflow Soldering Method

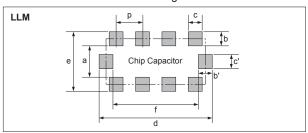


Table 4 LLM Series for Reflow Soldering Land Dimensions

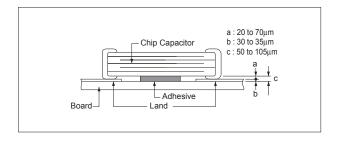
Part Number	Dimensions (mm)							
	а	b, b'	c, c'	d	е	f	р	
LLM21	0.6 to 0.8	(0.3 to 0.5)	0.3	2.0 to 2.6	1.3 to 1.8	1.4 to 1.6	0.5	
LLM31	1.0	(0.3 to 0.5)	0.4	3.2 to 3.6	1.6 to 2.0	2.6	0.8	

b=(c-e)/2, b'=(d-f)/2

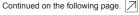
#### 2. Adhesive Application

- Thin or insufficient adhesive causes chips to loosen or become disconnected when flow soldered. The amount of adhesive must be more than dimension c shown in the drawing at right to obtain enough bonding strength. The chip's electrode thickness and land thickness must be taken into consideration.
- Low viscosity adhesive causes chips to slip after mounting. Adhesive must have a viscosity of 5000Pa ·s (500ps) min. (at 25°C)
- Adhesive Coverage\*

Traincoive ouverage			
Part Number	Adhesive Coverage*		
GRM18, GQM18	0.05mg min.		
GRM21, LLL21, GQM21	0.1mg min.		
GRM31, LLL31	0.15mg min.		



\*Nominal Value





Continued from the preceding page.

#### 3. Adhesive Curing

Insufficient curing of the adhesive causes chips to disconnect during flow soldering and causes deteriorated insulation resistance between outer electrodes due to moisture absorption.

Control curing temperature and time in order to prevent insufficient hardening.

#### Inverting the PCB

Make sure not to impose an abnormal mechanical shock on the PCB.

#### 4. Flux Application

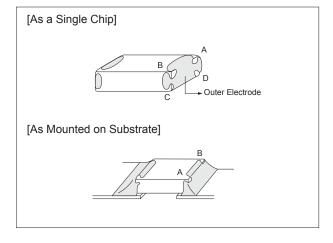
- An excessive amount of flux generates a large quantity of flux gas, causing deteriorated solderability. So apply flux thinly and evenly throughout. (A foaming system is generally used for flow soldering).
- Flux containing too high a percentage of halide may cause corrosion of the outer electrodes unless sufficiently

cleaned. Use flux with a halide content of 0.2wt% max. But do not use strong acidic flux.

Wash thoroughly because water soluble flux causes deteriorated insulation resistance between outer electrodes unless sufficiently cleaned.

#### 5. Flow Soldering

 Set temperature and time to ensure that leaching of the outer electrode does not exceed 25% of the chip end area as a single chip (full length of the edge A-B-C-D shown below) and 25% of the length A-B shown below as mounted on substrate.



(Reference Data 6. Thermal shock) (Reference Data 7. Solder heat resistance)

#### ■ Others

1. Resin Coating

When selecting resin materials, select those with low contraction.

2. Circuit Design

These capacitors in this catalog are not safety recognized products

#### 3. Remarks

The above notices are for standard applications and conditions. Contact us when the products are used in special mounting conditions. Select optimum conditions for operation as they determine the reliability of the product after assembly. The data herein are given in typical values, not guaranteed ratings.



#### 1. Solderability

#### (1) Test Method

Subject the chip capacitor to the following conditions. Then apply flux (an ethanol solution of 25% rosin) to the chip and dip it in 230°C eutectic solder for 2 seconds. Conditions:

Expose prepared at room temperature (for 6 months and 12 months, respectively)

Prepared at high temperature (for 100 hours at 85℃) Prepared left at high humidity (for 100 hours under 90%RH to 95%RH at 40°C)

#### (2) Test Samples

GRM21: Products for flow/reflow soldering.

#### (3) Acceptance Criteria

With a 60-power optical microscope, measure the surface area of the outer electrode that is covered with solder.

#### (4) Results

Refer to Table 1.

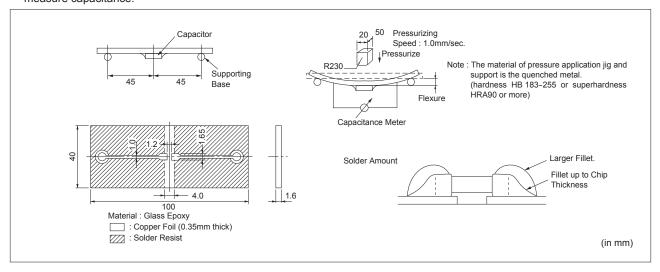
Table 1

Sample	Initial State Prepared at Room		om Temperature	Prepared at High Temperature for	Prepared at High Humidity for 100 Hours at 90 to	
	IIIIIIai State	6 months	12 months	100 Hours at 85°C	95% RH and 40℃	
GRM21 for flow/reflow soldering	95 to 100%	95 to 100%	95%	90 to 95%	95%	

#### 2. Board Bending Strength for Solder Fillet Height

#### (1) Test Method

Solder the chip capacitor to the test PCB with the amount of solder paste necessary to achieve the fillet heights. Then bend the PCB using the method illustrated and measure capacitance.



#### (2) Test Samples

GRM21: 5C/R7/F5 Characteristics T=0.6mm

#### (3) Acceptance Criteria

Products should be determined to be defective if the change in capacitance has exceeded the values specified in Table 2.

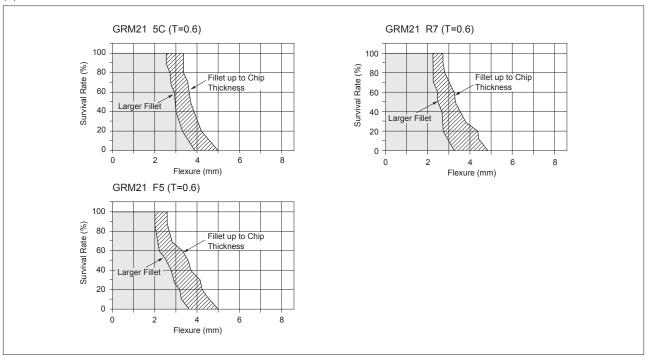
Table 2

Characteristics	Change in Capacitance	
5C	Within ±5% or ±0.5pF, whichever is greater	
R7 Within ±12.5%		
F5	Within ±20%	



Continued from the preceding page.

#### (4) Results



#### 3. Temperature Cycling for Solder Fillet Height

#### (1) Test Method

Solder the chips to the substrate of various test fixtures using sufficient amounts of solder to achieve the required fillet height. Then subject the fixtures to the cycle illustrated below 200 times.

#### ① Solder Amount

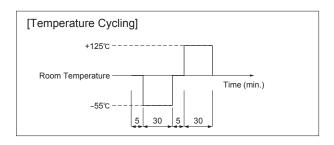
Alumina substrates are typically designed for reflow soldering.

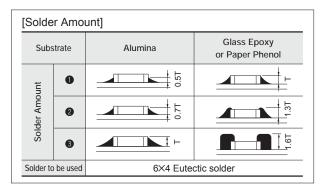
Glass epoxy or paper phenol substrates are typically used for flow soldering.

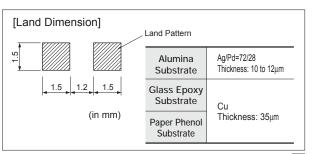
#### ② Material

Alumina (Thickness: 0.64mm) Glass epoxy (Thickness: 1.64mm) Paper phenol (Thickness: 1.64mm)

#### 3 Land Dimension







Continued from the preceding page.

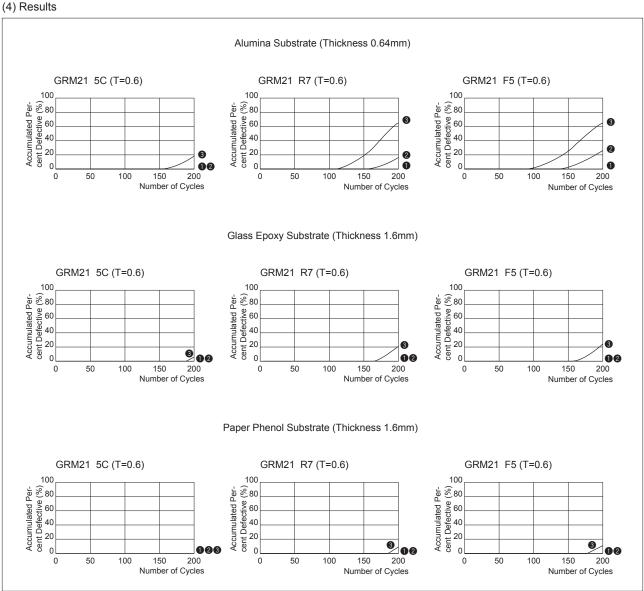
#### (2) Test Samples GRM21 5C/R7/F5 Characteristics T=0.6mm

#### (3) Acceptance Criteria

Products are determined to be defective if the change in capacitance has exceeded the values specified in Table 3.

Table 3

Characteristics	Change in Capacitance
5C	Within ±2.5% or ±0.25pF, whichever is greater
R7	Within ±7.5%
F5	Within ±20%



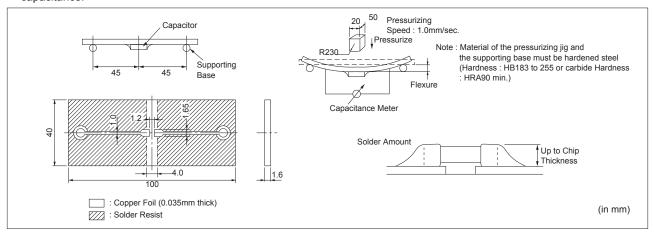


Continued from the preceding page.

#### 4. Board Bending Strength for Board Material

#### (1) Test Method

Solder the chip to the test board. Then bend the board using the method illustrated below, to measure capacitance.



#### (2) Test Samples GRM21 5C/R7/F5 Characteristics T=0.6mm typical

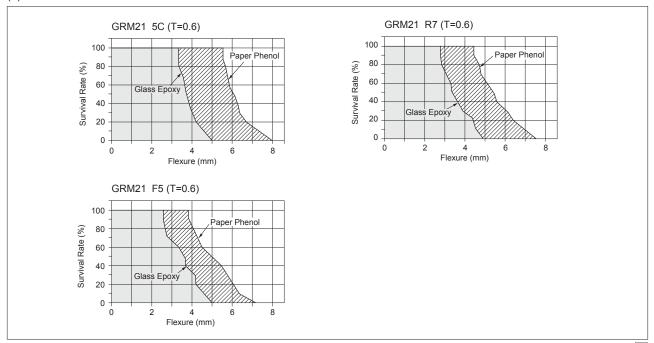
#### (3) Acceptance Criteria

Products should be determined to be defective if the change in capacitance has exceeded the values specified in Table 4.

Table 4

Characteristics	Change in Capacitance		
5C Within ±5% or ±0.5pF, whichever is greate			
R7	Within ±12.5%		
F5	Within ±20%		

#### (4) Results



Continued from the preceding page

#### 5. Break Strength

#### (1) Test Method

Place the chip on a steel plate as illustrated on the right. Increase load applied to a point near the center of the test sample.

#### (2) Test Samples

GRM21 5C/R7/F5 Characteristics GRM31 5C/R7/F5 Characteristics

#### (3) Acceptance Criteria

Define the load that has caused the chip to break or crack, as the bending force.

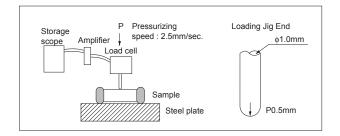
#### (4) Explanation

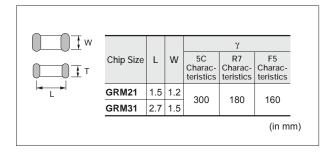
Break strength, P, is proportionate to the square of the thickness of the ceramic element and is expressed as a curve of secondary degree.

The formula is:

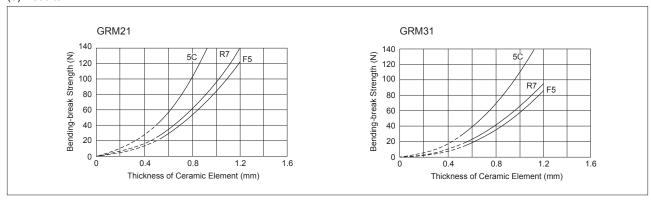
$$P = \frac{2\gamma WT^2}{3I} \quad (N)$$

W: Width of ceramic element (mm) T: Thickness of element (mm) L: Distance between fulcrums (mm) γ: Bending stress (N/mm<sup>2</sup>)





#### (5) Results



#### 6. Thermal Shock

#### (1) Test method

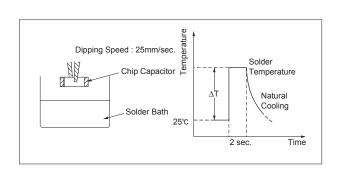
After applying flux (an ethanol solution of 25% rosin), dip the chip in a solder bath (6×4 eutectic solder) in accordance with the following conditions:

#### (2) Test samples

GRM21 5C/R7/F5 Characteristics T=0.6mm typical

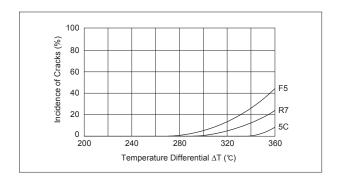
#### (3) Acceptance criteria

Visually inspect the test sample with a 60-power optical microscope. Chips exhibiting breaks or cracks should be determined to be defective.





- Continued from the preceding page.
- (4) Results



#### 7. Solder Heat Resistance

#### (1) Test Method

① Reflow soldering:

Apply about 300  $\mu m$  of solder paste over the alumina substrate. After reflow soldering, remove the chip and check for leaching that may have occurred on the outer electrode.

2 Flow soldering:

After dipping the test sample with a pair of tweezers in wave solder (eutectic solder), check for leaching that may have occurred on the outer electrode.

(2) Test samples

GRM21: For flow/reflow soldering T=0.6mm

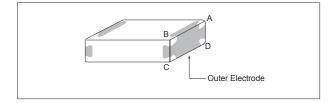
(3) Acceptance criteria

The starting time of leaching should be defined as the time when the outer electrode has lost 25% of the total edge length of A-B-C-D as illustrated:

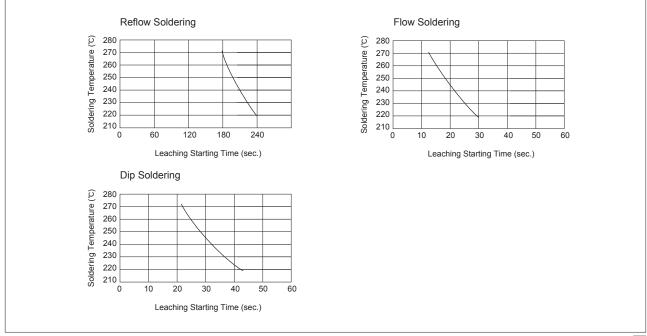
#### 3 Dip soldering:

After dipping the test sample with a pair of tweezers in static solder (eutectic solder), check for leaching that may have occurred on the outer electrode.

4 Flux to be used: An ethanol solution of 25% rosin.



#### (4) Results

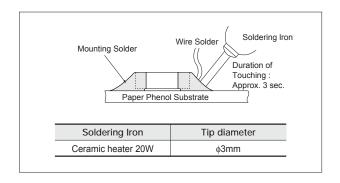


- Continued from the preceding page.
- 8. Thermal Shock when Making Corrections with a Soldering Iron
- (1) Test Method

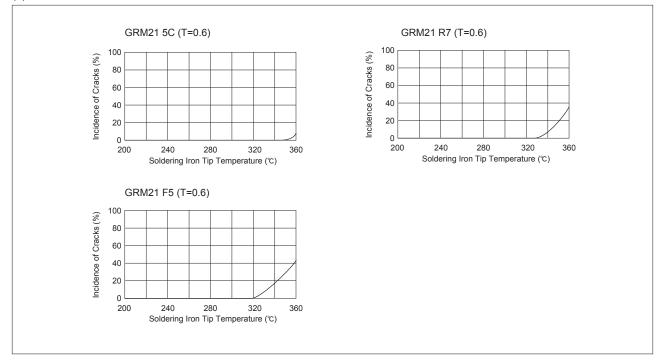
Apply a soldering iron meeting the conditions below to the soldered joint of a chip that has been soldered to a paper phenol board, while supplying wire solder. (Note: the soldering iron tip should not directly touch the ceramic element of the chip.)

(2) Test Samples GRM21 5C/R7/F5 Characteristics T=0.6mm

(3) Acceptance Criteria for Defects Observe the appearance of the test sample with a 60-power optical microscope. Those units displaying any breaks or cracks are determined to be defective.



#### (4) Results



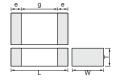
# **Chip Monolithic Ceramic Capacitors**



# **Medium Voltage Low Dissipation Factor**

#### ■ Features

- 1. Low-loss and suitable for high frequency circuits
- 2. Murata's original internal electrode structure realizes high flash-over voltage.
- A new monolithic structure for small, surfacemountable devices capable of operating at high voltage levels
- 4. Sn-plated external electrodes realize good solderability.
- 5. Use the GRM21/31 type with flow or reflow soldering, and other types with reflow soldering only.



Dimensions (mm)							
/ Т	e min.	g min.					
±0.2 10.0 (	٦ 2	0.7					
0.0							
1.25 +0,-	0.3	1.5*					
1.0 +0,-0	0.3	1.5					
1.25 +0,-	0.3						
0.2 1.0 +0,-0	0.3	2.9					
	$ \begin{array}{c cccc}  & T \\  & \pm 0.2 \\  & 0.2 \\  & 0.2 \\  \hline  & 1.0 + 0, - 0 \\  & 1.25 + 0, - 0 \\  & 1.25 + 0, - 0 \end{array} $	T e min. 1.0 +0,-0.3 0.2 1.25 +0,-0.3 0.2 1.25 +0,-0.3 1.25 +0,-0.3					

\* GRM31A7U3D, GRM32A7U3D, GRM32B7U3D : 1.8mm min.

#### Applications

Ideal for use on high frequency pulse circuits such as snubber circuits for switching power supplies, DC-DC converters, ballasts (inverter fluorescent lamps), etc.

Part Number	Rated Voltage (V)	TC Code (Standard)	Capacitance (pF)	Length L (mm)	Width W (mm)	Thickness T (mm)	Electrode g min. (mm)	Electrode e (mm)
GRM21A7U2E101JW31D	DC250	U2J (EIA)	100 ±5%	2.0	1.25	1.0	0.7	0.3 min.
GRM21A7U2E151JW31D	DC250	U2J (EIA)	150 ±5%	2.0	1.25	1.0	0.7	0.3 min.
GRM21A7U2E221JW31D	DC250	U2J (EIA)	220 ±5%	2.0	1.25	1.0	0.7	0.3 min.
GRM21A7U2E331JW31D	DC250	U2J (EIA)	330 ±5%	2.0	1.25	1.0	0.7	0.3 min.
GRM21A7U2E471JW31D	DC250	U2J (EIA)	470 ±5%	2.0	1.25	1.0	0.7	0.3 min.
GRM21A7U2E681JW31D	DC250	U2J (EIA)	680 ±5%	2.0	1.25	1.0	0.7	0.3 min.
GRM21A7U2E102JW31D	DC250	U2J (EIA)	1000 ±5%	2.0	1.25	1.0	0.7	0.3 min.
GRM21A7U2E152JW31D	DC250	U2J (EIA)	1500 ±5%	2.0	1.25	1.0	0.7	0.3 min.
GRM21A7U2E222JW31D	DC250	U2J (EIA)	2200 ±5%	2.0	1.25	1.0	0.7	0.3 min.
GRM31A7U2E332JW31D	DC250	U2J (EIA)	3300 ±5%	3.2	1.6	1.0	1.5	0.3 min.
GRM31A7U2E472JW31D	DC250	U2J (EIA)	4700 ±5%	3.2	1.6	1.0	1.5	0.3 min.
GRM31B7U2E682JW31L	DC250	U2J (EIA)	6800 ±5%	3.2	1.6	1.25	1.5	0.3 min.
GRM31B7U2E103JW31L	DC250	U2J (EIA)	10000 ±5%	3.2	1.6	1.25	1.5	0.3 min.
GRM31A7U2J100JW31D	DC630	U2J (EIA)	10 ±5%	3.2	1.6	1.0	1.5	0.3 min.
GRM31A7U2J150JW31D	DC630	U2J (EIA)	15 ±5%	3.2	1.6	1.0	1.5	0.3 min.
GRM31A7U2J220JW31D	DC630	U2J (EIA)	22 ±5%	3.2	1.6	1.0	1.5	0.3 min.
GRM31A7U2J330JW31D	DC630	U2J (EIA)	33 ±5%	3.2	1.6	1.0	1.5	0.3 min.
GRM31A7U2J470JW31D	DC630	U2J (EIA)	47 ±5%	3.2	1.6	1.0	1.5	0.3 min.
GRM31A7U2J680JW31D	DC630	U2J (EIA)	68 ±5%	3.2	1.6	1.0	1.5	0.3 min.
GRM31A7U2J101JW31D	DC630	U2J (EIA)	100 ±5%	3.2	1.6	1.0	1.5	0.3 min.
GRM31A7U2J151JW31D	DC630	U2J (EIA)	150 ±5%	3.2	1.6	1.0	1.5	0.3 min.
GRM31A7U2J221JW31D	DC630	U2J (EIA)	220 ±5%	3.2	1.6	1.0	1.5	0.3 min.
GRM31A7U2J331JW31D	DC630	U2J (EIA)	330 ±5%	3.2	1.6	1.0	1.5	0.3 min.
GRM31A7U2J471JW31D	DC630	U2J (EIA)	470 ±5%	3.2	1.6	1.0	1.5	0.3 min.
GRM31A7U2J681JW31D	DC630	U2J (EIA)	680 ±5%	3.2	1.6	1.0	1.5	0.3 min.
GRM31A7U2J102JW31D	DC630	U2J (EIA)	1000 ±5%	3.2	1.6	1.0	1.5	0.3 min.
GRM32A7U2J152JW31D	DC630	U2J (EIA)	1500 ±5%	3.2	2.5	1.0	1.5	0.3 min.
GRM32A7U2J222JW31D	DC630	U2J (EIA)	2200 ±5%	3.2	2.5	1.0	1.5	0.3 min.
GRM31A7U3A100JW31D	DC1000	U2J (EIA)	10 ±5%	3.2	1.6	1.0	1.5	0.3 min.
GRM31A7U3A150JW31D	DC1000	U2J (EIA)	15 ±5%	3.2	1.6	1.0	1.5	0.3 min.
GRM31A7U3A220JW31D	DC1000	U2J (EIA)	22 ±5%	3.2	1.6	1.0	1.5	0.3 min.
GRM31A7U3A330JW31D	DC1000	U2J (EIA)	33 ±5%	3.2	1.6	1.0	1.5	0.3 min.

Continued from the preceding page.

Part Number	Rated Voltage (V)	TC Code (Standard)	Capacitance (pF)	Length L (mm)	Width W (mm)	Thickness T (mm)	Electrode g min. (mm)	Electrode e (mm)
GRM31A7U3A470JW31D	DC1000	U2J (EIA)	47 ±5%	3.2	1.6	1.0	1.5	0.3 min.
GRM31A7U3A680JW31D	DC1000	U2J (EIA)	68 ±5%	3.2	1.6	1.0	1.5	0.3 min.
GRM31A7U3A101JW31D	DC1000	U2J (EIA)	100 ±5%	3.2	1.6	1.0	1.5	0.3 min.
GRM31A7U3A151JW31D	DC1000	U2J (EIA)	150 ±5%	3.2	1.6	1.0	1.5	0.3 min.
GRM31A7U3A221JW31D	DC1000	U2J (EIA)	220 ±5%	3.2	1.6	1.0	1.5	0.3 min.
GRM31A7U3A331JW31D	DC1000	U2J (EIA)	330 ±5%	3.2	1.6	1.0	1.5	0.3 min.
GRM31B7U3A471JW31L	DC1000	U2J (EIA)	470 ±5%	3.2	1.6	1.25	1.5	0.3 min.
GRM31A7U3D100JW31D	DC2000	U2J (EIA)	10 ±5%	3.2	1.6	1.0	1.8	0.3 min.
GRM31A7U3D120JW31D	DC2000	U2J (EIA)	12 ±5%	3.2	1.6	1.0	1.8	0.3 min.
GRM31A7U3D150JW31D	DC2000	U2J (EIA)	15 ±5%	3.2	1.6	1.0	1.8	0.3 min.
GRM31A7U3D180JW31D	DC2000	U2J (EIA)	18 ±5%	3.2	1.6	1.0	1.8	0.3 min.
GRM31A7U3D220JW31D	DC2000	U2J (EIA)	22 ±5%	3.2	1.6	1.0	1.8	0.3 min.
GRM31A7U3D270JW31D	DC2000	U2J (EIA)	27 ±5%	3.2	1.6	1.0	1.8	0.3 min.
GRM31A7U3D330JW31D	DC2000	U2J (EIA)	33 ±5%	3.2	1.6	1.0	1.8	0.3 min.
GRM31A7U3D390JW31D	DC2000	U2J (EIA)	39 ±5%	3.2	1.6	1.0	1.8	0.3 min.
GRM31A7U3D470JW31D	DC2000	U2J (EIA)	47 ±5%	3.2	1.6	1.0	1.8	0.3 min.
GRM31A7U3D560JW31D	DC2000	U2J (EIA)	56 ±5%	3.2	1.6	1.0	1.8	0.3 min.
GRM31A7U3D680JW31D	DC2000	U2J (EIA)	68 ±5%	3.2	1.6	1.0	1.8	0.3 min.
GRM32A7U3D820JW31D	DC2000	U2J (EIA)	82 ±5%	3.2	2.5	1.0	1.8	0.3 min.
GRM32A7U3D101JW31D	DC2000	U2J (EIA)	100 ±5%	3.2	2.5	1.0	1.8	0.3 min.
GRM32A7U3D121JW31D	DC2000	U2J (EIA)	120 ±5%	3.2	2.5	1.0	1.8	0.3 min.
GRM32A7U3D151JW31D	DC2000	U2J (EIA)	150 ±5%	3.2	2.5	1.0	1.8	0.3 min.
GRM32B7U3D181JW31L	DC2000	U2J (EIA)	180 ±5%	3.2	2.5	1.25	1.8	0.3 min.
GRM32B7U3D221JW31L	DC2000	U2J (EIA)	220 ±5%	3.2	2.5	1.25	1.8	0.3 min.
GRM42A7U3F270JW31L	DC3150	U2J (EIA)	27 ±5%	4.5	2.0	1.0	2.9	0.3 min.
GRM42A7U3F330JW31L	DC3150	U2J (EIA)	33 ±5%	4.5	2.0	1.0	2.9	0.3 min.
GRM42A7U3F390JW31L	DC3150	U2J (EIA)	39 ±5%	4.5	2.0	1.0	2.9	0.3 min.
GRM42A7U3F470JW31L	DC3150	U2J (EIA)	47 ±5%	4.5	2.0	1.0	2.9	0.3 min.
GRM42A7U3F560JW31L	DC3150	U2J (EIA)	56 ±5%	4.5	2.0	1.0	2.9	0.3 min.
GRM42A7U3F680JW31L	DC3150	U2J (EIA)	68 ±5%	4.5	2.0	1.0	2.9	0.3 min.
GRM42A7U3F820JW31L	DC3150	U2J (EIA)	82 ±5%	4.5	2.0	1.0	2.9	0.3 min.
GRM42A7U3F101JW31L	DC3150	U2J (EIA)	100 ±5%	4.5	2.0	1.0	2.9	0.3 min.

No.	Ite	em	Specifications	Test Method				
1	Operating Temperatu	ting −55 to +125°C −						
2	Appearar	nce	No defects or abnormalities	Visual inspection				
3	Dimensio	ns	Within the specified dimension	Using calipers				
4	Dielectric	Strength	No defects or abnormalities	No failure should be observed when voltage in Table is applied between the terminations for 1 to 5 sec., provided the charge/ discharge current is less than 50mA.  Rated voltage Test voltage  DC250V 200% of the rated voltage  DC630V 150% of the rated voltage  DC1kV, DC2kV 120% of the rated voltage  DC3.15kV DC4095V				
5	Insulation F (I.R.)	Resistance	More than $10,000 M\Omega$	The insulation resistance should be measured with DC500±50V (DC250±25V in case of rated voltage: DC250V) and within 60±5 sec. of charging.				
6	Capacita	nce	Within the specified tolerance	The capacitance/Q should be measured at the frequency and				
7	Q		1,000 min.	voltage shown as follows.       Capacitance     Frequency     Voltage       C<1,000pF				
8	Capacitance 8 Temperature Characteristics		Temp. Coefficient  -750±120 ppm/℃ (Temp. Range: +25 to +125℃)  -750+120, -347 ppm/℃ (Temp. Range: -55 to +25℃)	The capacitance measurement should be made at each step specified in Table.  Step Temperature (°C)  1 25±2 2 Min. Operating Temp.±3 3 25±2 4 Max. Operating Temp.±2 5 25±2				
9	Adhesive Strength of Termination		No removal of the terminations or other defect should occur.	Solder the capacitor to the testing jig (glass epoxy board) shown in Fig. 1.  Then apply 10N force in the direction of the arrow.  The soldering should be done using the reflow method and should be conducted with care so that the soldering is uniform and free of defects such as heat shock.  Glass Epoxy Board  Fig. 1				
		Appearance	No defects or abnormalities	Solder the capacitor to the test jig (glass epoxy board).				
		Capacitance	Within the specified tolerance	The capacitor should be subjected to a simple harmonic motion				
10	Vibration Resistance	tion		having a total amplitude of 1.5mm, the frequency being varied uniformly between the approximate limits of 10 and 55Hz. The frequency range, from 10 to 55Hz and return to 10Hz, should be traversed in approximately 1 min. This motion should be applied for a period of 2 hrs. in each of 3 mutually perpendicular directions (total of 6 hrs.).  Solder resist  Glass Epoxy Board				

$\Box$	Continued fr	om the prec	eding page.					
No.	Ite	em	Specifications	Test Method				
11	11 Deflection		No cracking or marking defects should occur.	Solder the capacitor to the testing jig (glass epoxy board) shown in Fig. 2.  Then apply a force in the direction shown in Fig. 3.  The soldering should be done using the reflow method and should be conducted with care so that the soldering is uniform and free of defects such as heat shock.  20 50 Pressurizing speed: 1.0mm/s Pressurize Pressurize (in mm)  Fig. 3				
12	Solderab Terminati	-	75% of the terminations are to be soldered evenly and continuously.	Immerse the capacitor in a solution of ethanol (JIS-K-8101) and rosin (JIS-K-5902) (25% rosin in weight proportion). Immerse in solder solution for 2±0.5 sec. Immersing speed: 25±2.5mm/s Temp. of solder: 245±5°C Lead Free Solder (Sn-3.0Ag-0.5Cu) 235±5°C H60A or H63A Eutectic Solder				
		Appearance	No marking defects	Preheat the capacitor at 120 to 150°C* for 1 min.				
	Resistance	Capacitance Change	Within ±2.5%	Immerse the capacitor in solder solution at 260±5°C for 10±1 sec. Let sit at room condition* for 24±2 hrs., then measure.  •Immersing speed: 25±2.5mm/s  *Preheating for more than 3.2×2.5mm				
13		Q I.R.	1,000 min. More than 10,000M $\Omega$					
	neat		,,,,,,,	Step Temperature Time				
		Dielectric Strength	In accordance with item No.4	1 100 to 120°C 1 min. 2 170 to 200°C 1 min.				
		Appearance	No marking defects	Fix the capacitor to the supporting jig (glass epoxy board) shown				
		Capacitance Change	Within ±2.5%	in Fig. 4.  Perform the 5 cycles according to the 4 heat treatments listed in the following table.  Let sit for 24±2 hrs. at room condition*, then measure.  Step Temperature (°C) Time (min.)				
		Q	500 min.					
14	Temperature Cycle	I.R.  Dielectric Strength	More than $10{,}000\text{M}\Omega$ In accordance with item No.4	1 Min. Operating Temp.±3 30±3 2 Room Temp. 2 to 3 3 Max. Operating Temp.±2 30±3 4 Room Temp. 2 to 3				
				Glass Epoxy Board Fig. 4				
		Appearance	No marking defects	-				
	Humidity	Capacitance Change	Within ±5.0%	Let the capacitor sit at 40±2°C and relative humidity of 90 to 95%				
15	(Steady	Q I.R.	350 min. More than 1,000M $Ω$	for 500 ± 2 0 hrs.  Remove and let sit for 24±2 hrs. at room condition*, then				
	State)	Dielectric Strength	In accordance with item No.4	measure.				
		Appearance	No marking defects					
		Capacitance Change	Within ±3.0%	Apply 120% of the rated voltage for 1,000 $\pm ^{48}_{0}$ hrs. at maximum				
16	Life	Q	350 min.	operating temperature ±3°C.  Remove and let sit for 24±2 hrs. at room condition*, then				
		I.R.  Dielectric Strength	More than 1,000M $\Omega$ In accordance with item No.4	measure.  The charge/discharge current is less than 50mA.				

<sup>\* &</sup>quot;Room condition" Temperature: 15 to 35°C, Relative humidity: 45 to 75%, Atmospheric pressure: 86 to 106kPa

# muRata

# Medium Voltage High Capacitance for General Use

#### ■ Features

- A new monolithic structure for small, high capacitance capable of operating at high voltage levels
- 2. Sn-plated external electrodes realizes good solderability.
- Use the GRM18/21/31 types with flow or reflow soldering, and other types with reflow soldering only.

#### ■ Applications

- Ideal for use on diode-snubber circuits for switching power supplies
- Ideal for use as primary-secondary coupling for DC-DC converter
- 3. Ideal for use on line filters and ringer detectors for telephones, facsimiles and modems





Part Number	Dimensions (mm)								
	L   W   T		е	g min.					
GRM188	1.6 ±0.1	0.8 ±0.1	0.8 ±0.1	0.2 to 0.5	0.4				
GRM21A	2.0 +0.2	1.25 +0.2	1.0 +0,-0.3		0.7				
GRM21B	2.0 ±0.2	1.25 ±0.2	1.25 ±0.2		0.7				
GRM31B	3.2 +0.2	1.6 ±0.2	1.25 +0,-0.3						
GRM31C	3.2 ±0.2	1.0 ±0.2	1.6 ±0.2		12				
GRM32Q	3.2 ±0.3	2.5 ±0.2	1.5 +0,-0.3	0.3 min.	1.2				
GRM32D	3.2 ±0.3	2.5 ±0.2	2.0 +0,-0.3						
GRM43Q	4.5 ±0.4 3.2 ±0.3		1.5 +0,-0.3		2.2				
GRM43D	4.5 ±0.4	3.2 ±0.3	2.0 +0,-0.3		2.2				
GRM55D	5.7 ±0.4	5.0 ±0.4	2.0 +0,-0.3		3.2				

Part Number	Rated Voltage (V)	TC Code (Standard)	Capacitance	Length L (mm)	Width W (mm)	Thickness T (mm)	Electrode g min. (mm)	Electrode e (mm)
GRM188R72E221KW07D	DC250	X7R (EIA)	220pF ±10%	1.6	0.8	0.8	0.4	0.2 to 0.5
GRM188R72E331KW07D	DC250	X7R (EIA)	330pF ±10%	1.6	0.8	0.8	0.4	0.2 to 0.5
GRM188R72E471KW07D	DC250	X7R (EIA)	470pF ±10%	1.6	0.8	0.8	0.4	0.2 to 0.5
GRM188R72E681KW07D	DC250	X7R (EIA)	680pF ±10%	1.6	0.8	0.8	0.4	0.2 to 0.5
GRM188R72E102KW07D	DC250	X7R (EIA)	1000pF ±10%	1.6	0.8	0.8	0.4	0.2 to 0.5
GRM21AR72E102KW01D	DC250	X7R (EIA)	1000pF ±10%	2.0	1.25	1.0	0.7	0.3 min.
GRM188R72E152KW07D	DC250	X7R (EIA)	1500pF ±10%	1.6	0.8	0.8	0.4	0.2 to 0.5
GRM21AR72E152KW01D	DC250	X7R (EIA)	1500pF ±10%	2.0	1.25	1.0	0.7	0.3 min.
GRM188R72E222KW07D	DC250	X7R (EIA)	2200pF ±10%	1.6	0.8	0.8	0.4	0.2 to 0.5
GRM21AR72E222KW01D	DC250	X7R (EIA)	2200pF ±10%	2.0	1.25	1.0	0.7	0.3 min.
GRM21AR72E332KW01D	DC250	X7R (EIA)	3300pF ±10%	2.0	1.25	1.0	0.7	0.3 min.
GRM21AR72E472KW01D	DC250	X7R (EIA)	4700pF ±10%	2.0	1.25	1.0	0.7	0.3 min.
GRM21AR72E682KW01D	DC250	X7R (EIA)	6800pF ±10%	2.0	1.25	1.0	0.7	0.3 min.
GRM21BR72E103KW03L	DC250	X7R (EIA)	10000pF ±10%	2.0	1.25	1.25	0.7	0.3 min.
GRM31BR72E153KW01L	DC250	X7R (EIA)	15000pF ±10%	3.2	1.6	1.25	1.2	0.3 min.
GRM31BR72E223KW01L	DC250	X7R (EIA)	22000pF ±10%	3.2	1.6	1.25	1.2	0.3 min.
GRM31CR72E333KW03L	DC250	X7R (EIA)	33000pF ±10%	3.2	1.6	1.6	1.2	0.3 min.
GRM31CR72E473KW03L	DC250	X7R (EIA)	47000pF ±10%	3.2	1.6	1.6	1.2	0.3 min.
GRM31BR72E683KW01L	DC250	X7R (EIA)	68000pF ±10%	3.2	1.6	1.25	1.2	0.3 min.
GRM32QR72E683KW01L	DC250	X7R (EIA)	68000pF ±10%	3.2	2.5	1.5	1.2	0.3 min.
GRM31CR72E104KW03L	DC250	X7R (EIA)	0.10μF ±10%	3.2	1.6	1.6	1.2	0.3 min.
GRM32DR72E104KW01L	DC250	X7R (EIA)	0.10μF ±10%	3.2	2.5	2.0	1.2	0.3 min.
GRM43QR72E154KW01L	DC250	X7R (EIA)	0.15μF ±10%	4.5	3.2	1.5	2.2	0.3 min.
GRM32DR72E224KW01L	DC250	X7R (EIA)	0.22μF ±10%	3.2	2.5	2.0	1.2	0.3 min.
GRM43DR72E224KW01L	DC250	X7R (EIA)	0.22μF ±10%	4.5	3.2	2.0	2.2	0.3 min.
GRM43DR72E334KW01L	DC250	X7R (EIA)	0.33μF ±10%	4.5	3.2	2.0	2.2	0.3 min.
GRM55DR72E334KW01L	DC250	X7R (EIA)	0.33μF ±10%	5.7	5.0	2.0	3.2	0.3 min.
GRM43DR72E474KW01L	DC250	X7R (EIA)	0.47μF ±10%	4.5	3.2	2.0	2.2	0.3 min.
GRM55DR72E474KW01L	DC250	X7R (EIA)	0.47μF ±10%	5.7	5.0	2.0	3.2	0.3 min.
GRM55DR72E105KW01L	DC250	X7R (EIA)	1.0μF ±10%	5.7	5.0	2.0	3.2	0.3 min.
GRM31BR72J102KW01L	DC630	X7R (EIA)	1000pF ±10%	3.2	1.6	1.25	1.2	0.3 min.
GRM31BR72J152KW01L	DC630	X7R (EIA)	1500pF ±10%	3.2	1.6	1.25	1.2	0.3 min.

Continued from the preceding page.

Part Number	Rated Voltage (V)	TC Code (Standard)	Capacitance	Length L (mm)	Width W (mm)	Thickness T (mm)	Electrode g min. (mm)	Electrode e (mm)
GRM31BR72J222KW01L	DC630	X7R (EIA)	2200pF ±10%	3.2	1.6	1.25	1.2	0.3 min.
GRM31BR72J332KW01L	DC630	X7R (EIA)	3300pF ±10%	3.2	1.6	1.25	1.2	0.3 min.
GRM31BR72J472KW01L	DC630	X7R (EIA)	4700pF ±10%	3.2	1.6	1.25	1.2	0.3 min.
GRM31BR72J682KW01L	DC630	X7R (EIA)	6800pF ±10%	3.2	1.6	1.25	1.2	0.3 min.
GRM31BR72J103KW01L	DC630	X7R (EIA)	10000pF ±10%	3.2	1.6	1.25	1.2	0.3 min.
GRM31CR72J153KW03L	DC630	X7R (EIA)	15000pF ±10%	3.2	1.6	1.6	1.2	0.3 min.
GRM32QR72J223KW01L	DC630	X7R (EIA)	22000pF ±10%	3.2	2.5	1.5	1.2	0.3 min.
GRM32DR72J333KW01L	DC630	X7R (EIA)	33000pF ±10%	3.2	2.5	2.0	1.2	0.3 min.
GRM32DR72J473KW01L	DC630	X7R (EIA)	47000pF ±10%	3.2	2.5	2.0	1.2	0.3 min.
GRM43QR72J683KW01L	DC630	X7R (EIA)	68000pF ±10%	4.5	3.2	1.5	2.2	0.3 min.
GRM43DR72J104KW01L	DC630	X7R (EIA)	0.10μF ±10%	4.5	3.2	2.0	2.2	0.3 min.
GRM55DR72J154KW01L	DC630	X7R (EIA)	0.15μF ±10%	5.7	5.0	2.0	3.2	0.3 min.
GRM55DR72J224KW01L	DC630	X7R (EIA)	0.22μF ±10%	5.7	5.0	2.0	3.2	0.3 min.
GRM31BR73A471KW01L	DC1000	X7R (EIA)	470pF ±10%	3.2	1.6	1.25	1.2	0.3 min.
GRM31BR73A102KW01L	DC1000	X7R (EIA)	1000pF ±10%	3.2	1.6	1.25	1.2	0.3 min.
GRM31BR73A152KW01L	DC1000	X7R (EIA)	1500pF ±10%	3.2	1.6	1.25	1.2	0.3 min.
GRM31BR73A222KW01L	DC1000	X7R (EIA)	2200pF ±10%	3.2	1.6	1.25	1.2	0.3 min.
GRM31BR73A332KW01L	DC1000	X7R (EIA)	3300pF ±10%	3.2	1.6	1.25	1.2	0.3 min.
GRM31BR73A472KW01L	DC1000	X7R (EIA)	4700pF ±10%	3.2	1.6	1.25	1.2	0.3 min.
GRM32QR73A682KW01L	DC1000	X7R (EIA)	6800pF ±10%	3.2	2.5	1.5	1.2	0.3 min.
GRM32QR73A103KW01L	DC1000	X7R (EIA)	10000pF ±10%	3.2	2.5	1.5	1.2	0.3 min.
GRM32DR73A153KW01L	DC1000	X7R (EIA)	15000pF ±10%	3.2	2.5	2.0	1.2	0.3 min.
GRM32DR73A223KW01L	DC1000	X7R (EIA)	22000pF ±10%	3.2	2.5	2.0	1.2	0.3 min.
GRM43DR73A333KW01L	DC1000	X7R (EIA)	33000pF ±10%	4.5	3.2	2.0	2.2	0.3 min.
GRM43DR73A473KW01L	DC1000	X7R (EIA)	47000pF ±10%	4.5	3.2	2.0	2.2	0.3 min.
GRM55DR73A104KW01L	DC1000	X7R (EIA)	0.10μF ±10%	5.7	5.0	2.0	3.2	0.3 min.

No.	Ite	m	Specifications	Test Method		
1	Operating Temperatu	re Range	-55 to +125℃	-		
2	Appearan	ce	No defects or abnormalities	Visual inspection		
3	Dimension	ns	Within the specified dimensions	Using calipers		
4	Dielectric Strength		No defects or abnormalities	No failure should be observed when 150% of the rated voltage (200% of the rated voltage in case of rated voltage: DC250V, 120% of the rated voltage in case of rated voltage: DC1kV) is applied between the terminations for 1 to 5 sec., provided the charge/discharge current is less than 50mA.		
5	Insulation R (I.R.)	Resistance	C≥0.01μF: More than 100M $\Omega$ • μF C<0.01μF: More than 10,000M $\Omega$	The insulation resistance should be measured with DC500±50V (DC250±25V in case of rated voltage: DC250V) and within 60±5 sec. of charging.		
6	Capacitar	nce	Within the specified tolerance	The capacitance/D.E. should be measured at a frequency of		
7	Dissipatio Factor (D.		0.025 max.	The capacitance/D.F. should be measured at a frequency of 1±0.2kHz and a voltage of AC1±0.2V(r.m.s.)		
8	Capacitan Temperatu Characteri	ure	Cap. Change Within ±15% (Temp. Range: −55 to +125℃)	The capacitance measurement should be made at each step specified in Table.  Step Temperature (℃)  1 25±2 2 Min. Operating Temp.±3 3 25±2 4 Max. Operating Temp.±2 5 25±2  •Pretreatment Perform a heat treatment at 150 <sup>+</sup> 0 °C for 60±5 min. and then let sit for 24±2 hrs. at room condition*.		
9	Adhesive of Termina		No removal of the terminations or other defect should occur.	Solder the capacitor to the testing jig (glass epoxy board) shown in Fig. 1.  Then apply 10N force in the direction of the arrow.  The soldering should be done using the reflow method and should be conducted with care so that the soldering is uniform and free of defects such as heat shock.  10N (5N : Size 1.6×0.8mm only), 10±1s  Glass Epoxy Board  Fig. 1		
		Appearance	No defects or abnormalities	Solder the capacitor to the test jig (glass epoxy board).		
		Capacitance	Within the specified tolerance	The capacitor should be subjected to a simple harmonic motion having a total amplitude of 1.5mm, the frequency being varied		
10	Vibration Resistance	D.F.	0.025 max.	uniformly between the approximate limits of 10 and 55Hz. The frequency range, from 10 to 55Hz and return to 10Hz, should be traversed in approximately 1 min. This motion should be applied for a period of 2 hrs. in each of 3 mutually perpendicular directions (total of 6 hrs.).  Solder resist		
* ""			<u> </u>			

<sup>\* &</sup>quot;Room condition" Temperature: 15 to 35°C, Relative humidity: 45 to 75%, Atmospheric pressure: 86 to 106kPa





Continued from the preceding page Specifications No. Item Test Method Solder the capacitor to the testing jig (glass epoxy board) shown No cracking or marking defects should occur. Then apply a force in the direction shown in Fig. 3. The soldering should be done using the reflow method and should be conducted with care so that the soldering is uniform and free of defects such as heat shock. 50 Pressurizing speed : 1.0mm/s Pressurize 11 Deflection Dimension (mm) LXW (mm) b Flexure=1 1 6×0 8 1.0 3.0 1.2 2.0×1.25 1.2 4.0 1.65 (in mm) 3.2×1.6 2.2 5.0 2.0 1.0 3.2×2.5 2.2 5.0 2.9 Fig. 3 4.5×3.2 3.5 7.0 3.7 5.7×5.0 4.5 8.0 5.6 Fig. 2 Immerse the capacitor in a solution of ethanol (JIS-K-8101) and rosin (JIS-K-5902) (25% rosin in weight proportion). Solderability of Immerse in solder solution for 2±0.5 sec. 12 75% of the terminations are to be soldered evenly and continuously Termination Immersing speed: 25±2.5mm/s Temp. of solder: 245±5°C Lead Free Solder (Sn-3.0Ag-0.5Cu) 235±5°C H60A or H63A Eutectic Solder Preheat the capacitor at 120 to 150°C\* for 1 min. Appearance No marking defects Immerse the capacitor in solder solution at 260±5℃ for 10±1 Capacitance Within ±10% sec. Let sit at room condition\* for 24±2 hrs., then measure. Change •Immersing speed: 25±2.5mm/s D.F. 0.025 max. Pretreatment Resistance Perform a heat treatment at 150 ± 10 °C for 60±5 min. and then C≥0.01 $\mu$ F: More than 100M $\Omega$  •  $\mu$ F 13 to Soldering I.R. let sit for 24±2 hrs. at room condition\*. C<0.01 $\mu$ F: More than 10,000M $\Omega$ Heat \*Preheating for more than 3.2×2.5mm Dielectric Step Temperature Time In accordance with item No.4 Strength 100 to 120℃ 1 min 170 to 200℃ 1 min No marking defects Appearance Fix the capacitor to the supporting jig (glass epoxy board) shown Capacitance Within ±7.5% Perform the 5 cycles according to the 4 heat treatments listed in Change the following table. D.F. 0.025 max. Let sit for 24±2 hrs. at room condition\*, then measure C≥0.01μF: More than 100MΩ • μF Step Temperature (℃) Time (min.) I.R. Min. Operating Temp.±3  $30 \pm 3$ C<0.01 $\mu$ F: More than 10,000M $\Omega$ 2 Room Temp. 2 to 3 3 Max. Operating Temp.±2  $30\pm3$ Room Temp. Temperature 14 Pretreatment Cycle Perform a heat treatment at 150  $^+_{-1}{}^{\circ}_{0}$  °C for 60±5 min. and then let sit for 24±2 hrs. at room condition\*. Dielectric In accordance with item No.4 Strength Solder resist Glass Epoxy Board Fig. 4 Appearance No marking defects Let the capacitor sit at 40±2°C and relative humidity of 90 to 95% Capacitance Within ±15% for 500 ±24 hrs. Change Humidity Remove and let sit for 24±2 hrs. at room condition\*, then D.F. 0.05 max. 15 measure (Steady State) C≥0.01 $\mu$ F: More than 10M $\Omega$  •  $\mu$ F Pretreatment I.R. C<0.01 $\mu$ F: More than 1,000M $\Omega$ Perform a heat treatment at 150 <sup>+</sup><sub>-10</sub> °C for 60±5 min. and then let sit for 24±2 hrs. at room condition\*. Dielectric In accordance with item No.4 Strength



<sup>\* &</sup>quot;Room condition" Temperature: 15 to 35℃, Relative humidity: 45 to 75%, Atmospheric pressure: 86 to 106kPa

Continued from the preceding page.

No.	Ite	em	Specifications	Test Method			
		Appearance	No marking defects	Apply 120% of the rated voltage (150% of the rated voltage in			
		Capacitance Change	Within ±15% (rated voltage: DC250V, DC630V) Within ±20% (rated voltage: DC1kV)	case of rated voltage: DC250V, 110% of the rated voltage in case of rated voltage: DC1kV) for 1,000 ± 48 hrs. at maximum			
16	Life	D.F.	0.05 max.	operating temperature ±3°C. Remove and let sit for 24 ±2 hrs. at room condition*, then measure.			
	Liic	I.R.	C≧0.01μF: More than 10MΩ • μF C<0.01μF: More than 1,000MΩ	The charge/discharge current is less than 50mA. •Pretreatment			
		Dielectric Strength	In accordance with item No.4	Apply test voltage for 60±5 min. at test temperature.  Remove and let sit for 24±2 hrs. at room condition*.			
		Appearance	No marking defects				
	Humidity Loading	Capacitance Change	Within ±15%	Apply the rated voltage at 40 $\pm2$ °C and relative humidity of 90 to 95% for 500 $\pm$ 2% hrs.			
17	(Application:	D.F.	0.05 max.	Remove and let sit for 24±2 hrs. at room condition*, then measure.			
17	DC250V, DC630V	I.R.	C≥0.01μF: More than 10MΩ • μF C<0.01μF: More than 1,000MΩ	Pretreatment Apply test voltage for 60±5 min. at test temperature.			
	item)	Dielectric Strength	In accordance with item No.4	Remove and let sit for 24±2 hrs. at room condition*.			

<sup>\* &</sup>quot;Room condition" Temperature: 15 to 35°C, Relative humidity: 45 to 75%, Atmospheric pressure: 86 to 106kPa





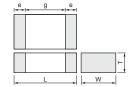


## **Only for LCD Backlight Inverter Circuit**

#### ■ Features

- 1. Low-loss and suitable for high frequency circuits
- 2. Murata's original internal electrode structure realizes high flash-over voltage.
- 3. A new monolithic structure for small, surfacemountable devices capable of operating at high voltage levels.
- 4. Sn-plated external electrodes realize good solderability.
- 5. Only for reflow soldering
- 6. The capacitors less than 22pF can be applied maximum 4.0kV peak to peak at 100kHz or less only for the ballast or the resonance usage in the LCD backlight inverter circuit.





Part Number	Dimensions (mm)						
Part Number	L	W	T	e min.	g min.		
GRM42A	4.5 ±0.3	2.0 ±0.2	1.0 +0, -0.3	0.3	2.9		

### ■ Applications

Ideal for use as the ballast in LCD backlight inverter.

Part Number	Rated Voltage (V)	TC Code (Standard)	Capacitance (pF)	Length L (mm)	Width W (mm)	Thickness T (mm)	Electrode g min. (mm)	Electrode e (mm)
GRM42A5C3F050DW01L	DC3150	C0G (EIA)	5.0 ±0.5pF	4.5	2.0	1.0	2.9	0.3 min.
GRM42A5C3F100JW01L	DC3150	C0G (EIA)	10 ±5%	4.5	2.0	1.0	2.9	0.3 min.
GRM42A5C3F120JW01L	DC3150	C0G (EIA)	12 ±5%	4.5	2.0	1.0	2.9	0.3 min.
GRM42A5C3F150JW01L	DC3150	COG (EIA)	15 ±5%	4.5	2.0	1.0	2.9	0.3 min.
GRM42A5C3F180JW01L	DC3150	COG (EIA)	18 ±5%	4.5	2.0	1.0	2.9	0.3 min.
GRM42A5C3F220JW01L	DC3150	C0G (EIA)	22 ±5%	4.5	2.0	1.0	2.9	0.3 min.
GRM42A5C3F270JW01L	DC3150	C0G (EIA)	27 ±5%	4.5	2.0	1.0	2.9	0.3 min.
GRM42A5C3F330JW01L	DC3150	C0G (EIA)	33 ±5%	4.5	2.0	1.0	2.9	0.3 min.
GRM42A5C3F390JW01L	DC3150	C0G (EIA)	39 ±5%	4.5	2.0	1.0	2.9	0.3 min.
GRM42A5C3F470JW01L	DC3150	COG (EIA)	47 ±5%	4.5	2.0	1.0	2.9	0.3 min.

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No.	Ite	·m	Specifications	Test Method
1	Operating Temperatu	ıre Range	−55 to +125°C	-
2	Appearar	ice	No defects or abnormalities	Visual inspection
3	Dimensio	ns	Within the specified dimension	Using calipers
4	Dielectric Strength		No defects or abnormalities	No failure should be observed when DC4095V is applied between the terminations for 1 to 5 sec., provided the charge/ discharge current is less than 50mA.
5	Insulation F	Resistance	More than 10,000M $\Omega$	The insulation resistance should be measured with DC500±50V and within 60±5 sec. of charging.
6	Capacita	nce	Within the specified tolerance	The capacitance/Q should be measured at a frequency of
7	Q		1,000 min.	1±0.2MHz and a voltage of AC0.5 to 5V(r.m.s.)
8	Capacitance		Temp. Coefficient 0±30 ppm/°C (Temp. Range: +25 to +125°C) 0+30, −72 ppm/°C (Temp. Range: −55 to +25°C)	The capacitance measurement should be made at each step specified in Table.  Step Temperature (°C)  1 25±2 2 Min. Operating Temp.±3 3 25±2 4 Max. Operating Temp.±2 5 25±2
9	Adhesive Strength of Termination		No removal of the terminations or other defect should occur.	Solder the capacitor to the testing jig (glass epoxy board) shown in Fig. 1.  Then apply 10N force in the direction of the arrow.  The soldering should be done using the reflow method and should be conducted with care so that the soldering is uniform and free of defects such as heat shock.  Toldering is uniform and free of defects such as heat shock.
		Appearance	No defects or abnormalities	Solder the capacitor to the test jig (glass epoxy board).
10	Capacitance		Within the specified tolerance  1,000 min.	The capacitor should be subjected to a simple harmonic motion having a total amplitude of 1.5mm, the frequency being varied uniformly between the approximate limits of 10 and 55Hz. The frequency range, from 10 to 55Hz and return to 10Hz, should be traversed in approximately 1 min. This motion should be applied for a period of 2 hrs. in each of 3 mutually perpendicular directions (total of 6 hrs.).  Solder resist  Glass Epoxy Board
			No cracking or marking defects should occur.	Solder the capacitor to the testing jig (glass epoxy board) shown
11	1 Deflection		LXW   Dimension (mm)	in Fig. 2. Then apply a force in the direction shown in Fig. 3. The soldering should be done using the reflow method and should be conducted with care so that the soldering is uniform and free of defects such as heat shock.  20 50 Pressurizing speed: 1.0mm/s Pressurize Pressurize (in mm)  Fig. 3

Continued from the preceding page.

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No.	Ite	em	Specifications	Test Method				
12	2 Solderability of Termination		75% of the terminations are to be soldered evenly and continuously.	Immerse the capacitor in a solution of ethanol (JIS-K-8101) and rosin (JIS-K-5902) (25% rosin in weight proportion). Immerse in solder solution for 2±0.5 sec. Immersing speed: 25±2.5mm/s Temp. of solder: 245±5°C Lead Free Solder (Sn-3.0Ag-0.5Cu) 235±5°C H60A or H63A Eutectic Solder				
		Appearance	No marking defects	Preheat the capacitor as table.				
		Capacitance Change	Within ±2.5%	Immerse the capacitor in solder solution at 260±5°C for 10±1 sec. Let sit at room condition* for 24±2 hrs., then measure.  •Immersing speed: 25±2.5mm/s				
13	Resistance to Soldering	Q	1,000 min.	minor sing speed. 2012.0mms				
13	Heat	I.R.	More than 10,000M $\Omega$	*Preheating				
		Dielectric Strength	In accordance with item No.4	Step         Temperature         Time           1         100 to 120°C         1 min.           2         170 to 200°C         1 min.				
		Appearance	No marking defects	Fix the capacitor to the supporting jig (glass epoxy board) shown				
		Capacitance Change	Within ±2.5%	in Fig. 4.  Perform the 5 cycles according to the 4 heat treatments listed in the following table.				
		Q	1,000 min.	Let sit for 24±2 hrs. at room condition*, then measure.				
		I.R.	More than $10,000M\Omega$	Step Temperature (°C) Time (min.)				
14	Temperature Cycle	Dielectric Strength	In accordance with item No.4	1 Min. Operating Temp.±3 30±3 2 Room Temp. 2 to 3 3 Max. Operating Temp.±2 30±3 4 Room Temp. 2 to 3  4 Room Temp. 2 to 3  Class Epoxy Board  Fig. 4				
		Appearance	No marking defects					
	Humidity	Capacitance Change	Within ±5.0%	Let the capacitor sit at 40±2°C and relative humidity of 90 to 95%				
15	(Steady	Q	350 min.	for 500 ±26 hrs.  Remove and let sit for 24±2 hrs. at room condition*, then				
	State)	I.R.	More than 1,000M $\Omega$	measure.				
		Dielectric Strength	In accordance with item No.4					
		Appearance	No marking defects					
		Capacitance Change	Within ±3.0%	Apply 120% of the rated voltage for 1,000 ±48 hrs. at maximum operating temperature ±3°C.				
16	Life	Q	350 min.	Remove and let sit for 24±2 hrs. at room condition*, then				
		I.R.	More than 1,000M $\Omega$	measure. The charge/discharge current is less than 50mA.				
		Dielectric Strength	In accordance with item No.4	The charge discharge current is less than some.				

<sup>\* &</sup>quot;Room condition" Temperature: 15 to 35°C, Relative humidity: 45 to 75%, Atmospheric pressure: 86 to 106kPa

## muRata

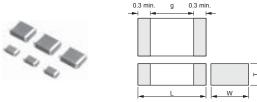
## Only for Information Devices/Tip & Ring

#### ■ Features

- These items are designed specifically for telecommunications devices (IEEE802.3) in Ethernet LAN and primary-secondary coupling for DC-DC converter.
- A new monolithic structure for small, high capacitance capable of operating at high voltage levels
- 3. Sn-plated external electrodes realizes good solderability.
- 4. Only for reflow soldering
- The low-profile type (thickness: 1.5mm max.) is available. Fit for use on thinner type equipment.

#### ■ Applications

- Ideal for use on telecommunications devices in Ethernet LAN
- Ideal for use as primary-secondary coupling for DC-DC converter



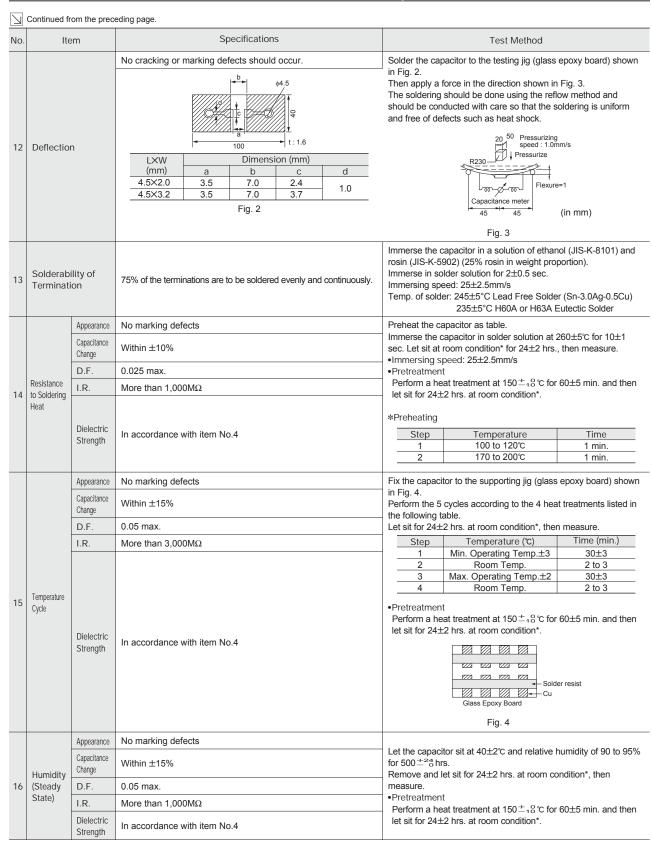
David Namelaan		Dimens	sions (mm)	
Part Number	L	W	Т	g min.
GR442Q	4.5 ±0.3 2.0 ±0.2		1.5 +0, -0.3	
GR443D	4.5 ±0.4	3.2 +0.3	2.0 +0, -0.3	2.5
GR443Q	4.5 ±0.4	3.2 ±0.3	1.5 +0, -0.3	
GR455D	5.7 ±0.4	5.0 ±0.4	2.0 +0, -0.3	3.2

Part Number	Rated Voltage (V)	TC Code (Standard)	Capacitance (pF)	Length L (mm)	Width W (mm)	Thickness T (mm)	Electrode g min. (mm)	Electrode e (mm)
GR442QR73D101KW01L	DC2000	X7R (EIA)	100 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GR442QR73D121KW01L	DC2000	X7R (EIA)	120 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GR442QR73D151KW01L	DC2000	X7R (EIA)	150 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GR442QR73D181KW01L	DC2000	X7R (EIA)	180 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GR442QR73D221KW01L	DC2000	X7R (EIA)	220 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GR442QR73D271KW01L	DC2000	X7R (EIA)	270 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GR442QR73D331KW01L	DC2000	X7R (EIA)	330 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GR442QR73D391KW01L	DC2000	X7R (EIA)	390 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GR442QR73D471KW01L	DC2000	X7R (EIA)	470 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GR442QR73D561KW01L	DC2000	X7R (EIA)	560 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GR442QR73D681KW01L	DC2000	X7R (EIA)	680 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GR442QR73D821KW01L	DC2000	X7R (EIA)	820 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GR442QR73D102KW01L	DC2000	X7R (EIA)	1000 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GR442QR73D122KW01L	DC2000	X7R (EIA)	1200 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GR442QR73D152KW01L	DC2000	X7R (EIA)	1500 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GR443QR73D182KW01L	DC2000	X7R (EIA)	1800 ±10%	4.5	3.2	1.5	2.5	0.3 min.
GR443QR73D222KW01L	DC2000	X7R (EIA)	2200 ±10%	4.5	3.2	1.5	2.5	0.3 min.
GR443QR73D272KW01L	DC2000	X7R (EIA)	2700 ±10%	4.5	3.2	1.5	2.5	0.3 min.
GR443QR73D332KW01L	DC2000	X7R (EIA)	3300 ±10%	4.5	3.2	1.5	2.5	0.3 min.
GR443QR73D392KW01L	DC2000	X7R (EIA)	3900 ±10%	4.5	3.2	1.5	2.5	0.3 min.
GR443DR73D472KW01L	DC2000	X7R (EIA)	4700 ±10%	4.5	3.2	2.0	2.5	0.3 min.
GR455DR73D103KW01L	DC2000	X7R (EIA)	10000 ±10%	5.7	5.0	2.0	3.2	0.3 min.

No.	Ite	em	Specifications		Test Method	
1	Operating Temperatu	ure Range	-55 to +125℃		-	
2	Appearan	nce	No defects or abnormalities	Visual inspection		
3	Dimensio	ns	Within the specified dimensions	Using calipers		
4	4 Dielectric Stre		No defects or abnormalities	between the termina is less than 50mA.	observed when voltage in tal titions, provided the charge/dis	
				Rated voltage	120% of the rated voltage	60±1 sec.
				DC2kV	AC1500V(r.m.s.)	60±1 sec.
5	Pulse Vol	tage	No self healing breakdowns or flash-overs have taken place in the capacitor.	10 impulse of alternating polarity is subjected. (5 impulse for each polarity) The interval between impulse is 60 sec. Applied Voltage: 2.5kV zero to peak		
6	Insulation F (I.R.)	Resistance	More than $6{,}000M\Omega$	The insulation resist and within 60±5 sec	ance should be measured wit c. of charging.	h DC500±50V
7	Capacita	nce	Within the specified tolerance	The canacitance/D	should be measured at a fre	equency of
8	Dissipation Factor (D		0.025 max.	· ·	tage of AC1±0.2V(r.m.s.)	equency of
9	Capacitance 9 Temperature Characteristics		Cap. Change within ±15% (Temp. Range: −55 to +125°C)	The capacitance measurement should be made at each step specified in Table.    Step		
10	O Adhesive Strength of Termination		No removal of the terminations or other defect should occur.	in Fig. 1. Then apply 10N force The soldering should	to the testing jig (glass epoxy be in the direction of the arrow do be done using the reflow me downth care so that the soldering such as heat shock.  10N, 10±1s  Glass Epoxy Boal  Fig. 1	ethod and ng is uniform
		Appearance	No defects or abnormalities	Solder the capacitor	to the test jig (glass epoxy bo	oard).
		Capacitance	Within the specified tolerance		d be subjected to a simple ha	
11	Vibration Resistance	D.F.	0.025 max.	uniformly between the frequency range, from traversed in approximation of 2 hrs. directions (total of 6	ude of 1.5mm, the frequency ne approximate limits of 10 an m 10 to 55Hz and return to 10 mately 1 min. This motion sho in each of 3 mutually perpendents.).  Solder resist class Epoxy Board	nd 55Hz. The DHz, should be ould be applied dicular

<sup>\* &</sup>quot;Room condition" Temperature: 15 to 35°C, Relative humidity: 45 to 75%, Atmospheric pressure: 86 to 106kPa





<sup>\* &</sup>quot;Room condition" Temperature: 15 to 35°C, Relative humidity: 45 to 75%, Atmospheric pressure: 86 to 106kPa



Continued from the preceding page.

No.	Ite	Item Specifications		Test Method
		Appearance	No marking defects	
		Capacitance Change	Within ±20%	Apply 110% of the rated voltage for 1,000 ±4% hrs. at maximum operating temperature ±3°C. Remove and let sit for 24 ±2 hrs. at room condition*, then measure.
17	Life	D.F.	0.05 max.	The charge/discharge current is less than 50mA.
		I.R.	More than $2{,}000M\Omega$	Pretreatment     Apply test voltage for 60±5 min. at test temperature.
		Dielectric Strength	In accordance with item No.4	Remove and let sit for 24±2 hrs. at room condition*.

<sup>\* &</sup>quot;Room condition" Temperature: 15 to 35°C, Relative humidity: 45 to 75%, Atmospheric pressure: 86 to 106kPa

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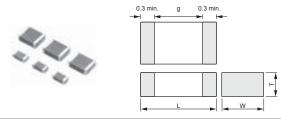
## **Only for Camera Flash Circuit**

### ■ Features

- 1. Suitable for the trigger of the flash circuit, because real capacitance is stable during operating voltage
- 2. The thin type fit for thinner camera.
- 3. Sn-plated external electrodes realizes good solderability.
- 4. For flow and reflow soldering

### Applications

For strobe circuit



Part Number	Dimensions (mm)						
Part Number	L	W	Т	g min.			
GR731A			1.0 +0, -0.3				
GR731B	3.2 ±0.2	1.6 ±0.2	1.25 +0, -0.3	1.2			
GR731C			1.6 ±0.2				

Part Number	Rated Voltage (V)	TC Code (Standard)	Capacitance (pF)	Length L (mm)	Width W (mm)	Thickness T (mm)	Electrode g min. (mm)	Electrode e (mm)
GR731AW0BB103KW01D	DC350	-	10000 ±10%	3.2	1.6	1.0	1.2	0.3 min.
GR731AW0BB153KW01D	DC350	-	15000 ±10%	3.2	1.6	1.0	1.2	0.3 min.
GR731BW0BB223KW01L	DC350	-	22000 ±10%	3.2	1.6	1.25	1.2	0.3 min.
GR731BW0BB333KW01L	DC350	-	33000 ±10%	3.2	1.6	1.25	1.2	0.3 min.
GR731CW0BB473KW03L	DC350	-	47000 ±10%	3.2	1.6	1.6	1.2	0.3 min.

No.	Ite	em	Specifications	Test Method		
1	Operating Temperatu	ıre Range	-55 to +125℃	-		
2	Appearan	nce	No defects or abnormalities	Visual inspection		
3	Dimensio	ns	Within the specified dimensions	Using calipers		
4	Dielectric Strength		No defects or abnormalities	No failure should be observed when DC500V is applied between the terminations for 1 to 5 sec., provided the charge/discharge current is less than 50mA.		
5	Insulation F (I.R.)	Resistance	C≥0.01μF: More than 100M $\Omega$ • μF C<0.01μF: More than 10,000M $\Omega$	The insulation resistance should be measured with DC250±50V and within 60±5 sec. of charging.		
6	Capacitar	nce	Within the specified tolerance			
7	Dissipation Factor (D		0.025 max.	The capacitance/D.F. should be measured at a frequency of 1±0.2kHz and a voltage of AC1±0.2V(r.m.s.)		
				The capacitance measurement should be made at each step specified in Table.		
8	Capacitance Temperature Characteristics		Cap. Change Within ±10% (Apply DC350V bias) Within ±33 % (No DC bias) (Temp. Range : -55 to +125℃)	Step         Temperature (°C)           1         25±2           2         Min. Operating Temp.±3           3         25±2           4         Max. Operating Temp.±2           5         25±2    •Pretreatment		
				Perform a heat treatment at 150 <sup>+0</sup> <sub>-10</sub> °C for 60±5 min. and then let sit for 24±2 hrs. at room condition*.		
9	Adhesive of Termin		No removal of the terminations or other defect should occur.	Solder the capacitor to the testing jig (glass epoxy board) shown in Fig. 1.  Then apply 10N force in the direction of the arrow.  The soldering should be done using the reflow method and should be conducted with care so that the soldering is uniform and free of defects such as heat shock.		
				Fig. 1		
		Appearance	No defects or abnormalities	Solder the capacitor to the test jig (glass epoxy board).  The capacitor should be subjected to a simple harmonic motion		
		Capacitance	Within the specified tolerance	having a total amplitude of 1.5mm, the frequency being varied		
10	Vibration Resistance	D.F.	0.025 max.	uniformly between the approximate limits of 10 and 55Hz. The frequency range, from 10 to 55Hz and return to 10Hz, should be traversed in approximately 1 min. This motion should be applied for a period of 2 hrs. in each of 3 mutually perpendicular directions (total of 6 hrs.).		
				Solder resist  Glass Epoxy Board		

<sup>\* &</sup>quot;Room condition" Temperature: 15 to 35°C, Relative humidity: 45 to 75%, Atmospheric pressure: 86 to 106kPa



Continued from the preceding page Specifications No. Item Test Method Solder the capacitor to the testing jig (glass epoxy board) shown No cracking or marking defects should occur. Then apply a force in the direction shown in Fig. 3. The soldering should be done using the reflow method and should be conducted with care so that the soldering is uniform and free of defects such as heat shock. 50 Pressurizing speed: 1.0mm/s Deflection Pressurize R230 LXW Dimension (mm) (mm) d Flexure=1 3.2X1.6 22 5.0 20 10 Capacitance mete Fig. 2 (in mm) Fig. 3 Immerse the capacitor in a solution of ethanol (JIS-K-8101) and rosin (JIS-K-5902) (25% rosin in weight proportion). Immerse in solder solution for 2±0.5 sec. Solderability of 12 75% of the terminations are to be soldered evenly and continuously. Immersing speed: 25±2.5mm/s Termination Temp. of solder: 245±5°C Lead Free Solder (Sn-3.0Ag-0.5Cu) 235±5°C H60A or H63A Eutectic Solder Appearance No marking defects Preheat the capacitor at 120 to 150°C\* for 1 min. Capacitance Within ±10% Immerse the capacitor in solder solution at 260±5℃ for 10±1 Change sec. Let sit at room condition\* for 24±2 hrs., then measure. Resistance 0.025 max. D.F. •Immersing speed: 25±2.5mm/s 13 to Soldering C≥0.01 $\mu$ F: More than 100M $\Omega$  •  $\mu$ F Pretreatment Heat I.R. C<0.01  $\mu\text{F}$ : More than 10,000  $\!M\Omega$ Perform a heat treatment at 150 <sup>+</sup><sub>−10</sub> °C for 60±5 min. and then let sit for 24±2 hrs. at room condition\*. Dielectric In accordance with item No.4 Strength No marking defects Fix the capacitor to the supporting jig (glass epoxy board) shown Appearance in Fig. 4. Capacitance Within ±7.5% Perform the 5 cycles according to the 4 heat treatments listed in Change the following table. D.F. 0.025 max. Let sit for 24±2 hrs. at room condition\*, then measure. Step Temperature (℃) Time (min.)  $C{\ge}0.01\mu\text{F}{:}$  More than  $100\text{M}\Omega$  •  $\mu\text{F}$ I.R.  $30 \pm 3$ C<0.01 $\mu$ F: More than 10,000M $\Omega$ 1 Min. Operating Temp.±3 2 Room Temp. 2 to 3 3 Max. Operating Temp.±2  $30\pm3$ Room Temp 4 2 to 3 Temperature 14 Cycle Pretreatment Perform a heat treatment at 150 <sup>+</sup><sub>1</sub>° ℃ for 60±5 min. and then let sit for 24±2 hrs. at room condition\*. Dielectric In accordance with item No.4 Strength Solder resist Cu Glass Epoxy Board Fig. 4 Appearance No marking defects Let the capacitor sit at 40±2℃ and relative humidity of 90 to 95% Capacitance Within ±15% for 500 ±24 hrs. Change Remove and let sit for 24±2 hrs. at room condition\*, then Humidity D.F. 0.05 max. 15 (Steady measure. C≥0.01 $\mu$ F: More than 10M $\Omega$  •  $\mu$ F State) Pretreatment I.R. C<0.01 $\mu$ F: More than 1,000M $\Omega$ Perform a heat treatment at 150 ± 10 °C for 60±5 min. and then

In accordance with item No.4

Dielectric

Strenath

Continued on the following page.

let sit for 24±2 hrs. at room condition\*.

<sup>\* &</sup>quot;Room condition" Temperature: 15 to 35℃, Relative humidity: 45 to 75%, Atmospheric pressure: 86 to 106kPa

Continued from the preceding page.

No.	Ite	m	Specifications	Test Method
		Appearance	No marking defects	
		Capacitance Change	Within ±15%	Apply DC350V for 1,000 ± 48 hrs. at maximum operating temperature ±3°C. Remove and let sit for 24 ±2 hrs. at room
16	Life	D.F.	0.05 max.	condition*, then measure.  The charge/discharge current is less than 50mA.
10	20	I.R.	C≧0.01μF: More than 10M $\Omega$ • μF C<0.01μF: More than 1,000M $\Omega$	Pretreatment     Apply test voltage for 60±5 min. at test temperature.
		Dielectric Strength	In accordance with item No.4	Remove and let sit for 24±2 hrs. at room condition*.
		Appearance No marking defects		
		Capacitance Change	Within ±15%	Apply the rated voltage at 40 $\pm2$ °C and relative humidity of 90 to 95% for 500 $\pm^26$ hrs.
17	Humidity	D.F.	0.05 max.	Remove and let sit for 24±2 hrs. at room condition*, then measure.
17	Loading	I.R.	C≥0.01μF: More than 10M $\Omega$ • μF C<0.01μF: More than 1,000M $\Omega$	Pretreatment Apply test voltage for 60±5 min. at test temperature.
		Dielectric Strength	In accordance with item No.4	Remove and let sit for 24±2 hrs. at room condition*.

<sup>\* &</sup>quot;Room condition" Temperature: 15 to 35°C, Relative humidity: 45 to 75%, Atmospheric pressure: 86 to 106kPa

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## AC250V (r.m.s.) Type (Which Meet Japanese Law)

#### ■ Features

- 1. Chip monolithic ceramic capacitor for AC lines
- A new monolithic structure for small, high capacitance capable of operating at high voltage levels
- Sn-plated external electrodes realizes good solderability.
- 4. Only for reflow soldering
- 5. Capacitance 0.01 to 0.1uF for connecting lines and 470 to 4700pF for connecting lines to earth

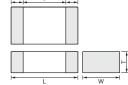
### ■ Applications

Noise suppression filters for switching power supplies, telephones, facsimiles, modems

### ■ Reference standard

GA2 series obtains no safety approval. This series is based on JIS C 5102, JIS C 5150, and the standards of the electrical appliance and material safety law of Japan (separated table 4).





			-						
Part Number	Dimensions (mm)								
Part Number	L	W	Т	e min.	g min.				
GA242Q	4.5 ±0.3	2.0 ±0.2	1.5 +0, -0.3						
GA243D	4.5 ±0.4	3.2 +0.3	2.0 +0, -0.3	0.3	2.5				
GA243Q	4.3 ±0.4	3.2 ±0.3	1.5 +0, -0.3	0.3					
GA255D	5.7 ±0.4	5.0 ±0.4	2.0 +0, -0.3		3.2				

Part Number	Rated Voltage (V)	TC Code (Standard)	Capacitance	Length L (mm)	Width W (mm)	Thickness T (mm)	Electrode g min. (mm)	Electrode e (mm)
GA242QR7E2471MW01L	AC250 (r.m.s.)	X7R (EIA)	470pF ±20%	4.5	2.0	1.5	2.5	0.3 min.
GA242QR7E2102MW01L	AC250 (r.m.s.)	X7R (EIA)	1000pF ±20%	4.5	2.0	1.5	2.5	0.3 min.
GA243QR7E2222MW01L	AC250 (r.m.s.)	X7R (EIA)	2200pF ±20%	4.5	3.2	1.5	2.5	0.3 min.
GA243QR7E2332MW01L	AC250 (r.m.s.)	X7R (EIA)	3300pF ±20%	4.5	3.2	1.5	2.5	0.3 min.
GA243DR7E2472MW01L	AC250 (r.m.s.)	X7R (EIA)	4700pF ±20%	4.5	3.2	2.0	2.5	0.3 min.
GA243QR7E2103MW01L	AC250 (r.m.s.)	X7R (EIA)	10000pF ±20%	4.5	3.2	1.5	2.5	0.3 min.
GA243QR7E2223MW01L	AC250 (r.m.s.)	X7R (EIA)	22000pF ±20%	4.5	3.2	1.5	2.5	0.3 min.
GA243DR7E2473MW01L	AC250 (r.m.s.)	X7R (EIA)	47000pF ±20%	4.5	3.2	2.0	2.5	0.3 min.
GA255DR7E2104MW01L	AC250 (r.m.s.)	X7R (EIA)	0.10μF ±20%	5.7	5.0	2.0	3.2	0.3 min.

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No.	Ite	em	Specifications	Test Method
1	Operating Temperatu	ıre Range	-55 to +125℃	-
2	Appearan	nce	No defects or abnormalities	Visual inspection
3	Dimensio	ns	Within the specified dimensions	Using calipers
4	4 Dielectric Strength		No defects or abnormalities	No failure should be observed when voltage in table is applied between the terminations for 60±1 sec., provided the charge/discharge current is less than 50mA.  Nominal Capacitance Test voltage  C≥10,000pF AC575V (r.m.s.)  C<10,000pF AC1500V (r.m.s.)
5	Insulation F	Resistance	More than $2,000M\Omega$	The insulation resistance should be measured with DC500±50V and within 60±5 sec. of charging.
6	Capacitar	nce	Within the specified tolerance	
7	Dissipation Factor (D.	on	0.025 max.	The capacitance/D.F. should be measured at a frequency of 1±0.2kHz and a voltage of AC1±0.2V (r.m.s.)
8	Capacitan Temperati Character	ure	Cap. Change Within ±15% (Temp. Range: −55 to +125°C)	The capacitance measurement should be made at each step specified in Table.  Step Temperature (°C)  1 25±2 2 Min. Operating Temp.±3 3 25±2 4 Max. Operating Temp.±2 5 25±2  • Pretreatment Perform a heat treatment at 150 <sup>+</sup> / <sub>-1</sub> % °C for 60±5 min. and then let sit for 24±2 hrs. at room condition*.
9	Discharge Test (Application: Nominal Capacitance C<10,000pF)	Appearance	No defects or abnormalities	As in Fig., discharge is made 50 times at 5 sec. intervals from the capacitor (Cd) charged at DC voltage of specified.  R3  R1  T 10kV  Ct Capacitor under test Cd: 0.001μF  R1: 1,000Ω R2: 100MΩ R3: Surge resistance
10	Adhesive Strength of Termination		No removal of the terminations or other defects should occur.	Solder the capacitor to the testing jig (glass epoxy board) shown in Fig. 1.  Then apply 10N force in the direction of the arrow. The soldering should be done using the reflow method and should be conducted with care so that the soldering is uniform and free of defects such as heat shock.  Glass Epoxy Board  Fig. 1
		Appearance	No defects or abnormalities	Solder the capacitor to the test jig (glass epoxy board).
		Capacitance	Within the specified tolerance	The capacitor should be subjected to a simple harmonic motion having a total amplitude of 1.5mm, the frequency being varied
11	Vibration Resistance	D.F.	0.025 max.	uniformly between the approximate limits of 10 and 55Hz. The frequency range, from 10 to 55Hz and return to 10Hz, should be traversed in approximately 1 min. This motion should be applied for a period of 2 hrs. in each of 3 mutually perpendicular directions (total of 6 hrs.).  Solder resist  Glass Epoxy Board

<sup>\* &</sup>quot;Room condition" Temperature: 15 to 35°C, Relative humidity: 45 to 75%, Atmospheric pressure: 86 to 106kPa



Continued from the preceding page Specifications No. Item Test Method Solder the capacitor to the testing jig (glass epoxy board) shown No cracking or marking defects should occur. Then apply a force in the direction shown in Fig. 3. The soldering should be done using the reflow method and should be conducted with care so that the soldering is uniform and free of defects such as heat shock. 50 Pressurizing speed: 1.0mm/s Pressurize 12 Deflection R230 t: 1.6 Flexure=1 Dimension (mm) LXW (mm) Capacitance mete d 4.5×2.0 3.5 7.0 2.4 (in mm) 4.5×3.2 3.5 7.0 3.7 1.0 Fig. 3  $5.7 \times 5.0$ 4.5 8.0 5.6 Fig. 2 Immerse the capacitor in a solution of ethanol (JIS-K-8101) and rosin (JIS-K-5902) (25% rosin in weight proportion). Immerse in solder solution for 2±0.5 sec. Solderability of 13 75% of the terminations are to be soldered evenly and continuously. Immersing speed: 25±2.5mm/s Termination Temp. of solder: 245±5°C Lead Free Solder (Sn-3.0Ag-0.5Cu) 235±5°C H60A or H63A Eutectic Solder Appearance No marking defects Capacitance Within ±15% Change The capacitor should be subjected to 40±2°C, relative humidity of Humidity 14 D.F 0.05 max. 90 to 98% for 8 hrs., and then removed in room condition\* for 16 Insulation hrs. until 5 cycles. I.R. More than 1,000M $\Omega$ Dielectric In accordance with item No.4 Strength No marking defects Appearance Preheat the capacitor as table. Immerse the capacitor in solder solution at 260±5℃ for 10±1 Capacitance Within ±10% sec. Let sit at room condition\* for 24±2 hrs., then measure. Change •Immersing speed: 25±2.5mm/s D.F. 0.025 max. Pretreatment Resistance Perform a heat treatment at 150 <sup>+</sup><sub>10</sub> °C for 60±5 min. and then I.R. More than 2,000M $\Omega$ 15 to Soldering let sit for 24±2 hrs. at room condition\*. Heat \*Preheating Dielectric In accordance with item No.4 Step Temperature Time Strength 100 to 120°C 1 min 170 to 200℃ 1 min Appearance No marking defects Fix the capacitor to the supporting jig (glass epoxy board) shown in Fig. 4. Capacitance Within ±15% Perform the 5 cycles according to the 4 heat treatments listed in Change the following table. D.F. 0.05 max. Let sit for 24±2 hrs. at room condition\*, then measure. Time (min.) Temperature (℃) More than  $2,000M\Omega$ Step I.R. Min. Operating Temp.±3 30±3 Room Temp. 2 to 3 Max. Operating Temp.±2 3 30 + 34 Room Temp. 2 to 3 Temperature 16 Cycle Pretreatment Perform a heat treatment at 150<sup>±</sup><sub>10</sub> °C for 60±5 min. and then let sit for 24±2 hrs. at room condition\*. Dielectric In accordance with item No.4 Strength M M M M-Glass Epoxy Board Fig. 4

<sup>\* &</sup>quot;Room condition" Temperature: 15 to 35℃, Relative humidity: 45 to 75%, Atmospheric pressure: 86 to 106kPa

Continued from the preceding page.

No.	Ite	m	Specifications	Test Method			
		Appearance	No marking defects				
	Humidity	Capacitance Change	Within ±15%	Let the capacitor sit at 40±2°C and relative humidity of 90 to 95% for 500±26 hrs.  Remove and let sit for 24±2 hrs. at room condition*, then			
17	(Steady	D.F.	0.05 max.	measure.			
	State)	I.R.	More than 1,000M $\Omega$	Perform a heat treatment at 150 ± 18 ℃ for 60±5 min. and then			
		Dielectric Strength	In accordance with item No.4	Perform a near treatment at 150 $_{-10}$ C for 60 $\pm$ 5 min. and ther let sit for 24 $\pm$ 2 hrs. at room condition*.			
		Appearance	No marking defects	Apply voltage and time as Table at 85±2℃. Remove and let sit			
		Capacitance Change	Within ±20%	for 24 ±2 hrs. at room condition*, then measure. The charge / discharge current is less than 50mA.			
	Life	D.F.	0.05 max.	Nominal Capacitance Test Time Test voltage  C≥10,000pF 1,000 <sup>+48</sup> <sub>0</sub> hrs. AC300V (r.m.s.)			
18		I.R.	More than 1,000M $\Omega$	C<10,000pF 1,500 <sup>+48</sup> <sub>0</sub> hrs. AC500V (r.m.s.)*			
		Dielectric Strength In accordance with item No.4		* Except that once each hour the voltage is increased to AC1,000V (r.m.s.) for 0.1 sec.      •Pretreatment     Apply test voltage for 60±5 min. at test temperature.     Remove and let sit for 24±2 hrs. at room condition*.			
		Appearance	No marking defects				
		Capacitance Change	Within ±15%	Apply the rated voltage at 40±2°C and relative humidity of 90 to 95% for 500±26 hrs.  Remove and let sit for 24±2 hrs. at room condition*, then			
19	Humidity Loading	D.F.	0.05 max.	measure.			
	Loading	I.R.	More than 1,000M $\Omega$	Pretreatment     Apply test voltage for 60±5 min. at test temperature.			
		Dielectric Strength	In accordance with item No.4	Remove and let sit for 24±2 hrs. at room condition*.			

<sup>\* &</sup>quot;Room condition" Temperature: 15 to 35°C, Relative humidity: 45 to 75%, Atmospheric pressure: 86 to 106kPa

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## Safety Standard Recognized Type GC (UL, IEC60384-14 Class X1/Y2)

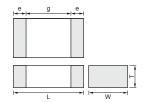
#### ■ Features

- 1. Chip monolithic ceramic capacitor (certified as conforming to safety standards) for AC lines
- A new monolithic structure for small, high capacitance capable of operating at high voltage levels
- 3. Compared to lead type capacitors, this new capacitor is greatly downsized and low-profiled to 1/10 or less in volume, and 1/4 or less in height.
- 4. The type GC can be used as an X1-class and Y2-class capacitor, line-by-pass capacitor of UL1414.
- 5. +125 degree C guaranteed
- 6. Only for reflow soldering

#### Applications

- Ideal for use as Y capacitor or X capacitor for various switching power supplies
- 2. Ideal for modem applications





Part Number		Dimensions (mm)							
Part Number	L	W	T	e min.	g min.				
GA355D	5.7 ±0.4	5.0 ±0.4	2.0 ±0.3	0.3	4.0				

### ■ Standard Recognition

	Standard No.	Status of R	Status of Recognition			
	Standard No.	Type GB	Type GC	Voltage		
UL	UL1414	_	0*			
BSI		_	0			
VDE	EN132400	0	0	AC250V		
SEV	EN 132400	0	0	(r.m.s.)		
SEMKO		0	0			
EN132400 Class		X2	X1, Y2			

<sup>\*:</sup> Line By-pass only

Part Number	Rated Voltage (V)	TC Code (Standard)	Capacitance (pF)	Length L (mm)	Width W (mm)	Thickness T (mm)	Electrode g min. (mm)	Electrode e (mm)
GA355DR7GC101KY02L	AC250 (r.m.s.)	X7R (EIA)	100 ±10%	5.7	5.0	2.0	4.0	0.3 min.
GA355DR7GC151KY02L	AC250 (r.m.s.)	X7R (EIA)	150 ±10%	5.7	5.0	2.0	4.0	0.3 min.
GA355DR7GC221KY02L	AC250 (r.m.s.)	X7R (EIA)	220 ±10%	5.7	5.0	2.0	4.0	0.3 min.
GA355DR7GC331KY02L	AC250 (r.m.s.)	X7R (EIA)	330 ±10%	5.7	5.0	2.0	4.0	0.3 min.





## Safety Standard Recognized Type GD (IEC60384-14 Class Y3)

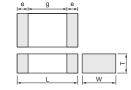
#### ■ Features

- Available for equipment based on IEC/EN60950 and UL1950
- 2. The type GD can be used as a Y3-class capacitor.
- A new monolithic structure for small, high capacitance capable of operating at high voltage levels
- 4. +125 degree C guaranteed
- 5. Only for reflow soldering
- 6. The low-profile type (thickness: 1.5mm max.) is available. Fit for use on thinner type equipment.

#### Applications

- Ideal for use on line filters and couplings for DAA modems without transformers
- 2. Ideal for use on line filters for information equipment





Part Number	Dimensions (mm)								
Part Number	L	W	T	e min.	g min.				
GA342A			1.0 +0, -0.3						
GA342D	$4.5 \pm 0.3$	2.0 ±0.2	2.0 ±0.3		2.5				
GA342Q			1.5 +0, -0.3	0.3					
GA343D	4.5 ±0.4	3.2 +0.3	2.0 +0, -0.3						
GA343Q	4.5 ±0.4	3.2 ±0.3	1.5 +0, -0.3						

### ■ Standard Recognition

	Standard	Class	Status of Recognition	Rated	
	No.	Class	Type GD	Voltage	
SEMKO	EN132400	Y3	0	AC250V(r.m.s.)	

**Applications** 

Size	Switching power supplies	Communication network devices such as a modem
4.5×3.2mm and under	_	0

Part Number	Rated Voltage (V)	TC Code (Standard)	Capacitance (pF)	Length L (mm)	Width W (mm)	Thickness T (mm)	Electrode g min. (mm)	Electrode e (mm)
GA342D1XGD100JY02L	AC250 (r.m.s.)	SL (JIS)	10 ±5%	4.5	2.0	2.0	2.5	0.3 min.
GA342D1XGD120JY02L	AC250 (r.m.s.)	SL (JIS)	12 ±5%	4.5	2.0	2.0	2.5	0.3 min.
GA342D1XGD150JY02L	AC250 (r.m.s.)	SL (JIS)	15 ±5%	4.5	2.0	2.0	2.5	0.3 min.
GA342D1XGD180JY02L	AC250 (r.m.s.)	SL (JIS)	18 ±5%	4.5	2.0	2.0	2.5	0.3 min.
GA342D1XGD220JY02L	AC250 (r.m.s.)	SL (JIS)	22 ±5%	4.5	2.0	2.0	2.5	0.3 min.
GA342A1XGD270JW31L	AC250 (r.m.s.)	SL (JIS)	27 ±5%	4.5	2.0	1.0	2.5	0.3 min.
GA342A1XGD330JW31L	AC250 (r.m.s.)	SL (JIS)	33 ±5%	4.5	2.0	1.0	2.5	0.3 min.
GA342A1XGD390JW31L	AC250 (r.m.s.)	SL (JIS)	39 ±5%	4.5	2.0	1.0	2.5	0.3 min.
GA342A1XGD470JW31L	AC250 (r.m.s.)	SL (JIS)	47 ±5%	4.5	2.0	1.0	2.5	0.3 min.
GA342A1XGD560JW31L	AC250 (r.m.s.)	SL (JIS)	56 ±5%	4.5	2.0	1.0	2.5	0.3 min.
GA342A1XGD680JW31L	AC250 (r.m.s.)	SL (JIS)	68 ±5%	4.5	2.0	1.0	2.5	0.3 min.
GA342A1XGD820JW31L	AC250 (r.m.s.)	SL (JIS)	82 ±5%	4.5	2.0	1.0	2.5	0.3 min.
GA342QR7GD101KW01L	AC250 (r.m.s.)	X7R (EIA)	100 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GA342QR7GD151KW01L	AC250 (r.m.s.)	X7R (EIA)	150 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GA342QR7GD221KW01L	AC250 (r.m.s.)	X7R (EIA)	220 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GA342QR7GD331KW01L	AC250 (r.m.s.)	X7R (EIA)	330 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GA342QR7GD471KW01L	AC250 (r.m.s.)	X7R (EIA)	470 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GA342QR7GD681KW01L	AC250 (r.m.s.)	X7R (EIA)	680 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GA342QR7GD102KW01L	AC250 (r.m.s.)	X7R (EIA)	1000 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GA342QR7GD152KW01L	AC250 (r.m.s.)	X7R (EIA)	1500 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GA343QR7GD182KW01L	AC250 (r.m.s.)	X7R (EIA)	1800 ±10%	4.5	3.2	1.5	2.5	0.3 min.
GA343QR7GD222KW01L	AC250 (r.m.s.)	X7R (EIA)	2200 ±10%	4.5	3.2	1.5	2.5	0.3 min.
GA343DR7GD472KW01L	AC250 (r.m.s.)	X7R (EIA)	4700 ±10%	4.5	3.2	2.0	2.5	0.3 min.



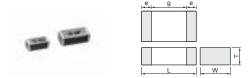
## Safety Standard Recognized Type GF (IEC60384-14 Class Y2, X1/Y2)

#### ■ Features

- Available for equipment based on IEC/EN60950 and UL1950. Besides, the GA352/355 types are available for equipment based on IEC/EN60065, UL1492, and UL6500
- 2. The type GF can be used as a Y2-class capacitor.
- A new monolithic structure for small, high capacitance capable of operating at high voltage levels
- 4. +125 degree C guaranteed
- 5. Only for reflow soldering
- 6. The low-profile type (thickness: 1.5mm max.) is available. Fit for use on thinner type equipment.

#### ■ Applications

- Ideal for use on line filters and couplings for DAA modems without transformers
- 2. Ideal for use on line filters for information equipment
- Ideal for use as Y capacitor or X capacitor for various switching power supplies (GA352/355 types only)



Part Number	Dimensions (mm)							
Part Number	L	L W T		e min.	g min.			
GA342A			1.0 +0, -0.3					
GA342D	4.5 ±0.3	2.0 ±0.2	2.0 ±0.2*		2.5			
GA342Q			1.5 +0, -0.3	0.3				
GA352Q		2.8 ±0.3	1.5 +0, -0.3	0.5				
GA355D	5.7 ±0.4	5.0 +0.4	2.0 +0, -0.3		4.0			
GA355Q	5.0	3.0 ±0.4	1.5 +0, -0.3					

<sup>\*</sup> GA342D1X : 2.0±0.3

### ■ Standard Recognition

			Status of R		
	Standard	Class	Туре	e GF	Rated
	No.		Size : 4.5×2.0mm	Size: 5.7×2.8mm and over	Voltage
UL	UL1414	X1, Y2	_	0	AC250V
SEMKO	EN132400	Y2	0	0	(r.m.s.)

(ppl	icatio	ons	

Size	Switching power supplies	Communication network devices such as a modem	
4.5×2.0mm	_	0	
5.7×2.8mm and over	0	0	

Part Number	Rated Voltage (V)	TC Code (Standard)	Capacitance (pF)	Length L (mm)	Width W (mm)	Thickness T (mm)	Electrode g min. (mm)	Electrode e (mm)
GA342D1XGF100JY02L	AC250 (r.m.s.)	SL (JIS)	10 ±5%	4.5	2.0	2.0	2.5	0.3 min.
GA342D1XGF120JY02L	AC250 (r.m.s.)	SL (JIS)	12 ±5%	4.5	2.0	2.0	2.5	0.3 min.
GA342D1XGF150JY02L	AC250 (r.m.s.)	SL (JIS)	15 ±5%	4.5	2.0	2.0	2.5	0.3 min.
GA342D1XGF180JY02L	AC250 (r.m.s.)	SL (JIS)	18 ±5%	4.5	2.0	2.0	2.5	0.3 min.
GA342D1XGF220JY02L	AC250 (r.m.s.)	SL (JIS)	22 ±5%	4.5	2.0	2.0	2.5	0.3 min.
GA342A1XGF270JW31L	AC250 (r.m.s.)	SL (JIS)	27 ±5%	4.5	2.0	1.0	2.5	0.3 min.
GA342A1XGF330JW31L	AC250 (r.m.s.)	SL (JIS)	33 ±5%	4.5	2.0	1.0	2.5	0.3 min.
GA342A1XGF390JW31L	AC250 (r.m.s.)	SL (JIS)	39 ±5%	4.5	2.0	1.0	2.5	0.3 min.
GA342A1XGF470JW31L	AC250 (r.m.s.)	SL (JIS)	47 ±5%	4.5	2.0	1.0	2.5	0.3 min.
GA342A1XGF560JW31L	AC250 (r.m.s.)	SL (JIS)	56 ±5%	4.5	2.0	1.0	2.5	0.3 min.
GA342A1XGF680JW31L	AC250 (r.m.s.)	SL (JIS)	68 ±5%	4.5	2.0	1.0	2.5	0.3 min.
GA342A1XGF820JW31L	AC250 (r.m.s.)	SL (JIS)	82 ±5%	4.5	2.0	1.0	2.5	0.3 min.
GA342QR7GF101KW01L	AC250 (r.m.s.)	X7R (EIA)	100 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GA342QR7GF151KW01L	AC250 (r.m.s.)	X7R (EIA)	150 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GA342DR7GF221KW02L	AC250 (r.m.s.)	X7R (EIA)	220 ±10%	4.5	2.0	2.0	2.5	0.3 min.
GA342DR7GF331KW02L	AC250 (r.m.s.)	X7R (EIA)	330 ±10%	4.5	2.0	2.0	2.5	0.3 min.
GA352QR7GF471KW01L	AC250 (r.m.s.)	X7R (EIA)	470 ±10%	5.7	2.8	1.5	4.0	0.3 min.
GA352QR7GF681KW01L	AC250 (r.m.s.)	X7R (EIA)	680 ±10%	5.7	2.8	1.5	4.0	0.3 min.
GA352QR7GF102KW01L	AC250 (r.m.s.)	X7R (EIA)	1000 ±10%	5.7	2.8	1.5	4.0	0.3 min.
GA352QR7GF152KW01L	AC250 (r.m.s.)	X7R (EIA)	1500 ±10%	5.7	2.8	1.5	4.0	0.3 min.
GA355QR7GF182KW01L	AC250 (r.m.s.)	X7R (EIA)	1800 ±10%	5.7	5.0	1.5	4.0	0.3 min.
GA355QR7GF222KW01L	AC250 (r.m.s.)	X7R (EIA)	2200 ±10%	5.7	5.0	1.5	4.0	0.3 min.
GA355QR7GF332KW01L	AC250 (r.m.s.)	X7R (EIA)	3300 ±10%	5.7	5.0	1.5	4.0	0.3 min.
GA355DR7GF472KW01L	AC250 (r.m.s.)	X7R (EIA)	4700 ±10%	5.7	5.0	2.0	4.0	0.3 min.



## Safety Standard Recognized Type GB (IEC60384-14 Class X2)

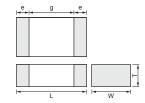
#### ■ Features

- 1. The type GB can be used as an X2-class capacitor.
- Chip monolithic ceramic capacitor (certified as conforming to safety standards) for AC lines
- A new monolithic structure for small, high capacitance capable of operating at high voltage levels
- 4. Compared to lead type capacitors, this new capacitor is greatly downsized and low-profiled to 1/10 or less in volume, and 1/4 or less in height.
- 5. +125 degree C guaranteed
- 6. Only for reflow soldering

#### Applications

Ideal for use as X capacitor for various switching power supplies





Part Number	Dimensions (mm)						
Part Number	L	W	T	e min.	g min.		
GA355D	5.7 +0.4	5.0 ±0.4	2.0 ±0.3	0.3	4.0		
GA355X	5.7 ±0.4		2.7 ±0.3	0.3			

### ■ Standard Recognition

	Standard No.	Status of R	Rated	
	Standard No.	Type GB	Type GC	Voltage
UL	UL1414	_	0*	
BSI		_	0	
VDE	EN132400	0	0	AC250V
SEV	EN 132400	0	0	(r.m.s.)
SEMKO		0	0	
EN13240	0 Class	X2	X1, Y2	

<sup>\*:</sup> Line By-pass only

Part Number	Rated Voltage (V)	TC Code (Standard)	Capacitance (pF)	Length L (mm)	Width W (mm)	Thickness T (mm)	Electrode g min. (mm)	Electrode e (mm)
GA355DR7GB103KY02L	AC250 (r.m.s.)	X7R (EIA)	10000 ±10%	5.7	5.0	2.0	4.0	0.3 min.
GA355DR7GB153KY02L	AC250 (r.m.s.)	X7R (EIA)	15000 ±10%	5.7	5.0	2.0	4.0	0.3 min.
GA355DR7GB223KY02L	AC250 (r.m.s.)	X7R (EIA)	22000 ±10%	5.7	5.0	2.0	4.0	0.3 min.
GA355XR7GB333KY06L	AC250 (r.m.s.)	X7R (EIA)	33000 ±10%	5.7	5.0	2.7	4.0	0.3 min.

No.	Ite	em	Specifications	Test Method		
1	Operating Temperati	ıre Range	-55 to +125℃	-		
2	Appearar	nce	No defects or abnormalities	Visual inspection		
3	Dimensio	ns	Within the specified dimensions	Using calipers		
4	4 Dielectric Strength		No defects or abnormalities	No failure should be observed when voltage in table is applied between the terminations for 60±1 sec., provided the charge/discharge current is less than 50mA.  Test Voltage Type GB DC1075V Type GC/GD/GF AC1500V (r.m.s.)		
5	Pulse Vol (Applicat GD/GF)	0	No self healing breakdowns or flash-overs have taken place in the capacitor.	10 impulse of alternating polarity is subjected. (5 impulse for each polarity) The interval between impulse is 60 sec. Applied Voltage: 2.5kV zero to peak		
6	Insulation (I.R.)	Resistance	More than $6,000M\Omega$	The insulation resistance should be measured with DC500±50V and within 60±5 sec. of charging.		
7	Capacita	nce	Within the specified tolerance			
8	Dissipation 8 Factor (D.F.) Q		Char.         Specification           X7R         D.F.≤0.025           SL         Q≥400+20C*² (C<30pF)	The capacitance/Q/D.F. should be measured at a frequency of 1±0.2kHz (SL char.: 1±0.2MHz) and a voltage of AC1±0.2V (r.m.s.).		
9	Capacitar Temperat Character	ure	Char. Capacitance Change X7R Within ±15%  Temperature characteristic guarantee is −55 to +125°C  Char. Temperature Coefficient SL +350 to −1000ppm/°C  Temperature characteristic guarantee is +20 to +85°C	The capacitance measurement should be made at each step specified in Table.  Step Temperature (°C)  1 25±2 (20±2 for SL char.)  2 Min. Operating Temp.±3  3 25±2 (20±2 for SL char.)  4 Max. Operating Temp.±2  5 25±2 (20±2 for SL char.)  SL char.:  The capacitance should be measured at even 85°C between step 3 and step 4.  • Pretreatment for X7R char.  Perform a heat treatment at 150±18°C for 60±5 min. and then let sit for 24±2 hrs. at room condition*1.		
		Appearance	No defects or abnormalities	As in Fig., discharge is made 50 times at 5 sec. intervals from		
		I.R.	More than 1,000MΩ	the capacitor (Cd) charged at DC voltage of specified.		
10	Discharge Test (Application: Type GC)	Dielectric Strength	In accordance with item No.4	Ct: Capacitor under test Cd: 0.001µF R1: 1,000Ω R2: 100MΩ R3: Surge resistance		
11	Adhesive of Termir	J	No removal of the terminations or other defect should occur.	Solder the capacitor to the testing jig (glass epoxy board) shown in Fig. 1.  Then apply 10N force in the direction of the arrow. The soldering should be done using the reflow method and should be conducted with care so that the soldering is uniform and free of defects such as heat shock.		

<sup>\*1 &</sup>quot;Room condition" Temperature: 15 to 35°C, Relative humidity: 45 to 75%, Atmospheric pressure: 86 to 106kPa





<sup>\*2 &</sup>quot;C" expresses nominal capacitance value (pF).

$\overline{A}$	Continued fr	om the prec	eding page.			
No	Ite	em	Specifications	Test Method		
		Appearance	No defects or abnormalities	Solder the capacitor to the test jig (glass epoxy board).		
		Capacitance	Within the specified tolerance	The capacitor should be subjected to a simple harmonic motion having a total amplitude of 1.5mm, the frequency being varied		
12	Vibration Resistance	D.F. Q	Char.         Specification           X7R         D.F.≤0.025           SL         Q≥400+20C*² (C<30pF)	uniformly between the approximate limits of 10 and 55Hz. The frequency range, from 10 to 55Hz and return to 10Hz, should be traversed in approximately 1 min. This motion should be applied for a period of 2 hrs. in each of 3 mutually perpendicular directions (total of 6 hrs.).  Solder resist  Glass Epoxy Board		
13	Deflection	n	No cracking or marking defects should occur.	Solder the capacitor to the testing jig (glass epoxy board) shown in Fig. 2.  Then apply a force in the direction shown in Fig. 3. The soldering should be done using the reflow method and should be conducted with care so that the soldering is uniform and free of defects such as heat shock.  20 50 Pressurizing speed: 1.0mm/s Pressurize  Pressurize  (in mm)  Fig. 3		
14	Solderab Terminati		75% of the terminations are to be soldered evenly and continuously.	Immerse the capacitor in a solution of ethanol (JIS-K-8101) and rosin (JIS-K-5902) (25% rosin in weight proportion).  Immerse in solder solution for 2±0.5 sec.  Immersing speed: 25±2.5mm/s  Temp. of solder: 245±5°C Lead Free Solder (Sn-3.0Ag-0.5Cu) 235±5°C H60A or H63A Eutectic Solder		
		Appearance	No marking defects	Preheat the capacitor as table. Immerse the capacitor in solder		
15	Resistance to Soldering	Capacitance Change	Char. Capacitance Change  X7R Within ±10%  SL Within ±2.5% or ±0.25pF (Whichever is larger)	solution at 260±5°C for 10±1 sec. Let sit at room condition*¹ for 24±2 hrs., then measure.  •Immersing speed: 25±2.5mm/s  •Pretreatment for X7R char.  Perform a heat treatment at 150±₁°C for 60±5 min. and then let sit for 24±2 hrs. at room condition*¹.		
	Heat	I.R.	More than 1,000M $\Omega$	WDrah acting		
		Dielectric Strength In accordance with item No.4		*Preheating         Step         Temperature         Time           1         100 to 120℃         1 min.           2         170 to 200℃         1 min.		

<sup>\*1 &</sup>quot;Room condition" Temperature: 15 to 35°C, Relative humidity: 45 to 75%, Atmospheric pressure: 86 to 106kPa



<sup>\*2 &</sup>quot;C" expresses nominal capacitance value (pF).

No.	Ite	em	Specifications	Test Method			
		Appearance  Capacitance	No marking defects  Char. Capacitance Change  X7R Within ±15%	Fix the capacitor to the supporting jig (glass epoxy board) shown in Fig. 4.  Perform the 5 cycles according to the 4 heat treatments listed in the following table.			
		Change	SL Within ±2.5% or ±0.25pF (Whichever is larger)	Let sit for 24±2 hrs. at room condition*1, then measure.  Step Temperature (°C) Time (min.)			
16	Temperature Cycle	D.F. Q	Char.         Specification           X7R         D.F.≤0.05           SL         Q≥400+20C*² (C<30pF)	1         Min. Operating Temp.±3         30±3           2         Room Temp.         2 to 3           3         Max. Operating Temp.±2         30±3           4         Room Temp.         2 to 3   •Pretreatment for X7R char.			
	2,5	I.R.	More than $3{,}000\text{M}\Omega$	Perform a heat treatment at 150 <sup>+</sup> <sub>1</sub> % <sup>o</sup> for 60±5 min. and then			
		Dielectric Strength	In accordance with item No.4	let sit for 24±2 hrs. at room condition*1.			
		Appearance	No marking defects	g			
		Capacitance Change	Char. Capacitance Change  X7R Within ±15%  SL Within ±5.0% or ±0.5pF (Whichever is larger)	Before this test, the test shown in the following is performed.  ·Item 11 Adhesive Strength of Termination (applied force is 5N) ·Item 13 Deflection			
17	Humidity (Steady State)	D.F. Q	Char.         Specification           X7R         D.F.≤0.05           SL         Q≥275+5/2C*² (C<30pF)	Let the capacitor sit at 40±2°C and relative humidity of 90 to 95% for 500±2°6 hrs.  Remove and let sit for 24±2 hrs. at room condition*¹, then measure.  •Pretreatment for X7R char.  Perform a heat treatment at 150±1°C for 60±5 min. and then			
		I.R.	More than 3,000M $\Omega$	let sit for 24±2 hrs. at room condition*1.			
		Dielectric Strength	In accordance with item No.4				
		Appearance Capacitance	No marking defects  Char. Capacitance Change X7R Within ±20%	Before this test, the test shown in the following is performed.  -Item 11 Adhesive Strength of Termination (apply force is 5N) -Item 13 Deflection  Front time (T1)=1.2µs=1.67T  Impulse Voltage			
		Change	SL Within ±3.0% or ±0.3pF (Whichever is larger)  Char. Specification	Each individual capacitor should be subjected to a 2.5kV (Type GC/GF: 5kV) Impulse (the voltage value means zero to			
18	Life	D.F. Q	X7R D.F.≤0.05  SL Q≥275+5/2C*² (C<30pF) Q≥350 (C≥30pF)	peak) for three times. Then the capacitors are applied to life test.  Apply voltage as Table for 1,000 hrs. at 125 ±6°C, relative			
		I.R.	More than 3,000M $\Omega$	humidity 50% max.			
		Dielectric Strength	In accordance with item No.4	Applied Voltage  GB AC312.5V (r.m.s.), except that once each hour the voltage is increased to AC1,000V (r.m.s.) for 0.1 sec.  GC GD AC425V (r.m.s.), except that once each hour the voltage is increased to AC1,000V (r.m.s.) for 0.1 sec.  Let sit for 24±2 hrs. at room condition*i, then measure.			

<sup>\*1 &</sup>quot;Room condition" Temperature: 15 to 35°C, Relative humidity: 45 to 75%, Atmospheric pressure: 86 to 106kPa

Continued on the following page.

let sit for 24±2 hrs. at room condition\*1.





<sup>\*2 &</sup>quot;C" expresses nominal capacitance value (pF).

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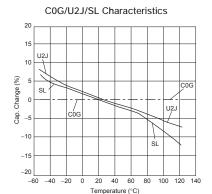
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No.	Ite	em	Specifications	Test Method			
	Appearance  Capacitance Change		No marking defects  Char. Capacitance Change X7R Within ±15% SL Within ±5.0% or ±0.5pF (Whichever is larger)	Before this test, the test shown in the following is performedItem 11 Adhesive Strength of Termination (apply force is 5N) -Item 13 Deflection			
19	Humidity Loading	D.F. Q	Char.         Specification           X7R         D.F.≤0.05           SL         Q≥275+5/2C*² (C<30pF)	Apply the rated voltage at $40\pm2^{\circ}\text{C}$ and relative humidity of 90 to 95% for $500^{+20}_{-0}^{\circ}$ hrs. Remove and let sit for $24\pm2$ hrs. at room condition*1, then measure.  •Pretreatment for X7R char.  Perform a heat treatment at $150^{+10}_{-10}^{\circ}$ for $60\pm5$ min. and then let sit for $24\pm2$ hrs. at room condition*1.			
		I.R. Dielectric Strength	More than 3,000M $\Omega$ In accordance with item No.4	let sit to 24.12 his. at footh condition .			
20	Active Flammab	ility	The cheesecloth should not be on fire.	The capacitor should be individually wrapped in at least one but not more than two complete layers of cheesecloth. The capacitor should be subjected to 20 discharges. The interval between successive discharges should be 5 sec. The UAC should be maintained for 2 min. after the last discharge.			
21	Passive Flammability		The burning time should not exceed 30 sec. The tissue paper should not ignite.	The capacitor under test should be held in the flame in the position which best promotes burning. Each specimen should only be exposed once to the flame. Time of exposure to flame: 30 sec.  Length of flame: 12±1mm Gas burner : Length 35mm min. Inside Dia. 0.5±0.1mm Outside Dia. 0.9mm max. Gas : Butane gas Purity 95% min.  Test Specimen  Tissue About 10mm Thick Board			

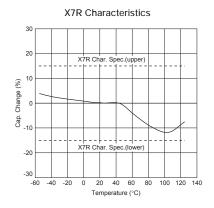
<sup>\*1 &</sup>quot;Room condition" Temperature: 15 to 35°C, Relative humidity: 45 to 75%, Atmospheric pressure: 86 to 106kPa

<sup>\*2 &</sup>quot;C" expresses nominal capacitance value (pF).

## GRM/GR4/GR7/GA2/GA3 Series Data (Typical Example)

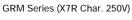
### ■ Capacitance - Temperature Characteristics

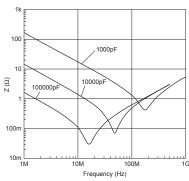




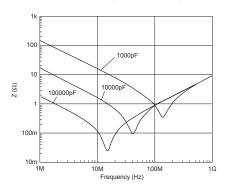
#### **GR4 Series** 20 10 Cap. Change (%) -10 -15 -20 -40 -20 40 60 100 120 140 -60 20 80 Temperature (°C)

### ■ Impedance - Frequency Characteristics





#### GRM Series (X7R Char. 630V)



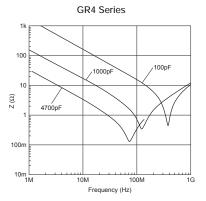


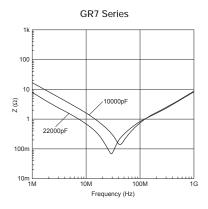


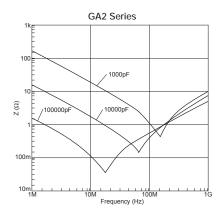
## GRM/GR4/GR7/GA2/GA3 Series Data (Typical Example)

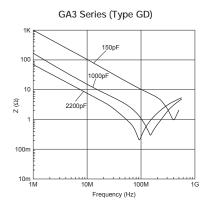
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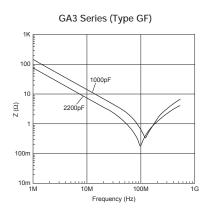
### ■ Impedance - Frequency Characteristics

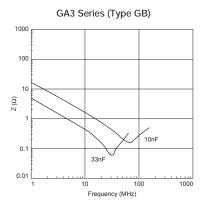










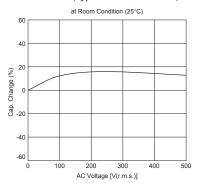




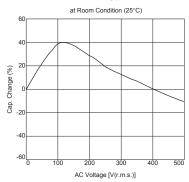
## GRM/GR4/GR7/GA2/GA3 Series Data (Typical Example)

## ■ Capacitance - AC Voltage Characteristics

### GA3 Series (Type GD/GF, X7R char.)



## GA3 Series (Type GB)



## Package

Taping is standard packaging method.

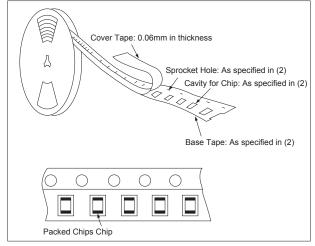
■ Minimum Quantity Guide

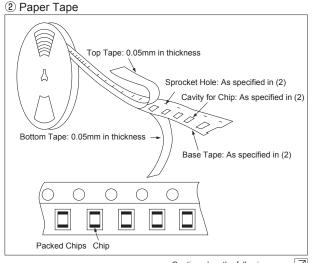
Part Number		Dimensions (mm)			Quantity (pcs.) ø180mm Reel	
Faitivu	ilibei	L	W	Т	Paper Tape	Embossed Tape
	GRM18	1.6	0.8	0.8	4,000	-
				1.0	4,000	-
	GRM21	2.0	1.25	1.25	-	3,000
				1.0	4,000	-
	GRM31/GR731	3.2	1.6	1.25	-	3,000
				1.6	-	2,000
				1.0	4,000	-
	ODMOO	2.0	2.5	1.25	-	3,000
/ledium-voltage	GRM32	3.2	2.5	1.5	-	2,000
				2.0	-	1,000
				1.0	-	3,000
	GRM42/GR442	4.5	2.0	1.5	-	2,000
				2.0	-	2,000
	GRM43/GR443 4.8			1.5	-	1,000
		4.5	3.2	2.0	-	1,000
				2.5	-	500
	GRM55/GR455	5.7	5.0	2.0	-	1,000
	GA242	4.5	2.0	1.5	-	2,000
AC250V	04040	4.5	0.0	1.5	-	1,000
AC250V	GA243	4.5	3.2	2.0	- 1,00	1,000
	GA255	5.7	5.0	2.0	-	1,000
				1.0	-	3,000
	GA342	4.5	2.0	1.5	-	2,000
				2.0	-	2,000
Safety Std.	GA343	4.5	3.2	1.5	-	1,000
Recognition	GA343	4.5	3.2	2.0	-	1,000
	GA352	5.7	2.8	1.5	-	1,000
				1.5	-	1,000
	GA355	5.7	5.0	2.0	-	1,000
				2.7	-	500

## ■ Tape Carrier Packaging

(1) Appearance of Taping

① Embossed Tape





## **Package**

- Continued from the preceding page.
- (2) Dimensions of Tape
- ① Embossed Tape

## 4.0±0.05 0.25±0.1 2.0±0.05 4.0±0.1 1.75±0.1 8.0±0.3

8mm width 4mm pitch Tape

## 12mm width 8mm/4mm pitch Tape $\phi_{1.5}^{+0.1}_{-0}$ 8.0±0.1\*1 2.0±0.05 $0.3\pm0.1$ 1.75±0.1 4.0±0.1 $12.0\pm0.3$ Direction of Feed 3.7 max.

Part Number	A*	B*
<b>GRM21</b> (T≧1.25mm)	1.45	2.25
GRM31/GR731 (T≥1.25mm)	2.0	3.6
<b>GRM32</b> (T≧1.25mm)	2.9	3.6

Direction of Feed

\*Nominal Value

2.5 max.

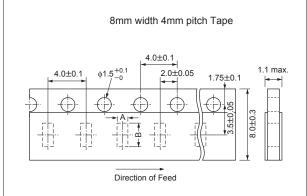
Part Number	A*	B*
GRM42/GR442/GA242/GA342	2.5	5.1
GRM43/GR443/GA243/GA343	3.6	4.9
GA352	3.2	6.1
GRM55/GR455/GA255/GA355	5.4	6.1

\*1 4.0±0.1mm in case of GRM42/GR442/GA242/GA342

\*Nominal Value

(in mm)

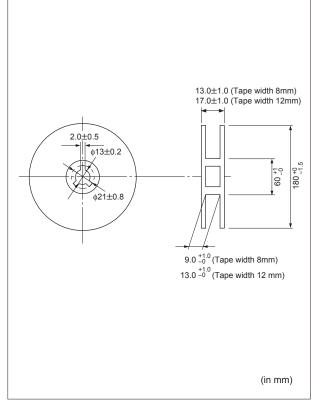
## 2 Paper Tape



Part Number	A*	B*
GRM18	1.05	1.85
<b>GRM21</b> (T=1.0mm)	1.45	2.25
<b>GRM31/GR731</b> (T=1.0mm)	2.0	3.6
<b>GRM32</b> (T=1.0mm)	2.9	3.6

\*Nominal value (in mm)

## (3) Dimensions of Reel

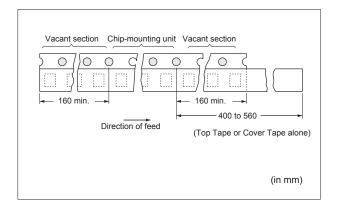


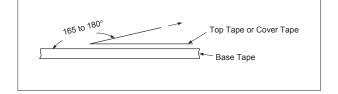
## **Package**

Continued from the preceding page.

#### (4) Taping Method

- $\ensuremath{\mathbb{1}}$  Tapes for capacitors are wound clockwise. The sprocket holes are to the right as the tape is pulled toward the user.
- 2 Part of the leader and part of the empty tape should be attached to the end of the tape as shown at right.
- 3 The top tape or cover tape and base tape are not attached at the end of the tape for a minimum of 5 pitches.
- 4 Missing capacitors number within 0.1% of the number per reel or 1 pc, whichever is greater, and are not continuous.
- 5 The top tape or cover tape and bottom tape should not protrude beyond the edges of the tape and should not cover sprocket holes.
- 6 Cumulative tolerance of sprocket holes, 10 pitches:
- 7 Peeling off force: 0.1 to 0.6N in the direction shown at right.









#### ■ Storage and Operating Conditions

Operating and storage environment Do not use or store capacitors in a corrosive atmosphere, especially where chloride gas, sulfide gas, acid, alkali, salt or the like are present. And avoid exposure to moisture. Before cleaning, bonding or molding this product, verify that these processes do not affect product quality by testing the performance of a cleaned, bonded or molded product in the intended equipment. Store the capacitors

where the temperature and relative humidity do not exceed 5 to 40 degrees centigrade and 20 to 70%. Use capacitors within 6 months after delivered. Check the solderability after 6 months or more.

FAILURE TO FOLLOW THE ABOVE CAUTIONS MAY RESULT, WORST CASE, IN A SHORT CIRCUIT AND CAUSE FUMING OR PARTIAL DISPERSION WHEN THE PRODUCT IS USED.

#### ■ Handling

- 1. Vibration and impact Do not expose a capacitor to excessive shock or vibration during use.
- 2. Do not directly touch the chip capacitor, especially the ceramic body. Residue from hands/fingers may create a short circuit environment.

FAILURE TO FOLLOW THE ABOVE CAUTIONS MAY RESULT, WORST CASE, IN A SHORT CIRCUIT AND CAUSE FUMING OR PARTIAL DISPERSION WHEN THE PRODUCT IS USED.



## **⚠**Caution

#### ■ Caution (Rating)

1. Operating Voltage

When DC-rated capacitors are to be used in AC or ripple current circuits, be sure to maintain the Vp-p value of the applied voltage or the Vo-p which contains DC bias within the rated voltage range.

When the voltage is applied to the circuit, starting or stopping may generate irregular voltage for a transit period because of resonance or switching. Be sure to use a capacitor with a rated voltage range that includes these irregular voltages.

Voltage	DC Voltage	DC+AC Voltage	AC Voltage	Pulse Voltage (1)	Pulse Voltage (2)
Positional Measurement	Vo-p	Vo-p	Vp-p	Vp-p	Vp-p

- 2. Operating Temperature, Self-generated Heat, and Lead Reduction at High-frequency voltage condition Keep the surface temperature of a capacitor below the upper limit of its rated operating temperature range. Be sure to take into account the heat generated by the capacitor itself. When the capacitor is used in a highfrequency voltage, pulse voltage, it may self-generate heat due to dielectric loss.
- (1) In case of X7R char.

Applied voltage should be the load such as selfgenerated heat is within 20°C on the condition of atmosphere temperature 25°C. When measuring, use a thermocouple of small thermal capacity -K of ø0.1mm in conditions where the capacitor is not affected by radiant heat from other components or surrounding ambient fluctuations. Excessive heat may lead to deterioration of the capacitor's characteristics and reliability. (Never attempt to perform measurement with the cooling fan running. Otherwise, accurate measurement cannot be ensured.)





Continued from the preceding page

#### (2) In case of COG, U2J char.

Due to the low self-heating characteristics of lowdissipation capacitors, the allowable electric power of these capacitors is generally much higher than that of X7R characteristic capacitors.

When a high frequency voltage which cause 20°C self heating to the capacitor is applied, it will exceed capacitor's allowable electric power.

#### <C0G char.>

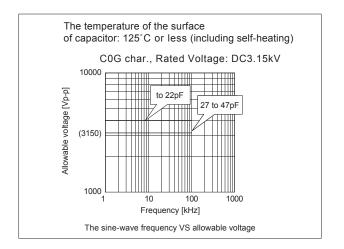
Therefore, in case of COG char., the frequency of the applied sine wave voltage should be less than 100kHz. The applied voltage should be less than the value shown in figure at right. The capacitors less than 22pF can be applied maximum 4.0kV peak to peak at 100kHz or less only for the ballast or the resonance usage in the LCD backlight inverter circuit.

#### <U2J char.>

In case of U2J char., the frequency of the applied sine wave voltage should be less than 500kHz (less than 100kHz in case of rated voltage: DC3.15kV). The applied voltage should be less than the value shown in figure below.

#### <Capacitor selection tool>

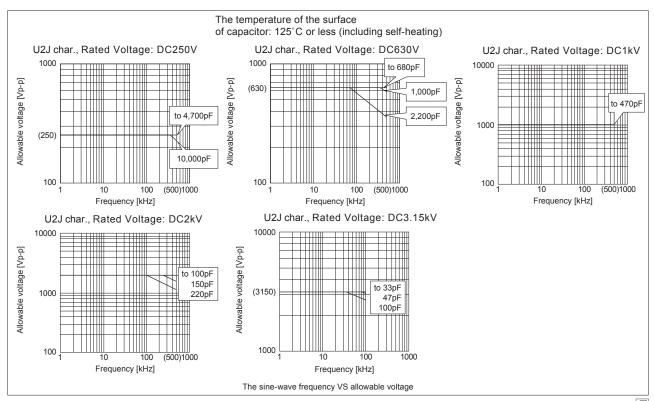
We are also offering free software the "capacitor selection tool: Murata Medium Voltage Capacitors Selection Tool by Voltage Form (\*)" which will assist you in selecting a suitable capacitor.



The software can be downloaded from Murata's Internet Website (http://www.murata.com/designlib/mmcsv\_e.html). By inputting capacitance values and applied voltage waveform of the specific capacitor series, this software will calculate the capacitor's power consumption and list suitable capacitors (non-sine wave is also available).

\* As of Jul. 2006, subject series are below.

· Temperature Characteristics C0G, U2J







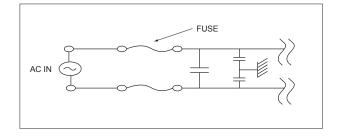
## **⚠**Caution

Continued from the preceding page.

#### 3. Fail-safe

Failure of a capacitor may result in a short circuit. Be sure to provide an appropriate fail-safe function such as a fuse on your product to help eliminate possible electric shock, fire, or fumes.

Please consider using fuses on each AC line if the capacitors are used between the AC input lines and earth (line bypass capacitors), to prepare for the worst case, such as a short circuit.



#### 4. Test condition for AC withstanding Voltage

#### (1) Test Equipment

Tests for AC withstanding voltage should be made with equipment capable of creating a wave similar to a 50/60 Hz sine wave.

If the distorted sine wave or overload exceeding the specified voltage value is applied, a defect may be caused.

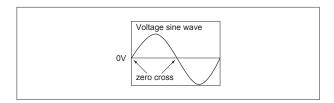
#### (2) Voltage applied method

The capacitor's leads or terminals should be firmly connected to the output of the withstanding voltage test equipment, and then the voltage should be raised from near zero to the test voltage. If the test voltage is applied directly to the capacitor without raising it from near zero, it should be applied with the zero cross\*. At the end of the test time, the test voltage should be reduced to near zero, and then the capacitor's leads or terminals should be taken off the output of the withstanding voltage test equipment. If the test voltage is applied directly to the capacitor without raising it from near zero, surge voltage may occur and cause a defect.

\*ZERO CROSS is the point where voltage sine wave pass 0V.

- See the figure at right -

FAILURE TO FOLLOW THE ABOVE CAUTIONS MAY RESULT, WORST CASE, IN A SHORT CIRCUIT AND CAUSE FUMING OR PARTIAL DISPERSION WHEN THE PRODUCT IS USED.





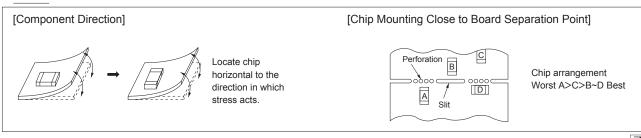
## ■ Caution (Soldering and Mounting)

1. Vibration and Impact Do not expose a capacitor to excessive shock or vibration during use.

#### 2. Circuit Board Material

In case that ceramic chip capacitor is soldered on the metal board, such as Aluminum board, the stress of heat expansion and contraction might cause the crack of ceramic capacitor, due to the difference of thermal expansion coefficient between metal board and ceramic chip.

3. Land Layout for Cropping PC Board Choose a mounting position that minimizes the stress imposed on the chip during flexing or bending of the board.





## **⚠**Caution

## Continued from the preceding page

#### 4. Reflow Soldering

- When sudden heat is given to the components, the mechanical strength of the components should go down because remarkable temperature change causes deformity of components inside. In order to prevent mechanical damage in the components, preheating should be required for both of the components and the PCB board. Preheating conditions are shown in Table 1. It is required to keep temperature differential between the soldering and the components surface (ΔT) as small as possible.
- Solderability of Tin plating termination chip might be deteriorated when low temperature soldering profile where peak solder temperature is below the Tin melting point is used. Please confirm the solderability of Tin plating termination chip before use.
- When components are immersed in solvent after mounting, be sure to maintain the temperature difference (ΔT) between the component and solvent within the range shown in the Table 1.

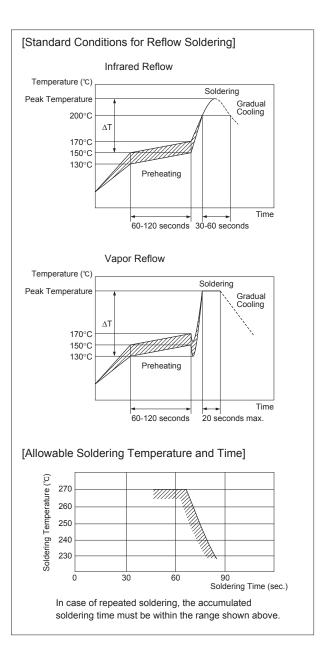
Table 1

Part Number	Temperature Differential	
G□□18/21/31	ΔΤ≦190℃	
G□□32/42/43/52/55	ΔΤ≦130℃	

#### **Recommended Conditions**

	Pb-Sn S	Lead Free Solder	
	Infrared Reflow	Vapor Reflow	Lead Free Solder
Peak Temperature	230-250°C	230-240°C	240-260°C
Atmosphere	Air	Air	Air or N2

Pb-Sn Solder: Sn-37Pb Lead Free Solder: Sn-3.0Ag-0.5Cu

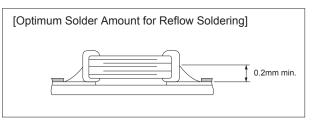


### Optimum Solder Amount for Reflow Soldering

- Overly thick application of solder paste results in excessive fillet height solder.
  - This makes the chip more susceptible to mechanical and thermal stress on the board and may cause cracked chips.
- Too little solder paste results in a lack of adhesive strength on the outer electrode, which may result in chips breaking loose from the PCB.
- Make sure the solder has been applied smoothly to the end surface to a height of 0.2mm min.

### Inverting the PCB

Make sure not to impose an abnormal mechanical shock on the PCB.





Continued from the preceding page.

#### 5. Flow Soldering

- When sudden heat is given to the components, the mechanical strength of the components should go down because remarkable temperature change causes deformity of components inside. And an excessively long soldering time or high soldering temperature results in leaching by the outer electrodes, causing poor adhesion or a reduction in capacitance value due to loss of contact between electrodes and end termination.
- In order to prevent mechanical damage in the components, preheating should be required for both of the components and the PCB board. Preheating conditions are shown in Table 2. It is required to keep temperature differential between the soldering and the components surface ( $\Delta T$ ) as small as possible.
- When components are immersed in solvent after mounting, be sure to maintain the temperature difference between the component and solvent within the range shown in Table 2. Do not apply flow soldering to chips not listed in Table 2.

Table 2

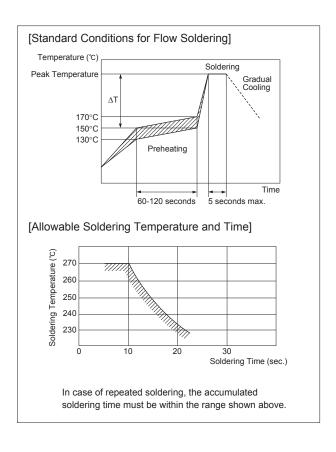
Part Number	Temperature Differential
G□□18/21/31	ΔT≦150°C

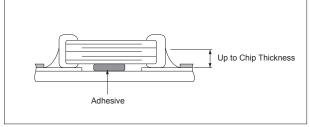
#### **Recommended Conditions**

	Pb-Sn Solder	Lead Free Solder
Peak Temperature	240-250°C	250-260°C
Atmosphere	Air	N <sub>2</sub>

Ph-Sn Solder: Sn-37Ph Lead Free Solder: Sn-3.0Ag-0.5Cu

 Optimum Solder Amount for Flow Soldering The top of the solder fillet should be lower than the thickness of components. If the solder amount is excessively big, the risk of cracking is higher during board bending or under any other stressful conditions.







## **1**Caution

- Continued from the preceding page.
- 6. Correction with a Soldering Iron
- (1) For Chip Type Capacitors
- When sudden heat is applied to the components by soldering iron, the mechanical strength of the components should go down because remarkable temperature change causes deformity of components inside. In order to prevent mechanical damage in the components, preheating should be required for both of the components and the PCB board. Preheating conditions are shown in Table 3. It is required to keep temperature differential between the soldering and the components surface ( $\Delta T$ ) as small as possible. After soldering, it should not be allowed to cool down rapidly.

Table 3

Part Number	Temperature Differential	Peak Temperature	Atmosphere
G□□18/21/31	ΔT≦190℃	300°C max. 3 sec. max. / termination (both sides total 6 sec. max.)	Air
G□□32/42/43/ 52/55	ΔT≦130°C	270°C max. 3 sec. max. / termination (both sides total 6 sec. max.)	Air

<sup>\*</sup>Applicable for both Pb-Sn and Lead Free Solder.

Pb-Sn Solder: Sn-37Pb

Lead Free Solder: Sn-3.0Ag-0.5Cu

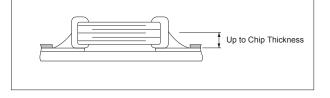
 Optimum Solder Amount when Corrections Are Made Using a Soldering Iron

The top of the solder fillet should be lower than the thickness of components. If the solder amount is excessively big, the risk of cracking is higher during board bending or under any other stressful conditions. Soldering iron ø3mm or smaller should be required. And it is necessary to keep a distance between the soldering iron and the components without direct touch. Thread solder with Ø0.5mm or smaller is required for soldering.



Excessive output of ultrasonic oscillation during cleaning causes PCBs to resonate, resulting in cracked chips or broken solder. Take note not to vibrate PCBs.

FAILURE TO FOLLOW THE ABOVE CAUTIONS MAY RESULT, WORST CASE, IN A SHORT CIRCUIT AND FUMING WHEN THE PRODUCT IS USED.

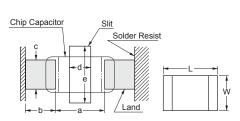


## **Notice**

#### ■ Notice (Soldering and Mounting)

1. Construction of Board Pattern After installing chips, if solder is excessively applied to the circuit board, mechanical stress will cause destruction resistance characteristics to lower. To prevent this, be extremely careful in determining shape and dimension before designing the circuit board diagram.

### Construction and Dimensions of Pattern (Example)



Preparing slit helps flux cleaning and resin coating on the back of the capacitor.

### Flow Soldering

L×W	а	b	С
1.6×0.8	0.6-1.0	0.8-0.9	0.6-0.8
2.0×1.25	1.0-1.2	0.9-1.0	0.8-1.1
3.2×1.6	2.2-2.6	1.0-1.1	1.0-1.4

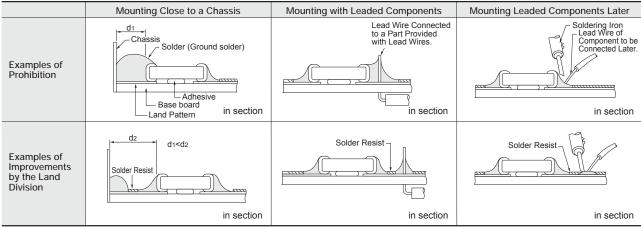
Flow soldering : 3.2×1.6 or less available.

#### Reflow Soldering

L×W	a	b	С	d	е
1.6×0.8	0.6-0.8	0.6-0.7	0.6-0.8	-	-
2.0×1.25	1.0-1.2	0.9-1.0	0.8-1.1	-	-
3.2×1.6	2.2-2.4	0.8-0.9	1.0-1.4	1.0-2.0	3.2-3.7
3.2×2.5	2.0-2.4	1.0-1.2	1.8-2.3	1.0-2.0	4.1-4.6
4.5×2.0	2.8-3.4	1.2-1.4	1.4-1.8	1.0-2.8	3.6-4.1
4.5×3.2	2.8-3.4	1.2-1.4	2.3-3.0	1.0-2.8	4.8-5.3
5.7×2.8	4.0-4.6	1.4-1.6	2.1-2.6	1.0-4.0	4.4-4.9
5.7×5.0	4.0-4.6	1.4-1.6	3.5-4.8	1.0-4.0	6.6-7.1

(in mm)

### Land Layout to Prevent Excessive Solder







### **Notice**

Continued from the preceding page.

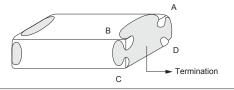
- 2. Mounting of Chips
- Thickness of adhesives applied Keep thickness of adhesives applied (50-105μm or more) to reinforce the adhesive contact considering the thickness of the termination or capacitor (20-70µm) and the land pattern (30-35µm).
- Mechanical shock of the chip placer When the positioning claws and pick-up nozzle are worn, the load is applied to the chip while positioning is concentrated in one position, thus causing cracks, breakage, faulty positioning accuracy, etc. Careful checking and maintenance are necessary to prevent unexpected trouble. An excessively low bottom dead point of the suction nozzle imposes great force on the chip during mounting, causing cracked chips. Please set the suction nozzle's bottom dead point on the upper surface of the board.

#### 3. Soldering

(1) Limit of losing effective area of the terminations and conditions needed for soldering.

Depending on the conditions of the soldering temperature and/or immersion (melting time), effective areas may be lost in some part of the terminations.

To prevent this, be careful in soldering so that any possible loss of the effective area on the terminations will securely remain at a maximum of 25% on all edge length A-B-C-D-A of part with A, B, C, D, shown in the Figure below.



 Please use it after confirming there is no problem in the reliability of the product beforehand with the intended equipment. The residue of flux might cause a decrease in nonconductivity and the corrosion of an external electrode, etc.



**Notice** 

Continued from the preceding page.

#### 4. Cleaning

Please confirm there is no problem in the reliability of the product beforehand when cleaning it with the intended

The residue after cleaning it might cause the decrease in the surface resistance of the chip and the corrosion of the electrode part, etc. As a result it might cause reliability to deteriorate. Please confirm beforehand that there is no problem with the intended equipment in ultrasonic cleansing.

#### 5. Resin Coating

Please use it after confirming there is no influence on the product with a intended equipment beforehand when the resin coating and molding.

A cracked chip might be caused at the cooling/heating cycle by the amount of resin spreading and/or bias

The resin for coating and molding must be selected as the stress is small when stiffening and the hygroscopic is low as possible.

#### Rating

- 1. Capacitance change of capacitor
- (1) In case of X7R char.

Capacitors have an aging characteristic, whereby the capacitor continually decreases its capacitance slightly if the capacitor is left on for a long time. Moreover, capacitance might change greatly depending on the surrounding temperature or an applied voltage. So, it is not likely to be suitable for use in a time constant circuit. Please contact us if you need detailed information.

(2) In case of any char. except X7R Capacitance might change a little depending on the surrounding temperature or an applied voltage. Please contact us if you intend to use this product in a strict time constant circuit.

2. Performance check by equipment

Before using a capacitor, check that there is no problem in the equipment's performance and the specifications.

Generally speaking, CLASS 2 (X7R char.) ceramic capacitors have voltage dependence characteristics and temperature dependence characteristics in capacitance. So, the capacitance value may change depending on the operating condition in the equipment. Therefore, be sure to confirm the apparatus performance of receiving influence in a capacitance value change of a capacitor, such as leakage current and noise suppression characteristics. Moreover, check the surge-proof ability of a capacitor in the equipment, if needed, because the surge voltage may exceed specific value by the inductance of the circuit.



## ISO 9001 Certifications

#### ■ Qualified Standards

The products listed here have been produced by ISO 9001 certified factory.

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Izumo Murata Mfg. Co. I td
izumo Murata Mig. Co., Etu.
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Murata Electronics Singapore (Pte.) Ltd.
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sales representatives or product engineers before ordering.

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- 9 Data-processing equipment
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